National Accreditation Board for Testing and Calibration Laboratories

SCOPE OF ACCREDITATION

Laboratory Name : UL INDIA LAB, UL INDIA PRIVATE LIMITED, LABORATORY BUILDING, KALYANI PLATINA CAMPUS, SY.NO.129/4, EPIP ZONE, PHASE II, WHITEFIELD, BENGALURU URBAN, BENGALURU, KARNATAKA, INDIA

Accreditation Standard ISO/IEC 17025:2017

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Validity 05/08/2021 to 04/08/2023 **Last Amended on** 13/01/2023

S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
LOCATION 1-LABORATORY BUILDING, KALYANI PLATINA CAMPUS, SY.NO.129/4, EPIP ZONE, PHASE II, WHITEFIELD, BENGALURU URBAN, BENGALURU, KARNATAKA, INDIA Permanent Facility				
1	ELECTRICAL- CELLS & BATTERIES	Secondary cells & Batteries Lithium Ion cells & batteries, Ni-MH cells & batteries	T2 : Thermal Test	UN 38.3 Clause. 4.2
2	ELECTRICAL- CELLS & BATTERIES	Secondary cells & Batteries Lithium Ion cells & batteries, Ni-MH cells & batteries	T3 : Vibration	UN 38.3 Clause. 4.3
3	ELECTRICAL- CELLS & BATTERIES	Secondary cells & Batteries Lithium Ion cells & batteries, Ni-MH cells & batteries	Transport Tests	UN38.3 (6th Edition), 2015
4	ELECTRICAL- SAFETY TESTING FACILITY	Electronic Equipment – Digital millimeter, digital power meter, clamp meter, digital ammeter, Digital voltmeter, Digital panel power meter.	Current measuring circuits	IEC 61010-2-030, Clause 101.2
5	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Dielectric voltage withstand Test	IEC 61010-1:2010+AMD1, Clause: 6.8.3
6	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Drop Test	IEC 61010-1:2010+AMD1, Clause 8.3.
7	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Durability of Marking	IEC 61010-1:2010+AMD1, Clause 5.3.
8	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Durability of Marking	UL 61010-1:2012 (3rd edition) Issued: 05/11/2012, Revised: 07/19/2019, Edition: 3, Clause 5.3.
9	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Humidity preconditioning	IEC 61010-1:2010+AMD1, Clause: 6.8.2,
10	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Humidity preconditioning	UL 61010-1:2012 (3rd edition) Issued: 05/11/2012, Revised: 07/19/2019, Edition: 3, Clause: 6.8.2
11	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Impact Test	IEC 61010-1:2010+AMD1, Clause 8.2.2
12	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Impedance of PROTECTIVE BONDING of plug-connected equipment	IEC 61010-1:2010+AMD1, Clause: 6.5.2.4
13	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Impedance of PROTECTIVE BONDING of plug-connected equipment	UL 61010-1:2012 (3rd edition) Issued: 05/11/2012, Revised: 07/19/2019, Edition: 3, Clause: 6.5.2.4
14	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Insulation between circuits and parts	UL 61010-1:2012 (3rd edition) Issued: 05/11/2012, Revised: 07/19/2019, Edition: 3, Clause: 4.4.2.12

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15	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Insulation between circuits and parts	IEC 61010-1:2010+AMD1, Clause: 4.4.2.12
16	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Limit values for ACCESSIBLE parts	IEC 61010-1:2010+AMD1, Clause: 6.3
17	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Limit values for ACCESSIBLE parts	UL 61010-1:2012 (3rd edition) Issued: 05/11/2012, Revised: 07/19/2019, Edition: 3, Clause: 6.3
18	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Limited Energy Circuit	IEC 61010-1:2010+AMD1, Clause 9.4
19	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Main supply	IEC 61010-1:2010+AMD1, Clause: 5.1.3
20	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Main supply	UL 61010-1:2012 (3rd edition) Issued: 05/11/2012, Revised: 07/19/2019, Edition: 3, Clause: 5.1.3
21	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Output abnormal Test	IEC 61010-1:2010+AMD1, Clause: 4.4.2.8
22	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Output abnormal Test	UL 61010-1:2012 (3rd edition) Issued: 05/11/2012, Revised: 07/19/2019, Edition: 3, Clause: 4.4.2.8
23	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Protective impedance Test	IEC 61010-1:2010+AMD1, Clause: 4.4.2.2
24	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Protective impedance Test	UL 61010-1:2012 (3rd edition) Issued: 05/11/2012, Revised: 07/19/2019, Edition: 3, Clause: 4.4.2.2
25	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Provisions for lifting and carrying (handel and grips)	IEC 61010-1:2010+AMD1, Clause: 7.5
26	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Provisions for lifting and carrying (handel and grips)	UL 61010-1:2012 (3rd edition) Issued: 05/11/2012, Revised: 07/19/2019, Edition: 3, Clause: 7.5
27	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Resistance To Heat	IEC 61010-1:2010+AMD1, Clause 10.5
28	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Stability Test	IEC 61010-1:2010+AMD1, Clause 7.4
29	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Static test (rigidity)	IEC 61010-1:2010+AMD1, Clause: 8.2.1

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30	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Static test (rigidity)	UL 61010-1:2012 (3rd edition) Issued: 05/11/2012, Revised: 07/19/2019, Edition: 3, Clause: 8.2.1
31	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Temperature Test	IEC 61010-1:2010+AMD1, Clause: 10.1 to 10.4
32	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Temperature Test	UL 61010-1:2012 (3rd edition) Issued: 05/11/2012, Revised: 07/19/2019, Edition: 3, Clause: 10.1 to 10.4,
33	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Transformer overload Test	IEC 61010-1:2010+AMD1, Clause: 4.4.2.7.3
34	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Transformer overload Test	UL 61010-1:2012 (3rd edition) Issued: 05/11/2012, Revised: 07/19/2019, Edition: 3, Clause: 4.4.2.7.3
35	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Transformer short circuit Test	UL 61010-1:2012 (3rd edition) Issued: 05/11/2012, Revised: 07/19/2019, Edition: 3, Clause: 4.4.2.7.2
36	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use	Wall Mounting Test	IEC 61010-1:2010+AMD1, Clause 7.6
37	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use –particular requirements for control equipment	Endurance test	IEC 61010-2-201, Clause 4.4.2.101.2
38	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use –particular requirements for control equipment	Endurance test	UL 61010-2-201 Issued: 05/14/2018, Edition: 2, "Clause 4.4.2.101.2
39	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use –particular requirements for control equipment	Impact test	IEC 61010-2-201, Clause 8.2.2
40	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use –particular requirements for control equipment	Impact test	UL 61010-2-201 Issued: 05/14/2018, Edition: 2", "Clause 8.2.2
41	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use –particular requirements for control equipment	Overload test	UL 61010-2-201 Issued: 05/14/2018, Edition: 2", "Clause 4.4.2.101-1,
42	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use –particular requirements for control equipment	Overload test	IEC 61010-2-201, Clause 4.4.2.101-1

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43	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use –particular requirements for control equipment	Over-range indication	IEC 61010-2-030, Clause 6.9.101
44	ELECTRICAL- SAFETY TESTING FACILITY	Safety requirements for electrical equipment for measurement, control, and laboratory use –particular requirements for control equipment	Over-range indication	UL 61010-2-030 Issued: 05/14/2018, Edition: 2, "Clause 6.9.101
45	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	"Contactors and motor-starters – Electromechanical contactors and motor-starters"	Verification of rated making and breaking capacities, Change-over ability and reversibility where applicable Overload test	IS/IEC 60947-4-1, Clause: 9.3.3.5
46	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	"Control circuit devices and switching elements – Electromechanical control circuit devices"	Degree of protection of enclosed control circuit devices	IEC 60947-5-1, Annex C
47	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	"Control circuit devices and switching elements – Electromechanical control circuit devices"	Degree of protection of enclosed control circuit devices	IEC 60947-1:2007/AMD2, Annex C
48	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Ancillary equipment - Protective conductor terminal blocks for copper conductors	Ageing test (for screwless-type terminal blocks only)	IEC 60947-7-2, Clause: 8.4.7
49	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Ancillary equipment - Protective conductor terminal blocks for copper conductors	Dielectric Tests	IEC 60947-7-2, Clause. 7.2.2, 8.4.3
50	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Ancillary equipment - Protective conductor terminal blocks for copper conductors	Short-time withstand current	IEC 60947-7-2, Clause. 7.2.3, 8.4.6
51	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Ancillary equipment - Protective conductor terminal blocks for copper conductors	Temperature rise	IEC 60947-7-2, Clause. 7.2.1, 8.4.5
52	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Ancillary equipment - Protective conductor terminal blocks for copper conductors	Verification of mechanical characteristics	IEC 60947-7-2, Clause. 8.3
53	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Ancillary equipment - Protective conductor terminal blocks for copper conductors	Verification of Voltage Drop	IEC 60947-7-2, Clause. 7.2.4, 8.4.4
54	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Ancillary equipment – Safety requirements for fuse terminal blocks	Mechanical properties of clamping units of a fuse terminal block	IEC 60947-7-3, Clause. 8.3.3
55	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Ancillary equipment – Safety requirements for fuse terminal blocks	Verification of mechanical Characteristics	IEC 60947-7-3, Clause. 8.3

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56	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Ancillary equipment – Safety requirements for fuse terminal blocks	Mechanical properties of clamping units of a fuse terminal block	IEC 60947-7-3, Clause. 8.3.3
57	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Ancillary equipment – Terminal blocks for copper conductors	Aging test (for screwless- type terminal blocks only)	IEC 60947-7-1, Clause 8.4.7
58	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Ancillary equipment – Terminal blocks for copper conductors	Dielectric Tests	IEC 60947-7-1, Clause. 8.4.3
59	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Ancillary equipment – Terminal blocks for copper conductors	Mechanical properties of clamping units	IEC 60947-7-1, Clause. 8.3.3
60	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Ancillary equipment – Terminal blocks for copper conductors	Short-time withstand current test	IEC 60947-7-1, Clause. 7.2.3, 8.4.6
61	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Ancillary equipment – Terminal blocks for copper conductors	Temperature rise	IEC 60947-7-1, Clause. 7.2.1, 8.4.5
62	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Ancillary equipment – Terminal blocks for copper conductors	Verification of creepage and clearances	IEC 60947-7-1, Clause. 8.4.2
63	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Ancillary equipment – Terminal blocks for copper conductors	Verification of thermal characteristcs	IEC 60947-7-1, Clause. 8.5
64	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Ancillary equipment – Terminal blocks for copper conductors	Verification of Voltage drop	IEC 60947-7-1, Clause. 7.2.4, 8.4.4
65	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Clearance and creepage distances	EN 60947-2:2017, EN 60947-2:2017/A1, Clause: 7.1.4
66	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Clearance and creepage distances	IEC 60947-2: 2016 + AMD1, Clause: 7.1.4
67	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Clearance and creepage distances	IS/IEC 60947-2, Clause: 7.1.4
68	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Dielectric properties	IEC 60947-2: 2016 + AMD1, Clause: 8.3.3.3
69	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Dielectric properties	EN 60947-2:2017/A1, Clause: 8.3.3.3

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70	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Dielectric properties	IS/IEC 60947-2, Clause: 8.3.3.3
71	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Individual pole short-circuit breaking capacity (Isu)	EN 60947-2:2017/A1, Annex C, C.2
72	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Individual pole short-circuit breaking capacity (Isu)	IEC 60947-2: 2016 + AMD1, Annex C, C.2
73	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Individual pole short-circuit breaking capacity (Isu)	IS/IEC 60947-2, Annex C, C.2
74	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Individual pole short-circuit test (IIT)	EN 60947-2:2017/A1, Annex H, H.2
75	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Individual pole short-circuit test (IIT)	IEC 60947-2: 2016 + AMD1, Annex H, H.2
76	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Individual pole short-circuit test (IIT)	IS/IEC 60947-2, Annex H, H.2
77	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Mechanical operation and operational performance capability	EN 60947-2:2017/A1, Clause: 8.3.3.4
78	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Mechanical operation and operational performance capability	IEC 60947-2: 2016 + AMD1, Clause: 8.3.3.4
79	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Mechanical operation and operational performance capability	IS/IEC 60947-2, Clause: 8.3.3.4
80	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Overload performance (where applicable)	IEC 60947-2: 2016 + AMD1, Clause: 8.3.3.5
81	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Overload performance (where applicable)	IS/IEC 60947-2, Clause: 8.3.3.5
82	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Overload performance (where applicable)	EN 60947-2:2017/A1, Clause: 8.3.3.5
83	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Rated service short-circuit breaking capacity	EN 60947-2:2017/A1, Clause: 8.3.4.2,8.3.8.4

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84	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Rated service short-circuit breaking capacity	IEC 60947-2: 2016 + AMD1, Clause: 8.3.4.2, 8.3.8.4
85	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Rated service short-circuit breaking capacity	IS/IEC 60947-2, Clause: 8.3.4.2, 8.3.8.4
86	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Rated short-time withstand current	EN 60947-2:2017/A1, Clause: 8.3.6.3, 8.3.8.3
87	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Rated short-time withstand current	IEC 60947-2: 2016 + AMD1, Clause: 8.3.6.3, 8.3.8.3
88	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Rated short-time withstand current	IS/IEC 60947-2, Clause: 8.3.6.3, 8.3.8.3
89	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Rated ultimate short circuit breaking capacity	EN 60947-2:2017/A1, Clause: 8.3.5.3
90	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Rated ultimate short circuit breaking capacity	IEC 60947-2: 2016 + AMD1, Clause: 8.3.5.3
91	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Rated ultimate short circuit breaking capacity	IS/IEC 60947-2, Clause: 8.3.5.3
92	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Short-circuit at 1,1 times take-over current	EN 60947-2:2017/A1, Clause: 8.3.7.6
93	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Short-circuit at 1,1 times take-over current	IEC 60947-2: 2016 + AMD1, Clause: 8.3.7.6
94	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Short-circuit at 1,1 times take-over current	IS/IEC 60947-2, Clause: 8.3.7.6
95	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Short-circuit at the selectivity limit current	EN 60947-2:2017/A1, Clause: 8.3.7.2
96	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Short-circuit at the selectivity limit current	IEC 60947-2: 2016 + AMD1, Clause: 8.3.7.2
97	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Short-circuit at the selectivity limit current	IS/IEC 60947-2, Clause: 8.3.7.2

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98	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Short-circuit at ultimate short-circuit breaking capacity	EN 60947-2:2017/A1, Clause: 8.3.7.7
99	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Short-circuit at ultimate short-circuit breaking capacity	IEC 60947-2: 2016 + AMD1, Clause: 8.3.7.7
100	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Short-circuit at ultimate short-circuit breaking capacity	IS/IEC 60947-2, Clause: 8.3.7.7
101	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Short-circuit breaking capacity at maximum short-time withstand current	EN 60947-2:2017/A1, Clause: 8.3.6.5
102	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Short-circuit breaking capacity at maximum short-time withstand current	IEC 60947-2: 2016 + AMD1, Clause: 8.3.6.5
103	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Short-circuit breaking capacity at maximum short-time withstand current	IS/IEC 60947-2, Clause: 8.3.6.5
104	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Tripping limits and characteristics	EN 60947-2:2017/A1, Clause: 8.3.3.2
105	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Tripping limits and characteristics	IEC 60947-2: 2016 + AMD1, Clause: 8.3.3.2
106	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Tripping limits and characteristics	IS/IEC 60947-2, Clause: 8.3.3.2
107	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Verification of dielectric withstand	EN 60947-2:2017/A1, Clause: 8.3.3.6, 8.3.4.4, 8.3.5.4, 8.3.6.6, 8.3.7.4, 8.3.7.8, 8.3.8.6, C.3, H.3
108	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Verification of dielectric withstand	IEC 60947-2: 2016 + AMD1, Clause: 8.3.3.7, 8.3.4.5, 8.3.6.4, 8.3.7.3, 8.3.8.7,
109	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Verification of dielectric withstand	IS/IEC 60947-2, Clause: 8.3.3.7, 8.3.4.5, 8.3.6.4, 8.3.7.3, 8.3.8.7,
110	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Verification of main contact position (for circuit breakers suitable for isolation)	IEC 60947-2: 2016 + AMD1, Clause: 8.3.3.10

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111	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Verification of main contact position (for circuit breakers suitable for isolation)	EN 60947-2:2017/A1, Clause: 8.3.3.10
112	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Verification of main contact position (for circuit breakers suitable for isolation)	IS/IEC 60947-2, Clause: 8.3.3.10
113	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Verification of Operational performance capability	EN 60947-2:2017/A1, Clause: 8.3.4.3, 8.3.8.5
114	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Verification of Operational performance capability	IEC 60947-2: 2016 + AMD1, Clause: 8.3.4.3, 8.3.8.5
115	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Verification of Operational performance capability	IS/IEC 60947-2, Clause: 8.3.4.3, 8.3.8.5
116	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Verification of overload releases	EN 60947-2:2017/A1, Clause: 8.3.3.8, 8.3.4.6, 8.3.5.2, 8.3.5.5, 8.3.6.2, 8.3.6.7, 8.3.7.5, 8.3.7.9, 8.3.8.2, 8.3.8.8, C.4, H.4
117	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Verification of overload releases	IEC 60947-2: 2016 + AMD1, Clause: 8.3.3.8, 8.3.4.6, 8.3.5.2, 8.3.5.5, 8.3.6.2,8.3.6.7, 8.3.7.5, 8.3.7.9, 8.3.8.2, 8.3.8.8, C.4, H.4
118	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Verification of overload releases	IS/IEC 60947-2, Clause: 8.3.3.8, 8.3.4.6, 8.3.5.2, 8.3.5.5, 8.3.6.2, 8.3.6.7, 8.3.7.5, 8.3.7.9, 8.3.8.2, 8.3.8.8, C.4, H.4
119	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Verification of temperature-rise	EN 60947-2:2017/A1, Clause: 8.3.3.7, 8.3.4.5, 8.3.6.4, 8.3.7.3, 8.3.8.7
120	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Verification of temperature-rise	IEC 60947-2: 2016 + AMD1, Clause: 8.3.3.7, 8.3.4.5, 8.3.6.4, 8.3.7.3, 8.3.8.7
121	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Verification of temperature-rise	IS/IEC 60947-2, Clause: 8.3.3.7, 8.3.4.5, 8.3.6.4, 8.3.7.3, 8.3.8.7
122	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Verification of under voltage and shunt releases (if applicable)	EN 60947-2:2017/A1, Clause: 8.3.3.9

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123	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Verification of under voltage and shunt releases (if applicable)	IEC 60947-2: 2016 + AMD1, Clause: 8.3.3.9
124	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Circuit-breakers	Verification of under voltage and shunt releases (if applicable)	IS/IEC 60947-2, Clause: 8.3.3.9
125	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	Glow wire test	EN 60947-4-1:2010/A1, Clause: 8.1.2.2
126	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	Glow wire test	IEC 60947-4-1, Clause: 8.1.2.2
127	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	Glow wire test	IS/IEC 60947-4-1, Clause: 8.1.2.2
128	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	performance under short-circuit conditions	EN 60947-4-1:2010/A1, Clause: 9.3.4
129	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	performance under short-circuit conditions	IEC 60947-4-1, Clause: 9.3.4
130	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	performance under short-circuit conditions	IS/IEC 60947-4-1, Clause: 9.3.4
131	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	verification of ability to withstand overload currents	EN 60947-4-1:2010/A1, Clause: 9.3.5
132	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	verification of ability to withstand overload currents	IEC 60947-4-1, Clause: 9.3.5
133	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	verification of ability to withstand overload currents	IS/IEC 60947-4-1, Clause: 9.3.5
134	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	verification of conventional operational performance	EN 60947-4-1:2010/A1, Clause: 9.3.3.6
135	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	verification of conventional operational performance	IEC 60947-4-1, Clause: 9.3.3.6
136	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	verification of conventional operational performance	IS/IEC 60947-4-1, Clause: 9.3.3.6

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137	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	verification of degrees of protection of enclosed contactors and starters	EN 60947-4-1:2010/A1:2012, Clause: 9.2.2 and 9.2.3
138	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	verification of degrees of protection of enclosed contactors and starters	IEC 60947-4-1, Clause: 9.2.2 and 9.2.3
139	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	verification of degrees of protection of enclosed contactors and starters	IS/IEC 60947-4-1 :2012, Clause: 9.2.2 and 9.2.3
140	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	Verification of dielectric properties	EN 60947-4-1:2010/A1, Clause: 9.3.3.4
141	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	Verification of dielectric properties	IEC 60947-4-1, Clause: 9.3.3.4
142	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	Verification of dielectric properties	IS/IEC 60947-4-1, Clause: 9.3.3.4
143	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	verification of mechanical properties of terminals	EN 60947-4-1:2010/A1:2012, Clause 8.2.4 of 60947-1-2007
144	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	verification of mechanical properties of terminals	IEC 60947-4-1, Clause: 9.2.2 and 9.2.3
145	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	verification of mechanical properties of terminals	IS/IEC 60947-4-1 :2012 Clause 8.2.4 of 60947-1, Clause: 9.2.2 and 9.2.3
146	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	Verification of operation and operating limits	EN 60947-4-1:2010/A1, Clause: 9.3.3.1, 9.3.3.2
147	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	Verification of operation and operating limits	IEC 60947-4-1, Clause: 9.3.3.1, 9.3.3.2
148	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	Verification of operation and operating limits	IS/IEC 60947-4-1, Clause: 9.3.3.1, 9.3.3.2
149	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	Verification of rated making and breaking capacities, Change-over ability and reversibility where applicable Overload test	EN 60947-4-1:2010/A1, Clause: 9.3.3.5

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150	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	Verification of rated making and breaking capacities, Change-over ability and reversibility where applicable Overload test	IEC 60947-4-1, Clause: 9.3.3.5
151	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	Verification of temperature rise	EN 60947-4-1:2010/A1, Clause: 9.3.3.3
152	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	Verification of temperature rise	IEC 60947-4-1, Clause: 9.3.3.3
153	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	Verification of temperature rise	IS/IEC 60947-4-1, Clause: 9.3.3.3
154	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	verification of degrees of protection of enclosed contactors and starters	IEC 60947-1:2007/AMD1, Annex C
155	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	verification of degrees of protection of enclosed contactors and starters	IEC 60947-1:2007/AMD1:2010, Annex C
156	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	verification of degrees of protection of enclosed contactors and starters	IEC 60947-1-2007, Clause 8.2.4
157	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	verification of mechanical properties of terminals	IEC 60947-1:2007/AMD1:2010
158	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	verification of mechanical properties of terminals	IEC 60947-1:2007/AMD2, Clause: 9.2.2 and 9.2.3:
159	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Contactors and motor-starters – Electromechanical contactors and motor-starters	verification of mechanical properties of terminals	IEC 60947-1-2007, AMD1:2010, AMD2, Clause 8.2.4
160	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Degree of protection of enclosed control circuit devices	EN 60947-5-1, Annex C
161	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Dielectric verification	EN 60947-5-1, Clause: 8.3.3.5.6 b)
162	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Dielectric verification	IEC 60947-5-1, Clause:8.3.3.5.6 b)

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163	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Dielectric verification	IS/IEC 60947-5-1, Clause: 8.3.3.5.5 b)
164	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Glow-wire test (on equipment)	EN 60947-5-1, Clause:8.2.1.1.1
165	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Glow-wire test (on equipment)	IEC 60947-5-1, Clause:8.2.1.1.1
166	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Making and breaking capacities of switching elements under abnormal conditions	EN 60947-5-1, Clause: 8.3.3.5.4
167	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Making and breaking capacities of switching elements under abnormal conditions	IEC 60947-5-1, Clause:8.3.3.5.4
168	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Making and breaking capacities of switching elements under abnormal conditions	IS/IEC 60947-5-1, Clause: 8.3.3.5.3
169	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Measurement of clearances and creepage distances	EN 60947-5-1
170	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Measurement of clearances and creepage distances	IEC 60947-5-1, Clause 7.1.4
171	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Measurement of clearances and creepage distances	IS/IEC 60947-5-1, Clause: 7.1.3
172	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Mechanical and electrical properties of terminals	EN 60947-5-1, Clause:8.2.4
173	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Mechanical and electrical properties of terminals	IEC 60947-5-1, Clause:8.2.4
174	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Mechanical and electrical properties of terminals	IS/IEC 60947-5-1, Clause:8.2.4
175	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Operating limits of contactor relays	EN 60947-5-1, Clause:8.3.3.2
176	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Operating limits of contactor relays	IEC 60947-5-1, Clause:8.3.3.2

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177	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Operating limits of contactor relays	IS/IEC 60947-5-1, Clause:8.3.3.2
178	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Performance under conditional short-circuit current	EN 60947-5-1, Clause: 8.3.4
179	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Performance under conditional short-circuit current	IEC 60947-5-1, Clause:8.3.4
180	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Performance under conditional short-circuit current	IS/IEC 60947-5-1, Clause: 8.3.4
181	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Temperature rise	EN 60947-5-1, Clause:8.3.3.3
182	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Temperature rise	IEC 60947-5-1, Clause:8.3.3.3
183	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Temperature rise	IS/IEC 60947-5-1, Clause:8.3.3.3
184	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of actuation force or moment	EN 60947-5-1, Clause:8.2.5
185	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of actuation force or moment	IEC 60947-5-1, Clause:8.2.5
186	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of actuation force or moment	IS/IEC 60947-5-1, Clause:8.2.5
187	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of dielectric properties	EN 60947-5-1, Clause:8.3.3.4
188	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of dielectric properties	IEC 60947-5-1, Clause:8.3.3.4
189	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of dielectric properties	IS/IEC 60947-5-1, Clause:8.3.3.4
190	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of limitation of rotation of a rotary switch	EN 60947-5-1, Annex K

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191	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of limitation of rotation of a rotary switch	EN 60947-5-1, Clause:8.2.6
192	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of limitation of rotation of a rotary switch	IEC 60947-5-1, Annex K
193	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of limitation of rotation of a rotary switch	IEC 60947-5-1, Clause:8.2.6
194	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of limitation of rotation of a rotary switch	IS/IEC 60947-5-1, Annex K
195	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of limitation of rotation of a rotary switch	IS/IEC 60947-5-1, Clause:8.2.6
196	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of rated making and breaking capacities under normal conditions	EN 60947-5-1, Clause: 8.3.3.5.3
197	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of rated making and breaking capacities under normal conditions	IEC 60947-5-1, Clause: 8.3.3.5.3
198	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of rated making and breaking capacities under normal conditions	IS/IEC 60947-5-1, Clause: 8.3.3.5.2
199	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Degree of protection of enclosed control circuit devices	IEC 60947-1:2007/AMD2, Annex C
200	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Measurement of clearances and creepage distances	IEC 60947-1:2007/AMD2, Clause 7.1.4
201	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of direct opening action	IEC 60947-5-1, Annex K - K.8.3.6
202	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of direct opening action	IEC 60947-5-5, Clause 5.2:1997+AMD1:2005 +AMD2
203	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of direct opening action	IS/IEC 60947-5-5, Clause 5.2
204	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of mechanical operation of position switches at limits of temperature	IEC 60947-5-1, Annex K - K.8.3.5

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205	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of mechanical operation of position switches at limits of temperature	IEC 60947-5-5, Clause 5.2:1997+AMD1:2005 +AMD2:
206	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of mechanical operation of position switches at limits of temperature	IS/IEC 60947-5-5, Clause 5.2
207	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of robustness of the actuating system	IEC 60947-5-1, Annex K - K.8.3.7
208	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of robustness of the actuating system	IEC 60947-5-5, Clause 5.2:1997+AMD1:2005 +AMD2
209	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Control circuit devices and switching elements – Electromechanical control circuit devices	Verification of robustness of the actuating system	IS/IEC 60947-5-5, Clause 5.2
210	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Conditioning procedures - Conditioning in a solution of 5 % NaCl test	IEC 60947-5-5, Clause 7.4 (IEC 60068-2-11):1997+AMD1:2005 +AMD2
211	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Conditioning procedures - Conditioning in a solution of 5 % NaCl test	IS/IEC 60947-5-5, Clause 7.4, (IEC 60068-2-11)
212	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Conditioning procedures - Dry atmosphere test (Test Bb)	IEC 60947-5-5, Clause 7.4 (IEC 60068-2-11):1997+AMD1:2005 +AMD2
213	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Conditioning procedures - Dry atmosphere test (Test Bb)	IS/IEC 60947-5-5, Clause 7.4, (IEC 60068-2-11)
214	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Conditioning procedures - Moist and cold atmosphere test (Test Ab)	IEC 60947-5-5, Clause 7.4 (IEC 60068-2-11):1997+AMD1:2005 +AMD2
215	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Conditioning procedures - Moist and cold atmosphere test (Test Ab)	IS/IEC 60947-5-5, Clause 7.4, (IEC 60068-2-11)
216	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Conditioning procedures - Moist and Warm atmosphere test	IEC 60947-5-5, Clause 7.4 (IEC 60068-2-11):1997+AMD1:2005 +AMD2
217	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Conditioning procedures - Moist and Warm atmosphere test	IS/IEC 60947-5-5, Clause 7.4, (IEC 60068-2-11)
218	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Durability test	IEC 60947-5-1, Clause 8.3.2.1 a)

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219	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Durability test	IEC 60947-5-5, Clause 7.3.3:1997+AMD1:2005 +AMD2
220	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Durability test	IS/IEC 60947-5-5, Clause 7.3.3
221	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Electrical requirements - Degree of protection of enclosed control circuit devices	IEC 60947-1, Annex C:2007/AMD2
222	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Electrical requirements - Utilization Categories selection, Verification of direct opening action, The degree of protection (IP tests), Making and breaking capacities of switching elements under normal conditions, Making and breaking capacities of switching elements under abnormal conditions, Electrical durability test	IEC 60947-5-5, Clause 5.1, 5.2, 5.3, 5.4, 5.5:1997+AMD1:2005 +AMD2
223	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Electrical requirements - Utilization Categories selection, Verification of direct opening action, The degree of protection (IP tests), Making and breaking capacities of switching elements under normal conditions, Making and breaking capacities of switching elements under abnormal conditions, Electrical durability test	IS/IEC 60947-5-5, Clause 5.1, 5.2, 5.3, 5.4, 5.5
224	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	General Design Inspection	IEC 60947-5-5, Clause 7.2:1997+AMD1:2005 +AMD2
225	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	General Design Inspection - verification by inspection of the mechanical structure of the emergency stop device, Check latching and resetting of the actuator manually, Verification by inspection of the fastening parts, and by pulling and turning the button and other parts of the device by hand	IS/IEC 60947-5-5, Clause 7.2

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226	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Marking and Product Information	IEC 60947-5-5, Clause 4.1, 4.2, 4.3, 4.4, 7.2.1 :1997+AMD1:2005 +AMD2
227	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Marking and Product Information	IS/IEC 60947-5-5, Clause 4.1, 4.2, 4.3, 4.4, 7.2.1
228	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Miscellaneous tests - Disengagement of wire or rope test	IEC 60947-5-5, Clause 7.8,6.4.2:1997+AMD1:2005 +AMD2
229	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Miscellaneous tests - Disengagement of wire or rope test	IS/IEC 60947-5-5 , Clause 7.8, 6.4.2
230	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Opening , Latching, resetting and impact tests	IEC 60947-5-1: K.8.3.4.4.1
231	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Opening , Latching, resetting and impact tests	IEC 60947-5-5, Clause 7.7.1, 7.7.2, 7.7.3, 7.7.4 & 7.7.5:1997+AMD1:2005 +AMD2
232	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Opening , Latching, resetting and impact tests	IS/IEC 60947-5-5, Clause 7.7.1, 7.7.2, 7.7.3, 7.7.4 & 7.7.5
233	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Procedure to determine reliability data for electrical emergency stop devices used in functional safety applications	IEC 60947-1:2007/AMD2
234	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Procedure to determine reliability data for electrical emergency stop devices used in functional safety applications	IEC 60947-5-5, Annex A (normative)::1997+AMD1:2005 +AMD2
235	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Procedure to determine reliability data for electrical emergency stop devices used in functional safety applications	IS/IEC 60947-5-5, Annex A (normative)
236	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Robustness of a button actuator	IEC 60947-5-5, Clause 7.3.2:1997+AMD1:2005 +AMD2
237	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Robustness of a button actuator	IS/IEC 60947-5-5, Clause 7.3.2

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238	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Shock Test	IEC 60947-5-5, Clause 7.5 (IEC 60068-2-27):1997+AMD1:2005 +AMD2
239	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Shock Test	IS/IEC 60947-5-5, Clause 7.5 (IEC 60068-2-27)
240	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Vibration Test	IEC 60947-5-5, Clause 7.6 (IEC 60068-2-6):1997+AMD1:2005 +AMD2
241	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Electrical emergency stop devices with mechanical latching function	Vibration Test	IS/IEC 60947-5-5, Clause 7.6 (IEC 60068-2-6)
242	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	"Enclosures for equipment degrees of protection of enclosed equipment Annex C "	EN 60947-1:2007/A1:2011/A2, Clause: 8.2.3
243	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	"Enclosures for equipment degrees of protection of enclosed equipment Annex C "	IEC 60947-1, Clause: 9.2.4
244	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	"Enclosures for equipment degrees of protection of enclosed equipment Annex C "	IEC 60947-1:2007 +AMD1:2010+AMD2:2014 CSV © IEC 2014, "Clause: 8.2.3
245	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	"Enclosures for equipment degrees of protection of enclosed equipment Annex C "	IS/IEC 60947-1, Clause: 8.2.3
246	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	"Verification of the effectiveness of indication of the main contact position of equipment suitable for isolation"	EN 60947-1:2007/A1:2011/A2, Clause: 8.2.5
247	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	"Verification of the effectiveness of indication of the main contact position of equipment suitable for isolation"	IEC 60947-1:2007 +AMD1:2010+AMD2:2014 CSV © IEC 2014, Clause: 8.2.5
248	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	"Verification of the effectiveness of indication of the main contact position of equipment suitable for isolation"	IEC 60947-1, Clause: 9.2.6

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249	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	"Verification of the effectiveness of indication of the main contact position of equipment suitable for isolation"	IS/IEC 60947-1 , Clause: 8.2.5
250	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	constructional requirements	EN 60947-1:2007/A1:2011/A2, Clause: 8.2
251	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	constructional requirements	IEC 60947-1, Clause: 8.1
252	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	constructional requirements	IEC 60947-1:2007 +AMD1:2010+AMD2:2014 CSV © IEC 2014, Clause:8.2
253	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	constructional requirements	IS/IEC 60947-1 , Clause:8.2
254	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Dielectric properties	EN 60947-1:2007/A1:2011/A2, Clause: 8.3.3.4
255	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Dielectric properties	IEC 60947-1:2007 +AMD1:2010+AMD2:2014 CSV © IEC 2014, "Clause:8.3.3.4
256	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Dielectric properties	IS/IEC 60947-1 , Clause:8.3.3.4
257	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Dielectric properties	IEC 60947-1, Clause: 8.2.3
258	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Glow wire testing	EN 60947-1:2007/A1:2011/A2, Clause: 8.2.1.1.1
259	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Glow wire testing	IEC 60947-1, Clause: 8.1.2.2
260	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Glow wire testing	IEC 60947-1:2007 +AMD1:2010+AMD2:2014 CSV © IEC 2014, , "Clause: 8.2.1.1.1
261	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Glow wire testing	IS/IEC 60947-1 , Clause: 8.2.1.1.1

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262	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Making and breaking capacities	IEC 60947-1, Clause: 9.3.3.5
263	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Making and breaking capacities	IEC 60947-1:2007 +AMD1:2010+AMD2:2014 CSV © IEC 2014, Clause:8.3.3.5
264	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Making and breaking capacities	EN 60947-1:2007/A1:2011/A2, Clause: 8.3.3.5
265	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Making and breaking capacities	IS/IEC 60947-1 , Clause:8.3.3.5
266	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Marking	EN 60947-1:2007/A1:2011/A2, Clause: 5.2
267	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Marking	IEC 60947-1, Clause: 6.2
268	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Marking	IEC 60947-1:2007 +AMD1:2010+AMD2:2014 CSV © IEC, Clause: 5.2
269	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Marking	IS/IEC 60947-1 , Clause:5.2
270	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Mechanical and electrical properties of terminals	EN 60947-1:2007/A1:2011/A2, Clause: 8.2.4
271	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Mechanical and electrical properties of terminals	IEC 60947-1:2007 +AMD1:2010+AMD2:2014 CSV © IEC 2014, Clause: 8.2.4
272	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Mechanical and electrical properties of terminals	IEC 60947-1, Clause: 9.2.5
273	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Mechanical and electrical properties of terminals	IS/IEC 60947-1 , Clause: 8.2.4
274	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Operating limits	EN 60947-1:2007/A1:2011/A2, Clause: 8.3.3.2
275	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Operating limits	IEC 60947-1, Clause: 9.2.3.2

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276	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Operating limits	IEC 60947-1:2007 +AMD1:2010+AMD2:2014 CSV © IEC 2014, Clause:8.3.3.2
277	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Operating limits	IS/IEC 60947-1 , Clause:8.3.3.2
278	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Operational performance	EN 60947-1:2007/A1:2011/A2, Clause:7.2.4.2, 8.3.3.6
279	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Operational performance	IEC 60947-1, Clause:8.2.4.2, 9.3.3.6
280	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Operational performance	IEC 60947-1:2007 +AMD1:2010+AMD2:2014 CSV © IEC 2014, "Clause:7.2.4.2, 8.3.3.6,
281	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Operational performance	IS/IEC 60947-1, Clause:7.2.4.2, 8.3.3.6
282	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Performance under short-circuit conditions	EN 60947-1:2007/A1:2011/A2, Clause: 8.3.4
283	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Performance under short-circuit conditions	IEC 60947-1:2007 +AMD1:2010+AMD2:2014 CSV © IEC 2014, Clause: 8.3.4
284	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Performance under short-circuit conditions	IEC 60947-1, Clause: 9.3.4
285	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Performance under short-circuit conditions	IS/IEC 60947-1 , Clause: 8.3.4
286	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Performance	IEC 60947-1:2007 +AMD1:2010+AMD2:2014 CSV © IEC 2014, Clause: 8.3
287	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Performance	EN 60947-1:2007/A1:2011/A2, Clause: 8.3
288	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Performance	IEC 60947-1, Clause: 9.3

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289	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Performance	IS/IEC 60947-1 , Clause: 8.3
290	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Short-circuit making and breaking capacities	EN 60947-1:2007/A1:2011/A2, Clause: 8.3.4.2
291	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Short-circuit making and breaking capacities	IEC 60947-1, Clause: 9.3.4.2
292	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Short-circuit making and breaking capacities	IEC 60947-1:2007 +AMD1:2010+AMD2:2014 CSV © IEC 2014, Clause:8.3.4.2
293	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Short-circuit making and breaking capacities	IS/IEC 60947-1 , Clause:8.3.4.2
294	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Temperature-rise	IEC 60947-1:2007 +AMD1:2010+AMD2:2014 CSV © IEC 2014, "Clause: 8.3.3.3
295	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Temperature-rise	EN 60947-1:2007/A1:2011/A2, Clause: 8.3.3.3
296	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Temperature-rise	IEC 60947-1, Clause: 8.2.2
297	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Low voltage switchgears and controlgear Equipments	Temperature-rise	IS/IEC 60947-1, Clause: 8.3.3.3
298	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Marking	IS/IEC 60898-1, Clause. 6
299	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	"Clearance and creepage distances (External parts only) Clearance and creepage distances (internal parts)"	EN 60898-1, Clause. 8.1.3
300	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	"Clearance and creepage distances (External parts only) Clearance and creepage distances (internal parts)"	IEC 60898-1:2015+AMD1, Clause. 8.1.3
301	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	"Clearance and creepage distances (External parts only) Clearance and creepage distances (internal parts)"	IS/IEC 60898-1, Clause. 8.1.3

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302	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	28 day test AC	EN 60898-1, Clause. 9.9
303	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	28 day test AC	IEC 60898-1:2015+AMD1, Clause. 9.9
304	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	28 day test AC	IS/IEC 60898-1, Clause. 9.9
305	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Dielectric strength of the main circuit	EN 60898-1, Clause 9.7.3
306	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Dielectric strength of the main circuit	IEC 60898-1:2015+AMD1, Clause 9.7.3
307	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Dielectric strength of the main circuit	IS/IEC 60898-1, Clause 9.7.3
308	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	General	EN 60898-1, Clause. 8.1.1
309	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	General	IEC 60898-1:2015+AMD1, Clause. 8.1.1,
310	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	General	IS/IEC 60898-1, Clause. 8.1.1
311	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Indelibility of marking	EN 60898-1, Clause 9.3
312	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Indelibility of marking	IEC 60898-1:2015+AMD1, Clause 9.3
313	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Indelibility of marking	IS/IEC 60898-1, Clause 9.3
314	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Insulation resistance and dielectric strength of auxiliary circuit	EN 60898-1, Clause 9.7.4
315	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Insulation resistance and dielectric strength of auxiliary circuit	IEC 60898-1:2015+AMD1, Clause 9.7.4

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316	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Insulation resistance and dielectric strength of auxiliary circuit	IS/IEC 60898-1, Clause 9.7.4
317	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Insulation resistance of the main circuit	EN 60898-1, Clause 9.7.2
318	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Insulation resistance of the main circuit	IEC 60898-1:2015+AMD1, Clause 9.7.2
319	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Insulation resistance of the main circuit	IS/IEC 60898-1, Clause 9.7.2,
320	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Marking	EN 60898-1, Clause. 6
321	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Marking	IEC 60898-1:2015+AMD1:2019, Clause. 6
322	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	mechanical and electrical endurance	EN 60898-1, Clause. 9.11
323	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	mechanical and electrical endurance	IEC 60898-1:2015+AMD1, Clause. 9.11
324	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	mechanical and electrical endurance	IS/IEC 60898-1, Clause. 9.11
325	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Mechanism	EN 60898-1, Clause. 8.1.2
326	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Mechanism	IEC 60898-1:2015+AMD1, Clause. 8.1.2
327	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Mechanism	IS/IEC 60898-1, Clause. 8.1.2
328	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Non-interchangeability	EN 60898-1, Clause. 8.1.6
329	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Non-interchangeability	IEC 60898-1:2015+AMD1, Clause. 8.1.6

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330	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Non-interchangeability	IS/IEC 60898-1, Clause. 8.1.6
331	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Performance at rated short-circuit capacity (icn)	EN 60898-1, Clause. 9.12.11.4.3
332	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Performance at rated short-circuit capacity (icn)	IEC 60898-1:2015+AMD1, Clause. 9.12.11.4.3
333	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Performance at rated short-circuit capacity (icn)	IS/IEC 60898-1, Clause. 9.12.11.4.3
334	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Performance at reduced short-circuit currents	EN 60898-1, Clause. 9.12.11.2.1
335	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Performance at reduced short-circuit currents	IEC 60898-1:2015+AMD1, Clause. 9.12.11.2.1
336	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Performance at reduced short-circuit currents	IS/IEC 60898-1, Clause. 9.12.11.2.1
337	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Performance at the making and breaking capacity on an individual pole (Icn1) of multipole circuit-breakers	IS/IEC 60898-1, Clause. 9.12.11.4.4
338	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Performance at the making and breaking capacity on an individual pole (Icn1) of multipole circuit-breakers	EN 60898-1, Clause. 9.12.11.4.4
339	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Performance at the making and breaking capacity on an individual pole (Icn1) of multipole circuit-breakers	IEC 60898-1:2015+AMD1, Clause. 9.12.11.4.4
340	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Resistance to abnormal heat and to fire	EN 60898-1, Clause 9.15
341	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Resistance to abnormal heat and to fire	IEC 60898-1:2015+AMD1, Clause 9.15
342	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Resistance to abnormal heat and to fire	IS/IEC 60898-1, Clause 9.15

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343	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Resistance to humidity	IS/IEC 60898-1, Clause 9.7.1
344	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Resistance to humidity	EN 60898-1, Clause 9.7.1
345	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Resistance to humidity	IEC 60898-1:2015+AMD1, Clause 9.7.1
346	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Resistance to mechanical stresses and impact	EN 60898-1, Clause 9.13
347	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Resistance to mechanical stresses and impact	IEC 60898-1:2015+AMD1, Clause 9.13
348	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Resistance to mechanical stresses and impact	IS/IEC 60898-1, Clause 9.13
349	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Resistance to rusting	EN 60898-1, Clause 9.16
350	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Resistance to rusting	IEC 60898-1:2015+AMD1, Clause 9.16
351	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Resistance to rusting	IS/IEC 60898-1, Clause 9.16,
352	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Service short-circuit capacity (ics)	EN 60898-1, Clause. 9.12.11.4.2
353	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Service short-circuit capacity (ics)	IEC 60898-1:2015+AMD1, Clause. 9.12.11.4.2
354	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Service short-circuit capacity (ics)	IS/IEC 60898-1, Clause. 9.12.11.4.2
355	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Short circuit performance at 1500 A	IEC 60898-1:2015+AMD1, Clause. 9.12.11.3
356	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Short circuit performance at 1500 A	EN 60898-1, Clause. 9.12.11.3

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357	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Short circuit performance at 1500 A	IS/IEC 60898-1, Clause. 9.12.11.3
358	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Short-circuit test on circuit-breakers rated 230 V, or 240 V or 230/400 V for verifying their suitability for use in IT systems	EN 60898-1, Clause. 9.12.11.2.2
359	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Short-circuit test on circuit-breakers rated 230 V, or 240 V or 230/400 V for verifying their suitability for use in IT systems	IEC 60898-1:2015+AMD1, Clause. 9.12.11.2.2
360	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Short-circuit test on circuit-breakers rated 230 V, or 240 V or 230/400 V for verifying their suitability for use in IT systems	IS/IEC 60898-1, Clause. 9.12.11.2.2
361	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Test of protection against electric shock	EN 60898-1, Clause 9.6
362	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Test of protection against electric shock	IEC 60898-1:2015+AMD1, Clause 9.6
363	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Test of protection against electric shock	IS/IEC 60898-1, Clause 9.6
364	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Test of reliability of screws, current-carrying parts and connections	EN 60898-1, Clause 9.4
365	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Test of reliability of screws, current-carrying parts and connections	IEC 60898-1:2015+AMD1, Clause 9.4
366	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Test of reliability of screws, current-carrying parts and connections	IS/IEC 60898-1, Clause 9.4
367	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Test of reliability of terminals for external conductors	EN 60898-1, Clause 9.5
368	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Test of reliability of terminals for external conductors	IEC 60898-1:2015+AMD1, Clause 9.5
369	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Test of reliability of terminals for external conductors	IS/IEC 60898-1, Clause 9.5

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370	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Test of resistance to heat	EN 60898-1, Clause 9.14
371	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Test of resistance to heat	IEC 60898-1:2015+AMD1, Clause 9.14
372	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Test of resistance to heat	IS/IEC 60898-1, Clause 9.14
373	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Test of temperature-rise	EN 60898-1, Clause 9.8
374	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Test of temperature-rise	IEC 60898-1:2015+AMD1, Clause 9.8
375	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Test of temperature-rise	IS/IEC 60898-1, Clause 9.8
376	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Test of tripping characteristic	EN 60898-1, Clause. 9.10
377	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Test of tripping characteristic	IEC 60898-1:2015+AMD1, Clause. 9.10
378	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Test of tripping characteristic	IS/IEC 60898-1, Clause. 9.10
379	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Verification of clearances with the impulse withstand voltage	EN 60898-1, Clause 9.7.5.2
380	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Verification of clearances with the impulse withstand voltage	IEC 60898-1:2015+AMD1, Clause 9.7.5.2
381	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Verification of clearances with the impulse withstand voltage	IS/IEC 60898-1, Clause 9.7.5.2
382	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Verification of resistance of the insulation of open contacts and basic insulation against an impulse voltage in normal conditions	EN 60898-1, Clause. 9.7.5.4

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383	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Verification of resistance of the insulation of open contacts and basic insulation against an impulse voltage in normal conditions	IEC 60898-1:2015+AMD1, Clause. 9.7.5.4
384	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Verification of resistance of the insulation of open contacts and basic insulation against an impulse voltage in normal conditions	IS/IEC 60898-1, Clause. 9.7.5.4
385	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Verification of the circuit-breaker after short-circuit tests	EN 60898-1, Clause 9.12.12
386	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Verification of the circuit-breaker after short-circuit tests	IEC 60898-1:2015+AMD1, Clause 9.12.12
387	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	MCB	Verification of the circuit-breaker after short-circuit tests	IS/IEC 60898-1, Clause 9.12.12
388	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	"Clearance and creepage distances (Internal Parts) Clearance and creepage distances (external parts only)"	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 8.1.3
389	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	"Clearance and creepage distances (Internal Parts) Clearance and creepage distances (external parts only)"	IEC 61009-1 :2010+A1:2012+A2, Clause 8.1.3
390	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	"Clearance and creepage distances (Internal Parts) Clearance and creepage distances (external parts only)"	IS 12640 (Part 2), Clause 8.1.3
391	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	ageing of electronic components	IS 12640 (Part 2), Clause 9.23
392	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	ageing of electronic components	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.23
393	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	ageing of electronic components	IEC 61009-1 :2010+A1:2012+A2, Clause 9.23
394	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	ageing of electronic components	IS 12640 (Part 2), Clause 9.23

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395	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Behaviour in case of failure of the line voltage	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.17
396	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Behaviour in case of failure of the line voltage	IEC 61009-1 :2010+A1:2012+A2, Clause 9.17
397	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Behaviour in case of failure of the line voltage	IS 12640 (Part 2) , Clause 9.17
398	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	behaviour in case of surge currents	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.19
399	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	behaviour in case of surge currents	IEC 61009-1 :2010+A1:2012+A2, Clause 9.19
400	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	behaviour in case of surge currents	IS 12640 (Part 2) , Clause 9.19
401	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Capability of control circuits connected to the main circuits withstanding high d.c. voltages due to insulation measurements	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.7.6,
402	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Capability of control circuits connected to the main circuits withstanding high d.c. voltages due to insulation measurements	IEC 61009-1 :2010+A1:2012+A2, Clause 9.7.6
403	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Capability of control circuits connected to the main circuits withstanding high d.c. voltages due to insulation measurements	IS 12640 (Part 2), Clause 9.7.6
404	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	D.C. components	IS 12640 (Part 2), Clause 9.21
405	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	D.C. components	IS 12640 (Part 2), Clause 9.21
406	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Dielectric properties	IS 12640 (Part 2), Clause 9.7

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407	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Dielectric strength of the main circuit	EN 61009-1:2012, A1:2014, A11:2015, A2, Clause 9.7.3
408	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Dielectric strength of the main circuit	IEC 61009-1 :2010+A1:2012+A2, Clause 9.7.3
409	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Dielectric strength of the main circuit	IS 12640 (Part 2) , Clause 9.7.3
410	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	General	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 8.1.1
411	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	General	IEC 61009-1 :2010+A1:2012+A2, Clause 8.1.1
412	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	General	IS 12640 (Part 2) , Clause 8.1.1
413	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	General	IS 12640 (Part 2), Clause 8.1.1
414	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Indelibility of marking	EN 61009-1:2012/A1:2014/A2:2014/A11, Caluse 9.3
415	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Indelibility of marking	IEC 61009-1 :2010+A1:2012+A2:2013, Clause 9.3
416	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Indelibility of marking	IS 12640 (Part 2), Clause 9.3
417	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Insulation resistance and dielectric strength of auxiliary circuit	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.7.4,
418	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Insulation resistance and dielectric strength of auxiliary circuit	IS 12640 (Part 2) , Clause 9.7.4
419	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Insulation resistance and dielectric strength of auxiliary circuit	IEC 61009-1 :2010+A1:2012+A2, Clause 9.7.4
420	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Insulation resistance of the main circuit	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.7.2,

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421	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Insulation resistance of the main circuit	IEC 61009-1 :2010+A1:2012+A2, Clause 9.7.2
422	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Insulation resistance of the main circuit	IS 12640 (Part 2), Clause 9.7.2
423	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Limiting value of overcurrent in case of a single phase load through a 3 pole or 4 pole RCBO	IS 12640 (Part 2) , Clause 9.18
424	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Marking	IS 12640 (Part 2) , Clause.6
425	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Marking	EN 61009-1:2012/A1:2014/A2:2014/A11, Caluse 6
426	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Marking	IEC 61009-1 :2010+A1:2012+A2, Clause.6
427	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Marking	IS 12640 (Part 2), Clause.6
428	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Mechanical and electrical endurance	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.10
429	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Mechanical and electrical endurance	IEC 61009-1 :2010+A1:2012+A2, Clause 9.10
430	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Mechanical and electrical endurance	IS 12640 (Part 2) , Clause 9.10
431	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Mechanical and electrical endurance	IS 12640 (Part 2) , Clause 9.10
432	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Mechanism	EN 61009-1/A11/A12, Caluse 8.1.2
433	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Mechanism	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 8.1.2

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434	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Mechanism	IEC 61009-1 :2010+A1:2012+A2, Clause 8.1.2
435	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Mechanism	IS 12640 (Part 2) , Clause 8.1.2
436	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Mechanism	IS 12640 (Part 2), Clause 8.1.2
437	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Non-interchangeability	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 8.1.6
438	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Non-interchangeability	IEC 61009-1 :2010+A1:2012+A2, Clause 8.1.6
439	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Non-interchangeability	IS 12640 (Part 2), Clause 8.1.6
440	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Operating characteristics under residual current conditions	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.9.1
441	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Operating characteristics under residual current conditions	IEC 61009-1 :2010+A1:2012+A2, Clause 9.9.1
442	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Operating characteristics under residual current conditions	IS 12640 (Part 2) , Clause 9.9.1
443	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Operating characteristics under residual current conditions	IS 12640 (Part 2), Clause 9.9.1
444	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Over Current Operating characteristics	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.9.2
445	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Over Current Operating characteristics	IEC 61009-1 :2010+A1:2012+A2, Clause 9.9.2
446	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Over Current Operating characteristics	IS 12640 (Part 2) , Clause 9.9.2
447	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Performance at I?m	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.12.13

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448	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Performance at I?m	IEC 61009-1 :2010+A1:2012+A2, Clause 9.12.13
449	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Performance at I?m	IS 12640 (Part 2) , Clause 9.12.13
450	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Performance at I?m	IS 12640 (Part 2), Clause 9.12.13
451	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Performance at rated short circuit capacity	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.12.11.4c)
452	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Performance at rated short circuit capacity	IEC 61009-1 :2010+A1:2012+A2, Clause 9.12.11.4c)
453	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Performance at rated short circuit capacity	IS 12640 (Part 2), Clause 9.12.11.4c)
454	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Performance at reduced short-circuit currents	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.12.11.2.1
455	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Performance at reduced short-circuit currents	IEC 61009-1 :2010+A1:2012+A2, Clause 9.12.11.2.1
456	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Performance at reduced short-circuit currents	IS 12640 (Part 2), Clause 9.12.11.2
457	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Performance at reduced short-circuit currents	IS 12640 (Part 2), Clause 9.12.11.2.1
458	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Performance at service short-circuit capacity	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.12.11.4b)
459	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Performance at service short-circuit capacity	IEC 61009-1 :2010+A1:2012+A2, Clause 9.12.11.4b)
460	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Performance at service short-circuit capacity	IS 12640 (Part 2) , Clause 9.12.11.4b)
461	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Performance at service short-circuit capacity	IS 12640 (Part 2), Clause 9.12.11.4b)

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462	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Protection against electric shock	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.6
463	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Protection against electric shock	IEC 61009-1 :2010+A1:2012+A2, Clause 9.6
464	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Protection against electric shock	IS 12640 (Part 2), Clause 9.6
465	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Reliability (climatic tests)	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.22.1
466	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Reliability (climatic tests)	IEC 61009-1 :2010+A1:2012+A2, Clause 9.22.1
467	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Reliability (climatic tests)	IS 12640 (Part 2), Clause 9.22.1
468	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Reliability at 40 °C	IS 12640 (Part 2), Clause 9.22.2
469	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Reliability at 40 °C	, EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.22.2
470	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Reliability at 40 °C	IEC 61009-1 :2010+A1:2012+A2, Clause 9.22.2
471	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Reliability at 40 °C	IS 12640 (Part 2), Clause 9.22.2
472	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Reliability of screws, current-carrying parts and connections	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.4,
473	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Reliability of screws, current-carrying parts and connections	IEC 61009-1 :2010+A1:2012+A2, Clause 9.4
474	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Reliability of screws, current-carrying parts and connections	IS 12640 (Part 2), Clause 9.4
475	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Reliability of screws, current-carrying parts and connections	IS 12640 (Part 2), Clause 9.4

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476	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Reliability of terminals for external conductors	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.5,
477	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Reliability of terminals for external conductors	IEC 61009-1 :2010+A1:2012+A2, Clause 9.5
478	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Reliability of terminals for external conductors	IS 12640 (Part 2) , Clause 9.5
479	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance of insulation against an impulse voltage	IS 12640 (Part 2) , Clause 9.20
480	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance of the insulation of open contacts and basic insulation against an impulse voltage in normal conditions	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.7.7.4,
481	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance of the insulation of open contacts and basic insulation against an impulse voltage in normal conditions	IEC 61009-1 :2010+A1:2012+A2, Clause 9.7.7.4
482	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance of the insulation of open contacts and basic insulation against an impulse voltage in normal conditions	IS 12640 (Part 2) , Clause 9.7.7.4
483	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance to abnormal heat and to fire	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.15,
484	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance to abnormal heat and to fire	IS 12640 (Part 2), Clause 9.15
485	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance to abnormal heat and to fire	IEC 61009-1 :2010+A1:2012+A2, Clause 9.15
486	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance to abnormal heat and to fire	IS 12640 (Part 2) , Clause 9.15
487	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance to heat	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.14,
488	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance to heat	IEC 61009-1 :2010+A1:2012+A2, Clause 9.14

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489	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance to heat	IS 12640 (Part 2) , Clause 9.14
490	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance to heat	IS 12640 (Part 2) , Clause 9.14
491	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance to humidity	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.7.1,
492	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance to humidity	IEC 61009-1 :2010+A1:2012+A2, Clause 9.7.1
493	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance to humidity	IS 12640 (Part 2), Clause 9.7.1
494	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance to Mechanical Shock and impact	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.13
495	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance to Mechanical Shock and impact	IEC 61009-1 :2010+A1:2012+A2, Clause 9.13
496	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance to Mechanical Shock and impact	IS 12640 (Part 2) , Clause 9.13
497	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance to Mechanical Shock and impact	IS 12640 (Part 2), Clause 9.13
498	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance to Rusting	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.25,
499	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance to Rusting	IEC 61009-1 :2010+A1:2012+A2, Clause 9.25
500	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Resistance to Rusting	IS 12640 (Part 2) , Clause 9.25
501	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Secondary circuit of detection transformers	EN 61009-1:2012, A1:2014, A11:2015, A2, Clause 9.7.5
502	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Secondary circuit of detection transformers	IEC 61009-1 :2010+A1:2012+A2, Clause 9.7.5

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503	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Secondary circuit of detection transformers	IS 12640 (Part 2), Clause 9.7.5
504	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Short Circuit Performance at Test at 1500 A	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.12.11.3
505	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Short Circuit Performance at Test at 1500 A	IEC 61009-1 :2010+A1:2012+A2, Clause 9.12.11.3
506	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Short Circuit Performance at Test at 1500 A	IS 12640 (Part 2), Clause 9.12.11.3
507	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Short-circuit test for verifying the suitability of RCBOs for use in IT systems	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.12.11.2.2
508	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Short-circuit test for verifying the suitability of RCBOs for use in IT systems	IEC 61009-1 :2010+A1:2012+A2, Clause 9.12.11.2.2
509	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Short-circuit test for verifying the suitability of RCBOs for use in IT systems	IS 12640 (Part 2), Clause 9.12.11.2.2
510	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Test Device	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.16
511	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Test Device	IEC 61009-1 :2010+A1:2012+A2, Clause 9.16
512	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Test Device	IS 12640 (Part 2) , Clause 9.16
513	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Test of temperature-rise	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.8,
514	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Test of temperature-rise	IEC 61009-1 :2010+A1:2012+A2, Clause 9.8
515	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Test of temperature-rise	IS 12640 (Part 2) , Clause 9.8
516	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Trip-free mechanism	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.11

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517	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Trip-free mechanism	IEC 61009-1 :2010+A1:2012+A2, Clause 9.11
518	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Trip-free mechanism	IS 12640 (Part 2), Clause 9.11
519	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Trip-free mechanism	IS 12640 (Part 2), Clause 9.11
520	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Verification of clearances with the impulse withstand voltage	EN 61009-1:2012, EN 61009-1:2012/A1:2014, EN 61009-1:2012/A11:2015, EN 61009-1:2012/A2, Clause 9.7.7.2
521	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Verification of clearances with the impulse withstand voltage	IEC 61009-1 :2010+A1:2012+A2, Clause 9.7.7.2
522	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Verification of clearances with the impulse withstand voltage	IS 12640 (Part 2), Clause 9.7.7.2
523	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Verification of the behaviour of components bridging the basic insulation	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.7.7.5a,
524	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Verification of the behaviour of components bridging the basic insulation	IS 12640 (Part 2) , Clause 9.7.7.5a
525	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Verification of the behaviour of components bridging the basic insulation	IEC 61009-1 :2010+A1:2012+A2, Clause 9.7.7.5a
526	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Verification of the RCBO after short-circuit tests	EN 61009-1:2012/A1:2014/A2:2014/A11, Clause 9.12.12
527	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Verification of the RCBO after short-circuit tests	IEC 61009-1 :2010+A1:2012+A2, Clause 9.12.12
528	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Verification of the RCBO after short-circuit tests	IS 12640 (Part 2) , Clause 9.12.12
529	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCBO	Verification of the RCBO after short-circuit tests	IS 12640 (Part 2), Clause 9.12.12

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530	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	General	IS 12640 (Part 1) , Clause. 8.1.1
531	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	" Behaviour in the case of failure of the line voltage"	IS 12640 (Part 1), Clause 9.17
532	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	" Behaviour in the case of failure of the line voltage"	EN 61008-1:2012/A12:, Clause 9.17
533	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	" Behaviour in the case of failure of the line voltage"	IEC 61008-1: 2010+A1:2012+A2, Clause 9.17
534	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	" Behaviour in the case of failure of the line voltage"	IS 12640 (Part 1), Clause 9.17
535	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	"Clearance and creepage distances (External parts only) Clearance and creepage distances (internal parts)"	EN 61008-1:2012/A12, Clause. 8.1.3
536	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	"Clearance and creepage distances (External parts only) Clearance and creepage distances (internal parts)"	IEC 61008-1: 2010+A1:2012+A2, Clause. 8.1.3
537	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	"Clearance and creepage distances (External parts only) Clearance and creepage distances (internal parts)"	IS 12640 (Part 1) , Clause. 8.1.3
538	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	"Unwanted tripping Behaviour in the case of surge currents. "	IEC 61008-1: 2010+A1:2012+A2, Clause 9.19
539	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	"Unwanted tripping Behaviour in the case of surge currents. "	EN 61008-1:2012/A12, Clause 9.19
540	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	"Unwanted tripping Behaviour in the case of surge currents. "	IS 12640 (Part 1) , Clause 9.19
541	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Ageing of electronic components	EN 61008-1:2012/A12, Clause 9.23
542	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Ageing of electronic components	IEC 61008-1: 2010+A1:2012+A2, Clause 9.23

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543	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Ageing of electronic components	IS 12640 (Part 1) , Clause 9.23
544	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Ageing of electronic components	IS 12640 (Part 1), Clause 9.23
545	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Capability of control circuits connected to the main circuits etc.	EN 61008-1:2012/A12:, Clause 9.7.6
546	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Capability of control circuits connected to the main circuits etc.	IEC 61008-1: 2010+A1:2012+A2, Clause 9.7.6
547	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Capability of control circuits connected to the main circuits etc.	IS 12640 (Part 1), Clause 9.7.6
548	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Coordination at Ideltac	IS 12640 (Part 1) , Clause. 9.11.2.4C)
549	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Coordination at Ideltac	IS 12640 (Part 1), Clause. 9.11.2.4C)
550	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Coordination at Ideltac	EN 61008-1:2012/A12:, Clause. 9.11.2.2
551	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Coordination at Ideltac	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.11.2.2
552	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Coordination at Im	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.11.2.4b)
553	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Coordination at Im	IS 12640 (Part 1) , Clause. 9.11.2.4b)
554	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Coordination at Im	IS 12640 (Part 1), Clause. 9.11.2.4b),
555	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Coordination at Im	EN 61008-1:2012/A12, Clause. 9.11.2.4b)
556	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Coordination at Inc	IS 12640 (Part 1) , Clause. 9.11.2.4a)

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557	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Coordination at Inc	EN 61008-1:2012/A12:, Clause. 9.11.2.4a)
558	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Coordination at Inc	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.11.2.4a),
559	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Coordination at Inc	IS 12640 (Part 1) , Clause. 9.11.2.4a),
560	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	D.C. components	IS 12640 (Part 1) , Clause 9.21
561	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	D.C. components	IS 12640 (Part 1), Clause 9.21
562	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Dielectric strength of the main circuit	IEC 61008-1: 2010+A1:2012+A2, Clause 9.7.3
563	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Dielectric strength of the main circuit	EN 61008-1:2012/A12:, Clause 9.7.3
564	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Dielectric strength of the main circuit	IS 12640 (Part 1) , Clause 9.7.3
565	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	General	EN 61008-1:2012/A12, Clause. 8.1.1
566	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	General	IEC 61008-1: 2010+A1:2012+A2, Clause. 8.1.1,
567	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	General	IS 12640 (Part 1) , Clause. 8.1.1
568	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Indelibility of marking	EN 61008-1:2012/A12, Clause. 9.3
569	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Indelibility of marking	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.3
570	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Indelibility of marking	IS 12640 (Part 1) , Clause. 9.3

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571	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Insulation resistance and dielectric strength of auxiliary circuit	EN 61008-1:2012/A12, Clause 9.7.4
572	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Insulation resistance and dielectric strength of auxiliary circuit	IEC 61008-1: 2010+A1:2012+A2, Clause 9.7.4
573	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Insulation resistance and dielectric strength of auxiliary circuit	IS 12640 (Part 1) , Clause 9.7.4
574	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Insulation resistance of the main circuit	EN 61008-1:2012/A12:, Clause 9.7.2
575	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Insulation resistance of the main circuit	IEC 61008-1: 2010+A1:2012+A2, Clause 9.7.2
576	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Insulation resistance of the main circuit	IS 12640 (Part 1) , Clause 9.7.2
577	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Marking	EN 61008-1:2012/A12:, Clause. 6
578	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Marking	IEC 61008-1: 2010+A1:2012+A2, Clause. 6
579	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Marking	IS 12640 (Part 1) , Clause. 6
580	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Marking	IS 12640 (Part 1), Clause. 6
581	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Mechanical and Electrical endurance	EN 61008-1:2012/A12, Clause 9.10
582	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Mechanical and Electrical endurance	IEC 61008-1: 2010+A1:2012+A2, Clause 9.10
583	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Mechanical and Electrical endurance	IS 12640 (Part 1), Clause 9.10
584	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Mechanical and Electrical endurance	IS 12640 (Part 1), Clause 9.10

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585	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Mechanism	EN 61008-1:2012/A12:, Clause. 8.1.2
586	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Mechanism	IEC 61008-1: 2010+A1:2012+A2, Clause. 8.1.2
587	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Mechanism	IS 12640 (Part 1) , Clause. 8.1.2
588	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Non-Operating current under over current conditions	EN 61008-1:2012/A12:, Clause. 9.18
589	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Non-Operating current under over current conditions	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.18
590	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Non-Operating current under over current conditions	IS 12640 (Part 1) , Clause. 9.18
591	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Performance at I?m	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.11.2.3a)b)
592	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Performance at I?m	EN 61008-1:2012/A12:, Clause. 9.11.2.3a)b)
593	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Performance at I?m	IS 12640 (Part 1) , Clause. 9.11.2.3
594	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Performance at I?m	IS 12640 (Part 1) , Clause. 9.11.2.3a)b)
595	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Performance at Im	IS 12640 (Part 1) , Clause. 9.11.2.2,
596	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Performance at Im	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.11.2.4c)
597	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Performance at Im	IS 12640 (Part 1) , Clause. 9.11.2.2
598	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Performance at Im	EN 61008-1:2012/A12, Clause. 9.11.2.4c)

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599	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	protection against electric shock	EN 61008-1:2012/A12:, Clause. 9.6
600	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	protection against electric shock	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.6
601	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	protection against electric shock	IS 12640 (Part 1) , Clause. 9.6
602	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	protection against electric shock	IS 12640 (Part 1), Clause. 9.6
603	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Relability Climatic test	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.22.1
604	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Relability Climatic test	IS 12640 (Part 1) , Clause. 9.22.1
605	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Relability Climatic test	IS 12640 (Part 1), Clause. 9.22.1
606	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Relability Climatic test	EN 61008-1:2012/A12:, Clause. 9.22.1
607	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Reliability at 40 °C	EN 61008-1:2012/A12, Clause 9.22.2
608	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Reliability at 40 °C	IEC 61008-1: 2010+A1:2012+A2, Clause 9.22.2
609	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Reliability at 40 °C	IS 12640 (Part 1) , Clause 9.22.2
610	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Reliability at 40 °C	IS 12640 (Part 1), Clause 9.22.2
611	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Reliability of screws, current-carrying parts and connections	EN 61008-1:2012/A12:, Clause. 9.4
612	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Reliability of screws, current-carrying parts and connections	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.4

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613	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Reliability of screws, current-carrying parts and connections	IS 12640 (Part 1) , Clause. 9.4
614	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Reliability of terminals for external conductors	EN 61008-1:2012/A12:, Clause. 9.5
615	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Reliability of terminals for external conductors	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.5
616	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Reliability of terminals for external conductors	IS 12640 (Part 1) , Clause. 9.5
617	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Reliability of terminals for external conductors	IS 12640 (Part 1) , Clause. 9.5
618	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Residual Operating Characteristics	IS 12640 (Part 1) , Clause 9.9
619	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Residual Operating Characteristics	EN 61008-1:2012/A12, Clause 9.9
620	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Residual Operating Characteristics	IEC 61008-1: 2010+A1:2012+A2, Clause 9.9
621	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Residual Operating Characteristics	IS 12640 (Part 1) , Clause 9.9
622	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Resistance of insulation against impulse voltage	IS 12640 (Part 1) , Clause 9.20
623	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Resistance of the insulation of open contacts and basic insulation against an impulse voltage in normal conditions	EN 61008-1:2012/A12:, Clause. 9.7.7.4
624	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Resistance of the insulation of open contacts and basic insulation against an impulse voltage in normal conditions	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.7.7.4
625	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Resistance of the insulation of open contacts and basic insulation against an impulse voltage in normal conditions	IS 12640 (Part 1) , Clause. 9.7.7.4

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626	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Resistance to abnormal heat and to fire	EN 61008-1:2012/A12:, Clause. 9.14
627	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Resistance to abnormal heat and to fire	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.14
628	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Resistance to abnormal heat and to fire	IS 12640 (Part 1) , Clause. 9.14
629	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	resistance to heat	EN 61008-1:2012/A12:, Clause. 9.13
630	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	resistance to heat	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.13
631	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	resistance to heat	IS 12640 (Part 1) , Clause. 9.13
632	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Resistance to humidity	IEC 61008-1: 2010+A1:2012+A2, Clause 9.7.1
633	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Resistance to humidity	IS 12640 (Part 1) , Clause 9.7.1
634	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Resistance to humidity	EN 61008-1:2012/A12, Clause 9.7.1
635	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Resistance to Mechanical shocks and impact	Clause. 9.12, IS 12640 (Part 1)
636	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Resistance to Mechanical shocks and impact	EN 61008-1:2012/A12, Clause. 9.12
637	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Resistance to Mechanical shocks and impact	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.12
638	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Resistance to Mechanical shocks and impact	IS 12640 (Part 1) , Clause. 9.12
639	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Resistance to Rusting	EN 61008-1:2012/A12:, Clause. 9.25

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640	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Resistance to Rusting	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.25
641	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Resistance to Rusting	IS 12640 (Part 1) , Clause. 9.25
642	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Secondary circuit of detection transformers	EN 61008-1:2012/A12, Clause 9.7.5
643	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Secondary circuit of detection transformers	IEC 61008-1: 2010+A1:2012+A2, Clause 9.7.5
644	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Secondary circuit of detection transformers	IS 12640 (Part 1) , Clause 9.7.5
645	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Test device	EN 61008-1:2012/A12, Clause. 9.16
646	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Test device	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.16
647	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Test device	IS 12640 (Part 1) , Clause. 9.16
648	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Test of Dielectric properties	IS 12640 (Part 1) , Clause. 9.7
649	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Test of temperature-rise	EN 61008-1:2012/A12, Clause 9.8
650	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Test of temperature-rise	IEC 61008-1: 2010+A1:2012+A2, Clause 9.8
651	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Test of temperature-rise	IS 12640 (Part 1) , Clause 9.8
652	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Trip-free mechanism	EN 61008-1:2012/A12:, Clause. 9.1.5
653	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Trip-free mechanism	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.1.5

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654	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Trip-free mechanism	IS 12640 (Part 1) , Clause. 9.15
655	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Verification of clearances with the impulse withstand voltage	EN 61008-1:2012/A12:, Cl.9.7.7.2
656	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Verification of clearances with the impulse withstand voltage	IEC 61008-1: 2010+A1:2012+A2, Cl.9.7.7.2
657	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Verification of clearances with the impulse withstand voltage	IS 12640 (Part 1) , Cl.9.7.7.2
658	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Verification of the behaviour of components bridging the basic insulation	IEC 61008-1: 2010+A1:2012+A2, Clause 9.7.7.5b
659	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Verification of the behaviour of components bridging the basic insulation	IS 12640 (Part 1), Clause 9.7.7.5b
660	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Verification of the behaviour of components bridging the basic insulation	Clause 9.7.7.5b, EN 61008-1:2012/A12
661	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Verification of the suitability of RCCBs for use in IT-systems	EN 61008-1:2012/A12:, Clause. 9.11.2.3C)
662	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Verification of the suitability of RCCBs for use in IT-systems	IEC 61008-1: 2010+A1:2012+A2, Clause. 9.11.2.3C)
663	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	RCCB	Verification of the suitability of RCCBs for use in IT-systems	IS 12640 (Part 1) , Clause. 9.11.2.3C)
664	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	"Circuit-breaker protected shortcircuit making"	EN 60947-3:2009/ A1:2012 /A2, "Clause: 9.3.7.2.1b),
665	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	"Circuit-breaker protected shortcircuit making"	IEC 60947-3, Clause: 9.3.7.2.1b)
666	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	"Circuit-breaker protected shortcircuit withstand"	IEC 60947-3, Clause: 9.3.7.2.1a)
667	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	"Circuit-breaker protected shortcircuit withstand"	EN 60947-3:2009/ A1:2012 /A2, "Clause: 9.3.7.2.1a),

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668	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Dielectric properties	EN 60947-3:2009/ A1:2012 /A2, Clause: 9.3.4.3
669	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Dielectric properties	IEC 60947-3:2020, Clause: 9.3.4.3
670	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Dielectric properties	IS/IEC 60947-3 : 2012, "Clause: 8.3.3.2
671	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Dielectric Test	EN 60947-3:2009/ A1:2012 /A2, Clause: 9.1.3.3
672	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Dielectric Test	IEC 60947-3, Clause: 9.1.3.3
673	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Dielectric Test	IS/IEC 60947-3 , Clause: 8.1.3.3
674	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Dielectric verification	EN 60947-3:2009/ A1:2012 /A2, "Clause: 9.3.4.5, 9.3.5.3, 9.3.6.4, 9.3.7.4, 9.3.8.3,
675	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Dielectric verification	IEC 60947-3:2020, "Clause: 9.3.4.5, 9.3.5.3, 9.3.6.4, 9.3.7.4, 9.3.8.3
676	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Dielectric verification	IS/IEC 60947-3 : 2012, "Clause: 8.3.3.4, 8.3.4.2, 8.3.5.3, 8.3.6.3, 8.3.7.2
677	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Fuse protected short-circuit making	IS/IEC 60947-3 , Clause: 8.3.6.2.1b)
678	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Fuse protected short-circuit withstand	IS/IEC 60947-3, Clause: 8.3.6.2.1a)
679	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Glow wire test	EN 60947-3:2009/ A1:2012 /A2, Clause: 8.1.3.3
680	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Glow wire test	IEC 60947-3, Clause: 8.1.2.2
681	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Glow wire test	IS/IEC 60947-3, Clause: 7.1.2.2

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682	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Leakage current	EN 60947-3:2009/ A1:2012 /A2, Clause: 9.3.4.6, 9.3.5.4, 9.3.6.5, 9.3.7.5, 9.3.8.4
683	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Leakage current	IEC 60947-3:2020, "Clause: 9.3.4.6, 9.3.5.4, 9.3.6.5, 9.3.7.5, 9.3.8.4
684	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Leakage current	IS/IEC 60947-3 : 2012, "Clause: 8.3.3.5, 8.3.4.3, 8.3.5.4, 8.3.6.4, 8.3.7.3
685	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	making and breaking capacities	EN 60947-3:2009/ A1:2012 /A2, "Clause: 9.3.4.4
686	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	making and breaking capacities	IEC 60947-3:2020, Clause: 9.3.4.4
687	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	making and breaking capacities	IS/IEC 60947-3, Clause: 8.3.3.3
688	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Mechanical and electrical properties of terminals	EN 60947-3:2009/ A1:2012 /A2, Clause: 9.2.5
689	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Mechanical and electrical properties of terminals	IEC 60947-3, Clause: 9.2.5
690	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Mechanical operation test	EN 60947-3:2009/ A1:2012 /A2, Clause: 9.1.3.2
691	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Mechanical operation test	IEC 60947-3, Clause: 9.1.3.2
692	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Mechanical operation test	IS/IEC 60947-3 , Clause: 8.1.3.2
693	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Mechanical properties of terminals	IS/IEC 60947-3 , Clause: 8.2.4
694	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Operational performance	EN 60947-3:2009/ A1:2012 /A2, Clause: 9.3.5.2
695	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Operational performance	IEC 60947-3, Clause: 9.3.5.2

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696	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Operational performance	IS/IEC 60947-3, Clause: 8.3.4.1
697	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Overload test	EN 60947-3:2009/ A1:2012 /A2, Clause: 9.3.8.2
698	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Overload test	IEC 60947-3, Clause: 9.3.8.2,
699	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Overload test	IS/IEC 60947-3 , Clause: 8.3.7.1
700	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	short-circuit making capacity	EN 60947-3:2009/ A1:2012 /A2, Clause: 9.3.6.3
701	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	short-circuit making capacity	IEC 60947-3, Clause: 9.3.6.3
702	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	short-circuit making capacity	IS/IEC 60947-3 , Clause: 8.3.5.2
703	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	short-time withstand current	EN 60947-3:2009/ A1:2012 /A2, Clause: 9.3.6.2
704	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	short-time withstand current	IEC 60947-3, Clause: 9.3.6.2
705	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	short-time withstand current	IS/IEC 60947-3 , Clause: 8.3.5.1
706	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Strength of actuator mechanism	IEC 60947-3:2020, Clause: 9.3.4.8
707	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Strength of actuator mechanism	EN 60947-3:2009/ A1:2012 /A2, Clause: 9.3.4.8
708	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Strength of actuator mechanism	IS/IEC 60947-3 : 2012, Clause: 8.3.3.7
709	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Temperature-rise Verification	EN 60947-3/A1:2012/A2, Clause: 9.3.4.7, 9.3.5.5, 9.3.6.6, 9.3.7.6, 9.3.8.5

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710	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Temperature-rise Verification	IEC 60947-3:2020, "Clause: 9.3.4.7, 9.3.5.5, 9.3.6.6, 9.3.7.6, 9.3.8.5
711	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Temperature-rise Verification	IS/IEC 60947-3, "Clause: 8.3.3.6, 8.3.4.4, 8.3.5.5, 8.3.6.5, 8.3.7.4,
712	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Temperature-rise	EN 60947-3:2009/ A1:2012 /A2, Clause: 9.3.4.2
713	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Temperature-rise	IEC 60947-3:2020, Clause: 9.3.4.2
714	ELECTRICAL-SWITCHGEAR & PROTECTIVE EQUIPMENT	Switches, disconnectors, switch-disconnectors and fuse-combination units	Temperature-rise	IS/IEC 60947-3 : 2012, "Clause: 8.3.3.1
715	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Clearances and Creepage Distances	EN 61439-1, Clause: 10.4
716	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Clearances and Creepage Distances	EN 61439-3:2012, Clause: 10
717	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Clearances and Creepage Distances	IEC 61439-1 (Edition 2.0) 2011-08, Clause: 10.4
718	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Clearances and Creepage Distances	IEC 61439-3, Ed:1.0, 2012-2, Clause: 10
719	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Degree of protection of assemblies (IP Code)	EN 61439-1:2011 and (IEC 60529), Clause: 10.3
720	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Degree of protection of assemblies (IP Code)	EN 61439-3:2012, Clause: 10.3
721	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Degree of protection of assemblies (IP Code)	IEC 61439-1 (Edition 2.0) 2011-08 and (IEC 60529), Clause: 10.3

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722	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Degree of protection of assemblies (IP Code)	IEC 61439-3, Ed:1.0, 2012-2, Clause: 10.3
723	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Dielectric properties	EN 61439-1, Clause: 10.9
724	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Dielectric properties	EN 61439-3:2012, Clause: 10
725	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Dielectric properties	IEC 61439-1 (Edition 2.0) 2011-08, Clause: 10.9
726	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Dielectric properties	IEC 61439-3, Ed:1.0, 2012-2, Clause: 10
727	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Effective earth continuity between the exposed-conductive-parts of the class I assembly and the protective circuit	EN 61439-1, Clause: 10.5.2
728	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Effective earth continuity between the exposed-conductive-parts of the class I assembly and the protective circuit	EN 61439-3:2012, Clause: 10
729	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Effective earth continuity between the exposed-conductive-parts of the class I assembly and the protective circuit	IEC 61439-1 (Edition 2.0) 2011-08, Clause: 10.5.2
730	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Effective earth continuity between the exposed-conductive-parts of the class I assembly and the protective circuit	IEC 61439-3, Ed:1.0, 2012-2, Clause: 10
731	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Marking	EN 61439-1, Clause: 10.2.7

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732	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Marking	EN 61439-3:2012, Clause: 10.2.7
733	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Marking	IEC 61439-1 (Edition 2.0) 2011-08, Clause: 10.2.7
734	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Marking	IEC 61439-3, Ed:1.0, 2012-2, Clause: 10.2.7
735	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Mechanical operation	EN 61439-1, Clause: 10.13
736	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Mechanical operation	EN 61439-3:2012, Clause: 10.13
737	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Mechanical operation	IEC 61439-1 (Edition 2.0) 2011-08, Clause: 10.13
738	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Mechanical operation	IEC 61439-3, Ed:1.0, 2012-2, Clause: 10.13
739	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Protection against electric shock and integrity of protective circuits	EN 61439-1, Clause: 10.5
740	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Protection against electric shock and integrity of protective circuits	EN 61439-3, Clause: 10
741	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Protection against electric shock and integrity of protective circuits	IEC 61439-1 (Edition 2.0) 2011-08, Clause: 10.5
742	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Protection against electric shock and integrity of protective circuits	IEC 61439-3, Ed:1.0, 2012-2, Clause: 10

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743	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Resistance to corrosion	EN 61439-1, Clause: 10.2.2
744	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Resistance to corrosion	EN 61439-3, Clause: 10
745	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Resistance to corrosion	IEC 61439-1 (Edition 2.0) 2011-08, Clause: 10.2.2
746	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Resistance to corrosion	IEC 61439-3, Ed:1.0, 2012-2, Clause: 10
747	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Short-circuit withstand strength	EN 61439-1, Clause: 10.11
748	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Short-circuit withstand strength	EN 61439-3, Clause: 10
749	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Short-circuit withstand strength	IEC 61439-1 (Edition 2.0) 2011-08, Clause: 10.11
750	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Short-circuit withstand strength	IEC 61439-3, Ed:1.0, 2012-2, Clause: 10
751	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Short-circuit withstand strength of the protective circuit	EN 61439-1, Clause: 10.5.3
752	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Short-circuit withstand strength of the protective circuit	EN 61439-3, Clause: 10
753	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Short-circuit withstand strength of the protective circuit	IEC 61439-1 (Edition 2.0) 2011-08, Clause: 10.5.3

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754	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Short-circuit withstand strength of the protective circuit	IEC 61439-3, Ed:1.0, 2012-2, Clause: 10
755	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Temperature-rise	EN 61439-1, Clause: 10.10
756	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Temperature-rise	EN 61439-3, Clause: 10
757	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Temperature-rise	IEC 61439-1 (Edition 2.0) 2011-08, Clause: 10.10
758	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Temperature-rise	IEC 61439-3, Ed:1.0, 2012-2, Clause: 10
759	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Verification of protection against mechanical impact (IK code)	EN 61439-1, Clause: 10.2.6
760	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Verification of protection against mechanical impact (IK code)	EN 61439-3, Clause: 10.2.6
761	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Verification of protection against mechanical impact (IK code)	IEC 61439-1 (Edition 2.0) 2011-08, Clause: 10.2.6
762	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Verification of protection against mechanical impact (IK code)	IEC 61439-3, Ed:1.0, 2012-2, Clause: 10.2.6
763	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Verification of resistance of insulating materials to abnormal heat and fire due to internal electric effects	EN 61439-1, Clause: 10.2.3.2
764	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Verification of resistance of insulating materials to abnormal heat and fire due to internal electric effects	EN 61439-3, Clause: 10.2.3.2

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765	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Verification of resistance of insulating materials to abnormal heat and fire due to internal electric effects	IEC 61439-1 (Edition 2.0) 2011-08, Clause: 10.2.3.2
766	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Distribution boards intended to be operated by ordinary persons (DBO)	Verification of resistance of insulating materials to abnormal heat and fire due to internal electric effects	IEC 61439-3, Ed:1.0, 2012-2, Clause: 10.2.3.2
767	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Clearances and Creepage Distances	EN 61439-1, Clause: 10.4
768	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Clearances and Creepage Distances	EN 61439-2:2011, Clause: 10
769	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Clearances and Creepage Distances	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.4
770	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Clearances and Creepage Distances	IEC 61439-2, Edition:3.0, 2020-07, Clause 10
771	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Degree of protection of ASSEMBLIES	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.3
772	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Degree of protection of ASSEMBLIES	IEC 61439-2, Edition:3.0, 2020-07, Clause 10
773	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Degree of protection of enclosures	EN 61439-1, Clause: 10.3
774	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Degree of protection of enclosures	EN 61439-2, Clause: 10
775	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Design verifaction	EN 61439-2, Clause: 10

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776	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Design verifaction	IEC 61439-2, Edition:3.0, 2020-07, Clause 10
777	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Design verification	EN 61439-1, Clause: 10
778	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Design Verification	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10
779	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Effective earth continuity between the exposed conductive parts of the assembly and the protective circuit	EN 61439-1, Clause: 10.5.2
780	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Effective earth continuity between the exposed conductive parts of the assembly and the protective circuit	EN 61439-2, Clause: 10
781	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Effective earth continuity between the exposed conductive parts of the assembly and the protective circuit	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.5.2
782	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Effective earth continuity between the exposed conductive parts of the assembly and the protective circuit	IEC 61439-2, Edition:3.0, 2020-07, Clause: 10
783	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Marking	IEC 61439-2, Edition:3.0, 2020-07, Clause 10
784	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Marking	EN 61439-1, Clause: 10.2.7
785	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Marking	EN 61439-2, Clause: 10

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786	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Marking	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.2.7
787	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Mechanical impact	EN 61439-1, Clause: 10.2.6
788	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Mechanical impact	EN 61439-2, Clause: 10
789	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Mechanical impact	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.2.6
790	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Mechanical impact	IEC 61439-2, Edition:3.0, 2020-07, Clause 10
791	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Mechanical Operations	EN 61439-1, Clause: 10.13
792	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Mechanical Operations	EN 61439-2, Clause: 10
793	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Mechanical Operations	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.13
794	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Mechanical Operations	IEC 61439-2, Edition:3.0, 2020-07, Clause 10
795	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Protection against electric shock and integrity of protective circuit	EN 61439-1, Clause: 10.5
796	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Protection against electric shock and integrity of protective circuit	EN 61439-2, Clause: 10

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797	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Protection against electric shock and integrity of protective circuit	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.5
798	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Protection against electric shock and integrity of protective circuit	IEC 61439-2, Edition:3.0, 2020-07, Clause 10
799	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Resistance to abnormal heat and fire due to internal electric effect	EN 61439-1, Clause: 10.2.3.2
800	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Resistance to abnormal heat and fire due to internal electric effect	EN 61439-2, Clause: 10
801	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Resistance to abnormal heat and fire due to internal electric effect	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.2.3.2
802	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Resistance to abnormal heat and fire due to internal electric effect	IEC 61439-2, Edition:3.0, 2020-07, Clause 10
803	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Resistance to corrosion (Damp Heat and Salt mist for enclosures and metallic parts)	EN 61439-1, Clause: 10.2.2
804	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Resistance to corrosion (Damp Heat and Salt mist for enclosures and metallic parts)	EN 61439-2, Clause: 10
805	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Resistance to corrosion (Damp Heat and Salt mist for enclosures and metallic parts)	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.2.2
806	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Resistance to corrosion (Damp Heat and Salt mist for enclosures and metallic parts)	IEC 61439-2, Edition:3.0, 2020-07, Clause 10
807	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Short circuit withstand strength	EN 61439-1, Clause: 10.11

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808	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Short circuit withstand strength	EN 61439-2, Clause: 10.11
809	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Short circuit withstand strength	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.11
810	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Short circuit withstand strength	IEC 61439-2, Edition:3.0, 2020-07, Clause: 10.11
811	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Short circuit withstand strength of protective Circuit	EN 61439-1, Clause: 10.5.3
812	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Short circuit withstand strength of protective Circuit	EN 61439-2, Clause: 10
813	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Short circuit withstand strength of protective Circuit	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.5.3
814	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Short circuit withstand strength of protective Circuit	IEC 61439-2, Edition:3.0, 2020-07, Clause: 10
815	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Thermal Stability	EN 61439-1, Clause: 10.2.3.1
816	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Thermal Stability	EN 61439-2, Clause: 10
817	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Thermal Stability	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.2.3.1
818	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Thermal Stability	IEC 61439-2, Edition:3.0, 2020-07, Clause: 10

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819	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Verification of temperature rise	EN 61439-1, Clause: 10.10
820	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Verification of temperature rise	EN 61439-2, Clause: 10.10
821	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Verification of temperature rise	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.10
822	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switch gear and control gear assemblies-power switch gear and control gear assemblies	Verification of temperature rise	IEC 61439-2, Edition:3.0, 2020-07, Clause: 10.10
823	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Ability to withstand mechanical loads	EN 61439-6, Clause.10.2.101
824	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Ability to withstand mechanical loads	IEC 61439-1 (Edition 2.0) 2011-08 Clause.10.2.101
825	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Ability to withstand mechanical loads	IEC 61439-6 (Edition 1.0): 2012-05, Clause.10.2.101
826	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Clearances and Creepage Distances	EN 61439-6, Clause.10.4
827	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Clearances and Creepage Distances	IEC 61439-1 (Edition 2.0) 2011-08, Clause.10.4
828	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Clearances and Creepage Distances	IEC 61439-6 (Edition 1.0): 2012-05, Clause.10.4
829	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Degree of protection of ASSEMBLIES	EN 61439-6:2012 and (IEC 60529), Clause.10.3

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830	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Degree of protection of ASSEMBLIES	IEC 61439-1 (Edition 2.0) 2011-08, Clause.10.3
831	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Degree of protection of ASSEMBLIES	IEC 61439-6 (Edition 1.0): 2012-05 and (IEC 60529), Clause.10.3
832	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Dielectric Properties	EN 61439-6, Clause.10.9
833	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Dielectric Properties	IEC 61439-1 (Edition 2.0) 2011-08, Clause.10.9
834	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Dielectric Properties	IEC 61439-6 (Edition 1.0): 2012-05, Clause.10.9
835	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Effective continuity between the exposed conductive parts of the BTS and the protective circuit	EN 61439-6, Clause.10.5.2
836	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Effective continuity between the exposed conductive parts of the BTS and the protective circuit	IEC 61439-1 (Edition 2.0) 2011-08, Clause.10.5.2
837	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Effective continuity between the exposed conductive parts of the BTS and the protective circuit	IEC 61439-6 (Edition 1.0): 2012-05, Clause.10.5.2
838	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Marking	EN 61439-6, Clause.10.2.7
839	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Marking	IEC 61439-1 (Edition 2.0) 2011-08, Clause.10.2.7
840	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Marking	IEC 61439-6 (Edition 1.0): 2012-05, Clause.10.2.7

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841	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Mechanical impact	EN 61439-6, Clause.10.2.6
842	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Mechanical impact	IEC 61439-1 (Edition 2.0) 2011-08, Clause.10.2.6
843	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Mechanical impact	IEC 61439-6 (Edition 1.0): 2012-05, Clause.10.2.6
844	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Mechanical Operations	EN 61439-6, Clause.10.13
845	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Mechanical Operations	IEC 61439-1 (Edition 2.0) 2011-08, Clause.10.13
846	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Mechanical Operations	IEC 61439-6 (Edition 1.0): 2012-05, Clause.10.13
847	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Protection against electric shock and integrity of protective circuit	EN 61439-6, Clause.10.5
848	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Protection against electric shock and integrity of protective circuit	IEC 61439-1 (Edition 2.0) 2011-08, Clause.10.5
849	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Protection against electric shock and integrity of protective circuit	IEC 61439-6 (Edition 1.0): 2012-05, Clause.10.5
850	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Resistance of the enclosure to crushing	EN 61439-6, Clause.10.2.101.3
851	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Resistance of the enclosure to crushing	IEC 61439-1 (Edition 2.0) 2011-08, Clause.10.2.101.3

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852	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Resistance of the enclosure to crushing	IEC 61439-6 (Edition 1.0): 2012-05, Clause.10.2.101.3
853	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Resistance to abnormal heat and fire due to internal electric effect	EN 61439-6, Clause.10.2.3.2
854	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Resistance to abnormal heat and fire due to internal electric effect	IEC 61439-1 (Edition 2.0) 2011-08, Clause.10.2.3.2
855	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Resistance to abnormal heat and fire due to internal electric effect	IEC 61439-6 (Edition 1.0): 2012-05, Clause.10.2.3.2
856	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Resistance to corrosion (Damp Heat and Salt mist for enclosures & metallic part)	EN 61439-6, Clause.10.2.2
857	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Resistance to corrosion (Damp Heat and Salt mist for enclosures & metallic part)	IEC 61439-1 (Edition 2.0) 2011-08, Clause.10.2.2
858	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Resistance to corrosion (Damp Heat and Salt mist for enclosures & metallic part)	IEC 61439-6 (Edition 1.0): 2012-05, Clause.10.2.2
859	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Short circuit withstand strength	EN 61439-6, Clause.10.11
860	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Short circuit withstand strength	IEC 61439-1 (Edition 2.0) 2011-08, Clause.10.11
861	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Short circuit withstand strength	IEC 61439-6 (Edition 1.0): 2012-05, Clause.10.11
862	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Short circuit withstand strength of protective Circuit	EN 61439-6, Clause.10.5.3

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863	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Short circuit withstand strength of protective Circuit	IEC 61439-1 (Edition 2.0) 2011-08, Clause.10.5.3
864	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Short circuit withstand strength of protective Circuit	IEC 61439-6 (Edition 1.0): 2012-05, Clause.10.5.3
865	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Temperature rise	EN 61439-6, Clause.10.10
866	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Temperature rise	IEC 61439-1 (Edition 2.0) 2011-08, Clause.10.10
867	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Temperature rise	IEC 61439-6 (Edition 1.0): 2012-05, Clause.10.10
868	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Thermal cycling test	EN 61439-6, Clause.10.2.102
869	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Thermal cycling test	IEC 61439-1 (Edition 2.0) 2011-08, Clause.10.2.102
870	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Thermal cycling test	IEC 61439-6 (Edition 1.0): 2012-05, Clause.10.2.102
871	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Thermal Stability	EN 61439-6, Clause.10.2.3.1
872	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Thermal Stability	IEC 61439-1 (Edition 2.0) 2011-08, Clause.10.2.3.1
873	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies-busbar trunking systems (busways)	Thermal Stability	IEC 61439-6 (Edition 1.0): 2012-05, Clause.10.2.3.1

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874	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies- power switchgear and control gear assemblies	Dielectric Properties	EN 61439-1, Clause: 10.9
875	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies- power switchgear and control gear assemblies	Dielectric Properties	EN 61439-2, Clause: 10
876	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies- power switchgear and control gear assemblies	Dielectric Properties	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.9
877	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	Low-voltage switchgear and control gear assemblies- power switchgear and control gear assemblies	Dielectric Properties	IEC 61439-2, Edition:3.0, 2020-07, Clause: 10
878	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV Control Gears & Switch Gears Assembly	Effective continuity between the exposed conductive parts of the assembly and the protective circuit	EN 61439-1, Clause: 10.5.2
879	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV Control Gears & Switch Gears Assembly	Effective continuity between the exposed conductive parts of the assembly and the protective circuit	EN 61439-2, Clause: 10
880	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV Control Gears & Switch Gears Assembly	Effective continuity between the exposed conductive parts of the assembly and the protective circuit	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.5.2
881	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV Control Gears & Switch Gears Assembly	Effective continuity between the exposed conductive parts of the assembly and the protective circuit	IEC 61439-2, Edition:3.0, 2020-07, Clause: 10
882	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV Control Gears & Switch Gears Assembly	Mechanical Operations	EN 61439-1, Clause: 10.2.8
883	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV Control Gears & Switch Gears Assembly	Mechanical Operations	EN 61439-2, Clause: 10.2.8
884	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV Control Gears & Switch Gears Assembly	Mechanical Operations	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.2.8

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885	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV Control Gears & Switch Gears Assembly	Mechanical Operations	IEC 61439-2, Edition:3.0, 2020-07, Clause: 10.2.8
886	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV switch gear and control gear assembly	Dielectric Properties	EN 61439-1, Clause: 10.9,10.9.2,10.9.3, 10.9.4
887	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV switch gear and control gear assembly	Dielectric Properties	EN 61439-2, Clause: 10
888	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV switch gear and control gear assembly	Dielectric Properties	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.9,10.9.2,10.9.3, 10.9.4
889	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV switch gear and control gear assembly	Dielectric Properties	IEC 61439-2, Edition:3.0, 2020-07, Clause: 10
890	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV switch gear and control gear assembly	Short circuit withstand strength	EN 61439-1, Clause: 10.11
891	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV switch gear and control gear assembly	Short circuit withstand strength	EN 61439-2, Clause: 10
892	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV switch gear and control gear assembly	Short circuit withstand strength	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.11
893	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV switch gear and control gear assembly	Short circuit withstand strength	IEC 61439-2, Edition:3.0, 2020-07, Clause: 10
894	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV Switch Gears & Control Gears	Short circuit withstand strength of protective devices	EN 61439-1, Clause: 10.5.3
895	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV Switch Gears & Control Gears	Short circuit withstand strength of protective devices	EN 61439-2, Clause: 10

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896	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV Switch Gears & Control Gears	Short circuit withstand strength of protective devices	IEC 61439-1, Edition 3.0, 2020-05, Clause: 10.5.3
897	ELECTRICAL-TRANSMISSION LINE EQUIPMENT & ACCESSORIES	LV Switch Gears & Control Gears	Short circuit withstand strength of protective devices	IEC 61439-2, Edition:3.0, 2020-07, Clause: 10
898	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Apparatus containing coin /button cell batteries	EN/IEC 60065, Clause. 12.7, 12.7.2,12.7.3
899	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Apparatus containing coin /button cell batteries	IS 616: 2017-Rev 5, Clause. 12.7, 12.7.2,12.7.3
900	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Batteries	EN/IEC 60065, Clause. 14.11.3
901	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Batteries	IS 616: 2017-Rev 5, Clause. 14.11.3
902	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Creepage Distances (Tracking Index test)	EN/IEC 60065:2014, Clause 13.4
903	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Creepage Distances (Tracking Index test)	IS 616: 2017-Rev 5, Clause 13.4
904	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Dielectric strength	EN/IEC 60065, Clause. 10.4
905	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Dielectric strength	IS 616: 2017-Rev 5, Clause. 10.4
906	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Drop Test	EN/IEC 60065, Clause. 12.1.5
907	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Drop Test	IS 616: 2017-Rev 5, Clause. 12.1.5
908	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Electrical Connections & mechanical fixings	EN/IEC 60065, Clause. 17.1 to 17.9
909	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Electrical Connections & mechanical fixings	IS 616: 2017-Rev 5, Clause. 17.1 to 17.9
910	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Enclosed and sealed parts	EN/IEC 60065, Clause. 13.7
911	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Enclosed and sealed parts	IS 616: 2017-Rev 5, Clause. 13.7
912	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Fault conditions Tests	EN/IEC 60065, Clause. 11

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913	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Fault conditions Tests	IS 616: 2017-Rev 5, Clause. 11
914	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Fault test	EN/IEC 60065, Clause. 4.3
915	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Fault test	IS 616: 2017-Rev 5, Clause. 4.3
916	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Heating under normal operating conditions	EN/IEC 60065, Clause. 7
917	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Heating under normal operating conditions	IS 616: 2017-Rev 5, Clause. 7
918	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Humidity treatment	EN/IEC 60065, Clause. 10.3
919	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Humidity treatment	IS 616: 2017-Rev 5, Clause. 10.3
920	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Humidity treatment	IS 616: 2017-Rev 5, Clause. 10.3
921	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Insulation resistance	EN/IEC 60065, Clause. 10.4
922	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Insulation resistance	IS 616: 2017-Rev 5, Clause. 10.4
923	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Internal forces	EN/IEC 60065, Clause. 8.14
924	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Internal forces	IS 616: 2017-Rev 5, Clause. 8.14
925	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Marking Legibility	EN/IEC 60065, Clause. 5
926	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Marking Legibility	IS 616: 2017-Rev 5, Clause. 5
927	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Mechanical strength – Impact	EN/IEC 60065, Clause. 12.1.4
928	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Mechanical strength – Impact	IS 616: 2017-Rev 5, Clause. 12.1.4
929	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Mechanical strength – Stress relief	EN/IEC 60065: 2014, Clause. 12.1.6
930	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Mechanical strength – Stress relief	IS 616: 2017-Rev 5, Clause. 12.1.6
931	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Normal operating conditions – Input Test	EN/IEC 60065, Clause. 4.1, 4.2

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932	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Normal operating conditions – Input Test	IS 616: 2017-Rev 5, Clause. 4.1, 4.2
933	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Resistance to external forces	EN/IEC 60065, Clause. 9.1.7
934	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Resistance to external forces	IS 616: 2017-Rev 5, Clause. 9.1.7
935	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Resistance to Heat, Fire and Tracking (Flame Test)	EN/IEC 60065: 2014, Clause. 20, Annexure. G
936	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Resistance to Heat, Fire and Tracking (Glow wire Test)	EN/IEC 60065: 2014, Clause. 20, Annexure. G
937	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Resistance to Heat, Fire and Tracking (Glow wire Test)	IS 616: 2017-Rev 5, Clause. 20, Annexure. G
938	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Resistance to Heat, Fire and Tracking (Needle flame)	EN/IEC 60065: 2014, Clause. 20, Annexure. G
939	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Resistance to Heat, Fire and Tracking (Needle flame)	IS 616: 2017-Rev 5, Clause. 20, Annexure. G
940	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Stress Relief	EN/IEC 60065, Clause. 12.1.6
941	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Stress Relief	IS 616: 2017-Rev 5, Clause. 12.1.6
942	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Vibration Test	EN/IEC 60065:2014, Clause 12.1.3
943	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Vibration Test	IS 616: 2017-Rev 5, Clause 12.1.3
944	ELECTRONICS- AUDIO EQUIPMENT	House Hold Electronic Appliances – CRT TV; LCD(with CCFL/LED backlighting); Plasma displays	On mode Power measurement	BEE Schedule 11
945	ELECTRONICS- AUDIO EQUIPMENT	House Hold Electronic Appliances – CRT TV; LCD(with CCFL/LED backlighting); Plasma displays	Standby power measurement	BEE Schedule 11
946	ELECTRONICS- AUDIO EQUIPMENT	House Hold Electronic Appliances – CRT TV; LCD(with CCFL/LED backlighting); Plasma displays	Standby power measurement	IS 13384 (Part 2)
947	ELECTRONICS- ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Change of Temperature(Test Na) (2 chamber method)	QM-333, Test no 4, Clause 3.4
948	ELECTRONICS- ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Cold Test	QM-333, Test no 1, Clause 3.1
949	ELECTRONICS- ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Damp heat, cyclic (Test Db)	QM-333, Test no 3, Clause 3.3

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950	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Damp Heat, steady state	QM-333, Test no 5, Clause 3.5
951	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Degrees of Protection): provided by enclosures	IEC 60068-2-78 (2nd Edition): 2012-10
952	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Drop Test	QM-333, Test no : 10, Clause 3.10
953	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Dry Heat	EN/IEC 60068-2-2: 2007
954	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Dry Heat	QM-333, Test number 2, Clause 3.2
955	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Dust- IP 1 x to IP 6 x	IEC 60529: 2013-08, (Edition 2.2)
956	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Fall Test	QM-333, Test no 12, Clause 3.12
957	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Salt Mist Test	IEC 60068-2-11, (3rd Edition): 1981
958	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Toppling Test	QM-333, Test no 11, Clause 3.11
959	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Dust- IP 1 x to IP 6 x	IEC 61850-3, Edition 2, 2013-12
960	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Salt Mist, Cyclic, Test Kb (sodium chloride solution)	IEC 60068-2-52 (3rd Edition): Edition 3.0 2017-11
961	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Test A: Cold	IEC 60068-2-1(6th Edition)
962	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Test Db: Damp heat, cyclic (12 h + 12 h cycle)	IEC 60068-2-30 (3rd Edition)

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963	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Test Nb: Change of temperature with specified rate of change (2 chamber method)	IEC 60068-2-14, (6th Edition)
964	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Water – IPX1 to IP X7 Degrees of Protection provided by enclosures	IEC 60529: 2013-08, (Edition 2.2)
965	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Water – IPX1 to IP X7 Degrees of Protection provided by enclosures	IEC 61850-3, Edition 2, 2013-12
966	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	PV Solar Module, Electronics & Electrical Items	Vibration test	QM333: 2010, Issue-Mar 2010, Test No 6 (Cl3.6.1 to Cl3.6.7)
967	ELECTRONICS- IT EQUIPMENT	IT Equipment	Abnormal operation Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 5.3.1)
968	ELECTRONICS- IT EQUIPMENT	IT Equipment	Batteries	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015, Cl. 4.3.8
969	ELECTRONICS- IT EQUIPMENT	IT Equipment	Capacitance discharge Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 2.1.1.7)
970	ELECTRONICS- IT EQUIPMENT	IT Equipment	Cord anchorages and strain relief Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 3.2.6)
971	ELECTRONICS- IT EQUIPMENT	IT Equipment	Cord guard Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 3.2.8)
972	ELECTRONICS- IT EQUIPMENT	IT Equipment	Direct plug-in equipment	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015,CL 4.3.6
973	ELECTRONICS- IT EQUIPMENT	IT Equipment	Drop Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 4.2.6)
974	ELECTRONICS- IT EQUIPMENT	IT Equipment	Durability of marking Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 1.7.11)
975	ELECTRONICS- IT EQUIPMENT	IT Equipment	Electric strength Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 Clause 5.2 (5.2.1, 5.2.2)
976	ELECTRONICS- IT EQUIPMENT	IT Equipment	Energy hazard	IS 13252 (Part 1): 2010 + Amd. 1: 2013 + Amd. 2: .,CL 2.1.1.5

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977	ELECTRONICS- IT EQUIPMENT	IT Equipment	Energy hazards - d.c. main supplies	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2,CL 2.1.1.8
978	ELECTRONICS- IT EQUIPMENT	IT Equipment	handles & manual controls	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015,CL4.3.2,4.3.3
979	ELECTRONICS- IT EQUIPMENT	IT Equipment	Hazardous moving Parts Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 4.4.2)
980	ELECTRONICS- IT EQUIPMENT	IT Equipment	Humidity Conditioning	IEC 60950-1 ((2nd Edition):2005+ Amd. 1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 2.9.2)
981	ELECTRONICS- IT EQUIPMENT	IT Equipment	Humidity conditioning	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 2.9.2)
982	ELECTRONICS- IT EQUIPMENT	IT Equipment	Impact Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 4.2.5)
983	ELECTRONICS- IT EQUIPMENT	IT Equipment	Input Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 1.6.2)
984	ELECTRONICS- IT EQUIPMENT	IT Equipment	Limitation of touch current to a telecommunication and cable distribution system	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 5.1.8.1)
985	ELECTRONICS- IT EQUIPMENT	IT Equipment	Limited current circuit measurements	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 Clause. 2.4 (2.4.1 to 2.4.3)
986	ELECTRONICS- IT EQUIPMENT	IT Equipment	Limited power source measurement Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 2.5)
987	ELECTRONICS- IT EQUIPMENT	IT Equipment	Mechanical test (Steady force Test)	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 Clause. 4.2 (4.2.1,4.2.2,4.2.3, 4.2.4)
988	ELECTRONICS- IT EQUIPMENT	IT Equipment	Non-separable thin sheet material	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.10.5.8
989	ELECTRONICS- IT EQUIPMENT	IT Equipment	Overload of operator accessible Parts	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 5.3.7)
990	ELECTRONICS- IT EQUIPMENT	IT Equipment	Protection against Hazardous moving Parts	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 Clause. 4.4 (4.4.1 to 4.4.4)

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991	ELECTRONICS- IT EQUIPMENT	IT Equipment	Protection against moving fan blades	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015, (Clause. 4.4.5)
992	ELECTRONICS- IT EQUIPMENT	IT Equipment	Protection against overload and abnormal operation	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 5.3.1, 5.3.2,5.3.3,5.3.6)
993	ELECTRONICS- IT EQUIPMENT	IT Equipment	Protection of equipment users from over voltages on telecommunication Networks	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 6.2.2)
994	ELECTRONICS- IT EQUIPMENT	IT Equipment	Protection of telecommunication network service persons, and users of other equipment connected to the network, from hazards in the equipment	IEC 60950-1, Amd.1 + Amd. 2, Clause. 6.1
995	ELECTRONICS- IT EQUIPMENT	IT Equipment	Protective bonding Test II	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 2.6.3.4)
996	ELECTRONICS- IT EQUIPMENT	IT Equipment	Requirement of separation between telecommunication network from earth	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 6.1.2)
997	ELECTRONICS- IT EQUIPMENT	IT Equipment	Resistance of earthing conductors and their terminations	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 2.6.3.4)
998	ELECTRONICS- IT EQUIPMENT	IT Equipment	Resistance to abnormal heat (ball pressure)	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015,CL 4.5.5
999	ELECTRONICS- IT EQUIPMENT	IT Equipment	SELV circuit Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 Clause. 2.2 (2.2.1,2.2.2, 2.2.3,2.2.4)
1000	ELECTRONICS- IT EQUIPMENT	IT Equipment	Simulation of single fault (Overload of operator accessible Parts)	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 5.3.7)
1001	ELECTRONICS- IT EQUIPMENT	IT Equipment	Stability Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 4.1)
1002	ELECTRONICS- IT EQUIPMENT	IT Equipment	Strain relief Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 3.2.6)

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1003	ELECTRONICS- IT EQUIPMENT	IT Equipment	Stress relief Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 4.2.7)
1004	ELECTRONICS- IT EQUIPMENT	IT Equipment	Thermal requirement	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 Clause. 4.5 (4.5.1 to 4.5.4)
1005	ELECTRONICS- IT EQUIPMENT	IT Equipment	Touch current & protective conductor current Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 5.1)
1006	ELECTRONICS- IT EQUIPMENT	IT Equipment	Touch current Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 5.1)
1007	ELECTRONICS- IT EQUIPMENT	IT Equipment	Transformer and wire insulation electric strength Test	IEC 60950-1, Amd.1 + Amd 2, Clause. 2.10.5.13
1008	ELECTRONICS- IT EQUIPMENT	IT Equipment	Voltage surge test	IEC 60950-1, Amd.1 + Amd. 2, Clause. 7.4.2
1009	ELECTRONICS- IT EQUIPMENT	IT Equipment	Wall or ceiling mounted equipment	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 CL4.2.10
1010	ELECTRONICS- IT EQUIPMENT	IT Equipment	Working voltage determination	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 2.10.2)
1011	ELECTRONICS- IT EQUIPMENT	IT Equipment	Working voltage measurement Test	IEC 60950-1, Amd.1 + Amd. 2, Clause. 2.10.2
1012	ELECTRONICS- IT EQUIPMENT	Mobile Phones	Language Input test & Verification	IS 16333 (Part 3) : 2017, Cl 5
1013	ELECTRONICS- IT EQUIPMENT	Mobile Phones	Language Input test & Verification	IS 16333(Part 3), Clause 5(Cl 5.1 & Cl 5.2)
1014	ELECTRONICS- IT EQUIPMENT	Radio Transmitting Equipment	Resistance to Ingress of Water	IEC 60215 (Edition 4):2016-04
1015	ELECTRONICS- IT EQUIPMENT	Radio Transmitting Equipment	Resistance to Ingress of Water	IS 10437: 1986
1016	ELECTRONICS- MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Thermal Cycling Test	IS 14286 (Part 1/Sec 3) , Clause 11.11
1017	ELECTRONICS- MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Accessibility Test	EN 61730-2:2007+A1:2012

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1018	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Accessibility Test	IEC 61730-2:2004/ AMD1 , (Clause. 10.2 MST 11)
1019	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Accessibility Test	IS/IEC 61730-2:2004+A1:2017, MST 11
1020	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Bonding Path resistance Test / Ground continuity Test	IEC 61730-2:2004/ AMD1:2011 (Clause. 10.4) MST 13
1021	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Bonding Path resistance Test / Ground continuity Test	IS/IEC 61730-2:2004+A1:2017 MST13
1022	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Bonding Path resistance Test / Ground continuity Test	EN 61730-2:2007+A1:2012
1023	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Bypass diode thermal Test	EN 61730-2:2007+A1:2012
1024	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Bypass diode thermal Test	IEC 61215 (2nd Edition): 2005-04, (Clause. 10.18)
1025	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Bypass diode thermal Test	IEC 61730-2:2004/ AMD1:2011, MST 25
1026	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Bypass diode thermal Test	IS 14286: 2010(FIRST REVISION), (Clause. 10.18)
1027	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Bypass diode thermal Test	IS/IEC 61730-2:2004+A1:2017, MST 25
1028	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Cut susceptibility Test	EN 61730-2:2007+A1:2012
1029	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Cut susceptibility Test	IEC 61730-2:2004/ AMD1:2011, (Clause. 10.3 MST 12)
1030	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Cut susceptibility Test	IS/IEC 61730-2:2004+A1:2017 MST 12
1031	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Damp heat Test	EN 61730-2:2007+A1:2012

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1032	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Damp heat Test	IEC 61215 (2nd Edition): 2005-04 (Clause. 10.13)
1033	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Damp heat Test	IEC 61730-2:2004/ AMD1:2011 MST 53
1034	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Damp heat Test	IS 14286: 2010(FIRST REVISION), (Clause. 10.13)
1035	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Damp heat Test	IS/IEC 61730-2:2004+A1:2017, MST 53
1036	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Dielectric Withstand Test	EN 61730-2:2007+ A1:2012
1037	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Dielectric Withstand Test	IEC 61730-2:2004/ AMD1:2011, (Clause 10.6)MST 16
1038	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Dielectric withstand test	IS/IEC 61730-2:2004+A1:2017, MST 16
1039	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Hail Test	IEC 61215 (2nd Edition): 2005-04, (Clause. 10.17)
1040	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Hail Test	IS 14286: 2010(FIRST REVISION), (Clause. 10.17
1041	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Hot-spot endurance Test	EN 61730-2:2007+A1:2012
1042	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Hot-spot endurance Test	IEC 61215 (2nd Edition): 2005-04, (Clause. 10.9)
1043	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Hot-spot endurance Test	IEC 61730-2:2004/ AMD1:2011 ,MST 22
1044	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Hot-spot endurance Test	IS 14286: 2010(FIRST REVISION), (Clause. 10.9)
1045	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Hot-spot endurance Test	IS/IEC 61730-2:2004+A1:2017, MST 22

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1046	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Humidity-freeze Test	EN 61730-2:2007+A1:2012
1047	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Humidity-freeze Test	IEC 61215 (2nd Edition): 2005-04, (Clause. 10.12)
1048	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Humidity-freeze Test	IEC 61730-2:2004/ AMD1:2011, MST 52
1049	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Humidity-freeze Test	IS 14286: 2010(FIRST REVISION), (Clause. 10.12)
1050	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Humidity-freeze Test	IS/IEC 61730-2:2004+A1:2017, MST 52
1051	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Impulse voltage Test	EN 61730-2:2007+A1:2012
1052	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Impulse voltage Test	IEC 61730-2:2004/ AMD1:2011, (MST 14
1053	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Impulse voltage Test	IS/IEC 61730-2:2004+A1:2017, MST 14
1054	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Insulation Test	IEC 61215 (2nd Edition): 2005-04 (Clause. 10.3)
1055	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Insulation Test	IS 14286: 2010(FIRST REVISION) (Clause. 10.3)
1056	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Maximum power determination / Voltage , current and power measurements Test	IEC 61215 (2nd Edition): 2005-04 (Clause. 10.2)
1057	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Maximum power determination / Voltage , current and power measurements Test	IS 14286: 2010(FIRST REVISION), (Clause. 10.2)
1058	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Maximum power determination / Voltage, current and power measurements Test	IEC 60904-2:2015 Clause 12.3
1059	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Measurement of temperature coefficients	IEC 61215 (2nd Edition): 2005-04 (Clause. 10.4)

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1060	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Measurement of temperature coefficients	IS 14286: 2010(FIRST REVISION), (Clause. 10.4)
1061	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Mechanical load Test	IEC 61215 (2nd Edition): 2005-04, (Clause. 10.16)
1062	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Mechanical load Test	IEC 61730-2:2004/ AMD1:2011, (Clause. 10.16) MST 34
1063	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Mechanical load Test	EN 61730-2:2007+A1:2012
1064	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Mechanical load Test	IS 14286: 2010(FIRST REVISION), (Clause. 10.16)
1065	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Mechanical load Test	IS/IEC 61730-2:2004+A1:2017 , MST 34
1066	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Module breakage Test	EN 61730-2:2007+ A1:2012
1067	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Module breakage Test	IEC 61730-2:2004/ AMD1:2011, MST 32
1068	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Module breakage Test	IS/IEC 61730-2:2004+A1:2017 MST 32
1069	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Outdoor exposure Test	IEC 61215 (2nd Edition): 2005-04, (Clause. 10.8),
1070	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Outdoor exposure Test	IS 14286: 2010(FIRST REVISION), (Clause. 10.8)
1071	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Partial discharge Test	EN 61730-2:2007+A1:2012
1072	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Partial discharge Test	IEC 61730-2:2004/ AMD1:2011, Clause. 11.1 MST 15
1073	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Partial discharge Test	IS/IEC 61730-2:2004+A1:2017, MST 15

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1074	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Performance at low irradiance	IEC 61215 (2nd Edition): 2005-04 (Clause. 10.7)
1075	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Performance at low irradiance	IS 14286: 2010(FIRST REVISION), (Clause. 10.7)
1076	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Performance at STC and NOCT	IEC 61215 (2nd Edition): 2005-04 (Clause. 10.6)
1077	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Performance at STC and NOCT	IS 14286: 2010(FIRST REVISION), (Clause. 10.6)
1078	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Preconditioning	IEC 61215 (2nd Edition): 2005-04
1079	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Preconditioning	IS 14286: 2010(FIRST REVISION)
1080	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Reverse Current Overload Test	EN 61730-2:2007+A1:2012
1081	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Reverse Current Overload Test	IEC 61730-2:2004/ AMD1:2011 (Clause. 10.9) MST 26
1082	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Reverse Current Overload Test	IS/IEC 61730-2:2004+A1:2017, MST 26
1083	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Robustness of terminations Test	EN 61730-2:2007+A1:2012
1084	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Robustness of terminations Test	IEC 61215 (2nd Edition): 2005-04. Clause. 10.14
1085	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Robustness of terminations Test	IEC 61730-2:2004/ AMD1:2011 MST 42
1086	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Robustness of terminations Test	IS 14286: 2010(FIRST REVISION), Clause 10.14
1087	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Robustness of terminations Test	IS/IEC 61730-2:2004+A1:2017 MST 42

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1088	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Temperature Test	EN 61730-2:2007+A1:2012
1089	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Temperature Test	IEC 61730-2:2004/ AMD1:2011 (Clause. 10.7 MST 21)
1090	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Temperature Test	IS/IEC 61730-2:2004+A1:2017 MST 21
1091	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Thermal cycling Test	EN 61730-2:2007+A1:2012
1092	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Thermal cycling Test	IEC 61215 (2nd Edition): 2005-04, (Clause. 10.11
1093	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Thermal cycling Test	IEC 61730-2:2004/ AMD1:2011, MST 51a, MST 51b
1094	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Thermal cycling Test	IS 14286: 2010(FIRST REVISION), (Clause. 10.11)
1095	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Thermal cycling Test	IS/IEC 61730-2:2004+A1:2017, MST 51a, MST 51b
1096	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	UV preconditioning Test	EN 61730-2:2007+A1:2012
1097	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	UV preconditioning Test	IEC 61215 (2nd Edition): 2005-04 (Clause. 10.10)
1098	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	UV preconditioning Test	IEC 61730-2:2004/ AMD1:2011, MST 54
1099	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	UV preconditioning Test	IS 14286: 2010(FIRST REVISION), (Clause. 10.10)
1100	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	UV preconditioning Test	IS/IEC 61730-2:2004+A1:2017, MST 54
1101	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Visual inspection	EN 61730-2:2007+ A1:2012

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1102	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Visual inspection	IEC 61215 (2nd Edition): 2005-04 (Clause. 10.1)
1103	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Visual inspection	IEC 61730-2: 2004/ AMD1:2011,MST01
1104	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Visual inspection	IS 14286: 2010(FIRST REVISION) (Clause. 10.1)
1105	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Visual inspection	IS/IEC 61730-2:2004+A1:2017 (MST01), (Clause. 10.1)
1106	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Wet leakage current Test	EN 61730-2:2007+A1:2012
1107	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Wet leakage current Test	IEC 61215 (2nd Edition): 2005-04 (Clause. 10.15)
1108	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Wet leakage current Test	IEC 61730-2:2004/ AMD1:2011, (MST 17)
1109	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Wet leakage current Test	IS 14286: 2010(FIRST REVISION), Clause 10.15
1110	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Wet leakage current Test	IS/IEC 61730-2:2004+A1:2017, MST 17
1111	ELECTRONICS-MISCELLANEOUS PRODUCTS	Part 1-2: Special requirements for testing of thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Robustness of Termination test	ANSI/UL 61215-1-2-2017, Clause 11.14
1112	ELECTRONICS-MISCELLANEOUS PRODUCTS	Part 1-3: Special requirements for testing of thin-film amorphous silicon based photovoltaic (PV) modules	Robustness of Termination test	ANSI/UL 61215-1-3-2017, Clause 11.14
1113	ELECTRONICS-MISCELLANEOUS PRODUCTS	Part 1-4: Special requirements for testing of thin-film Cu(In,Ga) (S,Se)2 based photovoltaic (PV) modules	Robustness of Termination test	ANSI/UL 61215-1-4-2017,Clause 11.14
1114	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) Module Safety Qualification Part 2 Requirements for Testing (First Revision)	Insulation Thickness Test	IS/IEC 61730-2:2016 ,Clause 10.5
1115	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) Module Safety Qualification Part 2 Requirements for Testing (First Revision)	Insulation Thickness Test	ANSI/UL 61730-2-2020, Clause 10.5

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1116	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module	High Temperature Condition	IEC 61853, Clause 7.5
1117	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module	High Temperature Condition	IS 16170 (Part 1), Clause 7.5
1118	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module	Irradiance and Temperature performance measurement	IEC 61853, Clause 8
1119	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module	Irradiance and Temperature performance measurement	IS 16170 (Part 1),Clause 8
1120	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module	Low Irradiance Condition	IEC 61853, Clause 7.4
1121	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module	Low Irradiance Condition	IS 16170 (Part 1), Clause 7.4
1122	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module	Low Temperature Condition	IEC 61853, Clause 7.6
1123	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module	Low Temperature Condition	IS 16170 (Part 1), Clause 7.6
1124	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module	Nominal Operating Cell Temperature	IEC 61853, Clause 7.3
1125	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module	Nominal Operating Cell Temperature	IS 16170 (Part 1), Clause 7.3
1126	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module	Standard Testing Condition	IEC 61853, Clause 7.2
1127	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module	Standard Testing Condition	IS 16170 (Part 1), Clause 7.2
1128	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module performance testing and energy rating	Marking	IEC 61853, Clause 4
1129	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module performance testing and energy rating	Marking	IS 16170 (Part 1), Clause 4

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1130	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module performance testing and energy rating	Power Rating Condition	IEC 61853, Clause 7
1131	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module performance testing and energy rating	Power Rating Condition	IS 16170 (Part 1), Clause 7
1132	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module performance testing and energy rating	Procedure for irradiance and temperature performance measurement	IEC 61853, Clause 8
1133	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module performance testing and energy rating	Procedure for irradiance and temperature performance measurement	IS 16170 (Part 1), Clause 8
1134	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module performance testing and energy rating - Part-1: Irradiance and temperature performance measurements and power rating	Rating of power/Power rating Clause 9 (Sub clause No. 9.1 and 9.2)	IEC 61853-1, Edition 1.0 Clause 9
1135	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module performance testing and energy rating - Part-1: Irradiance and temperature performance measurements and power rating	Rating of power/Power rating Clause 9 (Sub clause No. 9.1 and 9.2)	IS 16170 (Part 1) Clause 9
1136	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Bonding and grounding	EN 61730-1:2007+A1:2012+A2:2013+A11:2014
1137	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Bonding and grounding	IEC 61730-1:2004, AMD1:2011, AMD2:2013 (Clause 8)
1138	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Bonding and grounding	IS/IEC 61730-1:2004 + A1:2017 + A2:2017 (Clause 8)
1139	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Connections Accessibility test	EN 61730-1:2007+A1:2012+A2:2013+A11:2014
1140	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Connections Accessibility test	IEC 61730-1:2004, AMD1:2011, AMD2:2013 (Clause 7)
1141	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Connections Accessibility test	IS/IEC 61730-1:2004 + A1:2017 + A2:2017 (Clause 7)
1142	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Creepage and clearance distances	EN 61730-1:2007+A1:2012+A2:2013+A11:2014
1143	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Creepage and clearance distances	IEC 61730-1:2004, AMD1:2011, AMD2:2013 (Clause 9)

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1144	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Creepage and clearance distances	IS/IEC 61730-1:2004 + A1:2017 + A2:2017 (Clause 9)
1145	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Field wiring compartments with covers	EN 61730-1:2007+A1:2012+A2:2013+A11:2014
1146	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Field wiring compartments with covers	IEC 61730-1:2004, AMD1:2011, AMD2:2013 (Clause 10)
1147	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Field wiring compartments with covers	IS/IEC 61730-1:2004 + A1:2017 + A2:2017 (Clause 10)
1148	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Internal Wiring and current carrying parts	EN 61730-1:2007+A1:2012+A2:2013+A11:2014
1149	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Internal Wiring and current carrying parts	IEC 61730-1:2004, AMD1:2011, AMD2:2013 (Clause 6)
1150	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Internal Wiring and current carrying parts	IS/IEC 61730-1:2004 + A1:2017 + A2:2017 (Clause 6)
1151	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Partial Discharge test	EN 61730-1:2007+A1:2012+A2:2013+A11:2014
1152	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Partial Discharge test	IEC 61730-1:2004, AMD1:2011, AMD2:2013 (Clause 5)
1153	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Partial Discharge test	IS/IEC 61730-1:2004 + A1:2017 + A2:2017 (Clause 5)
1154	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Polymeric materials	EN 61730-1:2007+A1:2012+A2:2013+A11:2014
1155	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Polymeric materials	IEC 61730-1:2004, AMD1:2011, AMD2:2013 (Clause 5)
1156	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Polymeric materials	IS/IEC 61730-1:2004 + A1:2017 + A2:2017(Clause 5)
1157	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Temperature test	EN 61730-1:2007+A1:2012+A2:2013+A11:2014

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1158	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Temperature test	IEC 61730-1:2004, AMD1:2011, AMD2:2013 (Clause 5)
1159	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	Temperature test	IS/IEC 61730-1:2004 + A1:2017 + A2:2017 (Clause 5)
1160	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	UV Resistance test	EN 61730-1:2007+A1:2012+A2:2013+A11:2014
1161	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	UV Resistance test	IEC 61730-1:2004, AMD1:2011, AMD2:2013 (Clause 5)
1162	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part-1: Requirements for construction	UV Resistance test	IS/IEC 61730-1:2004 + A1:2017 + A2:2017 (Clause 5)
1163	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part2: requirement for testing a) Thin-film terrestrial photovoltaic (PV) modules b) Crystalline silicon terrestrial photovoltaic (PV) modules	A.3 Spread of flame test	IEC 61730-2: 2004/ AMD1:2011,MST23
1164	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part2: requirement for testing a) Thin-film terrestrial photovoltaic (PV) modules b) Crystalline silicon terrestrial photovoltaic (PV) modules	A.3 Spread of flame test	IS/IEC 61730-2:2004+A1:2017 MST 23
1165	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part2: requirement for testing a) Thin-film terrestrial photovoltaic (PV) modules b) Crystalline silicon terrestrial photovoltaic (PV) modules	A.4 Burning brand test	IEC 61730-2: 2004/ AMD1:2011,MST23
1166	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part2: requirement for testing a) Thin-film terrestrial photovoltaic (PV) modules b) Crystalline silicon terrestrial photovoltaic (PV) modules	A.4 Burning brand test	IS/IEC 61730-2:2004+A1:2017 ,MST 23
1167	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part2: requirement for testing a) Thin-film terrestrial photovoltaic (PV) modules b) Crystalline silicon terrestrial photovoltaic (PV) modules	Fire Test MST 23 (Annex A)	IEC 61730-2: 2004/ AMD1:2011,MST23
1168	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) module safety qualification-Part2: requirement for testing a) Thin-film terrestrial photovoltaic (PV) modules b) Crystalline silicon terrestrial photovoltaic (PV) modules	Fire Test MST 23 (Annex A)	IS/IEC 61730-2:2004+A1:2017 ,MST 23
1169	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) modules – Crystalline silicon	Electro luminescence imaging	Laboratory test method- 12-LO-S0884

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1170	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) modules- Crystalline silicon	Electro luminescence Imaging	IS 17210(Part 1), Clause 4.2 (f), 4.4 (d) Severity level as per 41/06/2015-16/PVSE – MNRE requirement guidelines
1171	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) modules- Crystalline silicon	Electro luminescence Imaging	Laboratory test method-12-LO-S0884: 2019
1172	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) modules- Crystalline silicon	Ground Continuity Test	IS 17210(Part 1), Clause 4.2 (g), Severity level as per 41/06/2015-16/PVSE – MNRE requirement guidelines
1173	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) modules- Crystalline silicon	Maximum Power Determination	IS 17210(Part 1), Clause 4.2 (C),4.4 (a) Severity level as per 41/06/2015-16/PVSE – MNRE requirement guidelines
1174	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) modules- Crystalline silicon	Performance at Low Irradiance	IS 17210(Part 1), Clause 4.2 (d), 4.4 (b)Severity level as per 41/06/2015-16/PVSE – MNRE requirement guidelines
1175	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) modules- Crystalline silicon	Preconditioning	IS 17210(Part 1), Clause 4.2 (a) Severity level as per 41/06/2015-16/PVSE – MNRE requirement guidelines
1176	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) modules- Crystalline silicon	Visual Inspection	IS 17210(Part 1), Clause 4.2 (b), 4.4 (e) Severity level as per 41/06/2015-16/PVSE – MNRE requirement guidelines
1177	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) modules- Crystalline silicon	Voltage Stress Test	IS 17210(Part 1), Clause 4.3, Severity level as per 41/06/2015-16/PVSE – MNRE requirement guidelines
1178	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic (PV) modules- Crystalline silicon	Wet Leakage Test	IS 17210(Part 1), Clause 4.2 (e), 4.4 (C)Severity level as per 41/06/2015-16/PVSE – MNRE requirement guidelines
1179	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic cells – crystalline silicon photovoltaic cells	Electro luminescence imaging	Laboratory test method- 12-LO-S0884
1180	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic cells – crystalline silicon photovoltaic cells	Electro luminescence imaging	IEC 63202-1, Clause 6.10

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1181	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic cells – crystalline silicon photovoltaic cells	Maximum Power determination (IV Measurement)	IEC 63202-1, Clause 6.1
1182	ELECTRONICS-MISCELLANEOUS PRODUCTS	Photovoltaic cells – crystalline silicon photovoltaic cells	Quasi-Stabilization	IEC 63202-1, Clause 6.2
1183	ELECTRONICS-MISCELLANEOUS PRODUCTS	Solar Photovoltaic modules, power conversion units and equipment which are intended for Corrosive environment	Salt Mist Test	IEC 61701 (Edition 3.0) 2020-06
1184	ELECTRONICS-MISCELLANEOUS PRODUCTS	Solar Photovoltaic modules, power conversion units and equipment which are intended for Corrosive environment	Salt Mist Test	IS/IEC 61701 : 2011
1185	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules Design qualification and type approval – Part 2: Test procedure Photovoltaic (PV) module safety qualification – Part 2: Requirements for testing	Fire Test	ANSI/UL 61730-2-2020, Clause 10.17 (Annexure B.3)
1186	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules Design qualification and type approval – Part 2: Test procedure Photovoltaic (PV) module safety qualification – Part 2: Requirements for testing	Ignitability Test	ANSI/UL 61730-2-2020, Clause 10.18
1187	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules Design qualification and type approval – Part 2: Test procedure Photovoltaic (PV) module safety qualification – Part 2: Requirements for testing	Lap Shear Strength Test	ANSI/UL 61730-2-2020 , Clasue 10.25
1188	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules Design qualification and type approval – Part 2: Test procedure Photovoltaic (PV) module safety qualification – Part 2: Requirements for testing	Peel Test	ANSI/UL 61730-2-2020 , Clause 10.24
1189	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules Design qualification and type approval – Part 2: Test procedure Photovoltaic (PV) module safety qualification – Part 2: Requirements for testing	Robustness of Termination test	ANSI/UL 61215-2-2017, Clause 4.14
1190	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules Design qualification and type approval – Part 2: Test procedure Photovoltaic (PV) module safety qualification – Part 2: Requirements for testing	Robustness of Termination test	ANSI/UL 61730-2-2020, Clause 10.27
1191	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Hot-spot endurance test	ANSI/UL 61215-1-1-2017, Clause 11.9
1192	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Hot-spot endurance test	ANSI/UL 61215-1-2-2017, Clause 11.9

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1193	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Hot-spot endurance test	ANSI/UL 61215-1-3-2017, Clause 11.9
1194	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Hot-spot endurance test	ANSI/UL 61215-1-4-2017, Clause 11.9
1195	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Hot-spot endurance test	ANSI/UL 61215-2-2017, Clause 4.9
1196	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Hot-spot endurance test	ANSI/UL 61730-2-2020, Clause 10.16
1197	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Maximum power determination	" ANSI/UL 61215-1-2017, Clause 6"
1198	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Maximum power determination	ANSI/UL 61215-1-1-2018, Clause 11.2
1199	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Maximum power determination	ANSI/UL 61215-1-2-2018, Clause 11.2
1200	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Maximum power determination	ANSI/UL 61215-1-3-2018, Clause 11.2
1201	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Maximum power determination	ANSI/UL 61215-1-4-2018, Clause 11.2
1202	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Maximum power determination	ANSI/UL 61730-2-2020, Clause 10.4
1203	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Temperature Test	ANSI/UL 61730-1-2020, Clause 5.5.2.3.3
1204	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Temperature test	ANSI/UL 61730-2-2020,, Clause 10.15
1205	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Visual inspection	ANSI/UL 61215-2-2017, Clause 4.1
1206	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules Requirements for construction Design qualification and type approval – Part 1:	Clearances and Creepage distances	ANSI/UL 61730-1-2020, Clause 5.6.3.4

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1207	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules Requirements for construction Design qualification and type approval – Part 1:	Distance through insulation (Dti)	ANSI/UL 61730-1-2020, Clause 5.6.4
1208	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules Design qualification and type approval – Part 1-1: Special requirements for testing of crystalline silicon photovoltaic (PV) Modules	Robustness of Termination test	ANSI/UL 61215-1-1-2017 , Clause 11.14
1209	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules	Major visual defects	IEC 61215-1, Clause 8
1210	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Accessibility test	IS/IEC 61730-2, Clause 10.9
1211	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Bypass diode functionality test	IS/IEC 61730-2, Clause 10.8
1212	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Bypass Diode Thermal Test	IEC 61215-2, Clause 4.18
1213	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Bypass Diode Thermal Test	IS 14286 (Part 2), Clause 4.18
1214	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Bypass Diode Thermal Test	IS/IEC 61730-2, Clause 10.19
1215	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Classification, applications and intended use	IS/IEC 61730-1, Clause 4
1216	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Clearances and Creepage distances	IS/IEC 61730-1, Clause 5.6.3.4
1217	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Cold conditioning test	IS/IEC 61730-2, Clause 10.32
1218	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Continuity test of equipotential bonding	IS/IEC 61730-2, Clause 10.11
1219	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Continuity test, Module Breakage Test, Robustness of Termination test, Peel Test, Lap Shear Test	IS/IEC 61730-1, Clause 5.4.6

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1220	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Cut susceptibility test	IS/IEC 61730-2, Clause 10.10
1221	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Damp-Heat test	IEC 61215-2, Clause 4.13
1222	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Damp-Heat test	IS 14286 (Part 2), Clause 4.13
1223	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Damp-Heat test	IS/IEC 61730-2, Clause 10.30
1224	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Distance through insulation (Dti)	IS/IEC 61730-1, Clause 5.6.4
1225	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Dry heat conditioning test	IS/IEC 61730-2, Clause 10.33
1226	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Durability of markings	IS/IEC 61730-2, Clause 10.6
1227	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Fire Test	IS/IEC 61730-2, Clause 10.17 (Annexure B.3)
1228	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Hail test	IEC 61215-2, Clause 4.17
1229	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Hail test	IS 14286 (Part 2), Clause 4.17
1230	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Hot-spot endurance test	IEC 61215-2, Clause 4.9
1231	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Hot-spot endurance test	IS 14286 (Part 2), Clause 4.9
1232	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Hot-spot endurance test	IS/IEC 61730-2, Clause 10.16
1233	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Humidity-freeze test	IEC 61215-2, Clause 4.12

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1234	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Humidity-freeze test	IS 14286 (Part 2), Clause 4.12
1235	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Humidity-freeze test	IS/IEC 61730-2, Clause 10.29
1236	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Ignitability Test	IS/IEC 61730-2, Clause 10.18
1237	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Ignitability Test, Peel Test, Lap Shear Strength Test	IS/IEC 61730-1, Clause 5.5.2.3.4
1238	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Impulse voltage test	IS/IEC 61730-2, Clause 10.12
1239	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Insulation test	IEC 61215-2, Clause 4.3
1240	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Insulation test	IS 14286 (Part 2), Clause 4.3
1241	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Insulation test	IS/IEC 61730-2, Clause 10.13
1242	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules	Insulation Thickness Test, Wet leakage current test	IEC 61215-1, Clause 7.4
1243	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules	Insulation Thickness Test, Wet leakage current test	IS 14286 (PART 1), Clause 7.4
1244	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Lap Shear Strength Test	IS/IEC 61730-2, Clause 10.25
1245	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Major visual defects	IS 14286 (PART 1), Clause 8
1246	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Marking and documentation	IEC 61215-1, Clause 5
1247	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Marking and documentation	IS 14286 (PART 1), Clause 5

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1248	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Materials creep test	IS/IEC 61730-2, Clause 10.26
1249	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Maximum power determination	IS/IEC 61730-2, Clause 10.4
1250	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules	Maximum Power point determination	IEC 61215-1, Clause 6
1251	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules	Maximum Power point determination	IS 14286 (PART 1), Rev 2.0, Clause 6
1252	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Measurement of temperature coefficients	IEC 61215-2, Clause 4.4
1253	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Measurement of temperature coefficients	IS 14286 (Part 2), Clause 4.4
1254	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Mechanical Load Test, Module Breakage Test, Material Creepage Test, Equipotential bonding Test	IS/IEC 61730-1, Clause 5.4.1 , 5.4.5
1255	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Module breakage test	IS/IEC 61730-2, Clause 10.21
1256	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Outdoor exposure test	IEC 61215-2, Clause 4.8
1257	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Outdoor exposure test	IS 14286 (Part 2), Clause 4.8
1258	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Peel Test	IS/IEC 61730-2, Clause 10.24
1259	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Performance at low irradiance	IEC 61215-2, Clause 4.7
1260	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Performance at low irradiance	IS 14286 (Part 2), Clause 4.7

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1261	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Performance at STC	IEC 61215-2 ,Clause 4.2
1262	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Performance at STC	IS 14286 (Part 2), Clause 4.2
1263	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Performance at STC	IS/IEC 61730-2, Clause 10.3
1264	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Performance at STC and NMOT	IEC 61215-2, Clause 4.6
1265	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Performance at STC and NMOT	IS 14286 (Part 2), Clause 4.6
1266	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Requirements for design and construction	IS/IEC 61730-1, Clause 5
1267	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Reverse Current overload test	IS/IEC 61730-2, Clause 10.20
1268	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Robustness of Termination test	IEC 61215-2, Clause 4.14
1269	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Robustness of Termination test	IS 14286 (Part 2), Clause 4.14
1270	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Robustness of Termination test	IS/IEC 61730-2, Clause 10.27
1271	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Screw Connection Test	IS/IEC 61730-1, Clause 5.4.2
1272	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Screw Connection Test	IS/IEC 61730-2, Clause 10.22
1273	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Sharp edge Test	IS/IEC 61730-2, Clause 10.7
1274	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Sharp Edge Test, Screw Connection Test	IS/IEC 61730-1, Clause 5.1

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
1275	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Stabilization	IEC 61215-2, Clause 4.19
1276	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Stabilization	IS 14286 (Part 2), Clause 4.19
1277	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Static mechanical load test	IEC 61215-2, Clause 4.16
1278	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Static mechanical load test	IS 14286 (Part 2), Clause 4.16
1279	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Static mechanical load test	IS/IEC 61730-2, Clause 10.23
1280	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Temperature Test	IS/IEC 61730-1, Clause 5.5.2.3.3
1281	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Temperature test	IS/IEC 61730-2, Clause 10.15
1282	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Thermal cycling test	IEC 61215-2, Clause 4.11
1283	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Thermal cycling test	IS 14286 (Part 2), Clause 4.11
1284	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Thermal cycling test	IS/IEC 61730-2, Clause 10.28
1285	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	UV preconditioning	IEC 61215-2, Clause 4.10
1286	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	UV preconditioning	IS 14286 (Part 2), Clause 4.10
1287	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules	Visual Inspection	ANSI/UL 61215-1-2017, Clause 8
1288	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Visual inspection	ANSI/UL 61730-2-2020, Clause 10.2

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1289	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules	Visual Inspection	IEC 61215-1, Clause 8
1290	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Visual inspection	IEC 61215-2, Clause 4.1
1291	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules	Visual Inspection	IS 14286 (PART 1), Clause 8
1292	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Visual inspection	IS 14286 (Part 2), Clause 4.1
1293	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Visual inspection	IS/IEC 61730, Clause 10.2
1294	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Visual Inspection, Accessibility Test	IS/IEC 61730-1, Clause 5.5.2.3.4
1295	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Visual Inspection, Bypass Thermal test , Hot Spot Endurance Test, Bypass diode Functionality Test	IS/IEC 61730-1, Clause 5.3.10
1296	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules	Visual Inspection, Insulation Test, Hot Spot Endurance Test, Wet Leakage Current Test, Stabilization	IEC 61215-1, Clause 6
1297	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules	Visual Inspection, Insulation Test, Hot Spot Endurance Test, Wet Leakage Current Test, Stabilization	IS 14286 (PART 1), Clause 6
1298	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Visual Inspection, Continuity Test, Screw Connection test	IS/IEC 61730-1, Clause 5.3.8.1
1299	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Wet leakage current test	IEC 61215, Clause 4.15
1300	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Wet leakage current test	IS 14286 (Part 2), Clause 4.15
1301	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Wet leakage current test	IS/IEC 61730-2, Clause 10.14

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1302	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules -crystalline silicon photovoltaic (PV) Modules	UV Preconditioning Test	IS 14286 (Part 1/Sec 1) , Clause 11.10
1303	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Visual Inspection	ANSI/UL 61215-1-3-2018, Clause 11.1:
1304	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Bypass Diode Thermal Test	IEC 61215-1-3, Clause 11.18
1305	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Bypass Diode Thermal Test	IS 14286 (Part 1/Sec 3) , Clause 11.18
1306	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Damp Heat Test	IEC 61215-1-3, Clause 11.13
1307	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Damp Heat Test	IS 14286 (Part 1/Sec 3) , Clause 11.13
1308	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Hail Test	IEC 61215-1-3, Clause 11.17
1309	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Hail Test	IS 14286 (Part 1/Sec 3), Clause 11.17
1310	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Hot Spot Endurance Test	IEC 61215-1-3, Clause 11.9
1311	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Hot Spot Endurance Test	IS 14286 (Part 1/Sec 3) , Clause 11.9
1312	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Humidity Freeze Test	IEC 61215-1-3, Clause 11.12
1313	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Humidity Freeze Test	IS 14286 (Part 1/Sec 3) , Clause 11.12
1314	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Insulation test	IEC 61215-1-3, Clause 11.3
1315	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Insulation test	IS 14286 (Part 1/Sec 3), Clause 11.3

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1316	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Maximum Power determination	IEC 61215-1-3, Clause 11.2
1317	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Maximum Power determination	IS 14286 (Part 1/Sec 3) , Clause 11.2
1318	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Measurement of Temperature coefficient	IEC 61215-1-3, Clause 11.4
1319	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Measurement of Temperature coefficient	IS 14286 (Part 1/Sec 3), Clause 11.4
1320	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Outdoor exposure test	IEC 61215-1-3, Clause 11.8
1321	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Outdoor exposure test	IS 14286 (Part 1/Sec 3) , Clause 11.8
1322	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Performance at Low Irradiance	IEC 61215-1-3, Clause 11.7
1323	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Performance at Low Irradiance	IS 14286 (Part 1/Sec 3) , Clause 11.7
1324	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Performance at STC and NMOT	IEC 61215-1-3, Clause 11.6
1325	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Performance at STC and NMOT	IS 14286 (Part 1/Sec 3) , Clause 11.6
1326	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Robustness of Termination test	IEC 61215-1-3, Clause 11.14
1327	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Robustness of Termination test	IS 14286 (Part 1/Sec 3) , Clause 11.14
1328	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Stabilization	IEC 61215-1-3, Clause 11.19
1329	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Stabilization	IS 14286 (Part 1/Sec 3) , Clause 11.19

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
1330	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Static Mechanical Load Test	IEC 61215-1-3, Clause 11.16
1331	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Static Mechanical Load Test	IS 14286 (Part 1/Sec 3) , Clause 11.16
1332	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Thermal Cycling Test	IEC 61215-1-3, Clause 11.11
1333	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	UV Preconditioning Test	IEC 61215-1-3, Clause 11.10
1334	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Visual Inspection	IEC 61215-1-3, Clause 11.1
1335	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Visual Inspection	IS 14286 (Part 1/Sec 3) , Clause 11.1
1336	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Wet Leakage Current Test	IEC 61215-1-3, Clause 11.15
1337	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Wet Leakage Current Test	IS 14286 (Part 1/Sec 3) , Clause 11.15
1338	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Visual Inspection	ANSI/UL 61215-1-2-2018, Clause 11.1
1339	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Bypass Diode Thermal Test	IEC 61215-1-2, Clause 11.18
1340	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Bypass Diode Thermal Test	IS 14286 (Part 1/Sec 2) , Clause 11.18
1341	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Damp Heat Test	IEC 61215-1-2, Clause 11.13
1342	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Damp Heat Test	IS 14286 (Part 1/Sec 2) , Clause 11.13
1343	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Hail Test	IEC 61215-1-2, Clause 11.17

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1344	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Hail Test	IS 14286 (Part 1/Sec 2) , Clause 11.17
1345	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Hot Spot Endurance Test	IEC 61215-1-2, Clause 11.9
1346	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Hot Spot Endurance Test	IS 14286 (Part 1/Sec 2), Clause 11.9
1347	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Humidity Freeze Test	IEC 61215-1-2, Clause 11.12
1348	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Humidity Freeze Test	IS 14286 (Part 1/Sec 2) , Clause 11.12
1349	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Insulation test	IEC 61215-1-2, Clause 11.3
1350	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Insulation test	IS 14286 (Part 1/Sec 2), , Clause 11.3
1351	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Maximum Power determination	IEC 61215-1-2, Clause 11.2
1352	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Maximum Power determination	IS 14286 (Part 1/Sec 2), Clause 11.2
1353	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Measurement of Temperature coefficient	IEC 61215-1-2, Clause 11.4
1354	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Measurement of Temperature coefficient	IS 14286 (Part 1/Sec 2) , Clause 11.4
1355	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Outdoor exposure test	IEC 61215-1-2, Clause 11.8
1356	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Outdoor exposure test	IS 14286 (Part 1/Sec 2) , Clause 11.8
1357	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Performance at Low Irradiance	IEC 61215-1-2, Clause 11.7

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1358	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Performance at Low Irradiance	IS 14286 (Part 1/Sec 2), Clause 11.7
1359	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Performance at STC and NMOT	IS 14286 (Part 1/Sec 2), Clause 11.6
1360	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Robustness of Termination test	IEC 61215-1-2, Clause 11.14
1361	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Robustness of Termination test	IS 14286 (Part 1/Sec 2), Clause 11.14
1362	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Stabilization	IEC 61215-1-2, Clause 11.19
1363	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Stabilization	IS 14286 (Part 1/Sec 2) , Clause 11.19
1364	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Static Mechanical Load Test	IEC 61215-1-2, Clause 11.16
1365	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Static Mechanical Load Test	IS 14286 (Part 1/Sec 2), Clause 11.16
1366	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Thermal Cycling Test	IEC 61215-1-2, Clause 11.11
1367	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Thermal Cycling Test	IS 14286 (Part 1/Sec 2) , Clause 11.11
1368	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	UV Preconditioning Test	IEC 61215-1-2, Clause 11.10
1369	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	UV Preconditioning Test	IS 14286 (Part 1/Sec 2) , Clause 11.10
1370	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Visual Inspection	IEC 61215-1-2, Clause 11.1
1371	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Visual Inspection	IS 14286 (Part 1/Sec 2), Clause 11.1

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1372	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Wet Leakage Current Test	IEC 61215-1-2, Clause 11.15
1373	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Wet Leakage Current Test	IS 14286 (Part 1/Sec 2) , Clause 11.15
1374	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Visual Inspection	ANSI/UL 61215-1-4-2018, Clause 11.1
1375	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Bypass Diode Thermal Test	IEC 61215-1-4, Clause 11.18
1376	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Bypass Diode Thermal Test	IS 14286 (Part 1/Sec 4) , Clause 11.18
1377	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Damp Heat Test	IEC 61215-1-4, Clause 11.13
1378	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Damp Heat Test	IS 14286 (Part 1/Sec 4) , Clause 11.13
1379	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Hail Test	IEC 61215-1-4, Clause 11.17
1380	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Hail Test	IS 14286 (Part 1/Sec 4) , Clause 11.17
1381	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Hot Spot Endurance Test	IEC 61215-1-4, Clause 11.9
1382	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Hot Spot Endurance Test	IS 14286 (Part 1/Sec 4) , Clause 11.9
1383	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Humidity Freeze Test	IEC 61215-1-4, Clause 11.12
1384	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Humidity Freeze Test	IS 14286 (Part 1/Sec 4) , Clause 11.12
1385	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Insulation test	IEC 61215-1-4, Clause 11.3

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1386	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Insulation test	IS 14286 (Part 1/Sec 4), , Clause 11.3
1387	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Maximum Power determination	IEC 61215-1-4, Clause 11.2
1388	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Maximum Power determination	IS 14286 (Part 1/Sec 4), Clause 11.2
1389	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Measurement of Temperature coefficient	IEC 61215-1-4, Clause 11.4
1390	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Measurement of Temperature coefficient	IS 14286 (Part 1/Sec 4) , Clause 11.4
1391	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Outdoor exposure test	IEC 61215-1-4, Clause 11.8
1392	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Outdoor exposure test	IS 14286 (Part 1/Sec 4) , Clause 11.8
1393	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Performance at Low Irradiance	IEC 61215-1-4, Clause 11.7
1394	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Performance at Low Irradiance	IS 14286 (Part 1/Sec 4) , Clause 11.7
1395	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Performance at STC and NMOT	IEC 61215-1-4, Clause 11.6
1396	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Performance at STC and NMOT	IS 14286 (Part 1/Sec 4) , Clause 11.6
1397	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Robustness of Termination test	IEC 61215-1-4, Clause 11.14
1398	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Robustness of Termination test	IS 14286 (Part 1/Sec 4) , Clause 11.14
1399	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Stabilization	IEC 61215-1-4, Clause 11.19

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1400	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Stabilization	IS 14286 (Part 1/Sec 4) , Clause 11.19
1401	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Static Mechanical Load Test	IEC 61215-1-4, Clause 11.16
1402	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Static Mechanical Load Test	IS 14286 (Part 1/Sec 4) , Clause 11.16
1403	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Thermal Cycling Test	IEC 61215-1-4, Clause 11.11
1404	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Thermal Cycling Test	IS 14286 (Part 1/Sec 4), Clause 11.11
1405	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	UV Preconditioning Test	IEC 61215-1-4, Clause 11.10
1406	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	UV Preconditioning Test	IS 14286 (Part 1/Sec 4) , Clause 11.10
1407	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Visual Inspection	IEC 61215-1-4, Clause 11.1
1408	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Visual Inspection	IS 14286 (Part 1/Sec 4), Clause 11.1
1409	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Wet Leakage Current Test	IEC 61215-1-4, Clause 11.15
1410	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Wet Leakage Current Test	IS 14286 (Part 1/Sec 4) , Clause 11.15
1411	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Visual Inspection	ANSI/UL 61215-1-1-2018, Clause 11.1
1412	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Bypass Diode Thermal Test	IEC 61215-1-1, Clause 11.18
1413	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Bypass Diode Thermal Test	IS 14286 (Part 1/Sec 1) , Clause 11.18

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1414	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Damp Heat Test	IEC 61215-1-1, Clause 11.13
1415	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Damp Heat Test	IS 14286 (Part 1/Sec 1) , Clause 11.13
1416	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Hail Test	IEC 61215-1-1, Clause 11.17
1417	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Hail Test	IS 14286 (Part 1/Sec 1) , Clause 11.17
1418	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Hot Spot Endurance Test	IEC 61215-1-1, Clause 11.9
1419	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Hot Spot Endurance Test	IS 14286 (Part 1/Sec 1) , Clause 11.9
1420	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Humidity Freeze Test	IEC 61215-1-1, Clause 11.12
1421	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Humidity Freeze Test	IS 14286 (Part 1/Sec 1), Clause 11.12
1422	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Insulation test	IEC 61215-1-1, Clause 11.3
1423	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Insulation test	IS 14286 (Part 1/Sec 1) , Clause 11.3
1424	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Maximum Power determination	IEC 61215-1-1, Clause 11.2
1425	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Maximum Power determination	IS 14286 (Part 1/Sec 1) , Clause 11.2
1426	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Measurement of Temperature coefficient	IEC 61215-1-1, Clause 11.4
1427	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Measurement of Temperature coefficient	IS 14286 (Part 1/Sec 1) , Clause 11.4

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1428	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Outdoor exposure test	IEC 61215-1-1, Clause 11.8
1429	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Outdoor exposure test	IS 14286 (Part 1/Sec 1) , Clause 11.8
1430	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Performance at Low Irradiance	IEC 61215-1-1, Clause 11.7
1431	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Performance at Low Irradiance	IS 14286 (Part 1/Sec 1) , Clause 11.7
1432	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Performance at STC and NMOT	IEC 61215-1-1, Clause 11.6
1433	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Performance at STC and NMOT	IS 14286 (Part 1/Sec 1) , Clause 11.6
1434	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Robustness of Termination test	IEC 61215-1-1, Clause 11.14
1435	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Robustness of Termination test	IS 14286 (Part 1/Sec 1) , Clause 11.14
1436	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Stabilization	IEC 61215-1-1, Clause 11.19
1437	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Stabilization	IS 14286 (Part 1/Sec 1) , Clause 11.19
1438	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Static Mechanical Load Test	IEC 61215-1-1, Clause 11.16
1439	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Static Mechanical Load Test	IS 14286 (Part 1/Sec 1) , Clause 11.16
1440	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Thermal Cycling Test	IEC 61215-1-1, Clause 11.11
1441	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Thermal Cycling Test	IS 14286 (Part 1/Sec 1), Clause 11.11

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1442	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	UV Preconditioning Test	IEC 61215-1-1, Clause 11.10
1443	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Visual Inspection	IEC 61215-1-1, Clause 11.1
1444	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Visual Inspection	IS 14286 (Part 1/Sec 1) , Clause 11.1
1445	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Wet Leakage Current Test	IEC 61215-1-1, Clause 11.15
1446	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Wet Leakage Current Test	IS 14286 (Part 1/Sec 1), Clause 11.15
1447	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin Film PV Module (Cd Te, CIS, a-Si)	Maximum Power Determination	IEC 60904-2:2015 Clause 12.3
1448	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Bypass diode thermal Test	IEC 61646 (2nd Edition): 2008-05. Clause. 10.18
1449	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Bypass diode thermal Test	IS 16077 : 2013, Clause 10.18
1450	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Damp heat Test	IEC 61646 (2nd Edition): 2008-05. Clause. 10.13
1451	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Damp heat Test	IS 16077 : 2013, Clause 10.13
1452	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Hail Test	IEC 61646 (2nd Edition) , Clause. 10.17
1453	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Hail Test	IS 16077, Clause 10.17
1454	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Hot-spot endurance Test	IEC 61646 (2nd Edition), Clause. 10.9
1455	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Hot-spot endurance Test	IS 16077 , Clause 10.9

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1456	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Humidity-freeze Test	IEC 61646 (2nd Edition) , Clause. 10.12
1457	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Humidity-freeze Test	IS 16077 , Clause 10.12
1458	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Insulation Test	IEC 61646 (2nd Edition) , Clause. 10.3
1459	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Insulation Test	IS 16077 , Clause 10.2
1460	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Light Soaking	IEC 61646 (2nd Edition) , Clause. 10.19
1461	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Light Soaking	IS 16077 , Clause 10.19
1462	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Maximum power determination	IEC 61646 (2nd Edition) , Clause. 10.2
1463	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Maximum power determination	IS 16077 , Clause 10.2
1464	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Measurement of temperature coefficients	IEC 61646 (2nd Edition) , Clause. 10.4
1465	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Measurement of temperature coefficients	IS 16077 , Clause 10.4
1466	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Mechanical load Test	IEC 61646 (2nd Edition) , Clause. 10.16
1467	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Mechanical load Test	IS 16077 , Clause 10.16
1468	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Outdoor exposure Test	IEC 61646 (2nd Edition) , Clause. 10.8
1469	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Outdoor exposure Test	IS 16077 , Clause 10.8

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1470	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Performance at low irradiance	IEC 61646 (2nd Edition) , Clause. 10.7
1471	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Performance at low irradiance	IS 16077 , Clause 10.7
1472	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Performance at STC and NOCT	IEC 61646 (2ndEdition) , Clause. 10.6
1473	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Performance at STC and NOCT	IS 16077 , Clause 10.6
1474	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Robustness of terminations Test	IEC 61646 (2nd Edition) , Clause. 10.14
1475	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Robustness of terminations Test	IS 16077 , Clause 10.14
1476	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Thermal cycling Test	IEC 61646 (2nd Edition) , Clause. 10.11
1477	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Thermal cycling Test	IS 16077 , Clause 10.11
1478	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	UV preconditioning Test	IEC 61646 (2nd Edition) , Clause. 10.10
1479	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	UV preconditioning Test	IS 16077 , Clause 10.10
1480	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Visual inspection	IEC 61646 (2nd Edition) , Clause. 10.1
1481	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Visual inspection	IS 16077 , Clause 10.1
1482	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Wet leakage current Test	IEC 61646 (2nd Edition), Clause. 10.15
1483	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Wet leakage current Test	IS 16077 , Clause 10.15

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1484	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Autonomy/Discharge of Lights/Fan loads	MNRE - Technical specifications for White led (W-LED) based Solar Photovoltaic Lighting Systems (Off-grid Solar Applications Scheme 2016)
1485	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Autonomy/Discharge of Lights/Fan loads	Technical specifications for 12W White-LED based Solar Street Lighting System
1486	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Average duty cycle, Light output during duty cycle	MNRE - Technical specifications for White led (W-LED) based Solar Photovoltaic Lighting Systems (Off-grid Solar Applications Scheme 2016)
1487	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Average duty cycle, Light output during duty cycle	Technical specifications for 12W White-LED based Solar Street Lighting System
1488	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Battery Temperature compensation	MNRE - Technical specifications for White led (W-LED) based Solar Photovoltaic Lighting Systems (Off-grid Solar Applications Scheme 2016)
1489	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Dusk to Dawn (only for Street lights)	MNRE - Technical specifications for White led (W-LED) based Solar Photovoltaic Lighting Systems (Off-grid Solar Applications Scheme 2016)
1490	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Dusk to Dawn (only for Street lights)	Technical specifications for 12W White-LED based Solar Street Lighting System-
1491	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Electronic Protections (No load/Open circuit, Short circuit, PV & Battery reverse polarity, Reverse flow of current through PV module)	MNRE - Technical specifications for White led (W-LED) based Solar Photovoltaic Lighting Systems (Off-grid Solar Applications Scheme 2016)
1492	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Electronic Protections (No load/Open circuit, Short circuit, PV & Battery reverse polarity, Reverse flow of current through PV module)	Technical specifications for 12W White-LED based Solar Street Lighting System

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1493	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Electronics Efficiency	MNRE - Technical specifications for White led (W-LED) based Solar Photovoltaic Lighting Systems (Off-grid Solar Applications Scheme 2016)
1494	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Facility for Mobile Charging via USB	MNRE - Technical specifications for White led (W-LED) based Solar Photovoltaic Lighting Systems (Off-grid Solar Applications Scheme 2016)
1495	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Idle current	MNRE - Technical specifications for White led (W-LED) based Solar Photovoltaic Lighting Systems (Off-grid Solar Applications Scheme 2016)
1496	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Impact resistance of casing	Technical specifications for 12W White-LED based Solar Street Lighting System
1497	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Indicators	MNRE - Technical specifications for White led (W-LED) based Solar Photovoltaic Lighting Systems (Off-grid Solar Applications Scheme 2016)
1498	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Indicators	Technical specifications for 12W White-LED based Solar Street Lighting System
1499	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Ingress Protection	Technical specifications for 12W White-LED based Solar Street Lighting System
1500	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	No load current	MNRE - Technical specifications for White led (W-LED) based Solar Photovoltaic Lighting Systems (Off-grid Solar Applications Scheme 2016)
1501	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Protection against Battery over charge & Deep discharge condition	MNRE - Technical specifications for White led (W-LED) based Solar Photovoltaic Lighting Systems (Off-grid Solar Applications Scheme 2016)

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1502	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Protection against Battery over charge & Deep discharge condition	Technical specifications for 12W White-LED based Solar Street Lighting System
1503	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	PV charging Efficiency/ MPPT Efficiency	MNRE - Technical specifications for White led (W-LED) based Solar Photovoltaic Lighting Systems (Off-grid Solar Applications Scheme 2016)
1504	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	PV charging Efficiency/ MPPT Efficiency	Technical specifications for 12W White-LED based Solar Street Lighting System
1505	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Voltage drop from module terminals to the battery	MNRE - Technical specifications for White led (W-LED) based Solar Photovoltaic Lighting Systems (Off-grid Solar Applications Scheme 2016)
1506	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Battery Temperature compensation	Technical specifications for Solar Study Lamp
1507	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Electronic Protections (No load/Open circuit, Short circuit, PV & Battery reverse polarity, Reverse flow of current through PV module)	Technical specifications for Solar Study Lamp
1508	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Electronics Efficiency	Technical specifications for Solar Study Lamp
1509	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Facility for Mobile Charging via USB	Technical specifications for Solar Study Lamp
1510	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	No load current	Technical specifications for Solar Study Lamp
1511	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Protection against Battery over charge & Deep discharge condition	Technical specifications for Solar Study Lamp

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1512	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Run Time	Technical specifications for Solar Study Lamp
1513	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – Power Conditioners-Photovoltaic Inverters (Up to 60 kW)	Utility-Interconnected Photovoltaic Inverter- Test for Islanding Prevention	IS 16169 , Clause 6
1514	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – Power Conditioners-Photovoltaic Inverters	DC Injection	IEC 61727 (2nd Edition),Clause. 4.4
1515	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – Power Conditioners-Photovoltaic Inverters	Dynamic MPPT Efficiency	EN 50530, Clause. 4.4
1516	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – Power Conditioners-Photovoltaic Inverters	Efficiency Measurement conditions, Efficiency Calculations, Efficiency Test circuits	IS/IEC 61683, Clause 4, 5, 6.
1517	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – Power Conditioners-Photovoltaic Inverters	Harmonics &Waveform Distortion	IEC 61727 (2nd Edition), Clause 4.6
1518	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – Power Conditioners-Photovoltaic Inverters	Limits for harmonic current emissions (equipment input current =16 A per phase)	IEC 61000-3-2 Ed 5.1
1519	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – Power Conditioners-Photovoltaic Inverters	Limits for harmonic currents produced by equipment connected to public low-voltage systems with input current >16 A and =75 A per phase	IEC 61000-3-12 Ed 2.0
1520	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – Power Conditioners-Photovoltaic Inverters	Loss of Utility Voltage	IEC 61727 (2nd Edition),Clause 5.1
1521	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – Power Conditioners-Photovoltaic Inverters	Over/Under Voltage and Frequency	IEC 61727 (2ndEdition),Clause:- 5.2
1522	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – Power Conditioners-Photovoltaic Inverters	Power Factor	IEC 61727 (2nd Edition),Clause. 4.7
1523	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – Power Conditioners-Photovoltaic Inverters	Response to Utility Recovery	IEC 61727 (2nd Edition),Clause 5.4
1524	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – Power Conditioners-Photovoltaic Inverters	Static MPPT Efficiency	EN 50530, Clause. 4.3
1525	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – Power Conditioners-Photovoltaic Inverters	Static Power Conversion Efficiency	EN 50530, Clause. 4.5
1526	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – Power Conditioners-Photovoltaic Inverters	Unintentional Islanding Test	IEEE 1547.1,Clause. 5.7

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1527	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – Power Conditioners-Photovoltaic Inverters	Utility-Interconnected Photovoltaic Inverter- Test for Islanding Prevention	IEC 62116 (Edition 2.0),Clause: 6.
1528	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Photovoltaic Systems – Power Conditioners-Photovoltaic Inverters	Utility-Interconnected Photovoltaic Inverter- Test for Islanding Prevention	IS 16169,Clause 6
1529	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Sonic pressure and sound level	IS 16221 (Part 1), Clause. 10.2
1530	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Additional requirements for openings in transportable equipment	IEC 62109-1 (Edition 1.0), Clause. 9.1.4.6
1531	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Additional requirements for openings in transportable equipment	IS 16221 (Part 1), Clause. 9.1.4.6
1532	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Back feed current test for equipment with more than one source of supply	IEC 62109-1 (Edition 1.0), Clause. 4.4.4.6
1533	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Back feed current test for equipment with more than one source of supply	IS 16221 (Part 1), Clause. 4.4.4.6
1534	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Back feed voltage protection test under normal condition	IEC 62109-1 (Edition 1.0), Clause. 4.6.1
1535	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Back feed voltage protection test under normal condition	IS 16221 (Part 1), Clause. 4.6.1
1536	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Back feed voltage protection test under single fault condition	IEC 62109-1 (Edition 1.0), Clause. 4.6.2
1537	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Back feed voltage protection test under single fault condition	IS 16221 (Part 1), Clause. 4.6.2
1538	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Chemical hazards	IEC 62109-1 (Edition 1.0), Clause. 12
1539	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Chemical hazards	IS 16221 (Part 1), Clause. 12
1540	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Circuits or components used as transient overvoltage limiting devices	IEC 62109-1 (Edition 1.0), Clause.14.7
1541	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Circuits or components used as transient overvoltage limiting devices	IS 16221 (Part 1), Clause.14.7

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1542	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Clearance Distance	IEC 62109-1 (Edition 1.0), Clause. 7.3.7.4
1543	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Clearance Distance	IS 16221 (Part 1), Clause. 7.3.7.4
1544	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Component fault tests	IEC 62109-1 (Edition 1.0),Clause. 4.4.4.1
1545	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Component fault tests	IS 16221 (Part 1), Clause. 4.4.4.1
1546	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Conditions for a fire enclosure	IEC 62109-1 (Edition 1.0), Clause. 9.1.2
1547	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Conditions for a fire enclosure	IS 16221 (Part 1), Clause. 9.1.2
1548	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Cooling system failure	IEC 62109-1 (Edition 1.0), Clause. 4.4.4.8
1549	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Cooling system failure	IS 16221 (Part 1), Clause. 4.4.4.8
1550	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Cord anchorages and strain relief	IEC 62109-1 (Edition 1.0), Clause. 13.3.2.5
1551	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Cord anchorages and strain relief	IS 16221 (Part 1), Clause. 13.3.2.5
1552	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Creepage distance	IEC 62109-1 (Edition 1.0), Clause. 7.3.7.5
1553	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Creepage distance	IS 16221 (Part 1), Clause. 7.3.7.5
1554	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Durability of markings	IEC 62109-1 (Edition 1.0), Clause. 5.1.2
1555	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Durability of markings	IS 16221 (Part 1), Clause. 5.1.2
1556	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Electrical ratings tests	IEC 62109-1 (Edition 1.0), Clause. 4.7, 4.7.1, 4.7.2
1557	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Electrical ratings tests	IS 16221 (Part 1), Clause. 4.7, 4.7.1, 4.7.2
1558	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Equipment or parts for short-term or intermittent operation	IEC 62109-1 (Edition 1.0), Clause. 4.4.4.2
1559	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Equipment or parts for short-term or intermittent operation	IS 16221 (Part 1),Clause. 4.4.4.2
1560	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Fluid pressure and leakage	IEC 62109-1 (Edition 1.0), Clause. 11.2

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1561	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Fluid pressure and leakage	IS 16221 (Part 1), Clause. 11.2
1562	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Handles and manual controls	IEC 62109-1 (Edition 1.0), Clause. 13.1
1563	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Handles and manual controls	IS 16221 (Part 1), Clause. 13.1
1564	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Heating devices	IEC 62109-1 (Edition 1.0), Clause. 4.4.4.9
1565	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Heating devices	IS 16221 (Part 1), Clause. 4.4.4.9
1566	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Humidity preconditioning	IEC 62109-1 (Edition 1.0), Clause. 4.5, 4.5.1, 4.5.2
1567	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Humidity preconditioning	IS 16221 (Part 1), Clause. 4.5, 4.5.1, 4.5.2
1568	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Humidity pre-conditioning	IEC 62109-1 (Edition 1.0), Clause. 7.5.2.3
1569	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Humidity pre-conditioning	IS 16221 (Part 1), Clause. 7.5.2.3
1570	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Impulse voltage test (type test)	IEC 62109-1 (Edition 1.0), Clause. 7.5.1
1571	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Impulse voltage test (type test)	IS 16221 (Part 1), Clause. 7.5.1
1572	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Ingress Protection	IEC 62109-1 (Edition 1.0), Clause. 6.3 (Reference IEC 60529)
1573	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Ingress Protection	IS 16221 (Part 1),Clause. 6.3, (Reference IEC 60529)
1574	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Limitation of current through protective impedance	EC 62109-1 (Edition 1.0), Clause. 7.3.5.3.1
1575	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Limitation of current through protective impedance	IS 16221 (Part 1), Clause. 7.3.5.3.1
1576	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Limited power source tests	IEC 62109-1 (Edition 1.0), Clause. 9.2.2
1577	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Limited power source tests	IS 16221 (Part 1), Clause. 9.2.2
1578	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Liquid containment, pressure and leakage	IEC 62109-1 (Edition 1.0), Clause. 11.1

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1579	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Liquid containment, pressure and leakage	IS 16221 (Part 1), Clause. 11.1
1580	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Material requirements for protection against fire hazard	IEC 62109-1 (Edition 1.0), Clause. 9.1.3
1581	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Material requirements for protection against fire hazard	IS 16221 (Part 1), Clause. 9.1.3
1582	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Mechanical resistance to deflection, impact, or drop	IEC 62109-1 (Edition 1.0), Clause. 13.7
1583	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Mechanical resistance to deflection, impact, or drop	IS 16221 (Part 1), Clause. 13.7
1584	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Mis-wiring with incorrect phase sequence or polarity	IEC 62109-1 (Edition 1.0), Clause. 4.4.4.13
1585	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Mis-wiring with incorrect phase sequence or polarity	IS 16221 (Part 1), Clause. 4.4.4.13
1586	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Motor overtemperature protection	IEC 62109-1 (Edition 1.0), Clause.14.2
1587	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Motor overtemperature protection	IS 16221 (Part 1), Clause.14.2
1588	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Motors (Lock rotor)	IEC 62109-1 (Edition 1.0), Clause. 4.4.4.3
1589	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Motors (Lock rotor)	IS 16221 (Part 1), Clause. 4.4.4.3
1590	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Moving Parts	IEC 62109-1 (Edition 1.0), Clause. 8.2
1591	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Moving Parts	IS 16221 (Part 1), Clause. 8.2
1592	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Openings in enclosures	IEC 62109-1 (Edition 1.0), Clause. 13.5
1593	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Openings in enclosures	IS 16221 (Part 1), Clause. 13.5
1594	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Openings in fire enclosures	IEC 62109-1 (Edition 1.0), Clause. 9.1.4
1595	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Openings in fire enclosures	IS 16221 (Part 1), Clause. 9.1.4
1596	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Output overload	IEC 62109-1 (Edition 1.0),Clause. 4.4.4.7
1597	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Output overload	IS 16221 (Part 1), Clause. 4.4.4.7

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1598	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Output short circuit	IEC 62109-1 (Edition 1.0),Clause. 4.4.4.5
1599	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Overtemperature protection devices	IEC 62109-1 (Edition 1.0), Clause. 14.3
1600	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Overtemperature protection devices	IS 16221 (Part 1), Clause. 14.3
1601	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Partial discharge test (type test or sample test)	IEC 62109-1 (Edition 1.0), Clause. 7.5.3
1602	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Partial discharge test (type test or sample test)	IS 16221 (Part 1), Clause. 7.5.3
1603	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Printed circuit boards	IEC 62109-1 (Edition 1.0), Clause.14.6
1604	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Printed circuit boards	IS 16221 (Part 1), Clause.14.6
1605	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Printed wiring board short-circuit test	IEC 62109-1 (Edition 1.0), Clause. 4.4.4.14
1606	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Printed wiring board short-circuit test	IS 16221 (Part 1), Clause. 4.4.4.14
1607	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	protection against direct contact	IEC 62109-1 (Edition 1.0), Clause. 7.3.4, 7.3.4.2
1608	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	protection against direct contact	IS 16221 (Part 1), Clause. 7.3.4, 7.3.4.2
1609	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection against electric shock	IEC 62109-1 (Edition 1.0),Clause. 7.3
1610	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection against electric shock	IS 16221 (Part 1),Clause. 7.3
1611	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection against energy hazards	IEC 62109-1 (Edition 1.0), Clause. 7.4
1612	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection against energy hazards	IS 16221 (Part 1), Clause. 7.4
1613	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection against indirect contact	IEC 62109-1 (Edition 1.0), Clause. 7.3.6.1, 7.3.6.2
1614	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection against indirect contact	IS 16221 (Part 1), Clause. 7.3.6.1, 7.3.6.2
1615	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection Against parts expulsion hazards	IS 16221 (Part 1),Clause.4.4.3.4
1616	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection against shock hazard	IEC 62109-1 (Edition 1.0),Clause. 4.4.3.1

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1617	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection against shock hazard	IS 16221 (Part 1), Clause 4.4.3.1
1618	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection against shock hazard due to stored energy	IEC 62109-1 (Edition 1.0), Clause. 7.3.9
1619	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection against shock hazard due to stored energy	IS 16221 (Part 1), Clause. 7.3.9
1620	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection against spread of fire	IEC 62109-1 (Edition 1.0), Clause.4.4.3.2
1621	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection against spread of fire	IS 16221 (Part 1),Clause.4.4.3.2
1622	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection by means of insulation of live parts	IEC 62109-1 (Edition 1.0), Clause. 7.3.4.3
1623	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection by means of insulation of live parts	IS 16221 (Part 1), Clause. 7.3.4.3
1624	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection by means of limited voltages	IEC 62109-1 (Edition 1.0), Clause. 7.3.5.4
1625	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection by means of limited voltages	IS 16221 (Part 1), Clause. 7.3.5.4
1626	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection in case of direct contact	IEC 62109-1 (Edition 1.0), Clause. 7.3.5, 7.3.5.2
1627	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection in case of direct contact	IS 16221 (Part 1), Clause. 7.3.5, 7.3.5.2
1628	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protective class I - Protective bonding and earthing	IEC 62109-1 (Edition 1.0), Clause. 7.3.6.3
1629	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protective class I - Protective bonding and earthing	IS 16221 (Part 1), Clause. 7.3.6.3
1630	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Provisions for external connections	IEC 62109-1 (Edition 1.0), Clause. 13.3
1631	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Provisions for external connections	IEC 62109-1 (Edition 1.0), Clause. 13.3
1632	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Provisions for lifting and carrying	IEC 62109-1 (Edition 1.0), Clause. 8.4
1633	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Provisions for lifting and carrying	IS 16221 (Part 1), Clause. 8.4
1634	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Rating of protective bonding	IEC 62109-1 (Edition 1.0), Clause. 7.3.6.3.3
1635	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Rating of protective bonding	IS 16221 (Part 1), Clause. 7.3.6.3.3

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1636	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Reverse d.c. connections	IEC 62109-1 (Edition 1.0), Clause. 4.4.4.11
1637	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Reverse d.c. connections	IS 16221 (Part 1), Clause. 4.4.4.11
1638	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Safety interlock systems	IEC 62109-1 (Edition 1.0), Clause. 4.4.4.10
1639	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Safety interlock systems	IS 16221 (Part 1), Clause. 4.4.4.10
1640	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Securing of parts	IS 16221 (Part 1), Clause. 13.2
1641	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Short-circuit and overcurrent protection	IEC 62109-1 (Edition 1.0), Clause. 9.3
1642	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Short-circuit and overcurrent protection	IS 16221 (Part 1), Clause. 9.3
1643	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Short-term limits of accessible voltages under fault conditions	IEC 62109-1 (Edition 1.0), Clause. 7.3.2.3
1644	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Short-term limits of accessible voltages under fault conditions	IS 16221 (Part 1), Clause. 7.3.2.3
1645	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Software and firmware performing safety functions	IEC 62109-1 (Edition 1.0), Clause.15
1646	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Software and firmware performing safety functions	IS 16221 (Part 1), Clause.15
1647	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Sonic pressure and sound level	IEC 62109-1 (Edition 1.0), Clause. 10.2
1648	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Stability	IEC 62109-1 (Edition 1.0), Clause. 8.3
1649	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Stability	IS 16221 (Part 1), Clause. 8.3
1650	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Stress Relief test	IEC 62109-1 (Edition 1.0), Clause. 13.6.2.1
1651	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Stress Relief test	IS 16221 (Part 1), Clause. 13.6.2.1
1652	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Thermal Tests (Maximum temperature, Touch temperature, temperature limits for mount surfaces)	IEC 62109-1 (Edition 1.0),Clause. 4.3, 4.3.2, 4.3.2.2, 4.3.2.3

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1653	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Thermal Tests (Maximum temperature, Touch temperature, temperature limits for mount surfaces)	IS 16221 (Part 1),Clause. 4.3, 4.3.2, 4.3.2.2, 4.3.2.3
1654	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Thickness requirements for metal enclosures	IS 16221 (Part 1), Clause. 13.8
1655	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Touch current measurement	IEC 62109-1 (Edition 1.0), Clause. 7.5.4
1656	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Touch current measurement	IS 16221 (Part 1), Clause. 7.5.4
1657	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Transformer short circuit tests	IEC 62109-1 (Edition 1.0), Clause. 4.4.4.4
1658	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Transformer short circuit tests	IS 16221 (Part 1),Clause. 4.4.4.4
1659	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Use of coating materials	IEC 62109-1 (Edition 1.0), Clause. 7.3.7.8.4.2
1660	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Use of coating materials	IS 16221 (Part 1), Clause. 7.3.7.8.4.2
1661	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Visibility and legibility requirements for warning markings	IEC 62109-1 (Edition 1.0), Clause. 5.2.1
1662	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Visibility and legibility requirements for warning markings	IS 16221 (Part 1),Clause. 5.2.1
1663	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Voltage selector mismatch	IEC 62109-1 (Edition 1.0), Clause. 4.4.4.12
1664	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Voltage selector mismatch	IS 16221 (Part 1), Clause. 4.4.4.12
1665	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Voltage test (dielectric strength test)	IEC 62109-1 (Edition 1.0), Clause.7.5.2
1666	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Voltage test (dielectric strength test)	IS 16221 (Part 1), Clause.7.5.2
1667	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Wall mounting	IEC 62109-1 (Edition 1.0), Clause. 8.5
1668	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Wall mounting	IS 16221 (Part 1), Clause. 8.5
1669	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Wire bending space for wires 10 mm2 and greater	IEC 62109-1 (Edition 1.0), Clause. 13.3.5

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1670	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Wire bending space for wires 10 mm2 and greater	IS 16221 (Part 1), Clause. 13.3.5
1671	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Working voltage and DVC	IEC 62109-1 (Edition 1.0), Clause. 7.3.2.6
1672	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Working voltage and DVC	IS 16221 (Part 1), Clause. 7.3.2.6
1673	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Component fault tests	IEC 62109-1 (Edition 1.0),Clause. 4.4.4.1
1674	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Limitation of discharging energy through protective impedance	IEC 62109-1 (Edition 1.0), Clause. 7.3.5.3.2
1675	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Limitation of discharging energy through protective impedance	IS 16221 (Part 1), Clause. 7.3.5.3.2
1676	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Output short circuit	IS 16221 (Part 1), Clause. 4.4.4.5
1677	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Protection Against parts expulsion hazards	IEC 62109-1 (Edition 1.0), Clause.4.4.3.4
1678	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems (Up to 60 kW)	Securing of parts	IEC 62109-1 (Edition 1.0), Clause. 13.2
1679	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	30 mA touch current type test for isolated inverters	IEC 62109-2 1st Edition, Clause. 4.8.3.2
1680	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	30 mA touch current type test for isolated inverters	IS 16221 (Part 2), Clause. 4.8.3.2
1681	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Additional requirements for stand-alone inverters	IEC 62109-2 1st Edition, Clause. 7.3.10
1682	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Additional requirements for stand-alone inverters	IS 16221 (Part 2), Clause. 7.3.10
1683	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Array insulation resistance detection for inverters for functionally grounded Arrays	IEC 62109-2 1st Edition, Clause. 4.8.2.2
1684	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Array insulation resistance detection for inverters for functionally grounded Arrays	IS 16221 (Part 2), Clause. 4.8.2.2
1685	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Array insulation resistance detection for inverters for ungrounded arrays	IEC 62109-2 1st Edition, Clause. 4.8.2.1
1686	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Array insulation resistance detection for inverters for ungrounded arrays	IS 16221 (Part 2), Clause. 4.8.2.1

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1687	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Components	IEC 62109-2 1st Edition, Clause. 14
1688	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Components	IS 16221 (Part 2), Clause. 14
1689	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Cooling system failure – Blanketing test	IS 16221 (Part 2), Clause. 4.4.4.17
1690	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Fault indication	IEC 62109-2 1st Edition, Clause.13.9
1691	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Fault indication	IS 16221 (Part 2), Clause.13.9
1692	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Fault-tolerance of automatic disconnecting means	IEC 62109-2 1st Edition, Clause. 4.4.4.15.2
1693	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Fault-tolerance of automatic disconnecting means	IS 16221 (Part 2), Clause. 4.4.4.15.2
1694	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Fault-tolerance of residual current monitoring	IEC 62109-2 1st Edition , Clause. 4.4.4.15
1695	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Fault-tolerance of residual current monitoring	IS 16221 (Part 2), Clause. 4.4.4.15
1696	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Fire hazard residual current type test for isolated inverters	IEC 62109-2 1st Edition, Clause. 4.8.3.3
1697	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Fire hazard residual current type test for isolated inverters	IS 16221 (Part 2), Clause. 4.8.3.3
1698	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Inverter backfeed current onto the array	IEC 62109-2 1st Edition, Clause. 9.3.4
1699	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Inverter backfeed current onto the array	IS 16221 (Part 2), Clause. 9.3.4
1700	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Load step response of the output voltage at nominal DC input	IEC 62109-2 1st Edition, Clause. 4.7.4.4
1701	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Load step response of the output voltage at nominal DC input	IS 16221 (Part 2), Clause. 4.7.4.4
1702	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Marking and Documentation	IEC 62109-2 1st Edition, Clause. 5
1703	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Marking and Documentation	IS 16221 (Part 2), Clause. 5
1704	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Measurement requirements for AC output ports for stand-alone inverters	IEC 62109-2 1st Edition, Clause. 4.7.3

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1705	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Measurement requirements for AC output ports for stand-alone inverters	IS 16221 (Part 2), Clause. 4.7.3
1706	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Non-sinusoidal output waveform requirements	IEC 62109-2 1st Edition, Clause. 4.7.5.3
1707	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Non-sinusoidal output waveform requirements	IS 16221 (Part 2), Clause. 4.7.5.3
1708	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Output voltage waveform requirements for inverters for dedicated loads	IEC 62109-2 1st Edition, Clause. 4.7.5.5
1709	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Output voltage waveform requirements for inverters for dedicated loads	IS 16221 (Part 2), Clause. 4.7.5.5
1710	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Physical requirement	IS 16221 (Part 2), Clause. 13
1711	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Physical requirements	IEC 62109-2 1st Edition, Clause. 13
1712	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Protection against electric shock and energy hazards	IEC 62109-2 1st Edition, Clause. 7
1713	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Protection against electric shock and energy hazards	IS 16221 (Part 2), Clause. 7
1714	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Protection against fire hazards	IEC 62109-2 1st Edition, Clause. 9
1715	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Protection against fire hazards	IS 16221 (Part 2), Clause. 9
1716	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Protection against mechanical hazards	IEC 62109-2 1st Edition, Clause. 8
1717	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Protection against mechanical hazards	IS 16221 (Part 2), Clause. 8
1718	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Protection by residual current monitoring	IEC 62109-2 1st Edition, Clause. 4.8.3.5
1719	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Protection by residual current monitoring	IS 16221 (Part 2), Clause. 4.8.3.5
1720	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Sinusoidal output voltage waveform requirements	IEC 62109-2 1st Edition, Clause. 4.7.5.2
1721	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Sinusoidal output voltage waveform requirements	IS 16221 (Part 2), Clause. 4.7.5.2
1722	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Stand-alone Inverter AC output voltage and frequency	IEC 62109-2 1st Edition, Clause. 4.7.4

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1723	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Stand-alone Inverter AC output voltage and frequency	IS 16221 (Part 2), Clause. 4.7.4
1724	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Stand-alone inverter output voltage waveform	IEC 62109-2 1st Edition, Clause.4.7.5
1725	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Stand-alone inverter output voltage waveform	IS 16221 (Part 2), Clause.4.7.5
1726	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Stand-alone inverters – Load transfer test	IEC 62109-2 1st Edition, Clause. 4.4.4.16
1727	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Stand-alone inverters – Load transfer test	IS 16221 (Part 2), Clause. 4.4.4.16
1728	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Steady state output frequency	IS 16221 (Part 2), Clause. 4.7.4.5
1729	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Steady state output voltage across the DC input range	IEC 62109-2 1st Edition, Clause. 4.7.4.3
1730	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Steady state output voltage across the DC input range	IS 16221 (Part 2), Clause. 4.7.4.3
1731	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Steady state output voltage at nominal DC input	IS 16221 (Part 2), Clause. 4.7.4.2
1732	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Cooling system failure – Blanketing test	IEC 62109-2 1st Edition, Clause. 4.4.4.17
1733	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Steady state output frequency	IEC 62109-2 1st Edition, Clause. 4.7.4.5
1734	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Power converters for use in photovoltaic power systems – Part 2: Particular requirements for Inverters (Up to 60 kW)	Steady state output voltage at nominal DC input	IEC 62109-2 1st Edition, Clause. 4.7.4.2
1735	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Solar Photovoltaic Charge Controller	Determination of End of Charge Voltages	IEC 62093, Edition 1 ,Clause. 11.2.1.2.3.1
1736	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Solar Photovoltaic Charge Controller	Determination of Low Charge disconnect and Reconnect Voltages	IEC 62093, Edition 1 ,Clause. 11.2.1.2.3.3
1737	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Solar Photovoltaic Charge Controller	Determining the charge equalising voltage	IEC 62093, Edition 1 , Clause. 11.2.1.2.3.2
1738	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Solar Photovoltaic Charge Controller	Insulation Test	IEC 62093, Edition 1 ,Clause. 11.4
1739	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Solar Photovoltaic Charge Controller	Overload protection test	IEC 62093, Edition 1 ,Clause. 11.3.1.4
1740	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Solar Photovoltaic Charge Controller	Protection Against Mechanical Impact(IK-code)	IEC 62093, Edition 1 ,Clause. 11.6

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1741	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Solar Photovoltaic Charge Controller	Reverse-polarity protection test	IEC 62093, Edition 1 ,Clause. 11.3.1.3
1742	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Solar Photovoltaic Charge Controller	Temperature Compensation for Thresholds	IEC 62093, Edition 1, Clause. 11.3.1.1
1743	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Solar Photovoltaic Charge Controller	Visual Inspection	IEC 62093, Edition 1 , Clause. 11.1
1744	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Solar Photovoltaic Charge Controller	Voltage Drop Test	IEC 62093, Edition 1, Clause. 11.3.1.2
1745	ELECTRONICS- POWER SUPPLIES & STABILIZERS	Systems – White LED Based Solar Photovoltaic Lighting such as Solar Lantern, Solar study lamp, Solar Home light system/ Solar Power packs and Solar street lighting system	Electronics Efficiency	Technical specifications for 12W White-LED based Solar Street Lighting System
1746	ELECTRONICS- POWER SUPPLIES & STABILIZERS	TPower converters for use in photovoltaic power systems (Up to 60 kW)	Thickness requirements for metal enclosures	IEC 62109-1 (Edition 1.0), Clause. 13.8
1747	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Clearance, creepage	EN 62368-1-2020 (Clause 5.4.2, 5.4.3, Annex O)
1748	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Clearance, creepage	IEC 62368-1 (ed 3.0 :2018) (Clause 5.4.2, 5.4.3, Annex O)
1749	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Humidity conditioning	EN 62368-1 (Clause 5.4.8)
1750	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Humidity Conditioning	EN 62368-1 (Clause 5.4.8)
1751	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Protective conductor & Terminals for protective conductors	EN 62368-1 (Clause 5.6, 5.6.5)
1752	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Protective conductor & Terminals for protective conductors	IEC 62368-1(ed 3.0: 2018) (Clause 5.6, 5.6.5)
1753	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Vibration test	IEC 62368-1 (ed3.0 :2018) Annex G 15.2.4
1754	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Shock Electro dynamic shaker-Half sine Trapezoidal Final peak saw tooth, Initial saw tooth.	IEC 60068-2-27
1755	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Shock Electro dynamic shaker-Half sine Trapezoidal Final peak saw tooth, Initial saw tooth.	IEC 61373 ED 2 :2010-05

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1756	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Shock Electro dynamic shaker- Half sine Trapezoidal Final peak saw tooth, Initial saw tooth.	MIL STD 202G, Method 201A
1757	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Shock Electro dynamic shaker- Half sine Trapezoidal Final peak saw tooth, Initial saw tooth.	MILSTD- 810G, Method 514.6
1758	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Sine and random vibration Test, Qualitative	IEC 60065
1759	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Sine and random vibration Test, Qualitative	IEC 60068-2-6
1760	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Sine and random vibration Test, Qualitative	IEC 60068-2-64
1761	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Sine and random vibration Test, Qualitative	IEC 61373
1762	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Sine and random vibration Test, Qualitative	IEC 62133
1763	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Sine and random vibration Test, Qualitative	MIL STD 202G
1764	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Sine and random vibration Test, Qualitative	MIL STD 202G: 2002 Method 201A ,2.4.1-Part 1
1765	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Sine and random vibration Test, Qualitative	MIL STD 883E: 1997 Method 2007.2, 2002 & 2026
1766	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Sine and random vibration Test, Qualitative	MILSTD- 810G
1767	ELECTRONICS- SAFETY TESTING FACILITY	Luminaires & Lighting Products	Vibration & Shock	IEC 60598-1, Cl 4.20
1768	ELECTRONICS- SAFETY TESTING FACILITY	Safety Testing Facility: Electronics Discipline Audio/Video, Information and Communication Technology Equipment	Clearance, creepage	EN 62368-1 (Clause 5.4.2, 5.4.3)
1769	ELECTRONICS- SAFETY TESTING FACILITY	Safety Testing Facility: Electronics Discipline Audio/Video, Information and Communication Technology Equipment	Clearance, creepage	IEC 62368-1 (ed 2 :2014) (Clause 5.4.2, 5.4.3)
1770	ELECTRONICS- SAFETY TESTING FACILITY	Secondary Batteries and Cells	Sine vibration	UN38.3 (Edition 6): 2015 (38.3.4.3)
1771	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics & Polymer Fiber Reinforced plastic products	Apparent interlaminar shear strength by short- beam method	ASTM D 2344
1772	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics & Polymer Fiber Reinforced plastic products	Compressive Modulus	ASTM D 3410

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1773	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics & Polymer Fiber Reinforced plastic products	Compressive Modulus	ASTM D 6641
1774	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics & Polymer Fiber Reinforced plastic products	Compressive Strength	ASTM D 3410
1775	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics & Polymer Fiber Reinforced plastic products	Compressive Strength	ASTM D 6641
1776	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics & Polymer Fiber Reinforced plastic products	Density and Specific Gravity (Relative Density) by displacement (Method A)	ISO 1183 -1 (Method A)
1777	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics & Polymer Fiber Reinforced plastic products	Density and Specific Gravity (Relative Density) by displacement (Method A)	ASTM D 792 (Method A)
1778	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics & Polymer Fiber Reinforced plastic products	Flexural Strength	ASTM D 7264
1779	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics & Polymer Fiber Reinforced plastic products	Shear Modulus of Elasticity	ASTM D 7078
1780	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics & Polymer Fiber Reinforced plastic products	Shear Strength of composite material by V Notch rail shear	ASTM 7078
1781	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics & Polymer Fiber Reinforced plastic products	Tensile E Modulus	ISO 527-4
1782	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics & Polymer Fiber Reinforced plastic products	Tensile E Modulus	ISO 527-5
1783	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics & Polymer Fiber Reinforced plastic products	Tensile Strength	ISO 527-4
1784	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics & Polymer Fiber Reinforced plastic products	Tensile Strength	ISO 527-5
1785	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics & Polymer Fiber Reinforced plastic products	Compressive Modulus	ISO 14126
1786	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics & Polymer Fiber Reinforced plastic products	Compressive Strength	ISO 14126
1787	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics & Polymer Fiber Reinforced plastic products	Tensile Modulus	ASTM D 3039
1788	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics & Polymer Fiber Reinforced plastic products	Tensile Strength	ASTM D 3039
1789	MECHANICAL- PLASTICS AND PLASTIC PRODUCTS	Plastics and Plastics Products	Flexural strength	ASTM D 790

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LOCATION 1-LABORATORY BUILDING, KALYANI PLATINA CAMPUS, SY.NO.129/4, EPIP ZONE, PHASE II, WHITEFIELD, BENGALURU URBAN, BENGALURU, KARNATAKA, INDIA Mobile Facility				
1	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Insulation Test	IEC 61215 (2nd Ed), (Cl 10.3)
2	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Insulation Test	IEC 61215-2:2021 (Cl 4.3 MQT03)
3	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Insulation Test	IEC 61215-2-1:2016 (Cl 4.3 MQT03)
4	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Insulation Test	IS 14286: (Cl.10.3)
5	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Maximum Power Determination	IEC 61215:,Cl. 10.2
6	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Maximum Power Determination	IEC 61215-2 , Cl. 4.2 (MQT 02)
7	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Maximum Power Determination	IEC 61215-2:(2nd Edition) 2021, Cl. 4.2 (MQT 02)
8	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Maximum Power Determination	IS 14286: ,(Cl.10.2)
9	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Performance Measurement at Low Irradiation	IEC 61215:2005, Cl 10.7
10	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Performance Measurement at Low Irradiation	IEC 61215-2:(2nd Edition) 2021, Cl 4.7 (MQT 07): 2021
11	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Performance Measurement at Low Irradiation	IEC 61215-2:2016, Cl 4.7 (MQT 07)
12	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Performance Measurement at Low Irradiation	IS 14286: 2010 (Cl.10.7)
13	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Preconditioning Test	IEC 61215 (2nd Ed):2005-04 (Cl 5): 2005

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14	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Stabilization	IEC 61215-1-1:2016 (Cl.11.19 MQT19)
15	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Stabilization	IEC 61215-1-1:2021 (Cl 4.19 MQT19)
16	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Visual Inspection	IEC 61215, 2005:04, Cl 10.1
17	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Visual Inspection	IEC 61215-2:(2nd Edition) 2021, Cl 4.1 (MQT01): 2021
18	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Visual Inspection	IEC 61215-2:2016, Cl 4.1 (MQT01)
19	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline Terrestrial PV Module	Visual Inspection	IS 14286: 2010 (Cl.10.1)
20	ELECTRONICS-MISCELLANEOUS PRODUCTS	PV Module	Electroluminescence imaging	Laboratory test method-12-LO-S0884

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LOCATION 2 - OAK BUILDING KALYANI PLATINA CAMPUS, SY.NO.129/4, EPIP ZONE, PHASE II, WHITEFIELD, BENGALURU URBAN, BENGALURU, KARNATAKA, INDIA Permanent Facility				
1	ELECTRICAL- CELLS & BATTERIES	Secondary cells & Batteries Lithium Ion cells & batteries, Ni-MH cells & batteries	T1 : Altitude Simulation	UN 38.3 Clause. 4.1
2	ELECTRICAL- CELLS & BATTERIES	Secondary cells & Batteries Lithium Ion cells & batteries, Ni-MH cells & batteries	T2 : Thermal Test	UN 38.3 Clause. 4.2
3	ELECTRICAL- CELLS & BATTERIES	Secondary cells & Batteries Lithium Ion cells & batteries, Ni-MH cells & batteries	T4 : Shock	UN 38.3 Clause. 4.4
4	ELECTRICAL- CELLS & BATTERIES	Secondary cells & Batteries Lithium Ion cells & batteries, Ni-MH cells & batteries	T5 : External Short Circuit	UN 38.3 Clause. 4.5
5	ELECTRICAL- CELLS & BATTERIES	Secondary cells & Batteries Lithium Ion cells & batteries, Ni-MH cells & batteries	T6 (a) : Impact & (Crush)	UN 38.3 Clause. 4.6
6	ELECTRICAL- CELLS & BATTERIES	Secondary cells & Batteries Lithium Ion cells & batteries, Ni-MH cells & batteries	T7 : Over Charge	UN 38.3 Clause. 4.7
7	ELECTRICAL- CELLS & BATTERIES	Secondary cells & Batteries Lithium Ion cells & batteries, Ni-MH cells & batteries	T8 : Forced Discharge	UN 38.3 clause 4.8
8	ELECTRICAL- CELLS & BATTERIES	Secondary cells & Batteries Lithium Ion cells & batteries, Ni-MH cells & batteries	Transport Tests	UN38.3 (6th Edition), 2015
9	ELECTRICAL- CELLS & BATTERIES	Secondary cells & Batteries Lithium Ion cells & batteries, Ni-MH cells & batteries	T1 : Altitude Simulation	UN 38.3 Clause. 4.1
10	ELECTRICAL- CELLS & BATTERIES	Secondary cells & Batteries Lithium Ion cells & batteries, Ni-MH cells & batteries	T4 : Shock	UN 38.3 Clause. 4.4
11	ELECTRICAL- CELLS & BATTERIES	Secondary cells & Batteries Lithium Ion cells & batteries, Ni-MH cells & batteries	T5 : External Short Circuit	UN 38.3 Clause. 4.5
12	ELECTRICAL- CELLS & BATTERIES	Secondary cells & Batteries Lithium Ion cells & batteries, Ni-MH cells & batteries	T6 (a) : Impact & (Crush)	UN 38.3 Clause. 4.6
13	ELECTRICAL- CELLS & BATTERIES	Secondary cells & Batteries Lithium Ion cells & batteries, Ni-MH cells & batteries	T7 : Over Charge	UN 38.3 Clause. 4.7
14	ELECTRICAL- CELLS & BATTERIES	Secondary cells & Batteries Lithium Ion cells & batteries, Ni-MH cells & batteries	T8 : Forced Discharge	UN 38.3 clause 4.8
15	ELECTRICAL- CELLS & BATTERIES	Secondary Lithium system cells & batteries	case stress at high ambient temperature(Batteries)	IS 16046 (Part2) : 2018 / IEC 62133-2 : 2017, Cl-7.2.2
16	ELECTRICAL- CELLS & BATTERIES	Secondary Lithium system cells & batteries	Charging procedure - Discharging	IS 16046 (Part2) : 2018 / IEC 62133-2 : 2017, Cl-7.1
17	ELECTRICAL- CELLS & BATTERIES	Secondary Lithium system cells & batteries	Charging Procedures for test purposes- Second Procedure	IS 16046 (Part2) : 2018 / IEC 62133-2 : 2017, Cl-7.1.2
18	ELECTRICAL- CELLS & BATTERIES	Secondary Lithium system cells & batteries	Continuous charge	IS 16046 (Part2) : 2018 / IEC 62133-2 : 2017, Cl-7.2.1

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19	ELECTRICAL- CELLS & BATTERIES	Secondary Lithium system cells & batteries	Crushing of cells	IS 16046 (Part2) : 2018 / IEC 62133-2 : 2017, Cl-7.3, Cl-7.3.5
20	ELECTRICAL- CELLS & BATTERIES	Secondary Lithium system cells & batteries	External short circuit	IS 16046 (Part2) : 2018 / IEC 62133-2 : 2017, Cl-7.3, Cl-7.3.1
21	ELECTRICAL- CELLS & BATTERIES	Secondary Lithium system cells & batteries	External short circuit	IS 16046 (Part2) : 2018 / IEC 62133-2 : 2017, Cl-7.3, Cl-7.3.2
22	ELECTRICAL- CELLS & BATTERIES	Secondary Lithium system cells & batteries	Forced discharge(Cell)	IS 16046 (Part2) : 2018 / IEC 62133-2 : 2017, Cl-7.3, Cl-7.3.7
23	ELECTRICAL- CELLS & BATTERIES	Secondary Lithium system cells & batteries	Free fall	IS 16046 (Part2) : 2018 / IEC 62133-2 : 2017, Cl-7.3, Cl-7.3.3
24	ELECTRICAL- CELLS & BATTERIES	Secondary Lithium system cells & batteries	Insulation and wiring	IS 16046 (Part2) : 2018 / IEC 62133-2 : 2017, Cl-5.2
25	ELECTRICAL- CELLS & BATTERIES	Secondary Lithium system cells & batteries	Measurement of Internal AC Resistance of Coin Cells	IS 16046 (Part2) : 2018 / IEC 62133-2 : 2017, Annex D,D2
26	ELECTRICAL- CELLS & BATTERIES	Secondary Lithium system cells & batteries	Mechanical shock(Crash hazard)	IS 16046 (Part2) : 2018 / IEC 62133-2 : 2017, Cl-7.3, Cl-7.3.8, Cl-7.3.8.2
27	ELECTRICAL- CELLS & BATTERIES	Secondary Lithium system cells & batteries	Overcharge	IS 16046 (Part2) : 2018 / IEC 62133-2 : 2017, Cl-7.3, Cl-7.3.6
28	ELECTRICAL- CELLS & BATTERIES	Secondary Lithium system cells & batteries	Thermal abuse(Cells)	IS 16046 (Part2) : 2018 / IEC 62133-2 : 2017, Cl-7.3, Cl-7.3.4
29	ELECTRICAL- CELLS & BATTERIES	Secondary Lithium system cells & batteries	Vibration	IS 16046 (Part2) : 2018 / IEC 62133-2 : 2017, Cl-7.3, Cl-7.3.8, Cl-7.3.8.1
30	ELECTRICAL- CELLS & BATTERIES	Secondary Nickel system cells & batteries	Case stress at high ambient temperature (Batteries)	IS 16046 (Part1) : 2018 / IEC 62133-1 : 2017, Cl-7.2, Cl-7.2.3
31	ELECTRICAL- CELLS & BATTERIES	Secondary Nickel system cells & batteries	Charging procedure - Discharging	IS 16046 (Part1) : 2018 / IEC 62133-1 : 2017, Cl-7.1
32	ELECTRICAL- CELLS & BATTERIES	Secondary Nickel system cells & batteries	Continuous Low-rate charging	IS 16046 (Part1) : 2018 / IEC 62133-1 : 2017, Cl-7.2, Cl-7.2.1
33	ELECTRICAL- CELLS & BATTERIES	Secondary Nickel system cells & batteries	Crushing of cells	IS 16046 (Part1) : 2018 / IEC 62133-1 : 2017, CL-7.3, Cl-7.3.6
34	ELECTRICAL- CELLS & BATTERIES	Secondary Nickel system cells & batteries	External short circuit	IS 16046 (Part1) : 2018 / IEC 62133-1 : 2017, Cl-7.3, Cl-7.3.2
35	ELECTRICAL- CELLS & BATTERIES	Secondary Nickel system cells & batteries	Forced discharge(Cell)	IS 16046 (Part1) : 2018 / IEC 62133-1 : 2017, Cl-7.3, Cl-7.3.9
36	ELECTRICAL- CELLS & BATTERIES	Secondary Nickel system cells & batteries	Free fall	IS 16046 (Part1) : 2018 / IEC 62133-1 : 2017, Cl-7.3, Cl-7.3.3

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
37	ELECTRICAL- CELLS & BATTERIES	Secondary Nickel system cells & batteries	Incorrect installation	IS 16046 (Part1) : 2018 / IEC 62133-1 : 2017, Cl-7.3, Cl-7.3.1
38	ELECTRICAL- CELLS & BATTERIES	Secondary Nickel system cells & batteries	Insulation and wiring	IS 16046 (Part1) : 2018 / IEC 62133-1 : 2017, Cl-5.2
39	ELECTRICAL- CELLS & BATTERIES	Secondary Nickel system cells & batteries	Low pressure(cells)	IS 16046 (Part1) : 2018 / IEC 62133-1 : 2017, Cl-7.3, Cl-7.3.7
40	ELECTRICAL- CELLS & BATTERIES	Secondary Nickel system cells & batteries	Mechanical shock (Crash hazard)	IS 16046 (Part1) : 2018 / IEC 62133-1 : 2017, Cl-7.3, Cl-7.3.4
41	ELECTRICAL- CELLS & BATTERIES	Secondary Nickel system cells & batteries	Overcharge	IS 16046 (Part1) : 2018 / IEC 62133-1 : 2017, Cl-7.3, Cl-7.3.8
42	ELECTRICAL- CELLS & BATTERIES	Secondary Nickel system cells & batteries	Temperature cycling	IS 16046 (Part1) : 2018 / IEC 62133-1 : 2017, Cl-7.2, Cl-7.2.4
43	ELECTRICAL- CELLS & BATTERIES	Secondary Nickel system cells & batteries	Thermal abuse(Cells)	IS 16046 (Part1) : 2018 / IEC 62133-1 : 2017, CL-7.3, Cl-7.3.5
44	ELECTRICAL- CELLS & BATTERIES	Secondary Nickel system cells & batteries	Vibration	IS 16046 (Part1) : 2018 / IEC 62133-1 : 2017, Cl-7.2, Cl-7.2.2
45	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Alternative method for determining minimum clearances	EN/IEC 60065:2014,Annex J
46	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Alternative method for determining minimum clearances	IS 616: 2017-Rev 5, Annex J
47	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Antenna coaxial sockets mounted on the apparatus	EN/IEC 60065:2014, Clause 12.5
48	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Antenna coaxial sockets mounted on the apparatus	IS 616: 2017-Rev 5, Clause 12.5
49	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Apparatus containing coin/button cell batteries-Crush test	EN/IEC 60065:2014, Clause 12.7.3.6
50	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Apparatus containing coin/button cell batteries-Crush test	IS 616: 2017-Rev 5, Clause 12.7.3.6
51	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Apparatus to be connected to the telecommunication networks	EN/IEC 60065:2014,Annex B
52	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Apparatus to be connected to the telecommunication networks	IS 616: 2017-Rev 5, Annex B

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53	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Component - Resistors	EN/IEC 60065: 2014, Clause. 14.2
54	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Component - Resistors	IS 616: 2017-Rev 5, Clause. 14.2
55	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Creepage and Clearance distances	EN/IEC 60065: 2014, Clause. 13
56	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Creepage and Clearance distances	IS 616: 2017-Rev 5, Clause. 13
57	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Determination of hazardous live Parts	EN/IEC 60065: 2014, Clause. 9.1.1.2
58	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Determination of hazardous live Parts	IS 616: 2017-Rev 5, Clause. 9.1.1.2
59	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Determination of operating voltage	EN/IEC 60065: 2014, Clause. 13.2
60	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Determination of operating voltage	IS 616: 2017-Rev 5, Clause. 13.2
61	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Devices forming a part of the MAINS plug	EN/IEC 60065:2014, Clause 15.4
62	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Devices forming a part of the MAINS plug	IS 616: 2017-Rev 5, Clause 15.4
63	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Dielectric strength	EN/IEC 60065: 2014, Clause. 10.4
64	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Dielectric strength	IS 616: 2017-Rev 5, Clause. 10.4
65	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Drawers	EN/IEC 60065:2014, Clause 12.4
66	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Drawers	IS 616: 2017-Rev 5, Clause 12.4
67	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Drop Test	EN/IEC 60065: 2014, Clause. 12.1.5
68	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Drop Test	IS 616: 2017-Rev 5, Clause. 12.1.5
69	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	External forces – windows & covers	EN/IEC 60065, Clause. 8.12, 8.13
70	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	External forces – windows & covers	IS 616: 2017-Rev 5, Clause. 8.12, 8.13
71	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Fault conditions Tests	EN/IEC 60065: 2014, Clause. 11

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72	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Fault conditions Tests	IS 616: 2017-Rev 5, Clause. 11
73	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Fixing Of Actuating Elements	EN/IEC 60065:2014, Clause 12.2
74	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Fixing Of Actuating Elements	IS 616: 2017-Rev 5, Clause 12.2
75	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Heating under normal operating conditions	EN/IEC 60065: 2014, Clause. 7
76	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Heating under normal operating conditions	IS 616: 2017-Rev 5, Clause. 7
77	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Horizontal force stability	EN/IEC 60065: 2014, Clause. 19.4
78	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Horizontal force stability	IS 616: 2017-Rev 5, Clause. 19.4
79	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Humidity treatment	EN/IEC 60065, Clause. 10.3
80	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Humidity treatment	IS 616: 2017-Rev 5, Clause. 10.3
81	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Hygroscopic materials	EN/IEC 60065: 2014, Clause. 8.3
82	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Hygroscopic materials	IS 616: 2017-Rev 5, Clause. 8.3
83	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Impulse test generators	EN/IEC 60065:2014,Annex K
84	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Impulse test generators	IS 616: 2017-Rev 5, Annex K
85	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Insulated winding wires for use without interleaved insulation	EN/IEC 60065:2014,Annex H
86	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Insulated winding wires for use without interleaved insulation	IS 616: 2017-Rev 5, Annex H
87	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Insulation resistance	EN/IEC 60065: 2014, Clause. 10.4
88	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Insulation resistance	IS 616: 2017-Rev 5, Clause. 10.4
89	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Internal forces	EN/IEC 60065, Clause. 8.14
90	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Internal forces	IS 616: 2017-Rev 5, Clause. 8.14

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91	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Marking Legibility	EN/IEC 60065: 2014, Clause. 5
92	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Marking Legibility	IS 616: 2017-Rev 5, Clause. 5
93	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Mechanical strength – Bump	EN/IEC 60065: 2014, Clause. 12.1.2
94	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Mechanical strength – Bump	IS 616: 2017-Rev 5, Clause. 12.1.2
95	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Mechanical strength – Impact	EN/IEC 60065: 2014, Clause. 12.1.4
96	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Mechanical strength – Impact	IS 616: 2017-Rev 5, Clause. 12.1.4
97	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Mechanical strength – Stress relief	EN/IEC 60065: 2014, Clause. 12.1.6
98	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Mechanical strength – Stress relief	IS 616: 2017-Rev 5, Clause. 12.1.6
99	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Mechanical strength- Bump	IS 616, Clause. 12.1.2
100	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Non-Separable Thin Sheet Insulation Test	EN/IEC 60065:2014, Clause 8.21
101	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Non-Separable Thin Sheet Insulation Test	IS 616: 2017-Rev 5, Clause 8.21
102	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Normal operating conditions – Input Test	EN/IEC 60065: 2014, Clause. 4.2
103	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Normal operating conditions – Input Test	IS 616: 2017-Rev 5, Clause. 4.1 to 4.3
104	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Preset controls	EN/IEC 60065: 2014, Clause. 9.1.5
105	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Preset controls	IS 616: 2017-Rev 5, Clause. 9.1.5
106	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Protection against electric shock	EN/IEC 60065:2014, Clause 8.17-8.21
107	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Protection against electric shock	IS 616: 2017-Rev 5, Clause 8.17-8.21
108	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Protection against electric shock - Accessibility	EN/IEC 60065, Clause. 9, 9.1.1.3, 9.2
109	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Protection against electric shock - Accessibility	IS 616, Clause. 9, 9.1.1.3, 9.2

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110	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Protection against electric shock – Opening in enclosure	EN/IEC 60065: 2014, Clause. 9.1.3
111	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Protection against electric shock – Opening in enclosure	IS 616: 2017-Rev 5, Clause. 9.1.3
112	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Protection against electric shock – Terminals	EN/IEC 60065: 2014, Clause. 9.1.4
113	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Protection against electric shock – Terminals	IS 616: 2017-Rev 5, Clause. 9.1.4
114	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Protection): against electric shock - Accessibility	EN/IEC 60065: 2014, Clause. 9, 9.1.1.3, 9.2
115	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Protection): against electric shock - Accessibility	IS 616: 2017-Rev 5, Clause. 9, 9.1.1.3, 9.2
116	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Provisions for protective resistance	EN/IEC 60065: 2014, Clause. 15.2
117	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Provisions for protective resistance	IS 616: 2017-Rev 5, Clause. 15.2
118	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Resistance to external forces	EN/IEC 60065: 2014, Clause. 9.1.7
119	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Resistance to external forces	IS 616: 2017-Rev 5, Clause. 9.1.7
120	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Stability Test	EN/IEC 60065: 2014, Clause. 19.2
121	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Stability Test	IS 616: 2017-Rev 5, Clause. 19.2
122	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Strain relief Test	EN/IEC 60065: 2014, Clause. 16.5
123	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Strain relief Test	IS 616: 2017-Rev 5, Clause. 16.5
124	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Surge Test	EN/IEC 60065: 2014, Clause. 10.2
125	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Surge Test	IS 616: 2017-Rev 5, Clause. 10.2
126	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Test of Edges and corners	EN/IEC 60065:2014, Clause 19.5
127	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Test of Edges and corners	IS 616: 2017-Rev 5, Clause 19.5
128	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Torque Test – Rod antenna	EN/IEC 60065: 2014, Clause. 12.6

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129	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Torque Test – Rod antenna	IS 616: 2017-Rev 5, Clause. 12.6
130	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Torque Test on covers	EN/IEC 60065: 2014, Clause. 17.7
131	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Torque Test on covers	IS 616: 2017-Rev 5, Clause. 17.7
132	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Torque Test on screw terminals	EN/IEC 60065: 2014, Clause. 17.1
133	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Torque Test on screw terminals	IS 616: 2017-Rev 5, Clause. 17.1
134	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Vertical force stability	EN/IEC 60065: 2014, Clause. 19.3
135	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Vertical force stability	IS 616: 2017-Rev 5, Clause. 19.3
136	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Wall Or Ceiling Or Equipment Rack Mounting Test	EN/IEC 60065: 2014, Clause. 19.7
137	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Wall Or Ceiling Or Equipment Rack Mounting Test	IS 616: 2017-Rev 5, Clause. 19.7
138	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Winding insulation Test	EN/IEC 60065: 2014, Clause. 8.8
139	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Winding insulation Test	IS 616: 2017-Rev 5, Clause. 8.8
140	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Withdrawal of main plug	EN/IEC 60065: 2014, Clause. 9.1.6
141	ELECTRONICS- AUDIO EQUIPMENT	Audio video and similar electronic apparatus	Withdrawal of main plug	IS 616: 2017-Rev 5, Clause. 9.1.6
142	ELECTRONICS- AUDIO EQUIPMENT	House Hold Electronic Appliances – CRT TV; LCD(with CCFL/LED backlighting); Plasma displays	On mode Power measurement	BEE Schedule 11
143	ELECTRONICS- AUDIO EQUIPMENT	House Hold Electronic Appliances – CRT TV; LCD(with CCFL/LED backlighting); Plasma displays	Standby power measurement	BEE Schedule 11
144	ELECTRONICS- AUDIO EQUIPMENT	House Hold Electronic Appliances – CRT TV; LCD(with CCFL/LED backlighting); Plasma displays	Standby power measurement	IS 13384 (Part 2)
145	ELECTRONICS- AUDIO EQUIPMENT	House Hold Electronic Appliances – CRT TV; LCD; Plasma displays	On mode Power measurement	IEC 62087 (Edition 3): 2011-04
146	ELECTRONICS- AUDIO EQUIPMENT	House Hold Electronic Appliances – CRT TV; LCD; Plasma displays	Standby power measurement	IEC 62301 (Edition 2): 2011-01
147	ELECTRONICS- AUDIO EQUIPMENT	House Hold Electronic Appliances – CRT TV; LCD; Plasma displays	On mode Power measurement	IS 13384 (Part 1)

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148	ELECTRONICS- AUDIO EQUIPMENT	House Hold Electronic Appliances – CRT TV; LCD; Plasma displays	On mode Power measurement	IS 13384 (Part 2)
149	ELECTRONICS- AUDIO EQUIPMENT	House Hold Electronic Appliances – CRT TV; LCD; Plasma displays	Standby power measurement	IS 13384 (Part 1)
150	ELECTRONICS- AUDIO EQUIPMENT	House Hold Electronic Appliances – CRT TV; LCD; Plasma displays	Standby power measurement	IS 13384 (Part 2)
151	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Change of Temperature (Test Na) (2 chamber method)	QM-333, Test no 4, Clause 3.4
152	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Cold Test	QM-333, Test no 1, Clause 3.1
153	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Damp heat, cyclic (Test Db)	QM-333, Test no 3, Clause 3.3
154	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Damp Heat, steady state	QM-333, Test no 5, Clause 3.5
155	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Drop Test	QM-333, Test no 10, Clause 3.10
156	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Dry Heat	QM-333, Test number 2, Clause 3.2
157	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Fall Test	QM-333, Test no 12, Clause 3.12
158	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Toppling Test	QM-333, Test no 11, Clause 3.11
159	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Change of temperature : Test Na & Test Nb	IEC 60068-2-14 (6th Edition)
160	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Test A: Cold	IEC 60068-2-1: (6th Edition)
161	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Test B: Dry heat	IEC 60068-2-2 (5th Edition)

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162	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Test Cab: Damp heat, steady state	IEC 60068-2-78 (2nd edition)
163	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Environmental Testing of Electronics & Electrical Items	Test Db:Damp heat, cyclic (12 h + 12 h cycle)	IEC 60068-2-30,(3rd Edition)
164	ELECTRONICS- IT EQUIPMENT	Desktop Computer, Notebook computers, Tablets, Small-scale servers, Thin Client, Workstations and Monitors	Measuring Short Idle Mode	IEC 62623 (Edition 1.0): 2012-10, (Section 5.3.5)
165	ELECTRONICS- IT EQUIPMENT	Desktop Computer, Notebook computers, Tablets, Smallscale servers, Thin Client, Workstations and Monitors	Measuring off mode	IEC 62623, Section 5.3.2
166	ELECTRONICS- IT EQUIPMENT	Desktop Computer,Notebook computers,Tablets,Small-scale servers,Thin Client,Workstations and Monitors	Measuring active mode	IEC 62623, Section 5.3.6
167	ELECTRONICS- IT EQUIPMENT	Desktop Computer,Notebook computers,Tablets,Small-scale servers,Thin Client,Workstations and Monitors	Measuring long idle mode	IEC 62623, Section 5.3.4
168	ELECTRONICS- IT EQUIPMENT	Desktop Computer,Notebook computers,Tablets,Small-scale servers,Thin Client,Workstations and Monitors	Measuring sleep mode	IEC 62623, Section 5.3.3
169	ELECTRONICS- IT EQUIPMENT	Desktop Computer,Notebook computers,Tablets,Small-scale servers,Thin Client,Workstations and Monitors	Overview of profile methodology	IEC 62623, Annex A
170	ELECTRONICS- IT EQUIPMENT	IT Equipment	Abnormal operating and fault conditions	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015,CL5.3.2, 5.3.3, 5.3.4, 5.3.5, 5.3.6, 5.3.7, 5.3.8, 5.3.9.1, 5.3.9.2
171	ELECTRONICS- IT EQUIPMENT	IT Equipment	Abnormal operating and fault conditions test	IEC 60950-1, Amd.1 + Amd. 2, Clause. 5.3.9
172	ELECTRONICS- IT EQUIPMENT	IT Equipment	Abnormal operation & Fault condition Test	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 5.3)
173	ELECTRONICS- IT EQUIPMENT	IT Equipment	Abnormal operation Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 5.3.1)
174	ELECTRONICS- IT EQUIPMENT	IT Equipment	Abrasion Resistance test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.10.8.4
175	ELECTRONICS- IT EQUIPMENT	IT Equipment	Access to ELV wiring	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.1.1.3
176	ELECTRONICS- IT EQUIPMENT	IT Equipment	Access to energized parts	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.1.1.1
177	ELECTRONICS- IT EQUIPMENT	IT Equipment	Access to hazardous voltage wiring	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.1.1.4

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178	ELECTRONICS- IT EQUIPMENT	IT Equipment	Adhesives for constructional	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015,CL4.6.5
179	ELECTRONICS- IT EQUIPMENT	IT Equipment	Audio amplifiers in IT Equipment	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.1.1.9
180	ELECTRONICS- IT EQUIPMENT	IT Equipment	Ball pressure Test (resistance to abnormal heat)	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 4.5.5)
181	ELECTRONICS- IT EQUIPMENT	IT Equipment	Barrier Adhesive test (Adhesives for constructional)	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 4.6.5)
182	ELECTRONICS- IT EQUIPMENT	IT Equipment	Batteries	IEC 60950-1 (2nd Edition): 2005-12-01 + Amd.1 Date. 2009-12-01 + Amd 2 2013-05-28 (Clause. 4.3.8)
183	ELECTRONICS- IT EQUIPMENT	IT Equipment	Batteries	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015, Cl. 4.3.8
184	ELECTRONICS- IT EQUIPMENT	IT Equipment	Capacitance discharge Test	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 2.1.1.7)
185	ELECTRONICS- IT EQUIPMENT	IT Equipment	Capacitance discharge Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 2.1.1.7)
186	ELECTRONICS- IT EQUIPMENT	IT Equipment	Clearances, Measurement of transient voltages, Clearances in secondary circuits	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.10.3, 2.10.3.9, 2.10.3.4
187	ELECTRONICS- IT EQUIPMENT	IT Equipment	Compliance criteria for abnormal operating and fault conditions	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 5.3.9)
188	ELECTRONICS- IT EQUIPMENT	IT Equipment	Components (Resistors bridging double insulation or reinforced insulation between the a.c. mains supply and other circuits)	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,1.5.7.2
189	ELECTRONICS- IT EQUIPMENT	IT Equipment	Components(Capacitors bridging insulation)	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 1.5.6
190	ELECTRONICS- IT EQUIPMENT	IT Equipment	Components(Interconnecting cables)	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 1.5.5

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191	ELECTRONICS- IT EQUIPMENT	IT Equipment	Components(Thermal controls)	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 ,CL 1.5.3
192	ELECTRONICS- IT EQUIPMENT	IT Equipment	Components(Transformers)	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 1.5.4
193	ELECTRONICS- IT EQUIPMENT	IT Equipment	Connection of TNV circuits to other circuits	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 Cl 2.3.4
194	ELECTRONICS- IT EQUIPMENT	IT Equipment	Connection to cable distribution Systems	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015,CL7.2,7.3
195	ELECTRONICS- IT EQUIPMENT	IT Equipment	Construction of Printed Boards	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.10.6.2-2.10.6.4
196	ELECTRONICS- IT EQUIPMENT	IT Equipment	Cord anchorages and strain relief	IEC 60950-1 (2nd Edition): 2005-12-01 + Amd.1 Date. 2009-12-01 + Amd 2 2013-05-28 (Clause. 3.2.6)
197	ELECTRONICS- IT EQUIPMENT	IT Equipment	Cord anchorages and strain relief Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 3.2.6)
198	ELECTRONICS- IT EQUIPMENT	IT Equipment	Cord guard Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 3.2.8)
199	ELECTRONICS- IT EQUIPMENT	IT Equipment	Creepage distances	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.10.4
200	ELECTRONICS- IT EQUIPMENT	IT Equipment	Creepage/clearance/distance through insulation, peak working voltage	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.10, 2.10.2.3
201	ELECTRONICS- IT EQUIPMENT	IT Equipment	Determination of Working voltage	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 Clause. 2.10.2 (2.10.2.1, 2.10.2.2,2.10.2.3)
202	ELECTRONICS- IT EQUIPMENT	IT Equipment	Dielectric strength Test	IEC 60950-1 ((2nd Edition):2005+Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 5.2)
203	ELECTRONICS- IT EQUIPMENT	IT Equipment	Direct plug in equipment	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015,CL4.3.6

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204	ELECTRONICS- IT EQUIPMENT	IT Equipment	Direct plug-in equipment	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 4.3.6)
205	ELECTRONICS- IT EQUIPMENT	IT Equipment	Drop Test	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 4.2.6)
206	ELECTRONICS- IT EQUIPMENT	IT Equipment	Drop Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 4.2.6)
207	ELECTRONICS- IT EQUIPMENT	IT Equipment	Durability	IEC 60950-1 ((2nd Edition):2005+ Amd. 1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 1.7.11)
208	ELECTRONICS- IT EQUIPMENT	IT Equipment	Durability of marking Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 1.7.11)
209	ELECTRONICS- IT EQUIPMENT	IT Equipment	Earthing Test	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 2.6.3.4)
210	ELECTRONICS- IT EQUIPMENT	IT Equipment	Electric strength Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 5.2.2)
211	ELECTRONICS- IT EQUIPMENT	IT Equipment	Electric Strength Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.10.8.3
212	ELECTRONICS- IT EQUIPMENT	IT Equipment	Enclosed and sealed parts	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.10.12
213	ELECTRONICS- IT EQUIPMENT	IT Equipment	Energy hazard	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.1.1.5
214	ELECTRONICS- IT EQUIPMENT	IT Equipment	Energy hazard measurement Test	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 2.1.1.8)
215	ELECTRONICS- IT EQUIPMENT	IT Equipment	Energy hazards - d.c. main supplies	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.1.1.8
216	ELECTRONICS- IT EQUIPMENT	IT Equipment	Evaluation measure of larger openings	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015,CL4.6.4.2

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
217	ELECTRONICS- IT EQUIPMENT	IT Equipment	handles & manual controls	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015,CL4.3.2,4.3.3
218	ELECTRONICS- IT EQUIPMENT	IT Equipment	Handles and manual controls	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 4.3.2)
219	ELECTRONICS- IT EQUIPMENT	IT Equipment	Household and home/office document/media shredders	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015,Annex EE
220	ELECTRONICS- IT EQUIPMENT	IT Equipment	Humidity Conditioning	IEC 60950-1 ((2nd Edition):2005+ Amd. 1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 2.9.2
221	ELECTRONICS- IT EQUIPMENT	IT Equipment	Humidity conditioning	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 2.9.2)
222	ELECTRONICS- IT EQUIPMENT	IT Equipment	Impact Test	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 4.2.5)
223	ELECTRONICS- IT EQUIPMENT	IT Equipment	Impact Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 4.2.5)
224	ELECTRONICS- IT EQUIPMENT	IT Equipment	Impulse test	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 7.4.3)
225	ELECTRONICS- IT EQUIPMENT	IT Equipment	Impulse Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015,CL6.2,7.4.3
226	ELECTRONICS- IT EQUIPMENT	IT Equipment	Input Test	IEC 60950-1 ((2nd Edition):2005+ Amd. 1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 1.6.2)
227	ELECTRONICS- IT EQUIPMENT	IT Equipment	Input Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 1.6.2)
228	ELECTRONICS- IT EQUIPMENT	IT Equipment	Insulation of conductor, Termination of conductor	IEC 60950-1 (2nd Edition): 2005-12-01 + Amd.1 Date. 2009-12-01 + Amd 2 2013-05-28 CL 3.1.4, 3.1.9

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229	ELECTRONICS- IT EQUIPMENT	IT Equipment	Insulation of conductor, Termination of conductor	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 3.1.4, 3.1.9
230	ELECTRONICS- IT EQUIPMENT	IT Equipment	Limitation of touch current to a telecommunication and cable distribution system	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 5.1.8.1)
231	ELECTRONICS- IT EQUIPMENT	IT Equipment	Limited current circuit measurement	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 2.4.1)
232	ELECTRONICS- IT EQUIPMENT	IT Equipment	Limited Current Circuits	IEC 60950-1 ((2nd Edition):2005+ Amd. 1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 2.4)
233	ELECTRONICS- IT EQUIPMENT	IT Equipment	Limited power source measurement Test	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 2.5)
234	ELECTRONICS- IT EQUIPMENT	IT Equipment	Limited power source measurement Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 2.5)
235	ELECTRONICS- IT EQUIPMENT	IT Equipment	Materials for fire enclosures	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 4.7.3,4.7.3.2)
236	ELECTRONICS- IT EQUIPMENT	IT Equipment	Materials used in high voltage components	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 CL4.7.3.6
237	ELECTRONICS- IT EQUIPMENT	IT Equipment	Motor tests under abnormal conditions Transformers	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015,Annex C
238	ELECTRONICS- IT EQUIPMENT	IT Equipment	Number and location of protective device	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.7.4
239	ELECTRONICS- IT EQUIPMENT	IT Equipment	Openings in enclosures	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 4.6)
240	ELECTRONICS- IT EQUIPMENT	IT Equipment	Overload of operator accessible Parts	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 5.3.7)
241	ELECTRONICS- IT EQUIPMENT	IT Equipment	Permanently connected equipment ,Appliance inlets	IEC 60950-1 (2nd Edition): 2005-12-01 + Amd.1 Date. 2009-12-01 + Amd 2 2013-05-28 CL 3.2.3, 3.2.4

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242	ELECTRONICS- IT EQUIPMENT	IT Equipment	Permanently connected equipment ,Appliance inlets	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 3.2.3, 3.2.4
243	ELECTRONICS- IT EQUIPMENT	IT Equipment	Protection against hazardous moving parts	IEC 60950-1 (2nd Edition): 2005-12-01 + Amd.1 Date. 2009-12-01 + Amd 2 2013-05-28 (Clause. 4.4)
244	ELECTRONICS- IT EQUIPMENT	IT Equipment	Protection against Hazardous moving Parts Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 Clause. 4.4 (4.4.1 , 4.4.2, 4.4.3, 4.4.4)
245	ELECTRONICS- IT EQUIPMENT	IT Equipment	Protection against moving fan blades	IEC 60950-1 (2nd Edition): 2005-12-01 + Amd.1 Date. 2009-12-01 + Amd 2 2013-05-28 (Clause. 4.4.5)
246	ELECTRONICS- IT EQUIPMENT	IT Equipment	Protection of equipment users from over voltages on telecommunication network	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015,CL6.2.1, 6.2.2,6.2.2.1,6.2.2.2
247	ELECTRONICS- IT EQUIPMENT	IT Equipment	Protection of equipment users from over voltages on telecommunication Networks	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 6.2)
248	ELECTRONICS- IT EQUIPMENT	IT Equipment	Protection of telecommunication network service persons, and users of other equipment connected to the network, from hazards in the equipment	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 6.1)
249	ELECTRONICS- IT EQUIPMENT	IT Equipment	Protection of the telecommunication wiring system from overheating	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015, Cl. 6.3
250	ELECTRONICS- IT EQUIPMENT	IT Equipment	Requirement of separation between telecommunication network from earth	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 6.1.2)
251	ELECTRONICS- IT EQUIPMENT	IT Equipment	Requirements for the mounting means of rack-mounted equipment	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015,Annex DD
252	ELECTRONICS- IT EQUIPMENT	IT Equipment	Resistance of earthing conductors and their terminations (Protective bonding Test)	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 2.6.3.4)
253	ELECTRONICS- IT EQUIPMENT	IT Equipment	Resistance to abnormal heat	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015,CL4.5.5

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254	ELECTRONICS- IT EQUIPMENT	IT Equipment	Resistance to fire	IEC 60950-1 ((2nd Edition):2005+Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 4.7)
255	ELECTRONICS- IT EQUIPMENT	IT Equipment	Resistance to fire purposes	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015Cl.4.7, 4.7.1, 4.7.2, 4.7.2.1, 4.7.2.2
256	ELECTRONICS- IT EQUIPMENT	IT Equipment	Safety Interlocks, Protection requirements, Inadvertent reactivation	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.8.2-2.8.8
257	ELECTRONICS- IT EQUIPMENT	IT Equipment	SELV Circuit Test	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 2.2)
258	ELECTRONICS- IT EQUIPMENT	IT Equipment	SELV Circuits	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.2 (2.2.1-2.2.4)
259	ELECTRONICS- IT EQUIPMENT	IT Equipment	Semiconductor Devices	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.10.5.4
260	ELECTRONICS- IT EQUIPMENT	IT Equipment	Separation from hazardous voltages	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 Cl 2.3.3
261	ELECTRONICS- IT EQUIPMENT	IT Equipment	Separation of TNV Ckts from other ckts & from accessible parts Protection by basic Insulation, Protection by Earthing, protection by other constructions	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 Cl 2.3.2, 2.3.2.1, 2.3.2.2, 2.3.2.3 2.3.2.4
262	ELECTRONICS- IT EQUIPMENT	IT Equipment	Short Circuit backup protection	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.7.3
263	ELECTRONICS- IT EQUIPMENT	IT Equipment	Simulation of single faults (Over load, O/P short, connector overload Test)	IEC 60950-1 ((2nd Edition):2005+ Amd. 1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 5.3.7)
264	ELECTRONICS- IT EQUIPMENT	IT Equipment	Solid Insulation, non-separable thin sheet material	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.10.5-2.10.5.14
265	ELECTRONICS- IT EQUIPMENT	IT Equipment	Stability Test	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 4.1)

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266	ELECTRONICS- IT EQUIPMENT	IT Equipment	Stability Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 4.1)
267	ELECTRONICS- IT EQUIPMENT	IT Equipment	Steady force Test	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 4.2.1)
268	ELECTRONICS- IT EQUIPMENT	IT Equipment	Steady force Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 4.2.1)
269	ELECTRONICS- IT EQUIPMENT	IT Equipment	Steady Force Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 4.2.3,4.2.4)
270	ELECTRONICS- IT EQUIPMENT	IT Equipment	Stress relief Test	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 4.2.7)
271	ELECTRONICS- IT EQUIPMENT	IT Equipment	Stress relief Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 4.2.7)
272	ELECTRONICS- IT EQUIPMENT	IT Equipment	Surge Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015,CL7.4.2
273	ELECTRONICS- IT EQUIPMENT	IT Equipment	Test for operating Voltages generated externally	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 Cl 2.3.5
274	ELECTRONICS- IT EQUIPMENT	IT Equipment	Test for pollution Degree 1 environment and for insulating compound	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.10.10
275	ELECTRONICS- IT EQUIPMENT	IT Equipment	Thermal cycling & thermal ageing	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.10.9
276	ELECTRONICS- IT EQUIPMENT	IT Equipment	Thermal requirement	IEC 60950-1 (2nd Edition): 2005-12-01 + Amd.1 Date. 2009-12-01 + Amd 2 2013-05-28 (Clause. 4.5.2)
277	ELECTRONICS- IT EQUIPMENT	IT Equipment	Thermal requirement	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 4.5.1)
278	ELECTRONICS- IT EQUIPMENT	IT Equipment	TNV Circuit	IEC 60950-1 ((2nd Edition):2005+ Amd. 1 Date. 2009-12-17 + Amd 2 2013-05-28 Clause. 2.3 (2.3.1, 2.3.2,2.3.3,2.3.4,2.3.5)

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279	ELECTRONICS- IT EQUIPMENT	IT Equipment	TNV Circuits	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd.,CL 2.3, 2.3.1, 2.3.2, 2.3.3, 2.3.4, 2.3.5
280	ELECTRONICS- IT EQUIPMENT	IT Equipment	Top and Side openings. Bottoms of fire enclosures	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015,CL4.6.1,4.6.2
281	ELECTRONICS- IT EQUIPMENT	IT Equipment	Touch current and protective conductor current	IEC 60950-1 ((2nd Edition):2005+Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 5.1)
282	ELECTRONICS- IT EQUIPMENT	IT Equipment	Touch current Test	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 5.1)
283	ELECTRONICS- IT EQUIPMENT	IT Equipment	Touch currents to telecommunication networks and cable distribution systems and from telecommunication networks	IEC 60950-1 ((2nd Edition):2005+Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 Clause. 5.1.8 (5.1.8.1, 5.1.8.2)
284	ELECTRONICS- IT EQUIPMENT	IT Equipment	Transformer and wire insulation electric strength Test	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 2.10.5.13)
285	ELECTRONICS- IT EQUIPMENT	IT Equipment	Voltage surge test	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 7.4.2)
286	ELECTRONICS- IT EQUIPMENT	IT Equipment	Wall or ceiling mounted equipment	IEC 60950-1 ((2nd Edition):2005+ Amd.1 Date. 2009-12-17 + Amd 2 2013-05-28 (Clause. 4.2.10)
287	ELECTRONICS- IT EQUIPMENT	IT Equipment	Wall or ceiling mounted equipment	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 CL4.2.10
288	ELECTRONICS- IT EQUIPMENT	IT Equipment	Working voltage determination	IS 13252 (Part 1): 2010 + Amd. 1: 2013 +Amd. 2: 2015 (Clause. 2.10.2)
289	ELECTRONICS- IT EQUIPMENT	Mobile Phones	Language Input test & Verification	IS 16333 (Part 3) : 2017, Cl 5
290	ELECTRONICS- IT EQUIPMENT	Mobile Phones	Language Input test & Verification	IS 16333 (Part 3), Clause 5 (Cl 5.1 & Cl 5.2)
291	ELECTRONICS- IT EQUIPMENT	Radio Transmitting Equipment	Creepage and Clearance distances	IEC 60215 (Edition 4):2016-04

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292	ELECTRONICS- IT EQUIPMENT	Radio Transmitting Equipment	Creepage and Clearance distances	IS 10437
293	ELECTRONICS- IT EQUIPMENT	Radio Transmitting Equipment	Fault conditions Tests	IEC 60215 (Edition 4):2016-04
294	ELECTRONICS- IT EQUIPMENT	Radio Transmitting Equipment	Fault conditions Tests	IS 10437
295	ELECTRONICS- IT EQUIPMENT	Radio Transmitting Equipment	High Temperatures	IEC 60215 (Edition 4):2016-04
296	ELECTRONICS- IT EQUIPMENT	Radio Transmitting Equipment	High Temperatures	IS 10437
297	ELECTRONICS- IT EQUIPMENT	Radio Transmitting Equipment	Ionizing radiation	IEC 60215 (Edition 4):2016-04
298	ELECTRONICS- IT EQUIPMENT	Radio Transmitting Equipment	Ionizing radiation	IS 10437
299	ELECTRONICS- IT EQUIPMENT	Radio Transmitting Equipment	Protection against electric shock	IEC 60215 (Edition 4):2016-04
300	ELECTRONICS- IT EQUIPMENT	Radio Transmitting Equipment	Protection against electric shock	IS 10437
301	ELECTRONICS- IT EQUIPMENT	Radio Transmitting Equipment	Protection against electric shock – Opening in enclosure	IS 10437
302	ELECTRONICS- IT EQUIPMENT	Radio Transmitting Equipment	Protection against electric shock – Opening in enclosure	IEC 60215 (Edition 4):2016-04
303	ELECTRONICS- IT EQUIPMENT	Radio Transmitting Equipment	Resistance To Humidity	IEC 60215 (Edition 4):2016-04
304	ELECTRONICS- IT EQUIPMENT	Radio Transmitting Equipment	Resistance To Humidity	IS 10437
305	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Ambulatory Electrocardiographic System	Common Mode Rejection	IEC 60601-2-47 (2nd Edition), Sub Clause. 201.12.4.4.103
306	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Ambulatory Electrocardiographic System	Drop Impact Test	IEC 60601-2-47 (2nd Edition), Sub Clause. 201.15.3.4.2
307	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Ambulatory Electrocardiographic System	Frequency Response	IEC 60601-2-47 (2nd Edition), Sub Clause. 201.12.4.4.108
308	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Ambulatory Electrocardiographic System	Function In the Presence of Pacemaker Pulses	IEC 60601-2-47 (2nd Edition), Sub Clause. 201.12.4.4.109
309	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Ambulatory Electrocardiographic System	Gain Accuracy	IEC 60601-2-47 (2nd Edition), Sub Clause. 201.12.4.4.104
310	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Ambulatory Electrocardiographic System	GAIN Settings and Switching	IEC 60601-2-47 (2nd Edition), Sub Clause. 201.12.4.4.111

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311	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Ambulatory Electrocardiographic System	Input Impedance	IEC 60601-2-47 (2nd Edition), Sub Clause. 201.12.4.4.102
312	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Ambulatory Electrocardiographic System	Linearity and dynamic range	IEC 60601-2-47 (2nd Edition), Sub Clause. 201.12.4.4.101
313	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Ambulatory Electrocardiographic System	Multichannel Crosstalk	IEC 60601-2-47 (2nd Edition), Sub Clause. 201.12.4.4.104
314	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Ambulatory Electrocardiographic System	Timing Accuracy	IEC 60601-2-47 (2nd Edition), Sub Clause. 201.12.4.4.110
315	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Computed tomography Equipment (Three Phase Voltage: Upto 600V AC, 120A, 50/60Hz Single Phase Voltage: Upto 300V AC, 100A, 50/60Hz)	LEAKAGE CURRENTS and PATIENT AUXILIARY CURRENTS	IEC 60601-2-44 (3rd Edition): 2009 Corr. 1: 2009 Amd. 2, Clause. 201.8.7
316	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Computed tomography Equipment (Three Phase Voltage: Upto 600V AC, 120A, 50/60Hz Single Phase Voltage: Upto 300V AC, 100A, 50/60Hz)	LEAKAGE CURRENTS and PATIENT AUXILIARY CURRENTS	IS 13450 (Part2/Sec44), Clause. 201.8.7
317	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Dental extra-oral X-ray Equipment (Three Phase Voltage: Upto 600V AC, 120A, 50/60Hz Single Phase Voltage: Upto 300V AC, 100A, 50/60Hz)	Marking on the outside of ME EQUIPMENT or ME EQUIPMENT parts	IEC 60601-2-63, (1st Edition): 2012 + Amd. 1, Clause. 201.7.2
318	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Dental extra-oral X-ray Equipment (Three Phase Voltage: Upto 600V AC, 120A, 50/60Hz Single Phase Voltage: Upto 300V AC, 100A, 50/60Hz)	Marking on the outside of ME EQUIPMENT or ME EQUIPMENT parts	IS 13450 (Part 2/Sec 63), Clause. 201.7.2
319	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Dental intra-oral X-ray Equipment (Three Phase Voltage: Upto 600V AC, 120A, 50/60Hz Single Phase Voltage: Upto 300V AC, 100A, 50/60Hz	Protection against excessive temperatures of X-RAY MONOBLOCK ASSEMBLIES	IEC 60601-2-65, (1st Edition): 2012 + Amd. 1, Clause. 201.11.101
320	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Dental intra-oral X-ray Equipment (Three Phase Voltage: Upto 600V AC, 120A, 50/60Hz Single Phase Voltage: Upto 300V AC, 100A, 50/60Hz	Protection against excessive temperatures of X-RAY MONOBLOCK ASSEMBLIES	IS 13450 (Part 2/Sec 65), Clause. 201.11.101
321	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Dental intra-oral X-ray Equipment (Three Phase Voltage: Upto 600V AC, 120A, 50/60Hz Single Phase Voltage: Upto 300V AC, 100A, 50/60Hz)	LEAKAGE CURRENTS and PATIENT AUXILIARY CURRENTS	IEC 60601-2-65, (1st Edition): 2012 + Amd. 1, Clause. 201.8.7
322	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Dental intra-oral X-ray Equipment (Three Phase Voltage: Upto 600V AC, 120A, 50/60Hz Single Phase Voltage: Upto 300V AC, 100A, 50/60Hz)	LEAKAGE CURRENTS and PATIENT AUXILIARY CURRENTS	IS 13450 (Part 2/Sec 65), Clause. 201.8.7
323	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electro cardiograph equipment	Defibrillation protection-common mode Test	IEC 60601-2-27 (3rd Edition), Clause. 201.8.5.5.1
324	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electro-cardiograph equipment	Channel crosstalk	IEC 60601-2-25 (2nd Edition), Clause. 201.12.4.106.2
325	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electro-cardiograph equipment	Common Mode Rejection	IEC 60601-2-25 (2nd Edition), Clause. 201.12.4.105.1
326	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electro-cardiograph equipment	Defibrillation protection	IEC 60601-2-25 (2nd Edition), Clause. 201.8.5.5.1

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Accreditation Standard	ISO/IEC 17025:2017
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327	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electro-cardiograph equipment	Goldberger and Wilson Leads	IEC 60601-2-25 (2nd Edition), Cl. 201.12.4.102.3.2
328	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electro-cardiograph equipment	Indication of inoperable Electrocardiograph	IEC 60601-2-25 (2nd Edition), Clause. 201.12.4.101
329	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electro-cardiograph equipment	Input impedance	IEC 60601-2-25 (2nd Edition), Clause. 201.12.4.103
330	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electro-cardiograph equipment	Linearity and dynamic range	IEC 60601-2-25 (2nd Edition), Cl. 201.12.4.107.2
331	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electro-cardiograph equipment	Low frequency (impulse) response	IEC 60601-2-25 (2nd Edition), Cl. 201.12.4.107.1.1.2
332	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electro-cardiograph equipment	Noise Level	IEC 60601-2-25 (2nd Edition), Clause. 201.12.4.106.1
333	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electro-cardiograph equipment	Overload tolerance	IEC 60601-2-25 (2nd Edition), Clause. 201.12.4.105.2
334	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electro-cardiograph equipment	Recording speed	IEC 60601-2-25 (2nd Edition), Cl. 201.12.4.108.3.2
335	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electro-cardiograph equipment	Recovery time	IEC 60601-2-25 (2nd Edition), Clause. 201.12.4.102.4
336	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electro-cardiograph equipment	Requirements for absolute interval and wave duration measurements	IEC 60601-2-25 (2nd Edition), Clause. 201.12.1.101.3.1
337	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electro-cardiograph equipment	Requirements for amplitude measurements	IEC 60601-2-25 (2nd Edition), Clause. 201.12.1.101.2
338	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electro-cardiograph equipment	Requirements for interval measurements on biological ECG	IEC 60601-2-25 (2nd Edition), Clause. 201.12.1.101.3.2
339	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electro-cardiograph equipment	Test with calibration ECGS	IEC 60601-2-25 (2nd Edition), Cl. 201.12.4.107.1.2
340	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electro-cardiograph equipment	Use with cardiac pacemakers	IEC 60601-2-25 (2nd Edition), Clause. 201.12.4.109
341	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Accuracy of signal reproduction	IEC 60601-2-27 (3rd Edition), Clause. 201.12.1.101.1
342	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Baseline reset	IEC 60601-2-27 (3rd Edition), Clause. 201.12.1.101.11
343	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Channel height and aspect ratio	IEC 60601-2-27 (3rd Edition), Cl. 201.12.1.101.16
344	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Common mode rejection	IEC 60601-2-27 (3rd Edition), Clause. 201.12.1.101.10

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345	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Differential mode Test	IEC 60601-2-27 (3rd Edition), Clause. 201.8.5.5.1
346	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Electrodes and Patient Cables	IEC 60601-2-27 (3rd Edition), Clause. 201.15.3.4.101
347	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Frequency and impulse response	IEC 60601-2-27 (3rd Edition), Clause. 2 01.12.1.101.8
348	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	GAIN control and stability	IEC 60601-2-27 (3rd Edition), Clause. 201.12.1.101.6
349	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Gain Indicator	IEC 60601-2-27 (3rd Edition), Clause2 01.12.1.101.9
350	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Heart rate range, accuracy, and QRS detection range	IEC 60601-2-27 (3rd Edition), Clause. 201.12.1.101.15
351	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Ingress of water or (Particulate matter into ME Equipment and ME System)	IEC 60601-2-27 (3rd Edition), Clause. 201.11.6.5
352	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Input dynamic range and differential offset voltage	IEC 60601-2-27 (3rd Edition), Clause. 201.12.1.101.2
353	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Input impedance	IEC 60601-2-27 (3rd Edition), Clause. 201.12.1.101.3
354	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Input Noise	IEC 60601-2-27 (3rd Edition), Clause. 201.12.1.101.4
355	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Interruption: of the power supply / supply mains to ME Equipment	IEC 60601-2-27 (3rd Edition), Clause. 201.11.8
356	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Multichannel crosstalk	IEC 60601-2-27 (3rd Edition), Clause. 201.12.1.101.5
357	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Rejection of pacemaker pulses	IEC 60601-2-27 (3rd Edition), Clause. 201.12.1.101.13
358	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Sweep speed	IEC 60601-2-27 (3rd Edition), Clause. 201.12.1.101.7
359	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Synchronizing pulse for cardio version	IEC 60601-2-27 (3rd Edition), Clause. 201.12.1.101.14
360	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Tall T-wave rejection capability	IEC 60601-2-27 (3rd Edition), Clause. 201.12.1.101.17
361	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Technical alarm condition indicating inoperable ME equipment	IEC 60601-2-27 (3rd Edition), Clause. 208.6.6.2.104
362	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Electrocardiographic monitoring Equipment	Time to alarm for heart rate alarm conditions	IEC 60601-2-27 (3rd Edition), Clause. 208.6.6.2.103

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363	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Actuating Parts of Controls	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 56.10 (Withdrawn Standard)
364	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Cord Connected Foot Switch Test	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 56.11 (Withdrawn Standard)
365	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Interruption of Power Supply	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 49 (Withdrawn Standard)
366	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Reversed Battery Connection by inspection	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 56.7 (Withdrawn Standard)
367	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Transformer Dielectric Voltage Withstand	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 57.9.4 (Withdrawn Standard)
368	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Transformer Overload and Short-Circuit Tests	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 57.9.1 (Withdrawn Standard)
369	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Suspension Systems without Safety Device Loading Test	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 28.4 (Withdrawn Standard)
370	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Transformer overload test	IS 13450 (Part 1), Clause. 15.5.1.3
371	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Abnormal operations and fault conditions Test	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2,Clause. 52 (Withdrawn Standard)
372	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Abnormal operations and fault conditions Test	IEC 60601-1 (3rd Edition): 2005 Amd 1, Clause. 13
373	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Abnormal operations and fault conditions Test	IS 13450 (Part 1), Clause. 13
374	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Actuating Parts of Control of ME Equipment	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 15.4.6
375	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Actuating Parts of Control of ME Equipment	IS 13450 (Part 1), Clause. 15.4.6

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376	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Ball pressure Test	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 59.2 (Withdrawn Standard)
377	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Ball pressure Test	IEC 60601-1 (3rd Edition): 2005 Amd 1, Clause. 8.8.4.1
378	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Ball pressure Test	IS 13450 (Part 1), Clause. 8.8.4.1
379	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Cleaning and Disinfection of ME Equipment's and ME Systems	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 11.6.6
380	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Cleaning and Disinfection of ME Equipment's and ME Systems	IS 13450 (Part 1), Clause. 11.6.6
381	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Cord – Connected Foot Operated Control Devices	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 15.4.7.1
382	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Cord – Connected Foot Operated Control Devices	IS 13450 (Part 1), Clause. 15.4.7.1
383	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Cord Anchorage	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Cl. 8.11.3.5
384	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Cord Anchorage	IS 13450 (Part 1), Clause. 8.11.3.5
385	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Cord Anchorages	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 57.4
386	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Cord Bending	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 57.4
387	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Cord Bending	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 8.11.3.6
388	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Cord Bending	IS 13450 (Part 1), Clause. 8.11.3.6
389	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Defib-Proof Applied Parts, Common mode test	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 8.5.5
390	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Defib-Proof Applied Parts, Common mode test	IS 13450 (Part 1), Clause. 8.5.5
391	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Defib-Proof Applied Parts, Differential mode test	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 8.5.5
392	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Defib-Proof Applied Parts, Differential mode test	IS 13450 (Part 1), Clause. 8.5.5

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393	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Defib-Proof Applied Parts, Energy Reduction	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 8.5.5.2
394	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Defib-Proof Applied Parts, Energy Reduction	IS 13450 (Part 1), Clause. 8.5.5.2
395	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Defibrillation-Proof Applied Parts	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 17 (Withdrawn standard)
396	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Dielectric voltage withstand Test	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2,Clause. 20.4
397	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Dielectric voltage withstand Test	IEC 60601-1 (3rd Edition), (Clause. 8.8)
398	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Dielectric voltage withstand Test	IEC 60601-1 (3rd Edition): 2005 Amd 1, Clause. 8.8
399	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Dielectric voltage withstand Test	IS 13450 (Part 1), Clause. 8.8
400	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Drop Impact Test	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 21.5 (Withdrawn Standard)
401	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Earthing and potential equalization Test	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2,Clause. 18 f (Withdrawn Standard)
402	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Enclosure mechanical strength	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 21a,b (Withdrawn Standard)
403	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Enclosure mechanical strength	IEC 60601-1 (3rd Edition): 2005 Amd 1, Clause. 15.3
404	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Enclosure mechanical strength	IS 13450 (Part 1), Clause. 15.3
405	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Handle Loading	IEC 60601-1 (3rd Edition):2005 Amd 1, Cl. 9.4.4
406	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Handle Loading	IS 13450 (Part 1), Clause. 9.4.4
407	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Handle Loading Test	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 21

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408	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Harmful Ingress	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 11.6.5
409	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Harmful Ingress	IS 13450 (Part 1), Clause. 11.6.5
410	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Humidity conditioning Test	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 44.5 (Withdrawn Standard)
411	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Humidity conditioning Test	IEC 60601-1 (3rd Edition): 2005 Amd 1, Clause. 5.7
412	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Humidity conditioning Test	IS 13450 (Part 1), Clause. 5.7
413	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Impedance and Current Carrying Capability	IEC 60601-1 (3rd Edition): 2005 Amd 1, Clause. 8.6.4 a
414	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Impedance and Current Carrying Capability	IS 13450 (Part 1), Clause 8.6.4 a
415	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Incorrect Polarity	IS 13450 (Part 1), Clause. 8.2.2
416	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Instability from Unwanted Lateral Movement(Including Sliding)	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 9.4.3.1
417	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Instability from Unwanted Lateral Movement(Including Sliding),	IS 13450 (Part 1), Clause. 9.4.3.1
418	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Instability Hazards	IEC 60601-1 (3rd Edition), Clause. 9.4.3
419	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Instability Hazards	IEC 60601-1 (3rd Edition): 2005 Amd 1, Clause. 9.4.3
420	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Instability Hazards	IS 13450 (Part 1), Clause. 9.4.3
421	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Interruption power supply Test	IEC 60601-1 (3rd Edition): 2005 Amd 1, Clause. 11.8
422	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Interruption power supply Test	IS 13450 (Part 1), Clause. 11.8
423	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Leakage	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 11.6.4
424	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Leakage	IS 13450 (Part 1), Clause. 11.6.4

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
425	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Leakage current Test	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 19 (Withdrawn Standard)
426	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Leakage current Test	IEC 60601-1 (3rd Edition): 2005 Amd 1, Clause. 8.7
427	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Leakage current Test	IS 13450 (Part 1), Clause. 8.7
428	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Legibility of Markings	IEC 60601-1 (3rd Edition): 2005 Amd 1, Clause. 7.1.2
429	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Legibility of Markings	IS 13450 (Part 1), Clause. 7.1.2
430	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Limitation of Voltage, Current or Power	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 8.4.2
431	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Limitation of Voltage, Current or Power	IS 13450 (Part 1), Clause. 8.4.2
432	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Marking durability Test	IEC 60601-1 (3rd Edition): 2005" Amd 1 Clause. 7.1.3
433	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Marking durability Test	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 6.1 (Withdrawn Standard)
434	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Marking durability Test	IS 13450 (Part 1), Clause. 7.1.3
435	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	ME System Leakage Current	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 16.6.1
436	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	ME System Leakage Current	IS 13450 (Part 1), Clause. 16.6.1
437	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Measurement of Gaps(Trapping Zones)	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 9.2.2.2
438	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Measurement of Gaps(Trapping Zones)	IS 13450 (Part 1), Clause. 9.2.2.2
439	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Mechanical Strength – Dynamic Forces	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 9.8.3.3
440	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Mechanical Strength – Dynamic Forces	IS 13450 (Part 1), Clause. 9.8.3.3
441	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Mechanical Strength – Foot Rest	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 9.8.3.2

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442	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Mechanical Strength – Foot Rest	IS 13450 (Part 1), Clause. 9.8.3.2
443	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Mechanical Strength - Foot Rests/Chairs	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 21.3 (Withdrawn Standard)
444	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Mechanical Strength - Patient Support System	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 21.3 (Withdrawn standard)
445	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Mechanical Strength- Patient Support System	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 9.8.3.1
446	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Mechanical Strength- Patient Support System	IS 13450 (Part 1), Clause. 9.8.3.1
447	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Mobile Equipment Force for Propulsion	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 9.4.2.4.2
448	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Mobile Equipment Force for Propulsion	IS 13450 (Part 1), Clause. 9.4.2.4.2
449	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Mobile Equipment Over a Threshold (wood thickness)	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 9.4.2.4.3
450	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Mobile Equipment Over a Threshold (wood thickness)	IS 13450 (Part 1), Cl. 9.4.2.4.3
451	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Overflow	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 11.6.2
452	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Overflow	IS 13450 (Part 1), Clause. 11.6.2
453	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Overflow, Spillage, Leakage, Cleaning, Disinfection, Harmful Ingress Of Liquids	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 44 (Withdrawn Standard)
454	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Patient Lead Connection	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 8.5.2.3
455	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Patient Lead Connection	IS 13450 (Part 1), Clause. 8.5.2.3
456	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Power input Test	IEC 60601-1 (3rd Edition):2005 Amd 1, Clause. 4.11
457	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Power input Test	IS 13450 (Part 1), Clause. 4.11

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458	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Reverse Battery Connection/Overcharging by inspection	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 15.4.3
459	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Reverse Battery Connection/Overcharging by inspection	IS 13450 (Part 1), Clause. 15.4.3
460	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Rough Handling – Drop Test	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 21.6 (Withdrawn Standard)
461	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Rough Handling – Roll Off Step Test	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 21.6 (Withdrawn Standard)
462	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Short Circuiting in Lieu of Spacing	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 8.9.2
463	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Short Circuiting in Lieu of Spacing	IS 13450 (Part 1), Clause 8.9.2
464	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Shorting one MOP	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 8.1b
465	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Shorting one MOP	IS 13450 (Part 1), Clause. 8.1b
466	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Spillage	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 11.6.3
467	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Spillage	IS 13450 (Part 1), Clause. 11.6.3
468	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Stability and transportability Test	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2,Clause. 24 (Withdrawn Standard)
469	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Stability and transportability Test	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 9.4.2
470	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Stability and transportability Test	IS 13450 (Part 1), Clause. 9.4.2
471	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Suspension system w/Safety Devices Loading	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 9.8.4
472	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Suspension system w/Safety Devices Loading	IS 13450 (Part 1), Clause. 9.8.4

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473	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Suspension System With Safety Devices Loading Test	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 28.3 (Withdrawn Standard)
474	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Temperature and Overload Control Device	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 15.4.2.1
475	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Temperature and Overload Control Device	IS 13450 (Part 1), Clause. 15.4.2.1
476	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Temperature Test	IEC 60601-1 (3rd Edition): 2005 Amd 1, Clause. 11
477	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Temperature Test	IS 13450 (Part 1), Clause. 11
478	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Thermal Cycling for spaces filled with insulating material	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 8.9.5
479	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Thermal Cycling for spaces filled with insulating material	IS 13450 (Part 1), Clause. 8.9.5
480	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Transformer Dielectric Voltage Withstand	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 15.5.2
481	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Transformer Dielectric Voltage Withstand	IS 13450 (Part 1), Clause. 15.5.2
482	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Transformer overload test	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 15.5.1.3
483	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Transformer Short Circuit	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 15. 5.1.2
484	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Transformer Short Circuit	IS 13450 (Part 1), Clause. 15. 5.1.2
485	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Voltage limitation Test	IEC 60601-1 (2nd Edition): 1988 AM 1: 1991, AM 2, Clause. 15 (Withdrawn Standard)
486	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Voltage mismatch	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 7.2.6
487	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Voltage mismatch	IS 13450 (Part 1), Clause. 7.2.6
488	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Voltage or Charge Limitation	IEC 60601-1 (3rd Edition):2005 Amd 1, Clause. 8.4.3
489	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Voltage or Charge Limitation	IS 13450 (Part 1), Clause. 8.4.3

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490	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Working Voltage Measurement	IEC 60601-1 (3rd Edition): 2005 Amd. 1, Clause. 8.5.4
491	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Working Voltage Measurement	IS 13450 (Part 1), Clause. 8.5.4
492	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems used in Home healthcare	ENVIRONMENTAL Test conditions of transport and storage	IEC 60601-1-11 (2nd Edition), Sub-Clause. 4.2.1
493	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems used in Home healthcare	ENVIRONMENTAL Test operation condition	IEC 60601-1-11 (2nd Edition), Sub-Clause. 4.2.2
494	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems used in Home healthcare	FREE FALL Test	IEC 60601-1-11 (2nd Edition), Clause: 10.1.3d
495	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems used in Home healthcare	Harmful Ingress of Liquids Test	IEC 60601-1 (2nd Ed.) 1988 AM 1: 1991, AM 2, Clause. 44.6
496	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems used in Home healthcare	Harmful Ingress of Liquids Test	IEC 60601-1-11 (2nd Edition), Sub-Clause. 8.3
497	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Multifunction patient monitor Equipment	Ingress of water or (Particulate matter into Medical Equipment and Medical Systems	IEC 60601-2-49 (2nd Edition), Clause. 201.11.6.5 (Withdrawn Standard)
498	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Multifunction patient monitor Equipment	Ingress of water or (Particulate matter into Medical Equipment and Medical Systems	IEC 80601-2-49 (1st Edition), Clause. 201.11.6.5
499	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Multifunction patient monitor Equipment	Interruption): of the power supply / Supply Mains to Medical Equipment	IEC 60601-2-49 (2nd Edition), Clause. 201.11.8 (Withdrawn Standard)
500	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Multifunction patient monitor Equipment	Interruption): of the power supply / Supply Mains to Medical Equipment	IEC 80601-2-49 (1st Edition), Clause. 201.11.8
501	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Multifunction patient monitor Equipment	Part Leakage Current	IEC 60601-2-49 (2nd Edition), Clause. 201.8.7.1.101 (Withdrawn Standard)
502	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Pulse oximeter Equipment	Additional requirements for ingress of water or (Particulate matter into ME equipment or ME system)	ISO 80601-2-61 (1st Edition), Clause. 201.11.6.5.101 (Withdrawn Standard)
503	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Pulse Oximeter Equipment	Additional requirements for ingress of water or (Particulate matter into ME equipment or ME system)	ISO 80601-2-61 (2nd Edition), Clause. 201.11.6.5.101

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504	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Pulse oximeter Equipment	Additional requirements for interruption of the power supply/SUPPLY MAINS to ME EQUIPMENT	ISO 80601-2-61 (1st Edition), Clause. 201.11.8.101 (Withdrawn Standard)
505	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Pulse Oximeter Equipment	Additional requirements for interruption of the power supply/SUPPLY MAINS to ME EQUIPMENT	ISO 80601-2-61 (2nd Edition), Clause. 201.11.8.101
506	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Pulse Oximeter Equipment	Detection of pulse oximeter probe faults and probe cable extender faults	ISO 80601-2-61 (1st Edition), Clause. 201.13.101 (Withdrawn Standard)
507	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	Pulse Oximeter Equipment	Detection of pulse oximeter probe faults and probe cable extender faults	ISO 80601-2-61 (2nd Edition), Clause. 201.13.101
508	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	X-Ray Equipment (Three Phase Voltage: Upto 600V AC, 120A, 50/60Hz Single Phase Voltage: Upto 300V AC, 100A, 50/60Hz)	Marking on the outside of ME EQUIPMENT or ME EQUIPMENT parts	IEC 60601-1-3 (2nd Edition): 2008 Amd. 1, Clause. 5.1
509	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	X-Ray Equipment (Three Phase Voltage: Upto 600V AC, 120A, 50/60Hz Single Phase Voltage: Upto 300V AC, 100A, 50/60Hz)	Marking on the outside of ME EQUIPMENT or ME EQUIPMENT parts	IS 13450 (Part 1/ Sec 3), Clause. 5.1
510	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	X-ray equipment for interventional procedures (Three Phase Voltage: Upto 600V AC, 120A, 50/60Hz Single Phase Voltage: Upto 300V AC, 100A, 50/60Hz)	Protection against excessive temperature	IEC60601-2-43(2nd edition) 2010 + Amd.1: 2017/Amd.2, Clause 203.2.1.11
511	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	X-ray equipment for interventional procedures (Three Phase Voltage: Upto 600V AC, 120A, 50/60Hz Single Phase Voltage: Upto 300V AC, 100A, 50/60Hz)	Protection against excessive temperature	IS 13450 (Part2/Sec 43), Clause 203.2.1.11
512	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	X-ray Equipment for Radiography and Radioscopy (Three Phase Voltage: Upto 600V AC, 120A, 50/60Hz Single Phase Voltage: Upto 300V AC, 100A, 50/60Hz)	LEAKAGE CURRENTS and PATIENT AUXILIARY CURRENTS	IEC 60601-2-54 (1st Edition): 2009 + Amd. 1: 2015 + Amd. 2, Clause. 201.8.7
513	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	X-ray Equipment for Radiography and Radioscopy (Three Phase Voltage: Upto 600V AC, 120A, 50/60Hz Single Phase Voltage: Upto 300V AC, 100A, 50/60Hz)	LEAKAGE CURRENTS and PATIENT AUXILIARY CURRENTS	IS 13450 (Part 2/Sec 54), Clause. 201.8.7
514	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	X-ray tube assemblies for medical diagnosis (Three Phase Voltage: Upto 600V AC, 120A, 50/60Hz Single Phase Voltage: Upto 300V AC, 100A, 50/60Hz)	Maximum temperature during NORMAL USE	IEC 60601-2-28 (3rd Edition), Clause. 201.11.1.1
515	ELECTRONICS- MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Measurement of nominal operating cell temperature (NOCT)	IEC 61215 (2nd Edition): 2005-04 Clause 10.5
516	ELECTRONICS- MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Measurement of nominal operating cell temperature (NOCT)	IS 14286: 2010(FIRST REVISION), Clause 10.5

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517	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Outdoor exposure Test	IEC 61215 (2nd Edition): 2005-04 (Clause 10.8)
518	ELECTRONICS-MISCELLANEOUS PRODUCTS	Crystalline silicon terrestrial photovoltaic (PV) modules - Design qualification and type approval	Outdoor exposure Test	IS 14286: 2010(FIRST REVISION),, (Clause 10.8)
519	ELECTRONICS-MISCELLANEOUS PRODUCTS	Part 1-2: Special requirements for testing of thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Measurement of Nominal operating temperature	IS 14286 (Part 1/Sec 2) : 2019 IEC 61215-1-2 : 2016, Clause 11.5
520	ELECTRONICS-MISCELLANEOUS PRODUCTS	Part 1-3: Special requirements for testing of thin-film amorphous silicon based photovoltaic (PV) modules	Measurement of Nominal operating temperature	IS 14286 (Part 1/Sec 3) : 2019 IEC 61215-1-3 : 2016, Clause 11.5
521	ELECTRONICS-MISCELLANEOUS PRODUCTS	Part 1-4: Special requirements for testing of thin-film Cu(In,Ga) (S,Se)2 based photovoltaic (PV) modules	Measurement of Nominal operating temperature	IS 14286 (Part 1/Sec 4) : 2019 IEC 61215-1-4 : 2016 , Clause 11.5
522	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules Design qualification and type approval – Part 1-1: Special requirements for testing of crystalline silicon photovoltaic (PV) Modules	Measurement of Nominal operating temperature	IS 14286 (Part 1/Sec 1) : 2019 , IEC 61215-1-1 : 2016, Clause 11.5
523	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Measurement of nominal module operating temperature (NMOT)	IS 14286 (Part 2), Clause 4.5
524	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Measurement of nominal module operating temperature (NMOT)	IEC 61215-2, Clause 4.5
525	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Outdoor exposure test	IEC 61215-2, Clause 4.8
526	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial Photovoltaic (PV) modules	Outdoor exposure test	IS 14286 (Part 2), Clause 4.8
527	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- crystalline silicon photovoltaic (PV) Modules	Outdoor exposure test	IS 14286 (Part 1/Sec 1), Clause 11.8
528	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Outdoor exposure test	IEC 61215-1-3, Clause 11.8
529	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film amorphous silicon based photovoltaic (PV) modules	Outdoor exposure test	IS 14286 (Part 1/Sec 3) , Clause 11.8
530	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Outdoor exposure test	IEC 61215-1-2, Clause 11.8

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
531	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cadmium Telluride (CdTe) based photovoltaic (PV) modules	Outdoor exposure test	IS 14286 (Part 1/Sec 2), Clause 11.8
532	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Outdoor exposure test	IEC 61215-1-4, Clause 11.8
533	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules- thin-film Cu(In,Ga)(S,Se)2 based photovoltaic (PV) modules	Outdoor exposure test	IS 14286 (Part 1/Sec 4) , Clause 11.8
534	ELECTRONICS-MISCELLANEOUS PRODUCTS	Terrestrial photovoltaic (PV) modules-crystalline silicon photovoltaic (PV) Modules	Outdoor exposure test	IEC 61215-1-1, Clause 11.8
535	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Measurement of nominal operating cell temperature (NOCT)	IEC 61646 (2nd Edition) : 2008-05. (Clause. 10.5)
536	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Measurement of nominal operating cell temperature (NOCT)	IS 16077 : 2013, Clause 10.5
537	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Outdoor exposure Test	IEC 61646 (2nd Edition) : 2008-05. Clause. 10.8
538	ELECTRONICS-MISCELLANEOUS PRODUCTS	Thin-film terrestrial photovoltaic (PV) modules - Design qualification and type approval	Outdoor exposure Test	IS 16077 : 2013, Clause 10.8
539	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Wheels or casters attachment requirement	IEC 62368-1 (ed3.0:2018) Clause 8.9 (8.9.1 & 8.9.2)
540	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Accessibility for an ordinary person / instructed person	IEC 62368-3, 1 Ed. (2017-12) Clause 6.3.2
541	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Accessibility for an ordinary person / instructed person	IEC 62368-3, Clause 6.3.2
542	ELECTRONICS- SAFETY TESTING FACILITY	Audio/Video, Information and Communication Technology Equipment	Accessibility to electrical energy sources and safeguards	EN 62368-1 (Clause 5.3.2)
543	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Accessibility to electrical energy sources and safeguards	EN 62368-1-2020 Clause 5.3, 5.3.1, 5.3.2, Annex V)
544	ELECTRONICS- SAFETY TESTING FACILITY	Audio/Video, Information and Communication Technology Equipment	Accessibility to electrical energy sources and safeguards	IEC 62368-1(ed 2 :2014) (Clause 5.3.2)
545	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Accessibility to electrical energy sources and safeguards	IEC 62368-1(ed 3.0 : 2018) (Clause 5.3, 5.3.1, 5.3.2, Annex V)

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
546	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Antenna Terminal Insulation	EN 62368-1 (Clause 5.4.5) Ed 3
547	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Antenna Terminal Insulation	EN 62368-1 (Clause 5.4.5) Ed. 2
548	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Antenna Terminal Insulation	IEC 62368-1(ed 2 :2014) (Clause 5.4.5)
549	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Antenna Terminal Insulation	IEC 62368-1(ed 3.0: 2018) (Clause 5.4.5)
550	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Back feed safeguard in battery backed up supplies	EN 62368-1-2020 (Clause 5.8)
551	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Back feed safeguard in battery backed up supplies	IEC 62368-1(ed 3.0: 2018) (Clause 5.8)
552	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Ball pressure test	EN 62368-1 (Clause 5.4.1.10.3) Ed. 2
553	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Ball pressure test	EN 62368-1-2020 (Clause 5.4.1.10.3) Ed. 3
554	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Ball pressure test	IEC 62368-1(ed 2 :2014) (Clause 5.4.1.10.3)
555	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Ball pressure test	IEC 62368-1-2020 (ed 3.0: 2018) (Clause 5.4.1.10.3)
556	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Battery and their Protection Circuit	EN 62368-1-2020 (Annex M.3.2,3.3, 4.4)
557	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Battery and their Protection Circuit	IEC 62368-1(ed 3.0 :2018) (Annex M.3.2,3.3, 4.4)
558	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Battery Replacement Test	EN 62368-1 , Clause 4.8.4.3 and 4.8.5
559	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Battery Replacement Test	EN 62368-1-2020 Clause 4.8.4.3
560	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Battery Replacement Test	IEC 62368-1(ed. 3.0 :2018) Clause 4.8.4.3
561	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Battery Replacement Test	IEC 62368-1, Clause 4.8.4.3 and 4.8.5
562	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Capacitor discharge	EN 62368-1 (Clause 5.5.2.2)
563	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Capacitor discharge	EN 62368-1-2020 (Clause 5.5.2.2)
564	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Capacitor discharge	IEC 62368-1 (ed 2 :2014) (Clause 5.5.2.2)

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565	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Capacitor discharge	IEC 62368-1 (ed 3.0 :2018) (Clause 5.5.2.2)
566	ELECTRONICS- SAFETY TESTING FACILITY	Audio/Video, Information and Communication Technology Equipment	Cart, stand or carrier loading test	EN 62368-1 (Clause 8.10.3)
567	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Cart, stand or carrier loading test	EN 62368-1-2020 (Clause 8.10.3,8.10.4,8.10.5,8.10.6)
568	ELECTRONICS- SAFETY TESTING FACILITY	Audio/Video, Information and Communication Technology Equipment	Cart, stand or carrier loading test	IEC 62368-1 (ed 2 :2014) (Clause 8.10.3)
569	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Cart, stand or carrier loading test	IEC 62368-1 (ed 3.0 :2018) Clause 8.10.3, 8.10.4, 8.10.5,8.10.6
570	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Classification and limits of electrical energy sources	EN 62368-1, Clause 5.2 Ed. 2
571	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Classification and limits of electrical energy sources	EN 62368-1-2020 (Clause 5.2, 5.2.1, 5.2.2)
572	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Classification and limits of electrical energy sources	IEC 62368-1(ed 3.0 : 2018) (Clause 5.2, 5.2.1, 5.2.2)
573	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Classification and limits of electrical energy sources	IEC 62368-1, Clause 5.2, 5.2.1, 5.2.2
574	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Clearance, creepage	EN 62368-1 (Clause 5.4.2, 5.4.3)
575	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Clearance, creepage	IEC 62368-1 (ed 2 :2014) (Clause 5.4.2, 5.4.3)
576	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Clearance, creepage	IEC 62368-1 (ed 3.0 :2018) (Clause 5.4.2, 5.4.3, Annex O)
577	ELECTRONICS- SAFETY TESTING FACILITY	Audio/Video, Information and Communication Technology Equipment	Compliance criteria (Force test)	EN 62368-1 (Clause 4.8.5)
578	ELECTRONICS- SAFETY TESTING FACILITY	Audio/Video, Information and Communication Technology Equipment	Compliance criteria (Force test)	IEC 62368-1(ed 2 :2014) (Clause 4.8.5)
579	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Criteria for telephone ringing signals (TNV circuit test)	EN 62368-1 (Annex H)
580	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Criteria for telephone ringing signals (TNV circuit test)	EN 62368-1-2020 (Annex H)
581	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Criteria for telephone ringing signals (TNV circuit test)	IEC 62368-1 (ed 2 :2014) (Annex H)
582	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Criteria for telephone ringing signals (TNV circuit test)	IEC 62368-1 (ed 3.0 :2018) (Annex H)

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583	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Crush test	EN 62368-1 (Clause 4.8.4.6)
584	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Crush test	EN 62368-1 -2020 (Clause 4.8.4.6)
585	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Crush test	IEC 62368-1(ed 2 :2014) (Clause 4.8.4.6)
586	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Crush test	IEC 62368-1(ed 3.0 : 2018) (Clause 4.8.4.6)
587	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Determining the adequacy of a clearance using an electric strength test	EN 62368-1 Clause 5.4.2.4
588	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Determining the adequacy of a clearance using an electric strength test	EN 62368-1, Clause 5.4.2.4 Ed. 2
589	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Determining the adequacy of a clearance using an electric strength test	EN 62368-1-2020 Clause 5.4.2.4 Ed. 3
590	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Determining the adequacy of a clearance using an electric strength test	IEC 62368-1 (ed2:2014) Clause 5.4.2.4
591	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Determining the adequacy of a clearance using an electric strength test	IEC 62368-1 (ed3.0:2018) Clause 5.4.2.4
592	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Determining the adequacy of a clearance using an electric strength test	IEC 62368-1, Clause 5.4.2.4
593	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Downward force test	EN 62368-1 Clause 8.6.2.3
594	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Downward force test	EN 62368-1-2020 Clause 8.6.2.3
595	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Downward force test	IEC 62368-1 (ed2:2014) Clause 8.6.2.3
596	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Downward force test	IEC 62368-1 (ed3.0:2018) Clause 8.6.2.3
597	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Drop Test	EN 62368-1 (Annex T.7)
598	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Drop Test	EN 62368-1-2020 Clause 4.8.4.4
599	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Drop Test	IEC 62368-1 (ed 2 :2014) (Annex T.7)

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
600	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Drop Test	IEC 62368-1(ed. 3.0 :2018) Clause 4.8.4.4, Annex T.7
601	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Electric strength test	EN 62368-1 (Clause 5.4.9)
602	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Electric strength test	EN 62368-1-2020 (Clause 5.4.9)
603	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Electric strength test	IEC 62368-1 (ed 2 :2014) (Clause 5.4.9)
604	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Electric strength test	IEC 62368-1 (ed 3.0 :2018) (Clause 5.4.9)
605	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Enclosure impact test	EN 62368-1 (Annex T.6)
606	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Enclosure impact test	EN 62368-1-2020 (Annex T.6)
607	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Enclosure impact test	IEC 62368-1 (ed 2 :2014) (Annex T.6)
608	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Enclosure impact test	IEC 62368-1 (ed 3.0 :2018) (Annex T.6)
609	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Equipment containing coin / button cell batteries (Stress Relief Test)	EN 62368-1-2020 Clause (Clause 4.8, 4.8.4.2, Annex T.8)
610	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Equipment containing coin / button cell batteries (Stress Relief Test)	IEC 62368-1(ed. 3.0 :2018) (Clause 4.8, 4.8.4.2, Annex T.8)
611	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Equipment for direct insertion into mains socket- outlets	EN 62368-1 (Clause 4.7)
612	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Equipment for direct insertion into mains socket- outlets	EN 62368-1-2020 (Clause 4.7)
613	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Equipment for direct insertion into mains socket- outlets	IEC 62368-1 (ed 2 :2014) (Clause 4.7)
614	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Equipment for direct insertion into mains socket- outlets	IEC 62368-1 (ed 3 :2018) (Clause 4.7, 4.7.1, 4.7.2, 4.7.3)
615	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Equipment mounted to a wall or ceiling	EN 62368-1 (Clause 8.7)
616	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Equipment mounted to a wall or ceiling	EN 62368-1-2020 (Clause 8.7.2)
617	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Equipment mounted to a wall or ceiling	IEC 62368-1(ed 2 :2014) (Clause 8.7)

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618	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Equipment mounted to a wall or ceiling	IEC 62368-1(ed 3.0 :2018) (Clause 8.7.2)
619	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Fixing Conductor	EN 62368-1 (Clause 4.6)
620	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Fixing Conductor	EN 62368-1-2020 Clause 4.6 (4.6.1,4.6.2)
621	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Fixing Conductor	IEC 62368-1(ed 2 :2014) (Clause 4.6)
622	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Fixing Conductor	IEC 62368-1(ed 3.0 : 2018) Clause 4.6 (4.6.1, 4.6.2)
623	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Force test (Battery Compartment door/Cover)	EN 62368-1 , Clause 4.8.5
624	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Force test (Battery Compartment door/Cover)	EN 62368-1-2020 (Clause 4.8.5)
625	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Force test (Battery Compartment door/Cover)	IEC 62368-1(ed 3.0 : 2018) (Clause 4.8.5)
626	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Force test (Battery Compartment door/Cover)	IEC 62368-1, Clause 4.8.5
627	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Glass Fragmentation Test	IEC 62368-1 (ed 3.0 :2018) (Annex T.10)
628	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Glass Impact test	EN 62368-1-2020 (Annex T.9)
629	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Glass Impact test	IEC 62368-1 (ed 3.0 :2018) (Annex T.9)
630	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Glass slide test	EN 62368-1 Clause 8.6.4
631	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Glass slide test	EN 62368-1-2020 Clause 8.6.4
632	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Glass slide test	IEC 62368-1 (ed2:2014) Clause 8.6.4
633	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Glass slide test	IEC 62368-1 (ed3.0:2018) Clause 8.6.4
634	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Handle strength	EN 62368-1 (Clause 8.8)
635	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Handle strength	EN 62368-1-2020 (Clause 8.8)
636	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Handle strength	IEC 62368-1(ed 2 :2014) (Clause 8.8)

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637	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Handle strength	IEC 62368-1(ed 3.0 :2018) (Clause 8.8)
638	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Horizontal force test	EN 62368-1 (Clause 8.6.5)
639	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Horizontal force test	IEC 62368-1 (ed 2 :2014) (Clause 8.6.5)
640	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Horizontal force test	IEC 62368-1 (ed 3.0 :2018) (Clause 8.6.5)
641	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Humidity conditioning	EN 62368-1 (Clause 5.4.8)
642	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Humidity conditioning	EN 62368-1-2020 (Clause 5.4.8)
643	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Humidity conditioning	IEC 62368-1 (ed3.0:2018) (Clause 5.4.8)
644	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Humidity conditioning	IEC 62368-1(ed 2 :2014) (Clause 5.4.8)
645	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Impact	EN 62368-1 , Clause 4.8.4.5
646	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Impact	EN 62368-1 Clause 4.8.4.5
647	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Impact	IEC 62368-1(ed 3.0 : 2018) Clause 4.8.4.5
648	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Impact	IEC 62368-1, Clause 4.8.4.5
649	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Impact (Battery Compartment)	EN 62368-1 Clause 4.8.4.5
650	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Impact (Battery Compartment)	IEC 62368-1 (ed2:2014) Clause 4.8.4.5
651	ELECTRONICS- SAFETY TESTING FACILITY	Audio/Video, Information and Communication Technology Equipment	Impact test	EN 62368-1 (Annex T.9)
652	ELECTRONICS- SAFETY TESTING FACILITY	Audio/Video, Information and Communication Technology Equipment	Impact test	IEC 62368-1 (ed 2 :2014) (Annex T.9)
653	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Impulse test	EN 62368-1 (Clause 5.4.10.2.2)
654	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Impulse test	EN 62368-1-2020 (Clause 5.4.10.2.2)
655	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Impulse test	IEC 62368-1 (ed 2 :2014) (Clause 5.4.10.2.2)

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656	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Impulse test	IEC 62368-1 (ed 3.0 :2018) (Clause 5.4.10.2.2)
657	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Input test	EN 62368-1 (Annex B.2.5)
658	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Input test	EN 62368-1, Annex B.2.5
659	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Input test	IEC 62368-1 (Annex B.2.5)
660	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Input test	IEC 62368-1 (ed3.0 :2018) (Annex B.2.5)
661	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Insulation breakdown test	EN 62368-1-2020 (Clause 5.4.10.3)
662	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Insulation breakdown test	IEC 62368-1 (ed 3.0 :2018) (Clause 5.4.10.3)
663	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Insulation of internal wire as a part of supplementary safeguard	EN 62368-1, Clause 5.4.6
664	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Insulation of internal wire as a part of supplementary safeguard	EN 62368-1-2020 Clause 5.4.6
665	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Insulation of internal wire as a part of supplementary safeguard	IEC 62368-1 (ed3.0:2018) Clause 5.4.6
666	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Insulation of internal wire as a part of supplementary safeguard	IEC 62368-1, Clause 5.4.6
667	ELECTRONICS- SAFETY TESTING FACILITY	Audio/Video, Information and Communication Technology Equipment	Leakage Current	EN 62368-1 (Annex M.6.2)
668	ELECTRONICS- SAFETY TESTING FACILITY	Audio/Video, Information and Communication Technology Equipment	Leakage Current	IEC 62368-1(ed 2 :2014) (Annex M.6.2)
669	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Limited power source	EN 62368-1 (Annex Q.1)
670	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Limited power source	EN 62368-1-2020 (Annex Q.1)
671	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Limited power source	IEC 62368-1(ed 2 :2014) (Annex Q.1)
672	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Limited power source	IEC 62368-1(ed 3.0 :2018) (Annex Q.1)

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673	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Mains supply connection (Cord anchorage)	EN 62368-1-2020 (Annex G.7.3, 7.3.2,7.3.2.1,7.3.2.2)
674	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Mains supply connection (Cord anchorage)	IEC 62368-1 (ed 3.0 :2018) (Annex G.7.3, 7.3.2,7.3.2.1,7.3.2.2)
675	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Mains supply connection (Cord anchorage)	EN 62368-1 (Annex G.7)
676	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Mains supply connection (Cord anchorage)	IEC 62368-1 (ed 2 :2014) (Annex G.7)
677	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Mandrel test	EN 62368-1 Clause 5.4.4.6.5
678	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Mandrel test	EN 62368-1, Clause 5.4.4.6.5
679	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Mandrel test	IEC 62368-1 (ed2:2014) Clause 5.4.4.6.5
680	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Mandrel test	IEC 62368-1 (ed3:2018) Clause 5.4.4.6.5
681	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Mandrel test	IEC 62368-1 , Clause 5.4.4.6.5
682	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Maximum operating temperature (Temperature measurement)	EN 62368-1-2020 (Clause 5.4.1.4, Annex B.1.5)
683	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Maximum operating temperature (Temperature measurement)	IEC 62368-1 (ed 3.0 :2018) (Clause 5.4.1.4, Annex B.1.5)
684	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Maximum operating temperature (Temperature measurement)	EN 62368-1 (Clause 5.4.1.4)
685	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Maximum operating temperature (Temperature measurement)	IEC 62368-1 (ed 2 :2014) (Clause 5.4.1.4)
686	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Mechanical strength test for SRME	IEC 62368-1 (ed3.0:2018) Clause 8.11.3 (8.11.3.1 to 8.11.4)
687	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Mounting means for rack mounted equipment	EN 62368-1 Clause 8.11 (8.11.1 to 8.11.5)
688	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Mounting means for rack mounted equipment	IEC 62368-1 (ed2:2014) Clause 8.11 (8.11.1 to 8.11.5)
689	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Power source circuit classification	EN 62368-1 (Clause 6.2.2)

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690	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Power source circuit classification	EN 62368-1-2020 (Clause 6.2.2)
691	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Power source circuit classification	IEC 62368-1 (ed 2 :2014) (Clause 6.2.2)
692	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Power source circuit classification	IEC 62368-1 (ed 3.0: 2018) (Clause 6.2.2)
693	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Power transfer using ES1 or ES2 voltages	IEC 62368-3, 1 Ed. (2017-12) Clause 5
694	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Prospective touch voltage, touch current and protective conductor current	EN 62368-1 (Clause 5.7)
695	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Prospective touch voltage, touch current and protective conductor current	EN 62368-1-2020 (Clause 5.7)
696	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Prospective touch voltage, touch current and protective conductor current	IEC 62368-1(ed 2 :2014) (Clause 5.7)
697	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Prospective touch voltage, touch current and protective conductor current	IEC 62368-1(ed 3.0: 2018) (Clause 5.7)
698	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Protection of equipment within an outdoor enclosure	EN 62368-1 Y 5.5
699	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Protection of equipment within an outdoor enclosure	EN 62368-1-2020 Y 5.5
700	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Protection of equipment within an outdoor enclosure	IEC 62368-1 (ed 3.0 :2018) Y 5.5
701	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Protection of equipment within an outdoor enclosure	IEC 62368-1, Y 5.5
702	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Relocation stability test	EN 62368-1 Clause 8.6.3
703	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Relocation stability test	IEC 62368-1 (ed2:2014) Clause 8.6.3
704	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Relocation stability test	IEC 62368-1 (ed3.0:2018) Clause 8.6.3.2
705	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Requirements for wireless power transmitters	EN 62368-1-2020 (Clause 9.6)
706	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Requirements for wireless power transmitters	IEC 62368-1(ed 3.0 :2018) (Clause 9.6)

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707	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Resistance of the Protective Bonding System (Earth bond test)	EN 62368-1 (Clause 5.6.6)
708	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Resistance of the Protective Bonding System (Earth bond test)	EN 62368-1 (Clause 5.6.6)
709	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Resistance of the Protective Bonding System (Earth bond test)	IEC 62368-1(ed 2 :2014) (Clause 5.6.6)
710	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Resistance of the Protective Bonding System (Earth bond test)	IEC 62368-1(ed 3.0: 2018) (Clause 5.6.6)
711	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	RFT-C - Limits under normal operating conditions	IEC 62368-3, 1 Ed. (2017-12) Clause 6.3.1.1.2
712	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	RFT-C - Limits under single fault conditions	IEC 62368-3, 1 Ed. (2017-12) Clause 6.3.1.1.3
713	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	RFT-C - Limits with one conductor earthed	IEC 62368-3, 1 Ed. (2017-12) Clause 6.3.1.1.4
714	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	RFT-V - Limits under normal operating conditions	IEC 62368-3, 1 Ed. (2017-12) Clause 6.3.1.2.1
715	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	RFT-V - Limits under single fault conditions	IEC 62368-3, 1 Ed. (2017-12) Clause 6.3.1.2.2
716	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	RFT-V - Limits under single fault conditions	IEC 62368-3, Clause 6.3.1.2.2
717	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	RFT-V - Limits with one conductor earthed	IEC 62368-3, 1 Ed. (2017-12) Clause 6.3.1.2.3
718	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	RMS working voltage / Peak working voltage (working voltage)	EN 62368-1 (Clause 5.4.1.8.2 / 5.4.1.8.3)
719	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	RMS working voltage / Peak working voltage (working voltage)	EN 62368-1-2020 (Clause 5.4.1.8)
720	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	RMS working voltage / Peak working voltage (working voltage)	IEC 62368-1 (ed3.0:2018) (Clause 5.4.1.8
721	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	RMS working voltage / Peak working voltage (working voltage)	IEC 62368-1, Clause 5.4.1.8
722	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Separation between external circuit and earth	EN 62368-1 Clause 5.4.11

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723	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Separation between external circuit and earth	IEC 62368-1 (ed3.0:2018) Clause 5.4.11
724	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Simulated abnormal operating conditions / Simulated single fault conditions	EN 62368-1 (Annex B.3.1-B.3.8; B.4.1 – B.4.9)
725	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Simulated abnormal operating conditions / Simulated single fault conditions	EN 62368-1 (Annex B.2.5)
726	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Simulated abnormal operating conditions / Simulated single fault conditions	EN 62368-1 (Annex B.3.1-B.3.7; B.4.1 – B.4.9)
727	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Simulated abnormal operating conditions / Simulated single fault conditions	IEC 62368-1(ed 2 :2014) (Annex B.2.5)
728	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Simulated abnormal operating conditions / Simulated single fault conditions	IEC 62368-1(ed 2 :2014) (Annex B.3.1-B.3.8; B.4.1 – B.4.9)
729	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Simulated abnormal operating conditions / Simulated single fault conditions	IEC 62368-1(ed 3.0 :2018) (Annex B.3.1-B.3.7; B.4.1 – B.4.9)
730	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Standard test procedure for non-separable thin sheet material	EN 62368-1 Clause 5.4.4.6.4
731	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Standard test procedure for non-separable thin sheet material	EN 62368-1 Clause 5.4.4.6.4
732	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Standard test procedure for non-separable thin sheet material	EN 62368-1, Clause 5.4.4.6.4
733	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Standard test procedure for non-separable thin sheet material	EN 62368-1-2020 Clause 5.4.4.6.4
734	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Standard test procedure for non-separable thin sheet material	IEC 62368-1 (ed2:2014) Clause 5.4.4.6.4
735	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Standard test procedure for non-separable thin sheet material	IEC 62368-1 (ed3.0:2018) Clause 5.4.4.6.4
736	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Standard test procedure for non-separable thin sheet material	IEC 62368-1 , Clause 5.4.4.6.4 Ed 2

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737	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Static stability test	EN 62368-1 Clause 8.6.2.2
738	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Static stability test	IEC 62368-1 (ed2:2014) Clause 8.6.2.2
739	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Static stability test	IEC 62368-1 (ed3.0:2018) Clause 8.6.2.2
740	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Steady force test	EN 62368-1 (Annex T.2)
741	ELECTRONICS- SAFETY TESTING FACILITY	Audio/Video, Information and Communication Technology Equipment	Steady force test	EN 62368-1 (Annex T.3)
742	ELECTRONICS- SAFETY TESTING FACILITY	Audio/Video, Information and Communication Technology Equipment	Steady force test	EN 62368-1 (Annex T.4)
743	ELECTRONICS- SAFETY TESTING FACILITY	Audio/Video, Information and Communication Technology Equipment	Steady force test	EN 62368-1 (Annex T.5)
744	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Steady force test	IEC 62368-1(ed 2 :2014) (Annex T.2)
745	ELECTRONICS- SAFETY TESTING FACILITY	Audio/Video, Information and Communication Technology Equipment	Steady force test	IEC 62368-1(ed 2 :2014) (Annex T.3)
746	ELECTRONICS- SAFETY TESTING FACILITY	Audio/Video, Information and Communication Technology Equipment	Steady force test	IEC 62368-1(ed 2 :2014) (Annex T.4)
747	ELECTRONICS- SAFETY TESTING FACILITY	Audio/Video, Information and Communication Technology Equipment	Steady force test	IEC 62368-1(ed 2 :2014) (Annex T.5)
748	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Steady force test	IEC 62368-1(ed 3.0 :2018) (Annex T.2,T.3,T.4,T.5)
749	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Steady-state test (electric strength test)	IEC 62368-1 (ed 3.0 :2018) (Clause 5.4.10.2.3)
750	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Steady-state test (electric strength test)	EN 62368-1 (Clause 5.4.10.2.3)
751	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Steady-state test (electric strength test)	IEC 62368-1 (ed 2 :2014) (Clause 5.4.10.2.3)
752	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Stress Relief Test	EN 62368-1 (Annex T.8)
753	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Stress Relief Test	IEC 62368-1 (ed 2 :2014) (Annex T.8)
754	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Test for telescoping or rod antennas	IEC 62368-1 (ed 3.0 :2018) (Annex T.11)
755	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Test for the permanence of marking	EN 62368-1 (Annex F.3.9)

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756	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Test for the permanence of marking	EN 62368-1-2020 (Annex F.3.10 (3.10.1.to 3.10.4)
757	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Test for the permanence of marking	IEC 62368-1 (ed 2 :2014) (Annex F.3.9)
758	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Test for the permanence of marking	IEC 62368-1 (ed 3.0 :2018) (3.10.1.to 3.10.4)
759	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Test method	EN 62368-1 Clause 8.5.4.2.4
760	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Test method	IEC 62368-1 (ed2:2014) Clause 8.5.4.2.4
761	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Test method and compliance criteria	EN 62368-1 Clause 5.4.11.3
762	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Test method and compliance criteria	IEC 62368-1 (ed2:2014) Clause 5.4.11.3
763	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Tests for semiconductor components and for cemented joints	EN 62368-1 Clause 5.4.7
764	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Tests for semiconductor components and for cemented joints	IEC 62368-1 (ed2:2014) Clause 5.4.7
765	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Thermal cycling	EN 62368-1 Clause 5.4.1.5.3
766	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Thermal cycling	EN 62368-1, Clause 5.4.1.5.3
767	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Thermal cycling	EN 62368-1-2020 Clause 5.4.1.5.3
768	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Thermal cycling	IEC 62368-1 (ed2:2014) Clause 5.4.1.5.3
769	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Thermal cycling	IEC 62368-1 (ed3.0:2018) Clause 5.4.1.5.3
770	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Thermal cycling	IEC 62368-1, Clause 5.4.1.5.3
771	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Top openings and top opening properties	EN 62368-1 , Clause 6.4.8.3.3
772	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Top openings and top opening properties	EN 62368-1 Clause 6.4.8.3.3
773	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Top openings and top opening properties	IEC 62368-1 (ed2:2014) Clause 6.4.8.3.3

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774	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Top openings and top opening properties	IEC 62368-1 , Clause 6.4.8.3.3
775	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Vibration test	EN 62368-1 (Annex G 15.2.4)
776	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Vibration test	IEC 62368-1, Annex G 15.2.4
777	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Wheels or casters attachment requirement	EN 62368-1 Clause 8.9 (8.9.1 & 8.9.2)
778	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Wheels or casters attachment requirement	EN 62368-1-2020 Clause 8.9 (8.9.1 & 8.9.2)
779	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Wheels or casters attachment requirement	IEC 62368-1 (ed2:2014) Clause 8.9 (8.9.1 & 8.9.2)
780	ELECTRONICS- SAFETY TESTING FACILITY	Batteries & Cells	Altitude Test	IEC 62133: 2017(Part 1 & 2)
781	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Altitude Test	IEC 60068-2-13
782	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Altitude Test	IEC 60721-1: 2002 (1.3)
783	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Combined cold/low air pressure Tests	IEC 60068-2-40
784	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Mechanical Shock Machine-Half sine Trapezoidal ,saw tooth	IEC 60068-2-27
785	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Mechanical Shock Machine-Half sine Trapezoidal ,saw tooth	Method 2002.3 MIL STD 202G
786	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Mechanical Shock Machine-Half sine Trapezoidal ,saw tooth	Method 213
787	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Mechanical Shock Machine-Half sine Trapezoidal ,saw tooth	Method 516.6 MIL STD 883E
788	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Mechanical Shock Machine-Half sine Trapezoidal ,saw tooth	MIL-STD-810G
789	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Mechanical Shock Machine-Half sine Trapezoidal, saw tooth	IEC 61373

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790	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Mechanical Shock Machine-Half sine Trapezoidal, saw tooth	UN38.3(Edition 6)
791	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Shock Electro dynamic shaker-Half sine Trapezoidal Final peak saw tooth, Initial saw tooth.	IEC 60068-2-27
792	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Shock Electro dynamic shaker-Half sine Trapezoidal Final peak saw tooth, Initial saw tooth.	IEC 61373
793	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Shock Electro dynamic shaker-Half sine Trapezoidal Final peak saw tooth, Initial saw tooth.	Method 201 A 514.6 MIL STD 202G
794	ELECTRONICS- SAFETY TESTING FACILITY	Electrical, Electronics and Mechanical products	Shock Electro dynamic shaker-Half sine Trapezoidal Final peak saw tooth, Initial saw tooth.	MILSTD-810G

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LOCATION 3 - 30/A, I STAGE VISHVESHWARYA INDUSTRIAL ESTATE, DODDANEKKUNDI INDUSTRIAL AREA, BENGALURU URBAN, BENGALURU, KARNATAKA, INDIA Permanent Facility				
1	ELECTRONICS- EMC TEST FACILITY	5.8GHz Fixed broadband data transmission system	Designation of Centre Frequencies & frequency error	ETSI EN 302 502 V2.1.1 (Clause 4.2.1)
2	ELECTRONICS- EMC TEST FACILITY	5.8GHz Fixed broadband data transmission system	Receiver Blocking	ETSI EN 302 502 V2.1.1 (Clause 4.2.7)
3	ELECTRONICS- EMC TEST FACILITY	5.8GHz Fixed broadband data transmission system	Receiver spurious emission - Conducted & Radiated	ETSI EN 302 502 V2.1.1 (Clause 4.2.5)
4	ELECTRONICS- EMC TEST FACILITY	5.8GHz Fixed broadband data transmission system	Transmitter RF Output Power, EIRP, TPC and EIRP Spectral Density	ETSI EN 302 502 V2.1.1 (Clause 4.2.2 & 4.2.4)
5	ELECTRONICS- EMC TEST FACILITY	5.8GHz Fixed broadband data transmission system	Transmitter unwanted emissions outside the 5 GHz RLAN bands – Conducted & Radiated	ETSI EN 302 502 V2.1.1 (Clause 4.2.3.1)
6	ELECTRONICS- EMC TEST FACILITY	5.8GHz Fixed broadband data transmission system	Transmitter Unwanted Emissions Within the 5725MHz to 5875MHz band	ETSI EN 302 502 V2.1.1 (Clause 4.2.3.2)
7	ELECTRONICS- EMC TEST FACILITY	5GHz RLAN	Adaptivity	ETSI EN 301 893 V2.1.1 (Clause 4.2.7)
8	ELECTRONICS- EMC TEST FACILITY	5GHz RLAN	Carrier Frequencies	ETSI EN 301 893 V2.1.1 (Clause 4.2.1)
9	ELECTRONICS- EMC TEST FACILITY	5GHz RLAN	Dynamic Frequency Selection (DFS)	ETSI EN 301 893 V2.1.1 (Clause 4.2.6)
10	ELECTRONICS- EMC TEST FACILITY	5GHz RLAN	Nominal and occupied channel bandwidth	ETSI EN 301 893 V2.1.1 (Clause 4.2.2)
11	ELECTRONICS- EMC TEST FACILITY	5GHz RLAN	Receiver blocking	ETSI EN 301 893 V2.1.1 (Clause 4.2.8)
12	ELECTRONICS- EMC TEST FACILITY	5GHz RLAN	Receiver spurious emission-Conducted & Radiated	ETSI EN 301 893 V2.1.1 (Clause 4.2.5)
13	ELECTRONICS- EMC TEST FACILITY	5GHz RLAN	RF output power Transmit Power Control (TPC) Power Density	ETSI EN 301 893 V2.1.1 (Clause 4.2.3)
14	ELECTRONICS- EMC TEST FACILITY	5GHz RLAN	Transmitter unwanted emissions outside the 5 GHz RLAN bands – Conducted & Radiated	ETSI EN 301 893 V2.1.1 (Clause 4.2.4.1)
15	ELECTRONICS- EMC TEST FACILITY	5GHz RLAN	Transmitter unwanted emissions within the 5 GHz RLAN bands	ETSI EN 301 893 V2.1.1 (Clause 4.2.4.2)

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16	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Band Edge Compliance	FCC Part 2 Clause 2.1051
17	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Band Edge Compliance	FCC Part 22 Subpart H Clause 22.917(a)
18	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Band Edge Compliance	FCC Part 24 Subpart E Clause 24.238(a)
19	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Band Edge Compliance	FCC Part 27 Subpart M Clause 27.53(h)
20	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Band Edge Compliance	RSS 130 Issue 2 Clause 4.7
21	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Band Edge Compliance	RSS 132 Issue 3 : Clause 5.5
22	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Band Edge Compliance	RSS 133 Issue 6 : Clause 6.5.1
23	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Band Edge Compliance	RSS 139 Issue 3 : Clause 6.6
24	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Band Edge Compliance	RSS 199 Issue 3 : Clause 4.5
25	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Field Strength of Spurious Radiation	FCC Part 2 Clause 2.1053
26	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Field Strength of Spurious Radiation	FCC Part 22 Subpart H Clause 22.917
27	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Field Strength of Spurious Radiation	FCC Part 24 Subpart E Clause 24.238
28	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Field Strength of Spurious Radiation	FCC Part 27 Subpart M Clause 27.53
29	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Field Strength of Spurious Radiation	RSS 130 Issue 2 Clause 4.7
30	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Field Strength of Spurious Radiation	RSS 132 Issue 3 Clause 5.5
31	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Field Strength of Spurious Radiation	RSS 133 Issue 6 Clause 6.5.1
32	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Field Strength of Spurious Radiation	RSS 139 Issue 3 Clause 6.6
33	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Field Strength of Spurious Radiation	RSS 199 Issue 3 Clause 4.5
34	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Frequency Stability	FCC Part 2 Clause 2.1055

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35	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Frequency Stability	FCC Part 22 Subpart H Clause 22.355
36	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Frequency Stability	FCC Part 24 Subpart E Clause 24.235
37	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Frequency Stability	FCC Part 24 Subpart M Clause 27.54
38	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Frequency Stability	RSS 130 Issue 2 Clause 4.3
39	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Frequency Stability	RSS 132 Issue 3 Clause 5.3
40	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Frequency Stability	RSS 133 Issue 6 Clause 6.3
41	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Frequency Stability	RSS 139 Issue 3 Clause 6.4
42	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Frequency Stability	RSS 199 Issue 3 Clause 4.3
43	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Occupied Bandwidth & 26dB Emission Bandwidth	FCC Part 2 Clause 2.1049
44	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Occupied Bandwidth & 26dB Emission Bandwidth	RSS Gen Issue 5 : 2019 Amendment 1 Clause 6.7
45	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Reciever Spurious Emission	RSS 132 Issue 3 Clause 5.6
46	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Reciever Spurious Emission	RSS 133 Issue 6 Clause 6.6
47	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Reciever Spurious Emission	RSS Gen Issue 5 Clause 5.2
48	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Spurious Emissions at Antenna Terminal	FCC Part 2 Clause 2.1051
49	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Spurious Emissions at Antenna Terminal	FCC Part 22 Subpart H Clause 22.917
50	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Spurious Emissions at Antenna Terminal	FCC Part 24 Subpart E Clause 24.238
51	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Spurious Emissions at Antenna Terminal	FCC Part 27 Subpart M Clause 27.53
52	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Spurious Emissions at Antenna Terminal	RSS 130 Issue 2 Clause 4.7
53	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Spurious Emissions at Antenna Terminal	RSS 132 Issue 3 Clause 5.5

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54	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Spurious Emissions at Antenna Terminal	RSS 133 Issue 6 Clause 6.5.1
55	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Spurious Emissions at Antenna Terminal	RSS 139 Issue 3 Clause 6.6
56	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Spurious Emissions at Antenna Terminal	RSS 199 Issue 3 Clause 4.5
57	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Tranmitter output Power (EIRP) & PAPR	FCC Part 24 Subpart E Clause 24.232
58	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Transmitter output Power (EIRP) & PAPR	RSS 139 Issue 3 Clause 4.1 & 6.5
59	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Transmitter output Power	FCC Part 2 Clause 2.1046
60	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Transmitter output Power (EIRP)	RSS 199 Issue 3 Clause 4.4
61	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Transmitter output Power (EIRP) & PAPR	FCC Part 27 Subpart M Clause 27.50
62	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Transmitter output Power (EIRP) & PAPR	RSS 132 Issue 3 Clause 5.4
63	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Transmitter output Power (EIRP) & PAPR	RSS 133 Issue 6 Clause 4.1 & 6.4
64	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Transmitter output Power (ERP) & PAPR	FCC Part 22 Subpart H Clause 22.913
65	ELECTRONICS- EMC TEST FACILITY	Cellular – GSM, WCDMA & LTE	Transmitter output Power (ERP) & PAPR	RSS 130 Issue 2 Clause 4.6
66	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Accumulated transmit time, Frequency Occupation & Hopping Sequence	ETSI EN 300 328 V2.2.2 Clause 4.3.1.4
67	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Adaptivity	ETSI EN 300 328 V2.2.2 Clause 4.3.1.7/4.3.2.6
68	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Duty cycle, Tx-Sequence Tx-gap	ETSI EN 300 328 V2.2.2 Clause 4.3.1.3/4.3.2.4
69	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Hopping Frequency Separation	ETSI EN 300 328 V2.2.2 Clause 4.3.1.5
70	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Medium Utilization	ETSI EN 300 328 V2.2.2 Clause 4.3.1.6/4.3.2.5
71	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Occupied Channel Bandwidth	ETSI EN 300 328 V2.1.1 Clause (4.3.1.8/4.3.2.7)

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72	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Occupied Channel Bandwidth	ETSI EN 300 328 V2.2.2 Clause 4.3.1.8/4.3.2.7
73	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Power Spectral density	ETSI EN 300 328 V2.1.1 (Clause 4.3.2.3)
74	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Power Spectral density	ETSI EN 300 328 V2.2.2 Clause 4.3.2.3
75	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Receiver Blocking	ETSI EN 300 328 V2.1.1 Clause (4.3.1.12/4.3.2.11)
76	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Receiver Blocking	ETSI EN 300 328 V2.1.1 Clause (4.3.1.12/4.3.2.11)
77	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Receiver spurious emission – Conducted & Radiated	ETSI EN 300 328 V2.2.2 Clause 4.3.1.11/4.3.2.10
78	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Receiver spurious emission - Conducted & Radiated	ETSI EN 300 328 V2.1.1 Clause (4.3.1.11/4.3.2.10)
79	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	RF Output Power	ETSI EN 300 328 V2.2.2 Clause 4.3.1.2/4.3.2.2
80	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Transmitter unwanted emissions in the OOB domain	ETSI EN 300 328 V2.1.1 Clause (4.3.1.9/4.3.2.8)
81	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Transmitter unwanted emissions in the OOB domain	ETSI EN 300 328 V2.2.2 Clause 4.3.1.9/4.3.2.8
82	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Transmitter unwanted emissions in the spurious domain – Conducted & Radiated	ETSI EN 300 328 V2.1.1 Clause (4.3.1.10/4.3.2.9)
83	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Transmitter unwanted emissions in the spurious domain – Conducted & Radiated	ETSI EN 300 328 V2.2.2 Clause 4.3.1.10/4.3.2.9
84	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Accumulated transmit time, Frequency Occupation & Hopping Sequence	ETSI EN 300 328 V2.1.1 (Clause 4.3.1.4)
85	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Adaptivity	ETSI EN 300 328 V2.1.1 Clause (4.3.1.7/4.3.2.6)
86	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Duty cycle, Tx-Sequence Tx-gap	ETSI EN 300 328 V2.1.1 (Clause 4.3.1.3/4.3.2.4)
87	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Hopping Frequency Separation	ETSI EN 300 328 V2.1.1 (Clause 4.3.1.5)
88	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Medium Utilization	ETSI EN 300 328 V2.1.1 Clause (4.3.1.6/4.3.2.5)

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89	ELECTRONICS- EMC TEST FACILITY	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	RF Output Power	EN 300 328 V2.1.1 (Clause 4.3.1.2/4.3.2.2)
90	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEEE Std 1613.1
91	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Click test	BS EN 55014-1
92	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Click test	CISPR 14-1 (Edition 6.0)
93	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Click test	CISPR 14-1 (Edition 6.1)
94	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Click test	CISPR 14-1 (Edition 7.0)
95	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Click test	EN 55014-1: 2006+ Amd. 2
96	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Click test	EN 55014-1:2017+A11
97	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE	IEC 61000-6-3 (Edition 2.1) Consol. with Amd. 1
98	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE	IEC 61000-6-4 (Edition 2.1 Consol. with Amd. 1) :
99	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	CFR 2010 Title 47 Vol.1(Part 18)
100	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	CISPR 11 (Edition 6.1) : (2015+AMD1)
101	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	CISPR 11 (Edition 6.2)
102	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	CISPR 14-1 (Edition 6.0)
103	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	CISPR 14-1 (Edition 7.0)
104	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	CISPR 15 (Edition 8.1): (2013+AMD1)
105	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	CISPR 15 (Edition 7.2)
106	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	CISPR 15 (Edition 8.0)
107	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	CISPR 15 (Edition 9.0)

SCOPE OF ACCREDITATION

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
108	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	CISPR 22 (Edition 6.0)
109	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	CISPR 32 (Edition 2.0)
110	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	CISPR 32 (Edition 2.1)
111	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 50121-3-2
112	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 50121-3-2: (2016+A1)
113	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 50121-4
114	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 50121-4:2016+A1
115	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 55011: (2016+A11)
116	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 55011: (2009+A1)
117	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 55011: (2016+A1)
118	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 55014-1
119	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 55014-1: 2006+ Amd. 2
120	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 55015
121	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 55015
122	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 55015: 2006+ Amd. 2
123	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 55015:2013+A1
124	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 55022
125	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 55032
126	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 60601-1-2: 2007/AC

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
127	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 61000-6-3: 2007/A1
128	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 61000-6-4
129	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 61000-6-4: 2007/A1
130	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 61131-2
131	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 61326-1
132	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 61326-2-1
133	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 61326-2-2
134	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 61326-2-3
135	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 61326-2-4
136	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 61326-2-5
137	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 61326-2-6
138	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 62040-2
139	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 62040-2
140	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 62052-11:2003+A1
141	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN60669-2-1
142	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN60669-2-1:2004+A12
143	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	ETSI EN 301 489-1 V2.2.1
144	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	ETSI EN 301 489-17 V3.2.0
145	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	ETSI EN 301 489-17 V3.2.2

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
146	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	ETSI EN 301 489-17 V3.2.4
147	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	ETSI EN 301 489-3 V2.1.1
148	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	FCC (Part 15) Sub part B (Clause 15.107)
149	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	FCC (Part 15) Subpart C (Clause.15.207)
150	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	FCC (Part 15) Subpart E(Clause 15.407 (b)(6) & 15.207)
151	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60034-1 (Edition 13.0):
152	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60255-1 (Edition 1.0)
153	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60255-26 (Edition 3.0)
154	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60601-1-2 (Edition 2.0)
155	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60601-1-2 (Edition 3.0)
156	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60601-1-2 (Edition 4.0)
157	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60601-1-2 (Edition 4.1):(2014-02+AMD1)
158	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60601-1-2 (Edition 2.1)
159	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60601-2-25: (Edition 2.0)
160	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60601-2-27 (Edition 3.0)
161	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60669-2-1 (Edition 4.1) : (2002+AMD1:
162	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60669-2-1 (Edition 4.2): (2002+AMD1:2008 +AMD2:
163	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60669-2-5 (Edition 1.0):
164	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60730-1 (Edition 5.0) :

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
165	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60730-1 (Edition 5.1) : (2013+AMD1:
166	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60730-1 (Edition 5.2) :
167	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60730-2-9 (Edition 4.0)
168	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60730-2-9 (Edition 4.1) : (2015+AMD1
169	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60730-2-9:2015+ AMD1: 2018 +AMD2:
170	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60945, (Edition 4.0)
171	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60947-1
172	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60974-10 (Edition 3.0) :
173	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60974-10 (Edition 3.1):
174	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 60974-10 (Edition 4.0):
175	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61000-6-3 (Edition 2.1) Consol. with Amd. 1
176	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61000-6-3 (Edition 3.0) :
177	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61000-6-4 (Edition 2.1 Consol. with Amd. 1) :
178	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61000-6-4 (Edition 3.0) :
179	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61131-2 (Edition 4.0)
180	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61326-1 (Edition 3.0) :
181	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61326-1 (Edition 2.0):
182	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61326-2-1 (Edition 2.0)
183	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61326-2-1 (Edition 3.0)

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
184	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61326-2-2 (Edition 2.0)
185	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61326-2-2 (Edition 3.0)
186	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61326-2-3 (Edition 2.0)
187	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61326-2-3 (Edition 3.0)
188	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61326-2-4 (Edition 2.0)
189	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61326-2-4 (Edition 3.0)
190	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61326-2-5 (Edition 2.0)
191	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61326-2-5 (Edition 3.0)
192	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61326-2-6 (Edition 2.0)
193	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61326-2-6 (Edition 3.0)
194	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61439-1 (Edition 2.0)
195	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 61439-1 (Edition 3.0)
196	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 62040-2 (Edition 3.0):
197	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 62052-11 (Edition 1.1): (2003-02+AMD1:
198	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 62052-11 (Edition 2.0) :
199	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IEC 80601-2-49 : (Edition 1.0)
200	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IS 13450 : Part 2 : Sec 25
201	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IS 13450 Part 1 Sec2
202	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IS 13779 (RA 2009)

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
203	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IS 14697 (RA 2009)
204	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IS 16102 (Part 2)
205	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IS 302-1
206	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IS 6842
207	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IS 6873 (Part 5)
208	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IS/IEC 60730-1
209	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IS/IEC 60730-2-9
210	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IS/IEC 60947-1
211	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IS/IEC 60947-2
212	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	IS/IEC 60947-3
213	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	ISO 80601-2-61 (Edition 2.0) : (2017-12) (Corrected version)
214	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	RSS Gen, Issue 5, (Clause 8.8) Amendment 1
215	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	TEC/SD/DD/EMC-221/05/OCT-16
216	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	TEC/SD/DD/TCP-222/01.Dec18
217	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	CISPR 14-2 (Edition 2.0) RLV
218	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	CISPR 14-2 (Edition 3.0)
219	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	CISPR 24 (Edition 2.0)
220	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	CISPR 24 (Edition 2.1)
221	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	CISPR 35 (Edition 1.0)

SCOPE OF ACCREDITATION

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
222	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 50121-3-2
223	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 50121-3-2:2016+A1
224	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 50121-4
225	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 50121-4:2016 +A1
226	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 55014-2
227	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 55014-2: 1997/ Amd. 2
228	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 55024
229	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 55035:2017+A11
230	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 60255-1
231	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 60255-26
232	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 60601-1-2: 2007/AC
233	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 60669-2-1:2004 +A12
234	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 60730-1
235	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 61000-4-6
236	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 61000-6-1
237	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 61000-6-2
238	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 61131-2
239	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 61326-1
240	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 61326-2-1

SCOPE OF ACCREDITATION

Laboratory Name :	UL INDIA LAB, UL INDIA PRIVATE LIMITED, LABORATORY BUILDING, KALYANI PLATINA CAMPUS, SY.NO.129/4, EPIP ZONE, PHASE II, WHITEFIELD, BENGALURU URBAN, BENGALURU, KARNATAKA, INDIA		
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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
241	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 61326-2-3
242	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 61326-2-4
243	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 61326-2-5
244	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 61326-2-6
245	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 61439-1
246	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 61547
247	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 61547:2009 +A12
248	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 62040-2
249	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	EN 62052-11:2003+A1
250	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	ETSI EN 300 339 V1.1.1
251	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	ETSI EN 300 386 V2.1.1
252	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	ETSI EN 301 090 V1.1.1
253	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	ETSI EN 301 489-1 V2.2.0
254	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	ETSI EN 301 489-1 V2.2.1
255	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	ETSI EN 301 489-17 V3.2.0
256	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	ETSI EN 301 489-17 V3.2.2
257	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	ETSI EN 301 489-3 V2.1.1
258	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 60255-1 (Edition 1.0)
259	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 60255-26 (Edition 3.0)

SCOPE OF ACCREDITATION

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Certificate Number	TC-6168
Validity	05/08/2021 to 04/08/2023

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
260	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 60601-1-2 (Edition 2.0)
261	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 60601-1-2 (Edition 2.1)
262	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 60601-1-2 (Edition 3.0)
263	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 60669-2-1 (Edition 4.2) 2002/AMD2
264	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 60669-2-5 (Edition 1.0)
265	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 60730-1 (Edition 5.1)
266	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 60730-1 : 2013+Amd1:2015+AMD2
267	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 60730-2-9:2015+ AMD 1 (Edition 4.1)
268	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 60730-2-9:2015+ AMD1: 2018+AMD2 CSV
269	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 60945, (Edition 4.0)
270	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 60947-1, (Edition 6.0)
271	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 60974-10 (Edition 3.0)
272	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 60974-10 (Edition 3.1)
273	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 60974-10(Edition 4.0)
274	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61000-2-27, (Edition 3.0)
275	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61000-25 (Edition 2.0)
276	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61000-6-1 (Edition 2.0)
277	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61000-6-1 (Edition 3.0)
278	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61000-6-2 (Edition 2.0)

SCOPE OF ACCREDITATION

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Accreditation Standard	ISO/IEC 17025:2017
Certificate Number	TC-6168
Validity	05/08/2021 to 04/08/2023

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
279	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61000-6-2 (Edition 3.0)
280	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61008-1(Edition 3.2)
281	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61009-1(Edition 3.2)
282	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61131-2 (Edition 4.0)
283	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61326-1 (Edition 2.0)
284	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61326-1 (Edition 3.0)
285	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61326-2-1 (Edition 3.0)
286	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61326-2-1: (Edition 2.0)
287	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61326-2-2 (Edition 2.0)
288	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61326-2-2 (Edition 3.0)
289	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61326-2-3 (Edition 2.0)
290	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61326-2-3 (Edition 3.0)
291	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61326-2-4 (Edition 2.0)
292	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61326-2-4 (Edition 3.0)
293	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61326-2-5 (Edition 2.0)
294	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61326-2-5 (Edition 3.0)
295	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61326-2-6 (Edition 2.0)
296	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61326-2-6 (Edition 3.0)
297	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61347-2-13:2014 +AMD1 CSV

SCOPE OF ACCREDITATION

Laboratory Name :	UL INDIA LAB, UL INDIA PRIVATE LIMITED, LABORATORY BUILDING, KALYANI PLATINA CAMPUS, SY.NO.129/4, EPIP ZONE, PHASE II, WHITEFIELD, BENGALURU URBAN, BENGALURU, KARNATAKA, INDIA
Accreditation Standard	ISO/IEC 17025:2017
Certificate Number	TC-6168
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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
298	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61439-1 (Edition 2.0)
299	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61439-1 (Edition 3.0)
300	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61543:1995, Amd 1
301	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61543:1995, Amd 2
302	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61543:1995/ AMD2
303	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61547 (Edition 2.0)
304	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61547 (Edition 3.0)
305	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61547 TR
306	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61850-3 (Edition 2.0)
307	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 62040-2 (Edition 2.0)
308	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 62040-2 (Edition 3.0)
309	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 62052-11 (Edition 1.1): 2003+AMD1
310	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 62052-11 (Edition 2.0)
311	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 80601-2-49 (Edition 1.0)
312	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEEE Std 1613.1
313	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IS 12640 (Part 1)
314	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IS 12640 (Part 2)
315	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IS 13450 Part 1 Sec2
316	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IS/IEC 60947-1

SCOPE OF ACCREDITATION

Laboratory Name : UL INDIA LAB, UL INDIA PRIVATE LIMITED, LABORATORY BUILDING, KALYANI PLATINA CAMPUS, SY.NO.129/4, EPIP ZONE, PHASE II, WHITEFIELD, BENGALURU URBAN, BENGALURU, KARNATAKA, INDIA

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
317	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IS/IEC 60947-3
318	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IS/IEC 60947-5-2
319	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	TEC/EMI/TEL-001/01/FEB-09
320	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	TEC/SD/DD/EMC-221/05/OCT-16
321	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	TEC/SD/DD/TCP-222/01.Dec18
322	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF¬ Immunity Test	EN 60601-1-2: 2007/AC
323	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF¬ Immunity Test	EN 61326-2-2
324	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF¬ Immunity Test	IEC 60335-1, (Edition 6.0)
325	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF¬ Immunity Test	IS/IEC 60730-1
326	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF¬ Immunity Test	IS/IEC 60730-2-9
327	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Common mode disturbances in the frequency range lower than 150 kHz	EN 61000-4-16
328	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Common mode disturbances in the frequency range lower than 150 kHz	IEC 61000-4-16, Edition 2.0
329	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Common mode disturbances in the frequency range lower than 150 kHz	IEC 61008-1(Edition 3.2)
330	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Common mode disturbances in the frequency range lower than 150 kHz	IEC 61009-1(Edition 3.2)
331	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Common mode disturbances in the frequency range lower than 150 kHz	IEC 61543:1995, Amd 1
332	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Common mode disturbances in the frequency range lower than 150 kHz	IEC 61543:1995, Amd 2

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Laboratory Name :	UL INDIA LAB, UL INDIA PRIVATE LIMITED, LABORATORY BUILDING, KALYANI PLATINA CAMPUS, SY.NO.129/4, EPIP ZONE, PHASE II, WHITEFIELD, BENGALURU URBAN, BENGALURU, KARNATAKA, INDIA		
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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
333	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Common mode disturbances in the frequency range lower than 150 kHz	IS 12640 (Part 1)
334	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Common mode disturbances in the frequency range lower than 150 kHz	IS 12640 (Part 2)
335	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 60730-1
336	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE	EN 60255-1
337	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 60255-1
338	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	EN 61439-1 (Withdrawn Standard)
339	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted Emission Test (CE)	ETSI EN 300 386 V2.1.1
340	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	ETSI EN 301 489-17 V3.2.4
341	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 60601-1-2 (Edition 4.0)
342	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 60601-1-2 (Edition 4.1)
343	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IEC 61000-4-6 (Edition 4.0)
344	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Conducted RF Immunity Test	IS/IEC 60947-2
345	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	BIS IS 13779 : 1999 AMD 5
346	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	CISPR 14-2 (Edition 3.0)
347	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	CISPR 14-2(Edition 2.0) RLV
348	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	CISPR 24 (Edition 2.0)
349	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	CISPR 24 (Edition 2.1)
350	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	CISPR 35 (Edition 1.0)

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Laboratory Name : UL INDIA LAB, UL INDIA PRIVATE LIMITED, LABORATORY BUILDING, KALYANI PLATINA CAMPUS, SY.NO.129/4, EPIP ZONE, PHASE II, WHITEFIELD, BENGALURU URBAN, BENGALURU, KARNATAKA, INDIA

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
351	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 50121-3-2
352	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 50121-3-2:2016+A1
353	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 50121-4
354	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 50121-4:2016+A1
355	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 55014-2
356	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 55014-2: 1997/ Amd. 2
357	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 55024
358	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 55035
359	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 55035:2017+A11
360	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 60255-1
361	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 60255-26
362	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 60601-1-2: 2007/AC
363	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 60669-2-1:2004 +A12
364	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 60730-1
365	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 61000-4-4
366	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 61000-6-1
367	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 61000-6-2
368	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 61000-6-2
369	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 61131-2

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
370	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 61326-1
371	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 61326-2-1
372	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 61326-2-2
373	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 61326-2-3
374	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 61326-2-4
375	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 61326-2-5
376	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 61326-2-6
377	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 61439-1
378	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 61547
379	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 62040-2
380	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	EN 62052-11:2003+A1
381	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	ETSI EN 300 339 V1.1.1
382	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	ETSI EN 300 386 V2.1.1
383	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	ETSI EN 301 090 V1.1.1
384	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	ETSI EN 301 489-1 V2.2.0
385	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	ETSI EN 301 489-1 V2.2.1
386	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	ETSI EN 301 489-17 V3.2.0
387	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	ETSI EN 301 489-17 V3.2.2
388	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	ETSI EN 301 489-17 V3.2.4

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389	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	ETSI EN 301 489-3 V2.1.1
390	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60255-1: (Edition 1.0)
391	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60255-26 : (Edition 3.0)
392	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60335-1, (Edition 6.0)
393	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60601-1-2 (Edition 2.1)
394	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60601-1-2 (Edition 3.0)
395	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60601-1-2 (Edition 4.0)
396	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60601-1-2 (Edition 4.1)
397	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60601-2-25, (Edition 2.0)
398	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60601-2-27, (Edition 3.0)
399	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60669-2-1:2002 +AMD1: 2008+ AMD2 CSV
400	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60669-2-5: (Edition 1.0)
401	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60730-1 (Edition 5.1)
402	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60730-1 : 2013+Amd1:2015+AMD2
403	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60730-2-9:2015+ AMD1:2018 +AMD2
404	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60730-2-9:2015+AMD 1 (Edition 4.1)
405	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60945, (Edition 4.0)
406	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60947-1, (Edition 6.0)
407	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60974-10 (Edition 3.1)

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408	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60974-10 (Edition 4.0)
409	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 60974-10: (Edition 3.0)
410	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61000-4-4 (Edition 3.0)
411	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61000-6-1 (Edition 2.0)
412	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61000-6-1 (Edition 3.0)
413	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61000-6-2 (Edition : 3.0)
414	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61000-6-2 (Edition 2.0)
415	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61008-1(Edition 3.2)
416	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61009-1(Edition 3.2)
417	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61131-2: (Edition 4.0)
418	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61326-1 (Edition 2.0)
419	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61326-1 (Edition 3.0)
420	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61326-2-1: (Edition 2.0)
421	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61326-2-1: (Edition 3.0)
422	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61326-2-2: (Edition 2.0)
423	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61326-2-2: (Edition 3.0)
424	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61326-2-3 (Edition 3.0)
425	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61326-2-3: (Edition 2.0)
426	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61326-2-4: (Edition 2.0)

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427	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61326-2-4: (Edition 3.0)
428	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61326-2-5: (Edition 2.0)
429	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61326-2-5: (Edition 3.0)
430	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61326-2-6: (Edition 2.0)
431	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61326-2-6: (Edition 3.0)
432	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61347-2-13:2014+AMD1 CSV
433	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61439-1: (Edition 3.0)
434	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61439-1:(Edition 2.0)
435	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61543:1995, Amd 1
436	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61543:1995, Amd 2
437	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61543:1995/ AMD2
438	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61547
439	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61547 (Edition 2.0)
440	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61547 (Edition 3.0)
441	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 61850-3 (Edition 2.0)
442	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 62040-2 (Edition 2.0)
443	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 62040-2: (Edition 3.0)
444	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 62052-11 (Edition 1.0)
445	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 62052-11: (Edition 2.0)

SCOPE OF ACCREDITATION

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
446	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 62052-11:2003+AMD1:2016 (Edition 1.1)
447	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IEC 80601-2-49 : (Edition 1.0)
448	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IS 12640 (Part 1)
449	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IS 12640 (Part 2)
450	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IS 13450 Part 1 Sec2
451	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IS 13779
452	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IS 14697: 1999 , Reaffirmed
453	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IS 14700 (Part 4/Sec 4)
454	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IS 302-1 : 2008 (Reaffirmed)
455	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IS/IEC 60730-1
456	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IS/IEC 60730-2-9
457	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IS/IEC 60947-1
458	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IS/IEC 60947-2
459	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IS/IEC 60947-3
460	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	IS/IEC 60947-5-2
461	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	TEC/EMI/TEL-001/01/FEB-09
462	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	TEC/SD/DD/EMC-221/05/OCT-16
463	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	TEC/SD/DD/TCP-222/01.Dec18

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464	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	BIS IS 13779 : 1999 AMD 5
465	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	CISPR 14-2 (Edition 2.0) RLV
466	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	CISPR 14-2 (Edition 3.0)
467	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	CISPR 24 (Edition 2.0)
468	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	CISPR 24 (Edition 2.1)
469	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	CISPR 35 (Edition 1.0)
470	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 50121-3-2
471	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 50121-3-2:2016+A1
472	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 50121-4
473	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 50121-4:2016+A1
474	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 55014-2
475	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 55014-2: 1997/ Amd. 2
476	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 55024
477	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 55035
478	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 55035:2017+A11
479	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 60255-1
480	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 60255-26
481	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 60601-1-2: 2007/AC
482	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 60669-2-1:2004 +A12

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483	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 60730-1
484	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 61000-4-2
485	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 61000-6-1
486	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 61000-6-2
487	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 61131-2
488	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 61326-1
489	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 61326-2-1
490	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 61326-2-2
491	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 61326-2-3
492	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 61326-2-4
493	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 61326-2-5
494	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 61326-2-6
495	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 61439-1
496	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 61547
497	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 62040-2
498	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 62040-2
499	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	EN 62052-11:2003+A1
500	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	ETSI EN 300 339 V1.1.1
501	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	ETSI EN 300 386 V2.1.1

SCOPE OF ACCREDITATION

Laboratory Name :	UL INDIA LAB, UL INDIA PRIVATE LIMITED, LABORATORY BUILDING, KALYANI PLATINA CAMPUS, SY.NO.129/4, EPIP ZONE, PHASE II, WHITEFIELD, BENGALURU URBAN, BENGALURU, KARNATAKA, INDIA
Accreditation Standard	ISO/IEC 17025:2017
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Last Amended on 13/01/2023

S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
502	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	ETSI EN 301 090 V1.1.1
503	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	ETSI EN 301 489-1 V2.2.1
504	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	ETSI EN 301 489-17 V3.2.0
505	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	ETSI EN 301 489-17 V3.2.2
506	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	ETSI EN 301 489-17 V3.2.4
507	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	ETSI EN 301 489-3 V2.1.1
508	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60255-1: (Edition 1.0)
509	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60255-26: (Edition 3.0)
510	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60335-1, (Edition 6.0)
511	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60601-1-2 (Edition 2.0)
512	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60601-1-2 (Edition 4.1):(2014-02+AMD1)
513	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60601-1-2 (Edition 2.1)
514	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60601-1-2 (Edition 3.0)
515	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60601-1-2 (Edition 4.0)
516	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60601-2-25 (Edition 2.0)
517	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60601-2-27 (Edition 3.0)
518	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60669-2-1:2002 +AMD1: 2008+ AMD2
519	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60669-2-5: (Edition 1.0)
520	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60730-1 (Edition 5.1)

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521	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60730-1 : 2013+Amd1:2015+AMD2
522	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60730-2-9:2015+AMD 1 (Edition 4.1)
523	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60730-2-9:2015+AMD1:2018 +AMD2
524	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60945, Edition 4.0
525	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60947-1, Edition 6.0
526	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60974-10 (Edition 3.1)
527	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60974-10(Edition 4.0)
528	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 60974-10: (Edition 3.0)
529	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61000-4-2 (Edition 2.0)
530	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61000-6-1 (Edition 2.0)
531	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61000-6-1 (Edition 3.0)
532	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61000-6-2 (Edition 2.0)
533	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61000-6-2 (Edition 3.0)
534	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61008-1(Edition 3.2)
535	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61009-1(Edition 3.2)
536	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61131-2: (Edition 4.0)
537	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61326-1 (Edition 3.0)
538	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61326-1 (Edition 2.0)

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539	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61326-2-1: (Edition 2.0)
540	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61326-2-1: (Edition 3.0)
541	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61326-2-2: (Edition 2.0)
542	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61326-2-2: (Edition 3.0)
543	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61326-2-3: (Edition 2.0)
544	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61326-2-3: (Edition 3.0)
545	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61326-2-4: (Edition 2.0)
546	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61326-2-4: (Edition 3.0)
547	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61326-2-5: (Edition 2.0)
548	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61326-2-5: (Edition 3.0)
549	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61326-2-6: (Edition 2.0)
550	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61326-2-6: (Edition 3.0)
551	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61347-2-13:2014+AMD1
552	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61439-1: (Edition 2.0)
553	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61439-1: (Edition 3.0)
554	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61543:1995, Amd 1
555	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61543:1995, Amd 2
556	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61543:1995/ AMD2
557	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61547 (Edition 2.0)

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558	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61547 (Edition 3.0)
559	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61547 TR
560	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 61850-3 (Edition 2.0)
561	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 62040-2: (Edition 3.0)
562	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 62052-11: (Edition 2.0)
563	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 62052-11:2003+AMD1: (Edition 1.1)
564	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEC 80601-2-49 : (Edition 1.0)
565	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IEEE Std 1613.1
566	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IS 12640 (Part 1)
567	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IS 12640 (Part 2)
568	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IS 13450 Part 1 Sec2
569	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IS 13779
570	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IS 14697: 1999 , Reaffirmed
571	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IS 14700 (Part 4/Sec 2)
572	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IS 302-1 : 2008 (Reaffirmed)
573	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IS/IEC 60730-1
574	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IS/IEC 60730-2-9
575	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IS/IEC 60947-1
576	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IS/IEC 60947-2

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577	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IS/IEC 60947-3
578	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	IS/IEC 60947-5-2
579	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	S 14700 (Part 4/Sec 2)
580	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	TEC/EMI/TEL-001/01/FEB-09
581	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	TEC/SD/DD/EMC-221/05/OCT-16
582	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Electrostatic Discharge Immunity Test	TEC/SD/DD/TCP-222/01.Dec18
583	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	EN 60601-1-2 (Edition 2.1)
584	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	EN 60601-1-2 (Edition 3.0)
585	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	EN 60601-1-2 (Edition 4.0)
586	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	EN 60669-2-1:2004 +A12
587	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	EN 60730-1
588	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	EN 60974-10:2014/AMD1
589	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	EN 61000-3-2
590	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	EN 61326-1
591	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	EN 61326-2-1
592	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	EN 61326-2-2
593	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	EN 61326-2-3
594	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	EN 61326-2-4
595	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	EN 61326-2-5

SCOPE OF ACCREDITATION

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596	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	EN 61326-2-6
597	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	EN 62040-2
598	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	ETSI EN 300 386 V2.1.1
599	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	ETSI EN 301 489-1 V2.2.1
600	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	ETSI EN 301 489-17 V3.2.0
601	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	ETSI EN 301 489-17 V3.2.2
602	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	ETSI EN 301 489-17 V3.2.3
603	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	ETSI EN 301 489-17 V3.2.4
604	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	ETSI EN 301 489-3 V2.1.1
605	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 60601-1-2 (Edition 2.0)
606	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 60601-1-2 (Edition 4.1):(2014-02+AMD1
607	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 60601-1-2 (Edition 4.0)
608	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 60601-1-2: Edition 2.1
609	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 60601-1-2: Edition 3.0
610	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 60669-2-1 (Edition 4.1) : (2002+AMD1
611	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 60669-2-1 (Edition 4.2): (2002+AMD1:2008 +AMD2
612	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 60669-2-5 (Edition 1.0)
613	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 60730-1: (Edition 5.1)
614	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 60730-1: (Edition 5.2)

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615	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 60730-2-9 (Edition 4.1)
616	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 60730-2-9 (Edition 4.2)
617	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 60974-10 (Edition 3.0)
618	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 60974-10(Edition 3.1)
619	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 60974-10: Edition 4
620	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 61000-3-2 : Edition 5.0
621	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 61000-6-3 (Edition 2.1)
622	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 61000-6-3 (Edition 2.1) Consol. with Amd. 1
623	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 61000-6-3 (Edition 3.0)
624	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 61326-1 (Edition 2.0)
625	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 61326-1 (Edition 3.0)
626	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 61326-2-3 (Edition 2.0)
627	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 61326-2-3 (Edition 3.0)
628	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 61326-2-4 (Edition 2.0)
629	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 61326-2-4 (Edition 3.0)
630	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 61326-2-5 (Edition 2.0)
631	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 61326-2-5 (Edition 3.0)
632	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 61326-2-6 (Edition 2.0)
633	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 61326-2-6 (Edition 3.0)

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634	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 62040-2 (Edition 3.0)
635	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 80601-2-49 : (Edition 1.0)
636	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IS 13450 Part 1 Sec2
637	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonic Current Emission Test	IS 14700 (Part 3/ Sec 2)
638	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonics and Inter-harmonics including mains signaling at AC power port, low frequency immunity tests	EN 61000-4-13: 2002/A2
639	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonics and Inter-harmonics including mains signaling at AC power port, low frequency immunity tests	IEC 60730-1 (Edition 5.1)
640	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonics and Inter-harmonics including mains signaling at AC power port, low frequency immunity tests	IEC 60730-1 : 2013+Amd1:2015+AMD2
641	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonics and Inter-harmonics including mains signaling at AC power port, low frequency immunity tests	IEC 60730-2-9:2015+ AMD1:2018 +AMD2
642	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonics and Inter-harmonics including mains signaling at AC power port, low frequency immunity tests	IEC 60730-2-9:2015+AMD 1 (Edition 4.1)
643	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Harmonics and Inter-harmonics including mains signaling at AC power port, low frequency immunity tests	IEC 61000-4-13: (Edition 1.0)
644	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 50121-4
645	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 50121-4:2016 +A1
646	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 55024
647	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 55035

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648	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 55035:2017+A11
649	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 60255-1
650	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 60255-26
651	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 60601-1-2: 2007/AC
652	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 60669-2-1:2004 +A12
653	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 61000-4-8
654	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 61000-6-1
655	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 61000-6-2
656	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 61131-2
657	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 61326-1
658	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 61326-2-1
659	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 61326-2-2
660	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 61326-2-3
661	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 61326-2-4
662	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 61326-2-5
663	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 61326-2-6
664	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 61439-1
665	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 61547
666	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 61547:2009 +A12

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667	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 62040-2
668	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 60255-1 (Edition 1.0)
669	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 60255-26 (Edition 3.0)
670	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 60335-1, (Edition 6.0)
671	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 60601-1-2 (Edition 2.0)
672	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 60601-1-2 (Edition 2.1)
673	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 60601-1-2 (Edition 3.0)
674	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 60601-1-2 (Edition 4.0)
675	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 60601-1-2 (Edition 4.1)
676	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 60601-2-25: (Edition 2.0)
677	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 60601-2-27 (Edition 3.0)
678	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 60669-2-1:2002+AMD1: 2008+AMD2 CSV
679	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 60669-2-5 (Edition 1.0)
680	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 60730-1 (Edition 5.1)
681	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 60730-1 : 2013+Amd1:2015+AMD2
682	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 60730-2-9:2015+ AMD 1 (Edition 4.1)
683	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 60730-2-9:2015+ AMD1: 2018 +AMD2
684	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 60947-1 (Edition 6.0)
685	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61000-4-8 (2nd Edition)

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686	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61000-6-1 (Edition 2.0)
687	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61000-6-1 (Edition 3.0)
688	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61000-6-2 (Edition 2.0)
689	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61000-6-2 (Edition 3.0)
690	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61131-2: (Edition 4.0)
691	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61326-1 (Edition 2.0)
692	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61326-1 (Edition 3.0)
693	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61326-2-1: (Edition 2.0)
694	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61326-2-1: (Edition 3.0)
695	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61326-2-2 (Edition 2.0)
696	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61326-2-2 (Edition 3.0)
697	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61326-2-3 (Edition 2.0)
698	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61326-2-3 (Edition 3.0)
699	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61326-2-4 (Edition 2.0)
700	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61326-2-4 (Edition 3.0)
701	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61326-2-5 (Edition 2.0)
702	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61326-2-5 (Edition 3.0)
703	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61326-2-6 (Edition 2.0)
704	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61326-2-6 (Edition 3.0)

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705	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61347-2-13:2014 +AMD1 CSV
706	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61439-1 (Edition 2.0)
707	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61439-1 (Edition 3.0)
708	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61547 (Edition 2.0)
709	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61547 (Edition 3.0)
710	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61547 TR
711	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 61850-3 (Edition 2.0)
712	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 62040-2 (Edition 2.0)
713	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 62040-2 (Edition 3.0)
714	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEC 80601-2-49 (Edition 1.0)
715	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IEEE Std 1613.1
716	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IS 13450 Part 1 Sec2
717	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IS/IEC 60730-1
718	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IS/IEC 60730-2-9
719	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IS/IEC 60947-1
720	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	IS/IEC 60947-5-2
721	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Electromagnetic Disturbances	CISPR 15 (Edition 8.1): (2013+AMD1)
722	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Electromagnetic Disturbances	CISPR 15 (Edition 7.2)
723	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Electromagnetic Disturbances	CISPR 15 (Edition 8.0)

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724	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Electromagnetic Disturbances	CISPR 15 (Edition 9.0)
725	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Electromagnetic Disturbances	EN 55015
726	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Electromagnetic Disturbances	EN 55015: 2006+ Amd. 2
727	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Electromagnetic Disturbances	EN 55015:2013+A1
728	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Electromagnetic Disturbances	IS 16102 (Part 2)
729	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	CISPR 11 (Edition 5.1) Consol. with Amd. 1
730	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	CISPR 11 (Edition 6.0)2015/AMD1
731	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	CISPR 11 (Edition 6.1)2015+AMD1
732	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	CISPR 11 (Edition 6.2)
733	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	CISPR 13 (Edition 5.1) 2009+AMD1
734	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	CISPR 14-1 (Edition 6.0)
735	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	CISPR 14-1 (Edition 7.0)
736	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	CISPR 15 (Edition 8.1): (2013+AMD1)
737	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	CISPR 15 (Edition 9.0)
738	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	CISPR 22 (Edition 6.0)
739	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	CISPR 32 (Edition 2.0)
740	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	CISPR 32:2015/AMD1
741	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 12015
742	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 301 511 V12.5.1 Clause 4.2.16, 4.2.17, 4.2.18 & 4.2.19

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743	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 50121-3-2
744	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 50121-4
745	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 50121-4:2016+A1
746	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 50370-1
747	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 55011: (2016+A11)
748	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 55011: (2009+A1)
749	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 55011: (2016+A1)
750	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 55014-1
751	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 55014-1: 2006/Amd. 2
752	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 55014-1:2017+A11
753	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 55015
754	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 55015
755	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 55015: 2006+ Amd. 2
756	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 55015:2013+A1
757	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 55032
758	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 60601-1-2
759	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 60601-1-2: 2007/AC
760	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 61000-6-3: 2007/Amd. 1
761	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 61000-6-4

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
762	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 61326-1
763	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 61326-2-1
764	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 61326-2-2
765	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 61326-2-3
766	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 61326-2-4
767	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 61326-2-5
768	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 61326-2-6
769	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 62040-2
770	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 62052-11
771	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 300 220-2 V3.1.1 Clause 4.2.2 & 4.3.1
772	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 300 328 V2.1.1 Clause 4.3.1.10/4.2.3.9 and 4.3.1.11/ 4.3.2.10
773	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 300 330 V2.1.1 Clause 4.3.9 & 4.4.2
774	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 300 330-2 V1.6.1
775	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 300 339 V1.1.1
776	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 300 386 V2.1.1
777	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 300 440 V2.1.1 Clause 4.2.4 & 4.3.5
778	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 301 090 V1.1.1
779	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 301 489-1 V2.2.0

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780	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 301 489-1 V2.2.1
781	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 301 489-17 V3.2.0
782	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 301 489-17 V3.2.2
783	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 301 489-17 V3.2.4
784	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 301 489-3 V2.1.1
785	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 301 489-3 V2.1.1
786	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 301 489-52 V1.1.0
787	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 301 893 V2.1.1 Clause 4.2.4.1 & 4.2.5
788	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 301 908-1 V11.1.1 (Clause 4.2.2)
789	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 302 502 V2.1.1 Clause 4.2.3 & 4.2.5
790	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	FCC part 15 Subpart B (Clause 15.109)
791	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	FCC Part 15 Subpart C (Clause 15.209 & 15.205, 15.249(a), 15.249(d))
792	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	FCC Part 15 Subpart E (Clause 15.209 & 15.407(b)
793	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	GR-1089-CORE, Issue 5
794	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	GR-1089-CORE, Issue 6
795	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60034-1 (Edition 13.0)
796	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60255-1 (Edition 1.0)
797	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60255-26 (Edition 3.0)

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798	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60255-26 (Edition 3.0)
799	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60601-1-2 (Edition 4.1):(2014-02+AMD1
800	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60601-1-2 (Edition 2.0)
801	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60601-1-2 (Edition 4.0)
802	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60601-1-2: (Edition 2.1)
803	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60601-1-2: (Edition 3.0)
804	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60669-2-1 (Edition 4.1) : (2002+AMD1)
805	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60669-2-1 (Edition 4.2): (2002+AMD1:2008 +AMD2
806	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60669-2-5 (Edition 1.0)
807	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60730-1 (Edition 5.0)
808	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60730-1 (Edition 5.1) : (2013+AMD1)
809	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60730-1 (Edition 5.2)
810	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60730-2-9 (Edition 4.0)
811	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60730-2-9 (Edition 4.1) : (2015+AMD1)
812	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60730-2-9:2015+ AMD1: 2018 +AMD2
813	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60870-2-1(Edition 2.0)
814	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60945, (Edition 4.0)
815	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60947-1, Edition 6.0
816	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60974-10 (Edition 3.0)

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817	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60974-10 (Edition 3.1)
818	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 60974-10 (Edition 4.0)
819	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61000-2-27 (Edition 3.0)
820	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61000-25, (Edition 2.0)
821	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61000-6-3 (Edition 2.1)
822	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61000-6-3 (Edition 2.1) Consol. with Amd. 1
823	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61000-6-3 (Edition 2.1) Consol. with Amd. 1
824	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61000-6-3 (Edition 3.0)
825	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61000-6-3 (Edition 3.0)
826	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61000-6-4 (Edition 2.1) Consol. with Amd. 1
827	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61000-6-4 (Edition 3.0)
828	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61131-2 (Edition 4.0)
829	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61326-1 (Edition 2.0)
830	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61326-1(Edition 3.0)
831	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61326-2-1 (Edition 2.0)
832	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61326-2-1 (Edition 3.0)
833	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61326-2-2 (Edition 2.0)
834	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61326-2-2 (Edition 3.0)
835	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61326-2-3 (Edition 2.0)

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836	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61326-2-3 (Edition 3.0)
837	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61326-2-4 (Edition 2.0)
838	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61326-2-4 (Edition 3.0)
839	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61326-2-5 (Edition 2.0)
840	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61326-2-5 (Edition 3.0)
841	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61326-2-6 (Edition 2.0)
842	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61326-2-6 (Edition 3.0)
843	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61439-1 (Edition 2.0)
844	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 61439-1 (Edition 3.0)
845	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 62040-2 (Edition 3.0)
846	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 62052-11 (Edition 1.1) 2003+AMD1
847	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 62052-11 (Edition 2.0)
848	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IEC 80601-2-49 (Edition 1.0)
849	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IS 13450 Part 1 Sec2
850	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IS/IEC 60730-1
851	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IS/IEC 60730-2-9
852	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IS/IEC 60947-1
853	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IS/IEC 60947-2
854	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IS/IEC 60947-3

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855	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	IS/IEC 60947-5-2
856	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ISO 80601-2-61 (Edition 2.0) : (2017-12) (Corrected version)
857	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	RSS 247 Issue 2 : (Clause 5.5 & 6.2)
858	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	RSS Gen Issue 5: (Clause 8.9 & 8.10)
859	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	TEC/EMI/TEL-001/01/FEB-09
860	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 50561-1
861	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 55022: 2010/AC
862	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	EN 55103-1: 2009/Amd. 1
863	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	ETSI EN 301 489-3 V2.1.1
864	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	TEC/SD/DD/EMC-221/05/OCT-16
865	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated Emission (RE)	TEC/SD/DD/TCP-222/01.Dec18
866	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	BIS IS 13779 : 1999 AMD 5
867	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	CISPR 14-2 (Edition 1.2) Consol. with Amd. 1 &2
868	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	CISPR 14-2 (Edition 2.0)
869	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	CISPR 14-2 (Edition 3.0)
870	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	CISPR 20
871	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	CISPR 20: (Edition 6.1) 2006+AMD1

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872	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	CISPR 24 (Edition 2.0)
873	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	CISPR 24 (Edition 2.1)
874	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	CISPR 35 (Edition 1.0)
875	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 12016
876	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 50121-3-2
877	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 50121-3-2:2016 +A1
878	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 50121-4
879	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 50121-4:2016 +A1
880	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 50130-4
881	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 50130-4:2011 +A1
882	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 50370-2:
883	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 55014-2
884	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 55014-2: 1997/ Amd. 2
885	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 55024

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
886	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 55024:2010+A1
887	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 55035
888	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 55035:2017+ A11
889	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 55103-2
890	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 60255-1
891	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 60601-1-2: 2007/AC
892	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 60669-2-1:2004 +A12
893	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 60730-1
894	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 61000-4-3
895	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 61000-4-3 : 2006 Amd. 2
896	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 61000-6-1
897	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 61000-6-2
898	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 61131-2
899	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 61326-1

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900	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 61326-2-1
901	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 61326-2-2
902	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 61326-2-3
903	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 61326-2-4
904	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 61326-2-5
905	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 61326-2-6
906	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 61439-1
907	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 61496-1
908	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 61547
909	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 61547:2009 +A12
910	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 62040-2
911	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 62052-11
912	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 62052-11:2003+A1
913	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 62053-21

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914	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	EN 62053-21: 2003+A1
915	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	ETSI EN 300 339 V1.1.1
916	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	ETSI EN 300 386 V2.1.1
917	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	ETSI EN 301 090 V1.1.1
918	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	ETSI EN 301 489-1 V2.2.0
919	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	ETSI EN 301 489-1 V2.2.1
920	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	ETSI EN 301 489-17 V3.2.0
921	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	ETSI EN 301 489-17 V3.2.2
922	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	ETSI EN 301 489-17 V3.2.4
923	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	ETSI EN 301 489-3 V2.1.1
924	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	ETSI EN 301 489-52 V1.1.0
925	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	GR-1089-CORE, Issue 5
926	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	GR-1089-CORE: Issue 6
927	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60255-1: (Edition 1.0)

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928	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60255-26 (Edition 3.0)
929	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60255-26: (Edition 3.0)
930	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60335-1, (Edition 6.0)
931	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60601-1-2 (Edition 4.1):(2014-02+AMD1)
932	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60601-1-2 (Edition 2.1)
933	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60601-1-2 (Edition 2.0)
934	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60601-1-2 (Edition 3.0)
935	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60601-1-2 (Edition 4.0)
936	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60669-2-1:2002 +AMD1: 2008+ AMD2 CSV
937	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60669-2-5: (Edition 1.0)
938	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60730-1 (Edition 5.1)
939	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60730-1 : 2013+Amd1:2015+AMD2
940	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60730-2-9: (Edition 4.1) : 2015+AMD 1
941	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60730-2-9:2015+ AMD1:2018 +AMD2

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942	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60870-2-1(Edition 2.0)
943	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60945, (Edition 4.0)
944	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60947-1, (Edition 6.0)
945	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60974-10(Edition 3.1)
946	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60974-10(Edition 4.0)
947	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 60974-10: (Edition 3.0)
948	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61000-2-27, (Edition 3.0)
949	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61000-25, (Edition 2.0)
950	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61000-4-3 (Edition 3.2) Consol. with Amd. 1 &2
951	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61000-4-3 (Edition 4.0)
952	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61000-6-1 (Edition 2.0)
953	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61000-6-1 (Edition 3.0)
954	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61000-6-2 (Edition 2.0)
955	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61000-6-2 (Edition 3.0)

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956	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61000-6-5 (Edition 1.0)
957	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61000-6-5:2015/COR1
958	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61008-1(Edition 3.2)
959	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61009-1(Edition 3.2)
960	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61326-1 (Edition 2.0)
961	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61326-1, (Edition 3.0)
962	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61326-2-1: (Edition 2.0)
963	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61326-2-1: (Edition 3.0)
964	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61326-2-2: (Edition 2.0)
965	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61326-2-2: (Edition 3.0)
966	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61326-2-3: (Edition 2.0)
967	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61326-2-3: (Edition 3.0)
968	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61326-2-4: (Edition 2.0)
969	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61326-2-4: (Edition 3.0)

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970	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61326-2-5: (Edition 2.0)
971	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61326-2-5: (Edition 3.0)
972	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61326-2-6: (Edition 2.0)
973	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61326-2-6: (Edition 3.0)
974	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61347-2-13:2014+AMD1 CSV
975	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61439-1: (Edition 2.0)
976	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61439-1: (Edition 3.0)
977	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61496-1 (Edition 3.0)
978	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61543:1995, Amd 1
979	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61543:1995, Amd 2
980	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61547
981	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61547 (Edition 2.0)
982	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 61547 (Edition 3.0)
983	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 62040-2 (Edition 2.0)

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984	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 62040-2: (Edition 3.0)
985	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 62052-11 (Edition 1.0)
986	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 62052-11, (Edition 2.0)
987	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 62052-11: (Edition 1.1) : 2003+AMD1
988	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 62053-21, (Edition 2.0)
989	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 62053-21: (Edition 1.1):2003/AMD1
990	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEC 80601-2-49 : (Edition 1.0)
991	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IEEE Std 1613.1
992	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IS 12640 (Part 1)
993	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IS 12640 (Part 2)
994	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IS 13450 (Part 2 : Sec 25)
995	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IS 13450 (Part 2/Sec 49)
996	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IS 13450 Part 1 Sec2
997	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IS 13779

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
998	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IS 14697: 1999 , Reaffirmed
999	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IS 14700 (Part 4/Sec 3)
1000	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IS 302-1 : 2008 (Reaffirmed)
1001	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IS/IEC 60730-1
1002	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IS/IEC 60730-2-9
1003	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IS/IEC 60947-1
1004	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IS/IEC 60947-2
1005	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IS/IEC 60947-3
1006	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	IS/IEC 60947-5-2
1007	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	ISO 80601-2-61 (Edition 2.0) : (2017-12) (Corrected version)
1008	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	TEC/EMI/TEL-001/01/FEB-09
1009	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	TEC/SD/DD/EMC-221/05/OCT-16
1010	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Radiated radio frequency electromagnetic field Immunity Test	TEC/SD/DD/TCP-222/01.Dec18
1011	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Ring wave Immunity Test	EN 61000-4-12

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
1012	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Ring wave Immunity Test	IEC 60335-1, (Edition 6.0)
1013	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Ring wave Immunity Test	IEC 61000-4-12
1014	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Ring wave Immunity Test	IEC 61000-4-12: (Edition 3.0)
1015	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Ring wave Immunity Test	IEC 61008-1(Edition 3.2)
1016	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Ring wave Immunity Test	IEC 61009-1(Edition 3.2)
1017	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Ring wave Immunity Test	IEC 61543:1995, Amd 1
1018	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Ring wave Immunity Test	IEC 61543:1995, Amd 2
1019	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Ring wave Immunity Test	IS 12640 (Part 1)
1020	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Ring wave Immunity Test	IS 12640 (Part 2)
1021	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Ring wave Immunity Test	IS/IEC 60730-1
1022	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Ring wave Immunity Test	IS/IEC 60730-2-9
1023	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Ripple on DC input power port immunity Test	EN 61000-4-17
1024	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Ripple on DC input power port immunity Test	EN61000-4-17:1999 +A2
1025	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Ripple on DC input power port immunity Test	IEC 61000-4-17: (Edition 1.0)
1026	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Ripple on DC input power port immunity Test	IEC 61000-4-17: (Edition 1.2)
1027	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	BIS IS 13779 : 1999 AMD 5
1028	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	CISPR 14-2 (Edition 2.0) RLV
1029	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	CISPR 14-2 (Edition 3.0)
1030	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	CISPR 24 (Edition 2.0)

SCOPE OF ACCREDITATION

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
1031	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	CISPR 24 (Edition 2.1)
1032	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	CISPR 35 (Edition 1.0)
1033	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 50121-3-2
1034	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 50121-3-2:2016+A1
1035	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 50121-4
1036	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 50121-4:2016+A1
1037	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 55014-2
1038	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 55014-2: 1997/ Amd. 2
1039	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 55024
1040	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 55035:2017+A11
1041	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 60255-1
1042	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 60255-26
1043	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 60601-1-2: 2007/AC
1044	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 60669-2-1:2004 +A12
1045	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 60730-1
1046	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 61000-4-5:2014+A1
1047	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 61000-6-1
1048	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 61000-6-2
1049	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 61131-2

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
1050	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 61326-1
1051	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 61326-2-1
1052	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 61326-2-2
1053	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 61326-2-3
1054	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 61326-2-4
1055	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 61326-2-5
1056	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 61326-2-6
1057	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 61439-1
1058	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 61547
1059	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 61547:2009 +A12
1060	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 62040-2
1061	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	EN 62052-11:2003+A1
1062	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	ETSI EN 300 339 V1.1.1
1063	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	ETSI EN 300 386 V2.1.1
1064	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	ETSI EN 301 090 V1.1.1
1065	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	ETSI EN 301 489-1 V2.2.0
1066	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	ETSI EN 301 489-1 V2.2.1
1067	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	ETSI EN 301 489-17 V3.2.0
1068	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	ETSI EN 301 489-17 V3.2.2

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1069	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	ETSI EN 301 489-17 V3.2.4
1070	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	ETSI EN 301 489-3 V2.1.1
1071	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60255-1: (Edition 1.0)
1072	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60255-26: (Edition 3.0)
1073	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60335-1, (Edition 6.0)
1074	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60601-1-2 (Edition 2.1)
1075	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60601-1-2 (Edition 2.0)
1076	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60601-1-2 (Edition 3.0)
1077	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60601-1-2 (Edition 4.0)
1078	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60601-1-2 (Edition 4.1)
1079	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60601-2-25: (Edition 2.0)
1080	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60601-2-27 (Edition 3.0)
1081	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60669-2-1 (Edition 4.2) 2002/AMD2
1082	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60669-2-5: (Edition 1.0)
1083	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60730-1 (Edition 5.1)
1084	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60730-1 : 2013+Amd1:2015+AMD2
1085	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60730-2-9: (Edition 4.1) 2015+AMD 1
1086	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60730-2-9: (Edition 4.2) 2015+AMD1:2018+AMD2
1087	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60945, (Edition 4.0)

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1088	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60974-10(Edition 3.1)
1089	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60974-10(Edition 4.0)
1090	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60974-10: (Edition 3.0)
1091	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61000-4-5 (Edition 3.0)
1092	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61000-4-5: (Edition 3.1) 2014/AMD1
1093	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61000-6-1 (Edition 2.0)
1094	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61000-6-1 (Edition 3.0)
1095	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61000-6-2 (Edition 2.0)
1096	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61000-6-2 (Edition 3.0)
1097	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61008-1(Edition 3.2)
1098	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61009-1(Edition 3.2)
1099	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61131-2: (Edition 4.0)
1100	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61326-1 (Edition 2.0)
1101	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61326-1 (Edition 3.0)
1102	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61326-2-1 (Edition 3.0)
1103	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61326-2-1: (Edition 2.0)
1104	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61326-2-2 (Edition 2.0)
1105	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61326-2-2 (Edition 3.0)
1106	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61326-2-3 (Edition 2.0)

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
1107	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61326-2-3 (Edition 3.0)
1108	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61326-2-4: (Edition 2.0)
1109	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61326-2-4: (Edition 3.0)
1110	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61326-2-5: (Edition 2.0)
1111	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61326-2-5: (Edition 3.0)
1112	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61326-2-6: (Edition 2.0)
1113	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61326-2-6: (Edition 3.0)
1114	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61347-2-13:2014 +AMD1 CSV
1115	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61439-1: (Edition 2.0)
1116	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61439-1: (Edition 3.0)
1117	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61543:1995, Amd 1
1118	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61543:1995, Amd 2
1119	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61543:1995/ AMD2
1120	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61547 (Edition 2.0)
1121	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61547 (Edition 3.0)
1122	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61547 TR
1123	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 61850-3 (Edition 2.0)
1124	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 62040-2 (Edition 2.0)
1125	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 62040-2 (Edition 3.0)

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1126	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 62052-11 (Edition 1.0)
1127	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 62052-11: (Edition 1.1) 2003+AMD1
1128	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 62052-11: (Edition 2.0)
1129	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 80601-2-49 : (Edition 1.0)
1130	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEEE Std 1613.1
1131	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IS 12640 (Part 1)
1132	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IS 12640 (Part 2)
1133	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IS 13450 Part 1 Sec2
1134	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IS 13779
1135	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IS 14697: 1999 , Reaffirmed
1136	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IS/IEC 60730-1
1137	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IS/IEC 60730-2-9
1138	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IS/IEC 60947-1
1139	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IS/IEC 60947-2
1140	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IS/IEC 60947-3
1141	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	TEC/EMI/TEL-001/01/FEB-09
1142	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	TEC/SD/DD/EMC-221/05/OCT-16
1143	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	TEC/SD/DD/TCP-222/ 01.Dec18
1144	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Surge Immunity Test	IEC 60947-1, (Edition 6.0)

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
1145	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Test for immunity to conducted, differential mode disturbances and signaling in the frequency range 2 kHz to 150 kHz at AC. power ports	EN 61000-4-19
1146	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Test for immunity to conducted, differential mode disturbances and signaling in the frequency range 2 kHz to 150 kHz at AC. power ports	IEC 61000-4-19: (Edition 1.0)
1147	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Variation of power Frequency Immunity Test	EN 61000-4-28
1148	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Variation of power Frequency Immunity Test	IEC 61000-4-28, (Edition 1.0)
1149	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Variation of power Frequency Immunity Test	IEC 61000-4-28:1999+AMD1:2001 +AMD2
1150	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	variations on DC. input power port immunity tests	TEC/EMI/TEL-001/01/FEB-09
1151	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	variations on DC. input power port immunity tests	TEC/SD/DD/TCP-222/01.Dec18
1152	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	CISPR 14-2 (Edition 2.0
1153	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	CISPR 14-2 (Edition 3.0)
1154	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	CISPR 24 (Edition 2.0)
1155	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	CISPR 24 (Edition 2.1)
1156	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	CISPR 35 (Edition 1.0)
1157	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 55014-2
1158	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 55014-2: 1997/ Amd. 2

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1159	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 55024
1160	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 55035:2017+A11
1161	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 60255-1
1162	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 60255-26
1163	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 60601-1-2: 2007/ AC
1164	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 60601-1-2: 2007/AC
1165	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 60669-2-1:2004 +A12
1166	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 60730-1
1167	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 61000-4-11
1168	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 61000-6-1
1169	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 61000-6-2
1170	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 61131-2
1171	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 61326-1
1172	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 61326-2-1

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1173	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 61326-2-2
1174	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 61326-2-3
1175	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 61326-2-4
1176	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 61326-2-5
1177	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 61326-2-6
1178	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 61439-1
1179	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 61547
1180	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 61547:2009 +A12
1181	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 62040-2
1182	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 62052-11
1183	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	EN 62052-11:2003+A1
1184	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	ETSI EN 300 339 V1.1.1
1185	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	ETSI EN 300 386 V2.1.1
1186	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	ETSI EN 301 090 V1.1.1

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1187	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	ETSI EN 301 489-1 V2.2.0
1188	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	ETSI EN 301 489-1 V2.2.1
1189	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	ETSI EN 301 489-17 V3.2.0
1190	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	ETSI EN 301 489-17 V3.2.2
1191	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	ETSI EN 301 489-17 V3.2.4
1192	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	ETSI EN 301 489-3 V2.1.1
1193	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60255-1 (Edition 1.0)
1194	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60255-26 (Edition 3.0)
1195	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60601-1-2 (Edition 2.0)
1196	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60601-1-2 (Edition 2.1)
1197	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60601-1-2 (Edition 2.1)
1198	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60601-1-2 (Edition 3.0)
1199	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60601-1-2 (Edition 4.0)
1200	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60601-1-2 (Edition 4.1)

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1201	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60669-2-1 2002+AMD1: 2008+AMD2 CSV
1202	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60669-2-5 (Edition 1.0)
1203	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60730-1 (Edition 5.1)
1204	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60730-1 : 2013+Amd1: 2015+AMD2
1205	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60730-2-9: (Edition 4.1) 2015+AMD 1
1206	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60730-2-9:2015+AMD1: 2018+AMD2 CSV
1207	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60945, (Edition 4.0)
1208	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60947-1, (Edition 6.0)
1209	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60974-10 (Edition 3.0)
1210	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60974-10 (Edition 4.0)
1211	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 60974-10(Edition 3.1)
1212	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61000-2-27 (Edition 3.0)
1213	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61000-25 (Edition 2.0)
1214	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61000-4-11 (Edition 2.0)

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1215	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61000-4-11 (Edition 2.1)
1216	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61000-4-11 (Edition 3.0)
1217	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61000-6-1 (Edition 2.0)
1218	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61000-6-1 (Edition 3.0)
1219	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61000-6-2 (Edition 2.0)
1220	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61000-6-2 (Edition 3.0)
1221	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61131-2 (Edition 4.0)
1222	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61326-1 (Edition 2.0)
1223	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61326-1 (Edition 3.0)
1224	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61326-2-1(Edition 2.0)
1225	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61326-2-1(Edition 3.0)
1226	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61326-2-2 (Edition 2.0)
1227	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61326-2-2 (Edition 3.0)
1228	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61326-2-3 (Edition 2.0)

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1229	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61326-2-3 (Edition 3.0)
1230	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61326-2-4 (Edition 2.0)
1231	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61326-2-4 (Edition 3.0)
1232	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61326-2-5 (Edition 2.0)
1233	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61326-2-5 (Edition 3.0)
1234	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61326-2-6 (Edition 2.0)
1235	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61326-2-6 (Edition 3.0)
1236	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61347-2-13:2014 +AMD1 CSV
1237	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61439-1 (Edition 3.0)
1238	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61439-1(Edition 2.0)
1239	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61547 (Edition 2.0)
1240	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61547 (Edition 3.0)
1241	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61547 TR
1242	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 61850-3 (Edition 2.0)

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1243	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 62052-11 (Edition 1.1) :2003+AMD1
1244	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 62052-11 (Edition 2.0)
1245	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IEC 80601-2-49 (Edition 1.0)
1246	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IS 13450 Part 1 Sec2
1247	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IS 14700 (Part 4/Sec 11)
1248	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IS 302-1 : 2008 (Reaffirmed)
1249	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IS/IEC 60730-1
1250	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IS/IEC 60730-2-9
1251	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IS/IEC 60947-1
1252	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IS/IEC 60947-2
1253	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	IS/IEC 60947-5-2
1254	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	TEC/EMI/TEL-001/01/FEB-09
1255	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	TEC/SD/DD/EMC-221/05/OCT-16
1256	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	TEC/SD/DD/TCP-222/01.Dec18

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1257	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage dips, short interruptions and voltage	EN 61000-4-29
1258	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage dips, short interruptions and voltage	TEC/SD/DD/EMC-221/05/OCT-16
1259	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage dips, short interruptions and voltage variations on DC. input power port immunity tests	IEC 61000-4-29: (Edition 01)
1260	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	EN 60601-1-2: (Edition 3.0)
1261	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	EN 60601-1-2: (Edition 4.0)
1262	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	EN 60669-2-1:2004 +A12
1263	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	EN 60730-1
1264	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	EN 61000-3-3
1265	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	EN 61000-3-3:2013+A1
1266	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	EN 61326-1
1267	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	EN 61326-2-1
1268	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	EN 61326-2-2
1269	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	EN 61326-2-3
1270	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	EN 61326-2-4
1271	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	EN 61326-2-5
1272	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	EN 61326-2-6
1273	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	ETSI EN 300 386 V2.1.1
1274	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	ETSI EN 301 489-1 V2.2.1

SCOPE OF ACCREDITATION

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
1275	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	ETSI EN 301 489-17 V3.2.0
1276	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	ETSI EN 301 489-17 V3.2.2
1277	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	ETSI EN 301 489-17 V3.2.3
1278	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	ETSI EN 301 489-17 V3.2.4
1279	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	ETSI EN 301 489-3 V2.1.1
1280	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 60601-1-2 (Edition 2.0)
1281	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 60601-1-2 (Edition 4.1):(2014-02+AMD1)
1282	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 60601-1-2 (Edition 2.1)
1283	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 60601-1-2 (Edition 4.0)
1284	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 60601-1-2: (Edition 2.1)
1285	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 60601-1-2: (Edition 3.0)
1286	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 60669-2-1 (Edition 4.1) : (2002+AMD1)
1287	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 60669-2-1 (Edition 4.2): (2002+AMD1:2008 +AMD2
1288	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 60669-2-5 (Edition 1.0)
1289	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 60730-1 (Edition 5.1)
1290	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 60730-1: (Edition 5.2)
1291	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 60730-2-9 (Edition 4.1)
1292	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 60730-2-9:2015+ AMD1: 2018 +AMD2
1293	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 60974-10 (Edition 3.1)

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1294	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 60974-10: (Edition 3.0)
1295	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 60974-10: (Edition 4.0)
1296	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 61000-3-3 (Edition 3.0)
1297	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 61000-3-3 (Edition 3.1)
1298	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 61000-6-3 (Edition 2.1)
1299	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 61000-6-3 (Edition 2.1) Consol. with Amd. 1
1300	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 61000-6-3 (Edition 3.0)
1301	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 61326-1 (Edition 2.0)
1302	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 61326-1 (Edition 3.0)
1303	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 61326-1 (Edition 3.0)
1304	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 61326-2-3 (Edition 2.0)
1305	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 61326-2-3 (Edition 3.0)
1306	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 61326-2-4(Edition 3.0)
1307	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 61326-2-4: (Edition 2.0)
1308	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 61326-2-5 (Edition 3.0)
1309	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 61326-2-5: (Edition 2.0)
1310	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 61326-2-6 (Edition 3.0)
1311	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IEC 61326-2-6: (Edition 2.0)
1312	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage Fluctuation & Flicker Test	IS 13450 Part 1 Sec2

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1313	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage fluctuation immunity test for equipment with input current not exceeding 16 A per phase	EN 61000-4-14:1999+A2
1314	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Voltage fluctuation immunity test for equipment with input current not exceeding 16 A per phase	IEC 61000-4-14: (Edition 1.2)
1315	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Conducted RF Immunity Test	ETSI EN 301 489-1 V2.2.3
1316	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Conducted RF Immunity Test	ETSI EN 301 489-19 V2.1.1
1317	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Conducted RF Immunity Test	ETSI EN 301 489-3 V3.2.4
1318	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Conducted RF Immunity Test	ETSI EN 301 489-52 V1.1.2
1319	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Conducted Emissions Test (CE	EN 301 489-52 V1.1.2
1320	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Conducted Emissions Test (CE	ETSI EN 301 489-19 V2.1.1
1321	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Conducted Emissions Test (CE)	ETSI EN 301 489-1 V2.2.3
1322	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Conducted Emissions Test (CE)	ETSI EN 301 489-3 V3.2.4
1323	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	ETSI EN 301 489-1 V2.2.3
1324	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	ETSI EN 301 489-19 V2.1.1
1325	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	ETSI EN 301 489-3 V3.2.4
1326	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Electrical Fast Transient (EFT) / Burst Immunity Test	ETSI EN 301 489-52 V1.1.2
1327	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Electro Static Discharge Immunity Test	ETSI EN 301 489-1 V2.2.3
1328	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Electro Static Discharge Immunity Test	ETSI EN 301 489-19 V2.1.1
1329	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Electro Static Discharge Immunity Test	ETSI EN 301 489-3 V3.2.4

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1330	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Electro Static Discharge Immunity Test	ETSI EN 301 489-52 V1.1.2
1331	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Harmonics and Inter-harmonics including mains signaling at AC power port, low frequency immunity tests	IEC 60335-1, (Edition 6.0)
1332	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Surge Immunity Test	ETSI EN 301 489-1 V2.2.3
1333	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Surge Immunity Test	ETSI EN 301 489-19 V2.1.1
1334	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Surge Immunity Test	ETSI EN 301 489-3 V3.2.4
1335	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Surge Immunity Test	ETSI EN 301 489-52 V1.1.2
1336	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	ETSI EN 301 489-1 V2.2.3
1337	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	ETSI EN 301 489-19 V2.1.1
1338	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	ETSI EN 301 489-3 V3.2.4
1339	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Voltage Dips, Short Interruption & Voltage variations Immunity Test	ETSI EN 301 489-52 V1.1.2
1340	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Voltage dips, short interruptions and voltage variations on DC. input power port immunity tests	IEC 60335-1, (Edition 6.0)
1341	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Voltage Fluctuation s & Flicker	ETSI EN 301 489-1 V2.2.3
1342	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Voltage Fluctuation s & Flicker	ETSI EN 301 489-19 V2.1.1
1343	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Voltage Fluctuation s & Flicker	ETSI EN 301 489-3 V2.1.1
1344	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Voltage Fluctuation s & Flicker	ETSI EN 301 489-3 V3.2.4
1345	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Instrument	Voltage Fluctuation s & Flicker	ETSI EN 301 489-52 V1.1.2

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1346	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Intrument	Harmonic Current Emission Test	ETSI EN 301 489-1 V2.2.3
1347	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Intrument	Harmonic Current Emission Test	ETSI EN 301 489-19 V2.1.1
1348	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Intrument	Harmonic Current Emission Test	ETSI EN 301 489-3 V2.1.1
1349	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Intrument	Harmonic Current Emission Test	ETSI EN 301 489-3 V3.2.4
1350	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Intrument	Harmonic Current Emission Test	ETSI EN 301 489-52 V1.1.2
1351	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Intrument	Radiated Emissions (RE)	ETSI EN 301 489-1 V2.2.3
1352	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Intrument	Radiated Emissions (RE)	ETSI EN 301 489-19 V2.1.1
1353	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Intrument	Radiated Emissions (RE)	ETSI EN 301 489-3 V3.2.4
1354	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Intrument	Radiated Emissions (RE)	ETSI EN 301 489-52 V1.1.2
1355	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Intrument	Radiated Radio Frequency Electromagnetic Field Immunity Test	ETSI EN 301 489-1 V2.2.3
1356	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Intrument	Radiated Radio Frequency Electromagnetic Field Immunity Test	ETSI EN 301 489-19 V2.1.1
1357	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Intrument	Radiated Radio Frequency Electromagnetic Field Immunity Test	ETSI EN 301 489-3 V2.1.1
1358	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Intrument	Radiated Radio Frequency Electromagnetic Field Immunity Test	ETSI EN 301 489-3 V3.2.4
1359	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical & Electronic Intrument	Radiated Radio Frequency Electromagnetic Field Immunity Test	ETSI EN 301 489-52 V1.1.2
1360	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical and Electronic Instrument	Conducted Emission Test (CE)	TEC/EMI/TEL-001/01/FEB-09
1361	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 61000-3-2 (Edition 4)
1362	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical and Electronic Instrument	Harmonic Current Emission Test	IEC 61000-3-2 (Edition 5.1)

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1363	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical and Electronic Instrument	Radiated Electromagnetic Disturbances	IS 16102 (Part 2)
1364	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing: Electrical and Electronic Instrument	Radiated Electromagnetic Disturbances	IS 6873 (Part 5)
1365	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Adjacent channel rejection - speech channels (TCH/FS)	3GPP TS 51 010-1 :Oct 2019 Clause 14.5.1 EN 301 511 V12.5.1 (2017-03) Clause 4.2.38
1366	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Blocking and spurious response in EGPRS configuration	EN 301 511 V12.5.1 Clause 4.2.30
1367	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Conducted spurious emissions - MS allocated a channel	3GPP TS 51 010-1:Oct 2019 Clause 12.1.1 EN 301 511 V12.5.1 (2017-03) Clause 4.2.12
1368	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Conducted spurious emissions – MS in idle mode	3GPP TS 51 010-1 :Oct 2019 Clause 12.1.2 EN 301 511 V12.5.1 (2017-03) Clause 4.2.13
1369	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Conducted spurious emissions for MS supporting the R-GSM or ER-GSM frequency band - MS in idle mode	EN 301 511 V12.5.1 Clause 4.2.15
1370	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Conducted spurious emissions for MS supporting the R-GSM or ER-GSM frequency band - MS allocated a channel	EN 301 511 V12.5.1 Clause 4.2.14
1371	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	EGPRS Transmitter output power	EN 301 511 V12.5.1 Clause 4.2.28
1372	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Frequency error and Modulation accuracy in EGPRS Configuration	EN 301 511 V12.5.1 Clause 4.2.26
1373	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Frequency error and phase error in GPRS multislot configuration	GPRS:3GPP TS 51 010-1 :Oct 2019 Clause 13.16.1 EN 301 511 V12.5.1 (2017-03) Clause 4.2.4
1374	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Frequency error under multipath and interference conditions in EGPRS Configuration	EN 301 511 V12.5.1 Clause 4.2.27
1375	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Intermodulation rejection - control channels	EN 301 511 V12.5.1 Clause 4.2.33

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1376	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Intermodulation rejection - EGPRS	EN 301 511 V12.5.1 Clause 4.2.34
1377	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Intermodulation rejection - speech channels	EN 301 511 V12.5.1 Clause 4.2.32
1378	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Minimum Input level for Reference Performance - EGPRS	EN 301 511 V12.5.1 Clause 4.2.45
1379	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Minimum Input level for Reference Performance - GPRS	EN 301 511 V12.5.1 Clause 4.2.44
1380	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Output RF spectrum in EGPRS configuration	EN 301 511 V12.5.1 Clause 4.2.29
1381	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Output RF spectrum in GPRS multi slot configuration	3GPP TS 51 010-1 :Oct 2019Clause 13.16.3 EN 301 511 V12.5.1 (2017-03) Clause 4.2.11
1382	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Receiver Blocking and spurious response - speech channels	3GPP TS 51 010-1 :Oct 2019 Clause 14.7.1 EN 301 511 V12.5.1 (2017-03) Clause 4.2.20
1383	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Receiver Blocking and spurious response - speech channels for MS supporting the R-GSM or ER-GSM frequency band	EN 301 511 V12.5.1 Clause 4.2.21
1384	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Reference sensitivity - FACCH/F	EN 301 511 V12.5.1 Clause 4.2.43
1385	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Reference sensitivity - TCH/FS for MS supporting the R-GSM or ER-GSM band	EN 301 511 V12.5.1 Clause 4.2.46
1386	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Reference Sensitivity Level (Speech channels)	3GPP TS 51 010-1 :Oct 2019Clause 14.2.1 EN 301 511 V12.5.1 Clause 4.2.42
1387	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Transmitter - Frequency error and phase error	3GPP TS 51 010-1 :Oct 2019 Clause 13.1 EN 301 511 V12.5.1 (2017-03) Clause 4.2.1
1388	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Transmitter - Frequency error under multipath and interference conditions	EN 301 511 V12.5.1 Clause 4.2.2
1389	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Transmitter - Output RF spectrum	3GPP TS 51 010-1 :Oct 2019 Clause 13.4 EN 301 511 V12.5.1 (2017-03) Clause 4.2.6

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1390	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Transmitter - Output RF spectrum for MS supporting the R-GSM or ER-GSM frequency band	EN 301 511 V12.5.1 Clause 4.2.9
1391	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Transmitter output power and burst timing	3GPP TS 51 010-1 :Oct 2019 Clause 13.3 EN 301 511 V12.5.1 (2017-03) Clause 4.2.5
1392	ELECTRONICS- EMC TEST FACILITY	GSM/GPRS/EGPRS user equipment	Transmitter output power in GPRS Multi slot configuration	3GPP TS 51 010-1 :Oct 2019 Clause 13.16.2 EN 301 511 V12.5.1 (2017-03) Clause 4.2.10
1393	ELECTRONICS- EMC TEST FACILITY	IMT cellular networks Evolved Universal Terrestrial Radio Access (E-UTRA) User Equipment (UE)	Receiver adjacent channel selectivity (ACS)	3GPP TS 36.521-1 July 2019 Clause 7.5 EN 301 908-13 V11.1.2 (2017-07) Clause 4.2.6
1394	ELECTRONICS- EMC TEST FACILITY	IMT cellular networks Evolved Universal Terrestrial Radio Access (E-UTRA) User Equipment (UE)	Receiver In-band Blocking	3GPP TS 36.521-1 July 2019 Clause 7.6.1 EN 301 908-13 V11.1.2 (2017-07) Clause 4.2.7
1395	ELECTRONICS- EMC TEST FACILITY	IMT cellular networks Evolved Universal Terrestrial Radio Access (E-UTRA) User Equipment (UE)	Receiver intermodulation characteristics	EN 301 908-13 V11.1.2 Clause 4.2.9
1396	ELECTRONICS- EMC TEST FACILITY	IMT cellular networks Evolved Universal Terrestrial Radio Access (E-UTRA) User Equipment (UE)	Receiver reference sensitivity level	3GPP TS 36.521-1 July 2019 Clause 7.3 EN 301 908-13 V11.1.2 (2017-07) Clause 4.2.12
1397	ELECTRONICS- EMC TEST FACILITY	IMT cellular networks Evolved Universal Terrestrial Radio Access (E-UTRA) User Equipment (UE)	Receiver spurious emissions in idle mode	3GPP TS 36.521-1 July 2019 Clause 7.9 EN 301 908-13 V11.1.2 (2017-07) Clause 4.2.10
1398	ELECTRONICS- EMC TEST FACILITY	IMT cellular networks Evolved Universal Terrestrial Radio Access (E-UTRA) User Equipment (UE)	Transmitter adjacent channel leakage power ratio	EN 301 908-13 V11.1.2 Clause 4.2.11
1399	ELECTRONICS- EMC TEST FACILITY	IMT cellular networks Evolved Universal Terrestrial Radio Access (E-UTRA) User Equipment (UE)	Transmitter Maximum output power	3GPP TS 36.521-1 July 2019 Clause 6.2.2 EN 301 908-13 V11.1.2 (2017-07) Clause 4.2.2
1400	ELECTRONICS- EMC TEST FACILITY	IMT cellular networks Evolved Universal Terrestrial Radio Access (E-UTRA) User Equipment (UE)	Transmitter minimum output power	EN 301 908-13 V11.1.2 Clause 4.2.5
1401	ELECTRONICS- EMC TEST FACILITY	IMT cellular networks Evolved Universal Terrestrial Radio Access (E-UTRA) User Equipment (UE)	Transmitter Spectrum emissions mask	3GPP TS 36.521-1 Clause 6.6.2.1
1402	ELECTRONICS- EMC TEST FACILITY	IMT cellular networks Evolved Universal Terrestrial Radio Access (E-UTRA) User Equipment (UE)	Transmitter spurious emissions in active mode	3GPP TS 36.521-1 July 2019 Clause 6.6.3.1, 6.6.3.2, 6.6.3.3 EN 301 908-13 V11.1.2 (2017-07) Clause 4.2.4
1403	ELECTRONICS- EMC TEST FACILITY	IMT cellular networks	Radiated Emissions (UE)	EN 301 908-1 V11.1.1 Clause 4.2.11

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1404	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators & Unlicensed National Information Infrastructure Devices	6 dB Bandwidth & 99% Occupied Channel bandwidth	RSS 247 Issue 2: Clause 5.2(a) & 6.2.4.1 RSS Gen Issue 5:Mar 2019 Clause 6.7
1405	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators & Unlicensed National Information Infrastructure Devices	Band Edge Compliance (Emissions in the Non-Restricted Frequency Band) and conducted spurious emission	RSS 247 Issue 2:Clause 5.5 & 6.2.3.2
1406	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators & Unlicensed National Information Infrastructure Devices	Filed Strength of Fundamental & Harmonics and Radiated Spurious Emissions	FCC Part 15 Subpart C Dec 2020, Clause 15.249(a), 15.209, 15.249(a).
1407	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators & Unlicensed National Information Infrastructure Devices	Maximum conducted output power	RSS 247 Issue 2: Clause 5.4 & 6.2
1408	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators & Unlicensed National Information Infrastructure Devices	Maximum power spectral density	RSS 247 Issue 2: Clause 5.2(b) & 6.2
1409	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators & Unlicensed National Information Infrastructure Devices	Radiated Spurious Emissions, Unwanted Emissions and Emissions in the restricted bands of operations	RSS 247 Issue 2 Feb 2017 Clause 5.5 & 6.2 RSS Gen Issue 5 Section 8.9 & 8.10
1410	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators	6 dB Bandwidth & 99% Occupied Channel bandwidth	FCC Part 15 Subpart C: Jan 2020:Dec 2020 Clause 15.247(a)(2), FCC 2.1049
1411	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators	Band Edge Compliance (Emissions in the Non-Restricted Frequency Band) and conducted spurious emission	FCC Part 15 Subpart C: Dec 2020 Clause 15.247(d)
1412	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators	Bandwidth Occupancy (20dB Bandwidth)	FCC Part 15 Subpart C: Dec 2020 Clause 15.247(a)(1)/15.215(c)
1413	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators	Bandwidth Occupancy (20dB Bandwidth)	RSS 247 Issue 2:Feb 2017 Clause 5.1 RSS Gen Issue 5:Mar 2019 Clause 6.7
1414	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators	Carrier frequency separation	FCC Part 15 Subpart C: Dec 2020 Clause 15.247(a)(1)
1415	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators	Carrier frequency separation	RSS 247: Issue 2 Clause 5.1(b)
1416	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators	Frequency Tolerance	FCC Part 15 Subpart C Dec 2020 Clause 15.225(e)
1417	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators	Frequency Tolerance	RSS 210 Issue 10:, Clause B.6

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1418	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators	Maximum conducted output power	FCC Part 15 Subpart C Clause 15.247(b)
1419	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators	Maximum power spectral density	FCC Part 15 Subpart C: Dec 2020 Clause 15.247(e)
1420	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators	Number of hopping channel	FCC Part 15 Subpart C: Dec 2020 Clause 15.247 (a)(1
1421	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators	Number of hopping channel	RSS 247 Issue 2: Clause 5.1(c), 5.1(d) & 5.1(e)
1422	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators	Radiated Spurious Emission & Emissions in the Restricted bands of operation	FCC Part 15 Subpart C Dec 2020 Clause 15.247(d), 15.205, 15.209
1423	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators	Time of occupancy	FCC Part 15 Subpart C Dec 2020 (Clause 15.247(a)(1)
1424	ELECTRONICS- EMC TEST FACILITY	Intentional Radiators	Time of occupancy	RSS 247 Issue 2 : Clause 5.1(c), 5.1(d) & 5.1(e) Feb
1425	ELECTRONICS- EMC TEST FACILITY	Radio Conformance Test for Devices having Cellular Wireless Interface using WCDMA/ HSPA Technology	Out-of-synchronization handling of output power	EN 301 908-2 V11.1.2 Clause 4.2.11
1426	ELECTRONICS- EMC TEST FACILITY	Radio Conformance Test for Devices having Cellular Wireless Interface using WCDMA/ HSPA Technology	Radiated spurious emissions - MS in idle mode	EN 301 511 V12.5.1 Clause 4.2.17 & 4.2.19
1427	ELECTRONICS- EMC TEST FACILITY	Radio Conformance Test for Devices having Cellular Wireless Interface using WCDMA/ HSPA Technology	Radiated spurious emissions - MS allocated a channel	EN 301 511 V12.5.1 Clause 4.2.16 & 4.2.18
1428	ELECTRONICS- EMC TEST FACILITY	Radio Conformance Test for Devices having Cellular Wireless Interface using WCDMA/ HSPA Technology	Receiver adjacent channel selectivity (ACS)	3GPP TS 34.121-1 July 2019 Clause 6.4 EN 301 908-2 V11.1.2 (2017-08) Clause 4.2.6
1429	ELECTRONICS- EMC TEST FACILITY	Radio Conformance Test for Devices having Cellular Wireless Interface using WCDMA/ HSPA Technology	Receiver In-band blocking	3GPP TS 34.121-1 July 2019 Clause 6.5.2.1 EN 301 908-2 V11.1.2 (2017-08) Clause 4.2.7
1430	ELECTRONICS- EMC TEST FACILITY	Radio Conformance Test for Devices having Cellular Wireless Interface using WCDMA/ HSPA Technology	Receiver intermodulation characteristics	EN 301 908-2 V11.1.2 Clause 4.2.9
1431	ELECTRONICS- EMC TEST FACILITY	Radio Conformance Test for Devices having Cellular Wireless Interface using WCDMA/ HSPA Technology	Receiver Reference sensitivity level	3GPP TS 34.121-1 July 2019 Clause 6.2 EN 301 908-2 V11.1.2 (2017-08) Clause 4.2.13
1432	ELECTRONICS- EMC TEST FACILITY	Radio Conformance Test for Devices having Cellular Wireless Interface using WCDMA/ HSPA Technology	Receiver spurious emission	3GPP TS 34.121-1 July 2019 Clause 6.8 EN 301 908-2 V11.1.2 (2017-08) Clause 4.2.10
1433	ELECTRONICS- EMC TEST FACILITY	Radio Conformance Test for Devices having Cellular Wireless Interface using WCDMA/ HSPA Technology	Transmitter adjacent channel leakage power ratio	EN 301 908-2 V11.1.2 Clause 4.2.12

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1434	ELECTRONICS- EMC TEST FACILITY	Radio Conformance Test for Devices having Cellular Wireless Interface using WCDMA/ HSPA Technology	Transmitter Maximum output power	3GPP TS 34.121-1 July 2019 Clause 5.2 EN 301 908-2 V11.1.2 (2017-08) Clause 4.2.2
1435	ELECTRONICS- EMC TEST FACILITY	Radio Conformance Test for Devices having Cellular Wireless Interface using WCDMA/ HSPA Technology	Transmitter Minimum Output Power	3GPP TS 34.121-1 July 2019 Clause 5.4.3 EN 301 908-2 V11.1.2 (2017-08) Clause 4.2.5
1436	ELECTRONICS- EMC TEST FACILITY	Radio Conformance Test for Devices having Cellular Wireless Interface using WCDMA/ HSPA Technology	Transmitter spectrum emission mask	3GPP TS 34.121-1 July 2019 Clause 5.9 EN 301 908-2 V11.1.2 (2017-08) Clause 4.2.3
1437	ELECTRONICS- EMC TEST FACILITY	Radio Conformance Test for Devices having Cellular Wireless Interface using WCDMA/ HSPA Technology	Transmitter spurious emissions	3GPP TS 34.121-1 July 2019 Clause 5.11 EN 301 908-2 V11.1.2 (2017-08) Clause 4.2.4
1438	ELECTRONICS- EMC TEST FACILITY	Short Range Devices & Inductive loop systems in the range 9 kHz to 25 MHz	Modulation bandwidth	ETSI EN 300 330 V2.1.1 Clause 4.3.3
1439	ELECTRONICS- EMC TEST FACILITY	Short Range Devices & Inductive loop systems in the range 9 kHz to 25 MHz	Operating frequency ranges	ETSI EN 300 330 V2.1.1 Clause 4.3.2
1440	ELECTRONICS- EMC TEST FACILITY	Short Range Devices & Inductive loop systems in the range 9 kHz to 25 MHz	Permitted range of operating frequencies	ETSI EN 300 330 V2.1.1 Clause 4.3.1
1441	ELECTRONICS- EMC TEST FACILITY	Short Range Devices & Inductive loop systems in the range 9 kHz to 25 MHz	Receiver spurious emissions	ETSI EN 300 330 V2.1.1 Clause 4.4.2
1442	ELECTRONICS- EMC TEST FACILITY	Short Range Devices & Inductive loop systems in the range 9 kHz to 25 MHz	Transmitter radiated spurious domain emission limits	ETSI EN 300 330 V2.1.1 Clause 4.3.8
1443	ELECTRONICS- EMC TEST FACILITY	Short Range Devices & Inductive loop systems in the range 9 kHz to 25 MHz	Transmitter radiated spurious domain emission limits > 30 MHz	ETSI EN 300 330 V2.1.1 Clause 4.3.9
1444	ELECTRONICS- EMC TEST FACILITY	Short Range devices in the Range 1GHz to 40GHz	Blocking or desensitization	ETSI EN 300 440 V2.1.1 Clause 4.3.4
1445	ELECTRONICS- EMC TEST FACILITY	Short Range devices in the Range 1GHz to 40GHz	E.I.R.P	ETSI EN 300 440 V2.1.1 Clause 4.2.2
1446	ELECTRONICS- EMC TEST FACILITY	Short Range devices in the Range 1GHz to 40GHz	Permitted range of operating frequencies	ETSI EN 300 440 V2.1.1 Clause 4.2.3
1447	ELECTRONICS- EMC TEST FACILITY	Short Range devices in the Range 1GHz to 40GHz	Spurious radiation	ETSI EN 300 440 V2.1.1 Clause 4.3.5
1448	ELECTRONICS- EMC TEST FACILITY	Short Range devices in the Range 1GHz to 40GHz	Unwanted emissions in the spurious domain	ETSI EN 300 440 V2.1.1 Clause 4.2.4
1449	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	Operating frequency	ETSI EN 300 220-2 V3.1.1 (2017-02) Clause 4.2.1 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.1

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1450	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	Operating frequency	ETSI EN 300 220-2 V3.2.1 (2018-06) Clause 4.2.1 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.1
1451	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	Rx Blocking	ETSI EN 300 220-2 V3.1.1 (2017-02) Clause 4.4.2 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.18
1452	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	Rx Blocking	ETSI EN 300 220-2 V3.2.1 (2018-06) Clause 4.4.2 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.18
1453	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	Rx Sensitivity	ETSI EN 300 220-2 V3.1.1 (2017-02) Clause 4.4.1 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.14
1454	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	Rx Sensitivity	ETSI EN 300 220-2 V3.2.1 (2018-06) Clause 4.4.1 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.14
1455	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	TX Adjacent channel power	ETSI EN 300 220-2 V3.1.1 (2017-02) Clause 4.3.7 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.11
1456	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	TX Adjacent channel power	ETSI EN 300 220-2 V3.2.1 (2018-06) Clause 4.3.7 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.11
1457	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	TX behavior under low voltage conditions	ETSI EN 300 220-2 V3.1.1 (2017-02) Clause 4.3.8 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.12
1458	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	TX behavior under low voltage conditions	ETSI EN 300 220-2 V3.2.1 (2018-06) Clause 4.3.8 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.12
1459	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	TX effective radiated power	ETSI EN 300 220-2 V3.1.1 (2017-02) Clause 4.3.1 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.2
1460	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	TX effective radiated power	ETSI EN 300 220-2 V3.2.1 (2018-06) Clause 4.3.1 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.2

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1461	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	TX Maximum e.r.p. spectral density	ETSI EN 300 220-2 V3.1.1 (2017-02) Clause 4.3.2 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.3
1462	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	TX Maximum e.r.p. spectral density	ETSI EN 300 220-2 V3.2.1 (2018-06) Clause 4.3.2 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.3
1463	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	TX Occupied bandwidth	ETSI EN 300 220-2 V3.1.1 (2017-02) Clause 4.3.4 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.6
1464	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	TX Occupied bandwidth	ETSI EN 300 220-2 V3.2.1 (2018-06) Clause 4.3.4 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.6
1465	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	TX out of band emissions	ETSI EN 300 220-2 V3.1.1 (2017-02) Clause 4.3.5 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.8
1466	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	TX out of band emissions	ETSI EN 300 220-2 V3.2.1 (2018-06) Clause 4.3.5 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.8
1467	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	TX Transient	ETSI EN 300 220-2 V3.1.1 (2017-02) Clause 4.3.6 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.10
1468	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	TX Transient	ETSI EN 300 220-2 V3.2.1 (2018-06) Clause 4.3.6 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.10
1469	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	Unwanted emissions in the spurious domain	ETSI EN 300 220-2 V3.1.1 (2017-02) Clause 4.2.2 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.9
1470	ELECTRONICS- EMC TEST FACILITY	Short Range Devices in the range 25 MHz to 1 GHz	Unwanted emissions in the spurious domain	ETSI EN 300 220-2 V3.2.1 (2018-06) Clause 4.2.2 ETSI EN 300 220-1 V3.1.1 (2017-02) Clause 5.9
1471	ELECTRONICS- EMC TEST FACILITY	Unlicensed National Information Infrastructure Devices	6 dB Bandwidth & 99% Occupied Channel bandwidth	FCC Part 15 Subpart E: Dec 2020 Clause 15.407(a) FCC 2.1049

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1472	ELECTRONICS- EMC TEST FACILITY	Unlicensed National Information Infrastructure Devices	Band Edge Compliance (Emissions in the Non-Restricted Frequency Band) and conducted spurious emission	FCC Part 15 Subpart E :Dec 2020 Clause 15.407(b)
1473	ELECTRONICS- EMC TEST FACILITY	Unlicensed National Information Infrastructure Devices	Dynamic Frequency Selection	FCC Part 15 Subpart E Dec 2020 Clause 15.407(h)
1474	ELECTRONICS- EMC TEST FACILITY	Unlicensed National Information Infrastructure Devices	Dynamic Frequency Selection	RSS 247 Issue 2 Clause 6.3
1475	ELECTRONICS- EMC TEST FACILITY	Unlicensed National Information Infrastructure Devices	Emission Bandwidth (X dB bandwidth)	FCC Part 15 Subpart E : Dec 2020 Clause 15.407(a)
1476	ELECTRONICS- EMC TEST FACILITY	Unlicensed National Information Infrastructure Devices	Emission Bandwidth (X dB bandwidth)	RSS Gen Issue 5 Clause 6.7
1477	ELECTRONICS- EMC TEST FACILITY	Unlicensed National Information Infrastructure Devices	Maximum conducted output power	FCC Part 15 Subpart E : Dec 2020 Clause 15.407(a)
1478	ELECTRONICS- EMC TEST FACILITY	Unlicensed National Information Infrastructure Devices	Maximum power spectral density	FCC Part 15 Subpart E : Dec 2020 Clause 15.407(a)
1479	ELECTRONICS- EMC TEST FACILITY	Unlicensed National Information Infrastructure Devices	Unwanted Emission/radiated spurious emissions and Emissions in restricted bands of operations	FCC Part 15 Subpart E Dec 2020 Clause 15.407(b), 15.209, 15.205
1480	ELECTRONICS- EMC TEST FACILITY	Wireless Hand held & Body worn electronic equipment, Wireless equipment held close proximity to human body	Low power SAR exemptions	EN 50360
1481	ELECTRONICS- EMC TEST FACILITY	Wireless Hand held & Body worn electronic equipment, Wireless equipment held close proximity to human body	Low power SAR exemptions	EN 62479
1482	ELECTRONICS- EMC TEST FACILITY	Wireless Hand held & Body worn electronic equipment, Wireless equipment held close proximity to human body	Low power SAR exemptions	IEC 62479, (Edition 1.0)
1483	ELECTRONICS- EMC TEST FACILITY	Wireless Hand held & Body worn electronic equipment, Wireless equipment held close proximity to human body	MPE (Maximum Permissible Emission	IEC 62311, (Edition 2.0)
1484	ELECTRONICS- EMC TEST FACILITY	Wireless Hand held & Body worn electronic equipment, Wireless equipment held close proximity to human body	MPE (Maximum Permissible Emission)	IEC 62311, (Edition 1.0)
1485	ELECTRONICS- EMC TEST FACILITY	Wireless Hand held & Body worn electronic equipment, Wireless equipment held close proximity to human body	MPE (Maximum Permissible Emission)	KDB-447498 DO 01
1486	ELECTRONICS- EMC TEST FACILITY	Wireless Hand held & Body worn electronic equipment, Wireless equipment held close proximity to human body	SAR – Wireless Devices used in close proximity to Head	EN 62209-1: (Edition 2.0)
1487	ELECTRONICS- EMC TEST FACILITY	Wireless Hand held & Body worn electronic equipment, Wireless equipment held close proximity to human body	SAR – Wireless Devices used in close proximity to Head	IEC 62209-1 (Edition 2.0)
1488	ELECTRONICS- EMC TEST FACILITY	Wireless Hand held & Body worn electronic equipment, Wireless equipment held close proximity to human body	SAR – Wireless Devices used in close proximity to Head	IEEE Std. 1528

SCOPE OF ACCREDITATION

Laboratory Name :	UL INDIA LAB, UL INDIA PRIVATE LIMITED, LABORATORY BUILDING, KALYANI PLATINA CAMPUS, SY.NO.129/4, EPIP ZONE, PHASE II, WHITEFIELD, BENGALURU URBAN, BENGALURU, KARNATAKA, INDIA		
Accreditation Standard	ISO/IEC 17025:2017		
Certificate Number	TC-6168	**Page No**	271 of 272
Validity	05/08/2021 to 04/08/2023	**Last Amended on**	13/01/2023

S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
1489	ELECTRONICS- EMC TEST FACILITY	Wireless Hand held & Body worn electronic equipment, Wireless equipment held close proximity to human body	SAR – Wireless Devices used in close proximity to Head	TEC/GR/SAR/001/01.MAR.09
1490	ELECTRONICS- EMC TEST FACILITY	Wireless Hand held & Body worn electronic equipment, Wireless equipment held close proximity to human body	SAR – Wireless Devices used in close proximity to Human Body	EN 50360
1491	ELECTRONICS- EMC TEST FACILITY	Wireless Hand held & Body worn electronic equipment, Wireless equipment held close proximity to human body	SAR – Wireless Devices used in close proximity to Human Body	EN 50566
1492	ELECTRONICS- EMC TEST FACILITY	Wireless Hand held & Body worn electronic equipment, Wireless equipment held close proximity to human body	SAR – Wireless Devices used in close proximity to Human Body	EN 62209-2
1493	ELECTRONICS- EMC TEST FACILITY	Wireless Hand held & Body worn electronic equipment, Wireless equipment held close proximity to human body	SAR – Wireless Devices used in close proximity to Human Body	EN 62479
1494	ELECTRONICS- EMC TEST FACILITY	Wireless Hand held & Body worn electronic equipment, Wireless equipment held close proximity to human body	SAR – Wireless Devices used in close proximity to Human Body	IEC 62209-2 (Edition 1.1) /AMD1
1495	ELECTRONICS- EMC TEST FACILITY	Wireless Hand held & Body worn electronic equipment, Wireless equipment held close proximity to human body	SAR – Wireless Devices used in close proximity to Human Body	IEC 62209-2: (Edition 1.0)
1496	ELECTRONICS- EMC TEST FACILITY	Wireless Hand held & Body worn electronic equipment, Wireless equipment held close proximity to human body	SAR – Wireless Devices used in close proximity to Human Body	TEC/GR/RS/SAR-002/01/JUL 17

SCOPE OF ACCREDITATION

Laboratory Name :	UL INDIA LAB, UL INDIA PRIVATE LIMITED, LABORATORY BUILDING, KALYANI PLATINA CAMPUS, SY.NO.129/4, EPIP ZONE, PHASE II, WHITEFIELD, BENGALURU URBAN, BENGALURU, KARNATAKA, INDIA
Accreditation Standard	ISO/IEC 17025:2017
Certificate Number	TC-6168
Validity	05/08/2021 to 04/08/2023

Last Amended on 13/01/2023

S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
LOCATION 3 - 30/A, I STAGE VISHVESHWARYA INDUSTRIAL ESTATE, DODDANEKKUNDI INDUSTRIAL AREA, BENGALURU URBAN, BENGALURU, KARNATAKA, INDIA Mobile Facility				
1	ELECTRONICS- EMC TEST FACILITY	EMI-EMC Testing : Electrical and Electronic Instrument	Power Frequency Magnetic Field Immunity Test	EN 50121-4